5045A DIGITAL IC TESTER

OPERATING AND SERVICE MANUAL

SERIAL PREFIX: 1932A

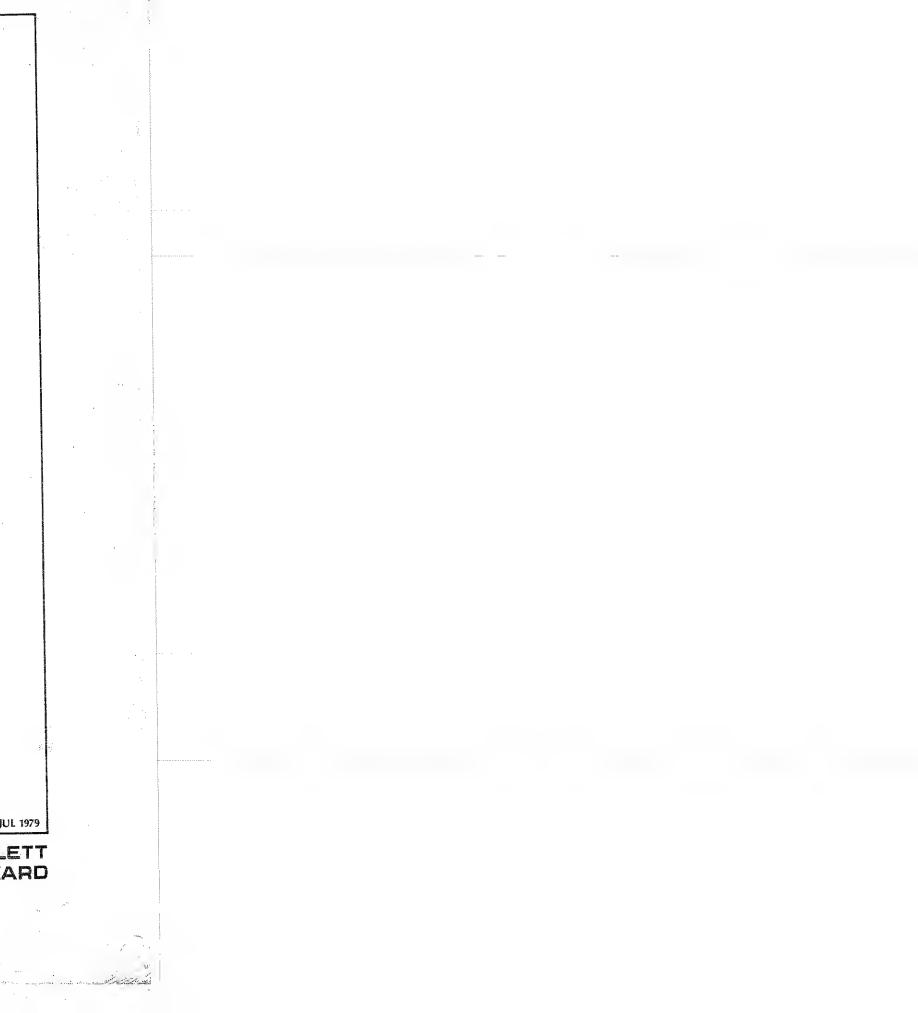
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Hewlett-Packard Company certifies that this instrument met its published specifications at the time of shipment from the factory. Hewlett-Packard Company further certifies that its calibration measurements are traceable to the United States National Bureau of Standards, to the extent allowed by the Bureau's calibration facility, and to the calibration facilities of other International Standards Organization members.

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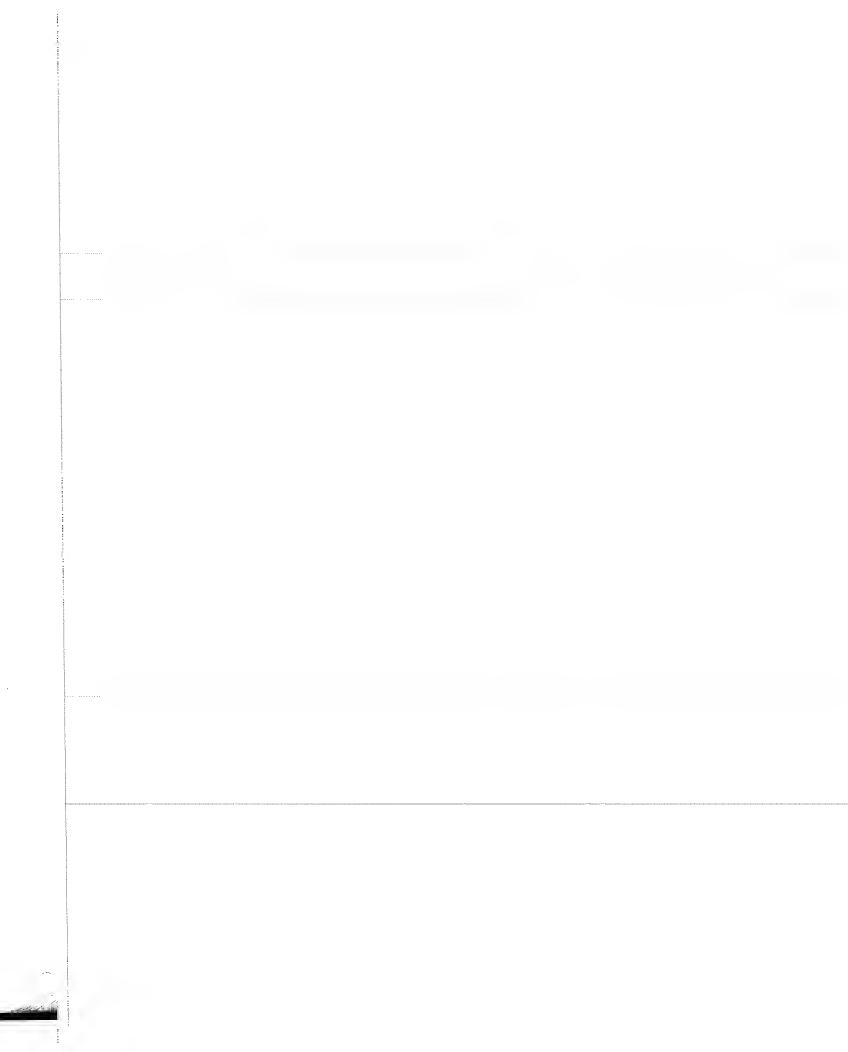


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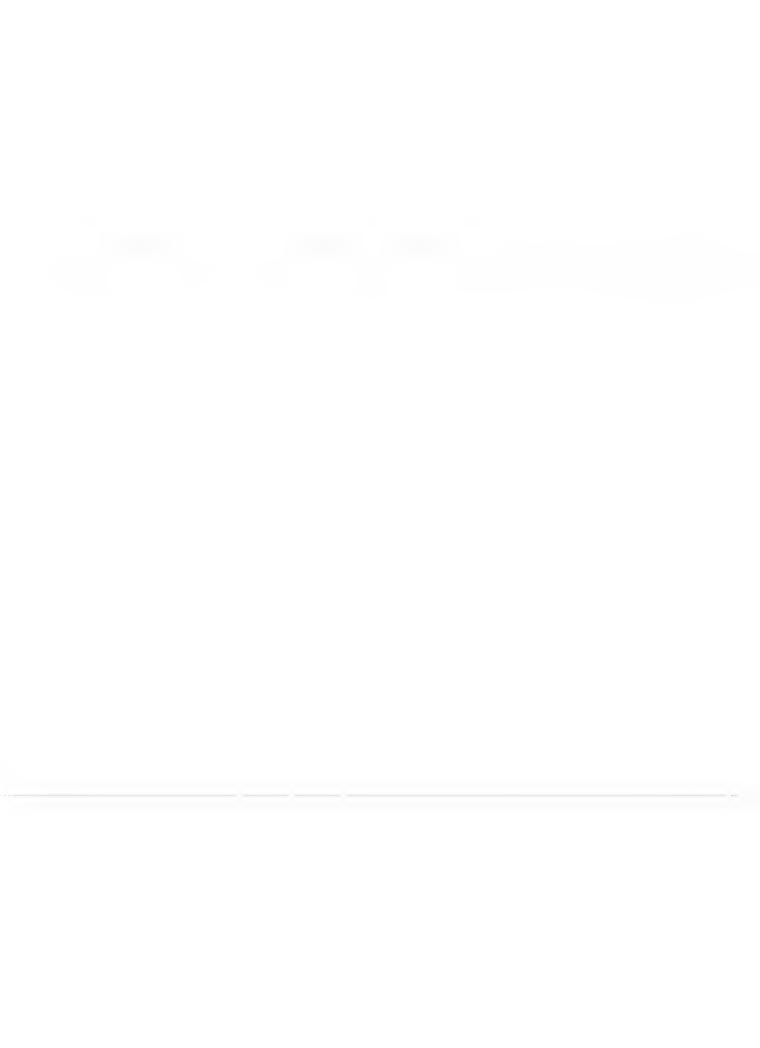


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SAFETY CONSIDERATIONS

GENERAL

This is a Safety Class I instrument. This instrument has been designed and tested according to IEC Publication 348, "Safety Requirements for Electronic Measuring Apparatus".

OPERATION

BEFORE APPLYING POWER verify that the power transformer primary is matched to the available line voltage and the correct fuse is installed (see Section II, Paragraph 2–6). Make sure that only fuses with the required rated current and of the specified type (normal blow, time delay, etc.) are used for replacement. The use of repaired fuses and the short-circuiting of fuseholders must be avoided.

SERVICE

Although this instrument has been designed in accordance with international safety standards, this manual contains information, cautions, and warnings which must be followed to ensure safe operation and to retain the instrument in safe condition. Service and adjustments should be performed only by qualified service personnel.

Any adjustment, maintenance, and repair of the opened instrument under voltage should be avoided as much as possible and, when inevitable, should be carried out only by a skilled person who is aware of the hazard involved.

Capacitors inside the instrument may still be charged even if the instrument has been disconnected from its source of supply.

Whenever it is likely that the protection has been impaired, the instrument must be made inoperative and be secured against any unintended operation.

CAUTION

Do not turn on the instrument if the pin drivers (A13 thru A24) are installed and A10, 11, 12 (any one) are removed. Damage to the pin drivers may result.

Model 5045A Safety Considerations

WARNING

IF THIS INSTRUMENT IS TO BE ENERGIZED VIA AN AUTO-TRANSFORMER (FOR VOLTAGE REDUCTION) MAKE SURE THE COMMON TERMINAL IS CONNECTED TO THE EARTHED POLE OF THE POWER SOURCE.

WARNING

BEFORE SWITCHING ON THE INSTRUMENT, THE PROTECTIVE EARTH TERMINALS OF THE INSTRUMENT MUST BE CONNECTED TO THE PROTECTIVE CONDUCTOR OF THE (MAINS) POWER CORD. THE MAINS PLUG SHALL ONLY BE INSERTED IN A SOCKET OUTLET PROVIDED WITH A PROTECTIVE EARTH CONTACT. THE PROTECTIVE ACTION MUST NOT BE NEGATED BY THE USE OF AN EXTENSION CORD (POWER CABLE) WITHOUT A PROTECTIVE CONDUCTOR (GROUNDING).

WARNING

THE SERVICE INFORMATION FOUND IN THIS MANUAL IS OFTEN USED WITH POWER SUPPLIED AND PROTECTIVE COVERS REMOVED FROM THE INSTRUMENT. ENERGY AVAILABLE AT MANY POINTS MAY, IF CONTACTED, RESULT IN PERSONAL INJURY.

CAUTION

BEFORE SWITCHING ON THIS INSTRUMENT:

- 1. MAKE SURE THE INSTRUMENT IS SET TO THE VOLTAGE OF THE POWER SOURCE.
- 2. ENSURE THAT ALL DEVICES CONNECTED TO THIS INSTRUMENT ARE CONNECTED TO THE PROTECTIVE (EARTH) GROUND.
- 3. ENSURE THAT THE LINE POWER (MAINS) PLUG IS CONNECTED TO A THREE-CONDUCTOR LINE POWER OUTLET THAT HAS A PROTECTIVE (EARTH) GROUND. (GROUNDING ONE CONDUCTOR OF A TWO-CONDUCTOR OUTLET IS NOT SUFFICIENT.)
- 4. MAKE SURE THAT ONLY FUSES WITH THE REQUIRED RATED CURRENT AND OF THE SPECIFIED TYPE (NORMAL BLOW, TIME DELAY, ETC.) ARE USED FOR REPLACEMENT. THE USE OF REPAIRED FUSES AND THE SHORT-CIRCUITING OF FUSE HOLDERS MUST BE AVOIDED.

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1-0

Model 5045A General Information

SECTION I GENERAL INFORMATION

1-1. INTRODUCTION

- 1-2. This manual provides operating and service information for the Hewlett-Packard Model 5045A Digital IC Tester. A separate User's Manual also accompanies the instrument to provide a more detailed description of the unit's operating characteristics.
- 1-3. This manual is divided into eight sections containing the following information:

SECTION I GENERAL INFORMATION covers a description of the tester, options, equipment supplied, accessories available, specifications, and recommended test equipment.

SECTION II INSTALLATION provides instructions for unpacking, inspection, preparation for use, shipment, and storage for the tester. Also covered is the power requirements for the tester.

SECTION III OPERATION covers the basic tester operating features. Describes functions of front-panel controls, programming the tester, printout data, and operator maintenance.

SECTION IV PERFORMANCE TESTS includes a list of recommended test equipment, an in-cabinet performance test and an operational verification test using magnetic cards.

SECTION V ADJUSTMENTS covers the adjustment procedure.

SECTION VI REPLACEABLE PARTS provide a complete list of the tester's replaceable parts and information for ordering parts.

SECTION VII MANUAL CHANGES provide information necessary to backdate the manual to cover earlier instruments.

SECTION VIII SERVICE contains block level theory of operation, schematic diagrams, and component locators.

1-4. DESCRIPTION

1-5. The 5045A DIGITAL IC TESTER performs complete truth table testing on digital IC's contained in standard package form. The unit is compatible with TTL, ECL, CMOS, DTL, RTL, HTL, and associated logic families and is programmed by magnetic cards which contain all test conditions, including test pattern and logic simulation information. Other features include a built-in digital recorder for retrieving failure data, the ability of the tester to "learn" a ROM's output for later transfer to a magnetic card, and the ability to interface with a high-speed handler.

1-6. APPLICATIONS

1-7. Probably the most common type of application for the IC Tester is in-coming inspection of purchased IC's. These parts can be tested manually by hand loading or with the use of a high-speed, automatic handler when large quantities of IC's are involved.

1-1

1-8. INSTRUMENT IDENTIFICATION

1–9. Hewlett-Packard instruments have a 2-section, 10-character serial number (0000A00000), which is located on the rear panel. The 4-digit serial prefix identifies instrument changes. If the serial prefix of your instrument differs from that listed on the title page of this manual, there are differences between this manual and your instrument. Instruments having higher serial prefixes are covered with a "Manual Changes" sheet included with this manual. If the change sheet is missing, contact the nearest Hewlett-Packard Sales and Service Office listed at the back of this manual. Instruments having a lower serial prefix than that listed on the title page, are covered in the Manual Changes Section VII.

1-10. EQUIPMENT SUPPLIED

1-11. Table 1-1 lists equipment supplied.

Table 1-1. Equipment Supplied

Description	HP Part Number
Detachable Power Cord 71/2 feet (231 cm) long	8120-1378
Head Cleaner Card for Magnetic Card Reader	8660-0463
Resistor Pack (R-Pack) Board	05045-60042
Diagnostic Card Kit	See paragraph 1-14
Dummy IC, 16-pin	05045-80019
Dummy IC, 24-pin (Option 024)	05045-80020
5045A User Manual	05045-90020
Monostable Multivibrator Adapter (20-pin)	05045-60041

1-12. Diagnostic Card Kit, 05045-60120

- 1-13. The diagnostic kit consists of the following three sets of magnetic cards:
 - a. A11 Adjustment Check Program Cards
 - DAC REF Check
 - 2. +/-V Zero Adjust
 - 3. DAC V Gain Adjust
 - 4. Current Gen Preset Adjust
 - 5. +/-I Zero 1-2 Adjust
 - b. Operational Verification Test Program Cards

R-Pack Test Cards:

- 1. V/I R-Pack 16-Pin
- 2. V/I R-Pack 24-Pin
- 3. R-Pack C-Current Modes 16-Pin
- 4. R-Rack C Current Modes 24-Pin
- 5. R-Pack Fail Detect Check 16-Pin
- 6. R-Pack Fail Detect Check 24-Pin

Self-Check Cards:

- 7. Self Check 1 16-Pin
- 8. Self Check 1 24-Pin
- 9. Self Check 2 16-Pin
- 10. Self Check 2 24-Pin
- 11. Self Check 3 16-Pin
- 12. Self Check 3 24-Pin

Model 5045A General Information

- c. Performance Test Program Cards
 - 1. DAC Adjust Check
 - 2. Analog Voltage Check Part 1
 - 3. Analog Voltage Check Part 2
 - 4. Analog Current Check Low Range
 - 5. Analog Current Check 200 mA Range
 - 6. Pin Driver C-Current Modes 1-8
 - 7. Pin Driver C-Current Modes 9-16
 - 8. Pin Driver C-Current Modes 17-24
 - 9. Cross Talk Part 1
 - 10. Cross Talk Part 2
 - 11. V/I Results Voltage Check 16-Pin
 - 12. V/I Results Voltage Check 24-Pin
 - 13. V/I Results Current Check 16-Pin
 - 14. V/I Results Current Check 24-Pin
 - 15. V/I Offset Check 16-Pin
 - 16. V/I Offset Check 24-Pin
 - 17. Relay Check 16-Pin
 - 18. Relay Check 24-Pin
 - 19. Op Code Check
 - 20. Pos Fast Edge Check
 - 21. Neg Fast Edge Check
 - 22. Printer Check

1-14. ACCESSORIES AVAILABLE

1-15. Operating Accessories

- 1-16. The 5045A is programmed by prerecorded magnetic cards that are available as accessories. Each card that covers a common type IC is listed in the IC Program Catalog, Part No. 5952-7383. Cards not listed in the program catalog may be programmed at the factory. Contact the factory through your local HP Sales and Service Office (listed at the back of this manual) regarding price and delivery.
- 1-17. Any card listed in the IC Program Catalog may be ordered directly from the factory by prepaid coupon. When the coupon is received, the order is filled and returned by airmail. The coupons are ordered in books of ten by Model No. 10846A.
- 1-18. Other accessories available are:

		- 41
4	Blank magnetic cards (Pass/Fail)	 P/N 9164-0071
1.	Didir Hagiscuc Cards (1 dss/ 1 di)	

- 2. Blank Magnetic Cards (Diagnostic) P/N 9164-0072
- 3. 250 foot roll of thermal paper (minimum order of six rolls) P/N 9281-0401
- 4. Coupon book containing ten coupons each redeemable in one preprogrammed magnetic card which is listed in the IC PROGRAM CATALOG. The coupons are mailed directly to the factory and the appropriate program card is returned by mail. The coupons expire two years from the date of receipt... Order No. 10846A

1-3

1-19. SERVICE ACCESSORY

1-20. A special Extender Board, part no. 05045-60100 is available for troubleshooting the 5045A. This board plugs into a 44-pin connector in place of a PC board to allow the PC board to be extended for access.

1-21. COMPLEMENTARY EQUIPMENT

1-22. The 5045A is designed to allow high volume testing using automatic IC handlers. The optional interface equipment used to interface the tester to popular makes of automatic handlers is described in paragraph 1-25. The special circuits used to generate the fast rise and fall times necessary in testing digital circuits are contained in the tester's removable test head. This allows the test head to be placed within inches of the IC under test and eliminates ringing, oscillation, and slow rise/fall times problems created by long cables between tester and handler.

1-23. SPECIFICATIONS

1-24. Specifications for the 5045A are listed in Table 1-2.

1-25. OPTIONS

- 1-26. Several options are available for the 5045A as listed below.
 - a. Option 004 International Production Technology (IPT) Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and cable to extend the test head. A cable to interface the control signals between the 5045A and the IPT automatic handler is also included. For more information and documentation obtain Installation Note K04-59994A.
 - b. Option 005 Symtek Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Symtek automatic handler is also included. For more information and documentation obtain Installation Note K05-59994A.
 - c. Option 006 Daymarc Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Daymarc automatic handler is also included. For more information and documentation obtain Installation Note K06-59994A.
 - d. Option 007 Micro Component Technology Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head. A cable to interface the control and indication signals between the 5045A and the Micro Component Technology automatic handlers is also included. For more information and documentation obtain Installation Note K07-59994A.
- e. Option 008 Delta Design, Inc. Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head. A cable to interface the control and indication signals between the 5045A and the Delta Design automatic handler is also included. For more information and documentation obtain Installation Note K08-59994A.
- f. Option 009 Contrel Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A connector to allow the control and indication signals from the 5045A to be interfaced with the Control automatic handler is also included. For more information and documentation obtain Installation Note K03-59994A.

Model 5045A General Information

Accuracy

±0.4 mA or ±6%**

Table 1-2. Specifications

TEST SET-UP METHOD:

Preprogrammed magnetic card. All test conditions including parametric information, input stimuli, and corresponding outputs are contained on the card. The program is verified each time it is loaded.

LOGIC FAMILY COMPATIBILITY:

Compatible with ECL, CMOS, TTL, DTL, HTL, RTL and the associated sub-families. See the IC Program Catalog for available programs.

LOGIC FUNCTION COMPATIBILITY:

Gates, flip-flops, monostable multivibrators, counters, shift registers, priority encoders, Schmitt triggers, parity generators/ checkers, decoders/encoders, optical isolators, dual-in-line reed relays, adders, arithmetic logic units, ROM's, PROM's, static RAM's, and many more*.

DUAL TEST FOR EACH IC:

Two test programs (Pass/Fail and Diagnostic) are supplied in the test package for each circuit. Each test is on a separate card. The Pass/Fail and Diagnostic programs are tailored to the testing requirements of the individual Logic Family.

TEST STRUCTURE:

Functional Tests-Truth table is verified by direct comparison between the output of a software generated IC simulator (or stored truth table for certain circuits) and the output of the device under test.

Parametric Tests-All DC parameters (voltages and currents) are tested to the manufacturers' data sheet specifications except where limited by the specifications of the Tester. Test limits are indicated in the information accompanying each magnetic

Continuity Test-Verifies pin contact by checking for the presence of current flow into or out of all active pins (failure of this test is shown on the "CONT" indicator).

TEST PATTERN GENERATION:

Test Patterns are derived through algorithmic techniques or from stored truth tables and are individually tailored to each IC.

PASS/FAIL COUNTER:

Prints the number of passed and failed devices. Count is initiated when the magnetic card is inserted.

UNIVERSAL PIN DRIVERS:

Note: The same circuit is used for driving and monitoring a pin whether that pin is an input, output, power supply, or clock. All voltages and currents can be set individually and uniquely on each pin. External test fixtures are not required.

Voltage applied to the device under test:

. single approach to the delice allaci	
(Supply Voltage, Input Voltage, an	d Output Voltage)
Range	Accuracy
(15 volts)	
$-7.5V \le to < -1.875V$	±25 mV
$-1.875V \le \text{to} \le +1.875V$	±15 mV
$+1.875V < to \le +7.5V$	±25 mV

Current applied to the device under test:

(Supply Current, Input Current, and Output Current) Range Accuracy

-200 mA ≤ to < -2.5 mA	±0.4 mA or ±6%**
-2.5 mA ≤ to ≤ +2.5 mA	±10 μA or ±6%**
+2.5 mA < to ≤ +200 mA	±0.4 mA or ±6%**
Slew Rate: 30 ns/volt	

DIGITAL VOLTMETER/MILLIAMMETER FOR FAILED PINS:

Note: When a failure is encountered (with PRINTER: ON, V and | RESULTS: ON), the printing digital Voltmeter/ Milliammeter records the voltage and current present on the failed pin(s). In addition, the 5045A reduces the driving parameter which caused the failure (voltage for input pins, current for output pins) until the device no longer fails. The second voltage/current pair is also recorded.

Voltage

-7,5V ≤ to < -1.875V	±35 mV
$-1.875V \le to \le + 1.875V$	±15 mV
+1.875V < to ≤ +7.5V	±35 mV
Current	
Range	Ассигасу
- 200 mA ≤ to < -2.5 mA	±0.4 mA or ±6%**
$-2.5 \text{ mA} \le \text{to} \le \pm 2.5 \text{ mA}$	±10 μA or ±6%**

+2.5 mA < to ≤ +200 mA **REAR PANEL OUTPUTS:**

Automatic Handler Interface: 14 pin Amphenol connector provides "End of Test", "Pass", "Fail" and "Fail Continuity" signais and accepts "Start Test". Also available is a +5V line capable of supplying up to 200 mA.

GENERAL:

Power: 100/120/220/240V (+5%, -10%), 48-66 Hz, 345 VA. Dimensions: 19 cm high, 42.5 cm wide, 58 cm deep (7.5 in. x 16.7 in. x 22.8 in.)

Shipping Weight: 39.1 kg (86 lbs.) Net Weight: 27.7 kg (61 lbs) 47. Operating Temperature: 0°C to 50°C

Relative Humidity: 80%

OPTIONS AND ACCESSORIES:

Option 004†: Interface package for IPT Model 800 Automatic

Option 6051: Interface package for Sym-Tek Model 7191ND Automatic IC Handler and other related models

Option 8061: Interface package for Daymarc 952/3 Automatic IC Handler

Option 007†: Interface package for Micro Component Technology Model 2604 and 2608 Automatic IC Handler.

Option 008: Interface package for Delta Model 8040 Ambient Naked DIP Handler.

Option 009: Interface package for Contrel Model H310 Automatic IC Handler.

Option 010: Interface package for PAE Model 3033 HR/LP Naked

Option 013: Interface package for Trigon T2000 Series Multisize Ambient Test Handler.

Option 024: Expands the capability of the 5045A to 24 pins

Option 025: Flat-Pack adapter for 14, 16, and 24-pin IC

Option 908: Rack flange kit ,

Option 910: Set of additional product manuals 9164-0071 Blank magnetic program card (Pass/Fail) 9164-0072 Blank magnetic program card (Diagnostic)

9281-0401 250 foot roll of thermal print paper. (minimum order six rolls)

10845A Preprogrammed magnetic card for any device fisted in the IC PROGRAM CATALOG. The specific cards required are designated on the program card order sheet.

10846A Coupon book containing ten coupons each redeemable In one preprogrammed magnetic card which is listed in the IC PROGRAM CATALOG. The coupons are mailed directly to the factory and the appropriate program card is returned by mail. The coupons expire two years from the date of receipt.

1-5

^{*} Some circuits require the optional 24 pin capability.

^{**}Whichever is greater

[†] All interface packages include a test head extender cable, an interface board unique to the particular handler, and a cable to supply the control signals to the handler. This enables the test head electronics to be mounted within inches of the device under test.

- g. Option 010 Precision Automated Equipment Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Precision automatic handler is also included. For more information and documentation obtain Installation Note K15-59994A.
- h. Option 013 Trigon Interface. This provides a printed-circuit board to replace the standard socket assembly board on the test head and a cable to extend the test head. A cable to interface the control and indication signals between the 5045A and the Trigon automatic handler is also included. For more information obtain Installation Note K14-59994A.
- i. Option 024 24-Pin Test Capability. This provides the required circuits to test 24-pin integrated circuits.
- j. Option 025 Flat-Pack Adapter. This provides connector adapters for testing flat package integrated circuits.
- k. **Option 908** Rack Flange Kit Part No. 5060-8741. This provides the required hardware to rack mount the 5045A IC Tester.
- I. Option 910. This provides an extra set of product manuals.
- m. **K19-59994A.** Teledyne TAC Interface. This provides a cable to extended the test head. The test head is then connected to the handler. A cable to interface the control signals between the 5045A and the Teledyne automatic handler is also included. For more information and documentation obtain Installation Note K19-59994A.

1-27. RECOMMENDED TEST EQUIPMENT

1-28. Test equipment recommended for testing, calibration, and repair of the 5045A is listed in Table 1-3.

Table 1-3. Recommended Test Equipment

Instrument Required Characteristics		Recommended Type
Oscilloscope	50 MHz	HP 1707B
Vertical	50 mV/div Sens >5 ns rise time	HP 1707B
Horizontal	10 ns/div bandwidth	HP 1707B
Logic State Analyzer	8 MHz, 12 channel	HP 1601L
TTL Trigger Probe	8 MHz, 4 channel w/inverting inputs	HP 10250A
TTL Logic Probe	Bad Level Detect, 10 MHz bandwidth, 10 ns pulse detect	HP 545A
TTL Logic Pulser	1 μs pulse width TTL levels	HP 546A
Voltmeter, Digital DC	±20V, 4-1/2 digit	HP 3465
Ammeter, Digital DC	5 μA -100 ms, .5% accuracy \int	117 3403
Power Supply DC	0-10VDC, 0-1A, current limiting	6214A

SECTION II

2-1. INTRODUCTION

2-2. This section contains information for unpacking, inspection, storage, and installation. Field installation of optional equipment is included.

2-3. UNPACKING AND INSPECTION

2-4. If the shipping carton is damaged, inspect the tester for visible damage (scratches, dents, etc.). If the tester is damaged, notify the carrier and the nearest Hewlett-Packard Sales and 5ervice Office immediately (offices are listed at the back of this manual). Keep the shipping carton and packing material for the carrier's inspection. The Hewlett-Packard 5ales and and 5ervice Office will arrange for repair or replacement of your instrument without waiting for the claim against the carrier to be settled.

2-5. INSTALLATION REQUIREMENTS

CAUTION

BEFORE CONNECTING THE INSTRUMENT TO AC POWER LINES, BE SURE THAT THE VOLTAGE SELECTOR IS PROPERLY POSITION AS DESCRIBED BELOW.

- 2-6. LINE VOLTAGE REQUIREMENT5. The 5045A is equipped with a power module that contains a printed-circuit line voltage selector to select 100, 120, 220, or 240-volt ac operation. Before applying power, the pc selector must be set to the correct position and the correct fuse must be installed as described below.
- 2–7. Power line connections are selected by the position of the plug-in circuit card in the module. When the card is plugged into the module, the only visible markings on the card indicate the line voltage to be used. The correct value of line fuse, with a 250 volt rating, must be installed after the card is inserted. This instrument uses a 3AT fuse (HP Part No. 2110-0003) for 100/120 volt operation; a 1.5AT fuse (HP Part No. 2110-0043) for 220/240 volt operation.
- 2-8. To convert from one line voltage to another, the power cord must be disconnected from the power module before the sliding window covering the fuse and card compartment can be moved to expose the fuse and circuit card.
- 2–9. Pull on the fuse lever to remove the fuse and then pull the card out of the module. The fuse lever must be held to one side to extract and insert the card. Insert the card so the marking that agrees with the line voltage to be used is visible.
- 2-10. Return fuse lever to normal position, insert correct fuse, slide plastic window over the compartment, and connect the power cord to complete the conversion.

2-11. Power Cables

WARNING

TO PROTECT OPERATING AND SERVICING PERSONNEL, THIS INSTRUMENT IS EQUIPPED WITH A THREE-PIN POWER RECEPTACLE. THE CENTER PIN OF THE RECEPTACLE CONNECTS THE INSTRUMENT CHASSIS AND PANELS TO EARTH GROUND WHEN USED WITH A PROPERLY WIRED THREE-CONDUCTOR OUTLET AND POWER CABLE. IMPROPERLY GROUNDED EQUIPMENT CAN RESULT IN HAZARDOUS POTENTIALS BETWEEN EQUIPMENT.

- 2-12. LINE FREQUENCY REQUIREMENTS. The tester operates at line frequencies between 48 Hz and 66 Hz.
- 2-13. THREE-CONDUCTOR POWER CABLE. To protect the operator, the tester uses a grounded three-conductor detachable power cable shown in Figure 2-1. The male connector end is a NEMA type connector, and the female connector end is a C.E.E. type connector that mates with the 5045A rear panel power connector. Connect the power cable to a power source receptacle with a NEMA grounded third conductor. If the line power receptacle is a standard two-pin type instead of the NEMA three-pin receptacle, use a two-to-three pin adaptor (HP Part No. 1251-0048) and connect the green pigtail on the adaptor to ground.

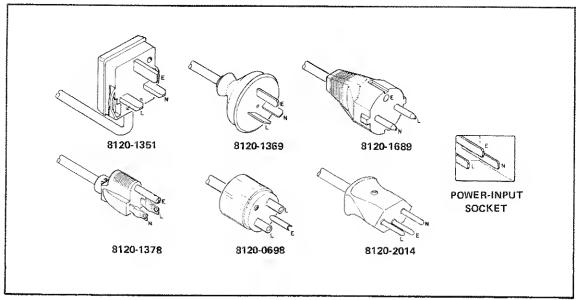


Figure 2-1. Power Cable HP Part Numbers versus Mains Plugs Available

2-14. REPACKING FOR SHIPMENT

2–15. If it becomes necessary to reship the tester, good commercial packing should be used. Contract packaging companies in many cities can provide dependable custom packaging on short notice. Instruments should be packed securely in a strong corrugated container (350 lb./sq. in. bursting test) with suitable filler pads between the instrument and container. The 4-corner support is not adequate, tester must also have center support. Before returning instruments to Hewlett-Packard, contact the nearest Hewlett-Packard Sales and Service Office for instructions.

2-16. ENVIRONMENT DURING STORAGE AND SHIPMENT

2-17. Conditions during storage and shipment should normally be limited as follows:

a. Maximum altitude: 25,000 feet.

b. Minimum temperature: -40°F (-40°C).
 c. Maximum temperature: +167°F (+75°C).

2-18. Installation of 24-Pin Option 024

2-19. To extend the testing capability of the 5045A to IC's with up to 24 pins, install Option 024 as follows:

a. Disconnect power and remove top cover of 5045A.

CAUTION

Pin driver boards are wrapped in anti-static protective bags. These boards are very susceptible to static discharge damage. Remove each board from its bag separately and handle only by the large black heat sink or by the board extractors.

- b. Insert the four-pin driver board (Part No. 05045-60013) into slots A17, A18, A19, and A20.
- c. Perform the Operational Verification Test in Section IV to ensure proper operation.

2-20. Installation and Rack Mount Option 908

2-21. Install the Optional rack mount flange kit, Part No. 5061-0078 per instructions on the label provided with the kit.

2-22. AUTOMATIC HANDLER SIGNALS

2-23. When an automatic handler is to be installed, the interface signals are connected via the 5045A rear panel connector J5. All signals are negative-true logic. Table 2-1 lists the signals at each active pin of connector J5. The name of the signal indicates the condition that occurs at that pin (relative to front panel indicators). Figure 2-2 shows the timing of the signals in reference to the End of Test signal. The signals occur only when the named signal condition exists. The duration of all signals is as shown, within ±5 milliseconds.

2-24. INSTALLATION AND OPERATION OF MONOSTABLE MULTIVIBRATOR ADAPTER A36

2-25. Insert adapter (A36) in the 24-pin test socket on the 5045A standard test head assembly. Follow card loading procedure (see paragraph 3-7) and set the switches on A36 to the ON position as noted in the IC header printout. All other switches must be set in the OFF position. The following printouts are typical for use of the multivibrator adapter.

74123 DIAGNOSTIC USE BOARD 5045-60041 SWITCH ON: ABGHINP 74123 P/F USE WITH HANDLER OR FLATPACKS ---SEE DATA SHEET---

Table 2-1. Automatic Handler Signals

J5 Pin	Signal			
	NOTE			
	Signals are TTL levels (true = $\pm 0.4V \otimes 6$ mA, False $\pm 2.4V$).			
1	Fail Cont			
2	End of Test			
5, 12	+5V @ 100 mA			
6, 13	System Common			
9	Pass			
10	*Start Test			
11	Fail Function			
*The Start T	est signal is sent from the handler. It must have			

*The Start Test signal is sent from the handler. It must have a 5 ms minimum duration and then go False at the time the End of Test signal goes true (true = 0.4V @ 6 mA, False = 2.4V).

Note: the Handler Signal Timing may be verified by executing a procedure outlined in the Performance Test, see Section IV.

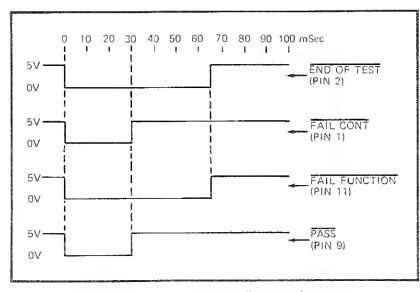


Figure 2-2. Automatic Handler Signal Timing

Model 5045A Operation

SECTION III OPERATION

3-1. INTRODUCTION

3-2. This section contains operating information for the 5045A. This includes a description of the controls and indicators, proper setup for use with an automatic handler, printout data, a self-check procedure, and operator's maintenance. Also see 5045A Users Manual for detailed operating instructions.

3-3. PROGRAM CARDS

3-4. The program cards store all information unique to the testing of a particular IC. The underside of the card contains a coating of magnetic material responsible for storing this information. When using the cards, try not to touch its magnetic coating since the oil film left from your fingers can cause the card to slip as its being pulled through the card reader. Figure 3-1 shows the proper method of holding the card.

NOTE

To prevent accidental "erasure" of the card, keep the card away from electrical motors and other such devices. Do not lay the card on top of the tester.

CAUTION

LAYING THE CARD ON ABRASIVE SURFACES CAN CAUSE PERMANENT DAMAGE TO THE CARD'S MAGNETIC COATING. RETURN THE CARD TO ITS FOLDER AFTER USE.

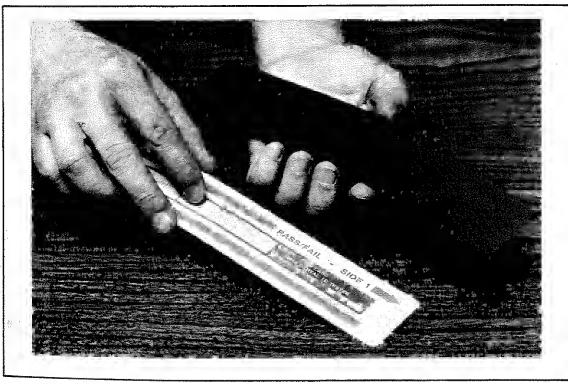


Figure 3-1. Handling the Program Cards

3-5. Two Tests Available

3-6. There are two program cards for each IC. One card contains a PASS/FAIL test while the other card performs a DIAGNOSTIC test. Using the PASS/FAIL test results in faster test times because of the consolidation of tests and the reduced amount of failure data available for printing. Figure 3-2 describes the pertinent information on the cards.

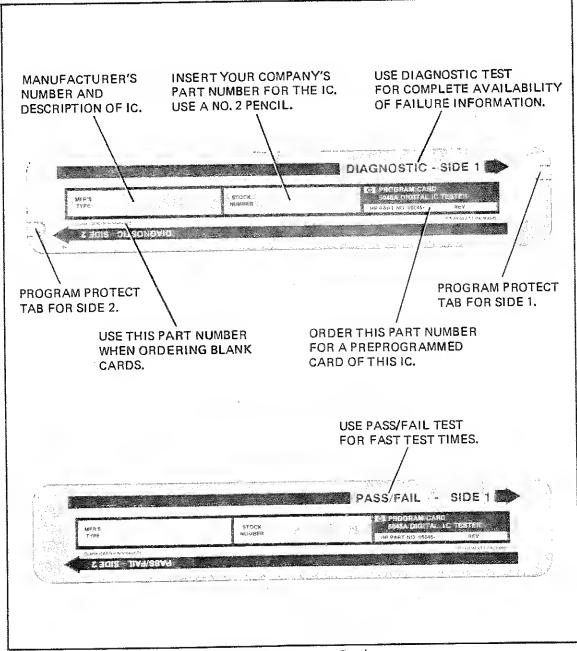


Figure 3-2. Program Cards

3-7. Loading the Card

3-8. Apply power, select one of the test cards, push the LOAD button, and insert side 1 of the card face up into the lower front panel slot. The instrument will automatically route the card into the machine and out the other slot. If the LOAD light stays on, it is an indication that more information is needed. Load side 2 of the magnetic card in the same manner.

Operation

3-9. Verification of Load Operation

3-10. Once the card is loaded, note the printer paper. If the tester accepted the card's information, it will print the manufacture's IC number and the type of test to be performed. If the tester determines that the check sum does not agree with the sum recorded on the card, it will print the word "RELOAD". In this case, push the LOAD button and reload the card.

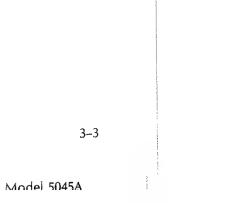
RELOAD

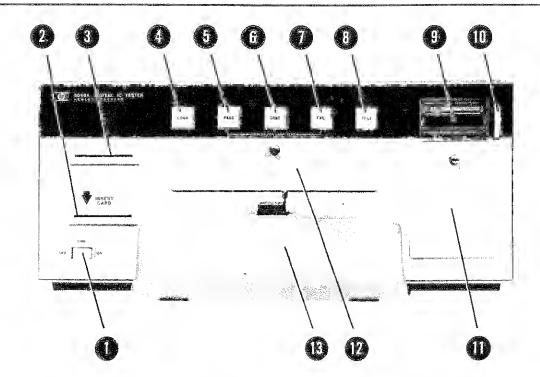
7476 PRSS/FHIL

7476 DIAGNOSTIC

3-11. Program Protect Tabs

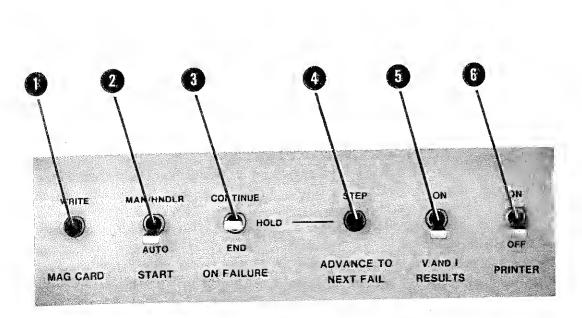
3-12. Each card contains two program protect tabs, located near the arrowheads. Removing either of these tabs prevents the operator from accidentally writing over the existing program. Once the tabs are removed, however, the card cannot be reprogrammed. If the tabs have not been removed, the card can be reprogrammed, but it is highly recommended that the card first be bulk erased.





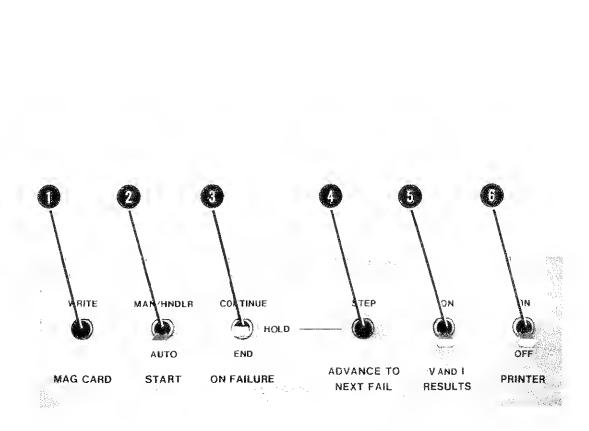
- a. LINE switch . ON position supplies line power to the tester.
- b. Input slot of the card reader. Accepts the magnetic program card when LOAD button is pushed. Enter card with white side up. Check that the arrow on card matches up.
- c. Output slot of the card reader. Magnetic program card exits here as program information is being accessed.
- d. LOAD button . Allows card reader to accept program card.
- e. PASS light lights to indicate the IC passed the tests given it and is considered good.
- f. CONT light lights to indicate the IC has failed the continuity test.
- g. FAIL light flashes red when the IC fails any of its tests.
- h. TEST button . Push to initiate one test sequence on an IC. Used in the manual mode. Lamp lights to indicate that test is in progress. Can be used to terminate a test sequence by pressing while a test is in progress.
- i. Paper Deflector/Cutoff Bar a guides paper out of thermal printer. Knife edge on plastic bar allows paper to tear off cleanly.
- j. Paper Advance knob . Manually rotating the knob downward advances the paper past the print head. Do not advance paper by pulling on tape or the paper will bind.
- k. Paper Tray door **(1)** . To gain access to paper roll, rotate knob counterclockwise and pull.
- I. Control Panel door

 O . To gain access to controls, rotate knob counterclockwise and pull. See Figure 3-4 for description of controls.
- m. Test Head . Holds special sockets for testing IC's. Removed when using an automatic handler.



- a. MAG CARD WRITE button ①. When pushed, enables tester to duplicate program data onto a blank card. A preprogrammed card must be entered prior to pushing the button.
- b. START switch selects AUTO (automatic) or MAN/HNDLR (Manual/handler) position.
 - 1. In AUTO position, tester runs multiple test sequences on a single IC. Automatically initiates new test when present test is completed. Also can be used in manual test operation (see users manual).
 - Use MAN/HNDLR position when using an automatic IC handler or when manually testing using the TEST button.
- c. ON FAILURE switch affects the advance of the tests once a failure is detected.
 - 1. END ON FAILURE position terminates test sequence when a failure is detected.
 - 2. HOLD ON FAILURE position stops test sequence where the failure occurs. See description for ADVANCE TO NEXT FAIL button.
 - 3. CONTINUE ON FAILURE position allows completion of test sequences, regardless of failures. With printer on, provides a summary of failures.
- d. ADVANCE TO NEXT FAIL button is functional only when ON FAILURE switch is in the HOLD position. Pushing button advances test sequence to next failure where test sequence stops again.
- e. V AND I RESULTS switch saffects content of printout when printer is turned on and an IC fails under test. Off (down) position allows printout of basic failure data. The ON position allows printout of all pins, including their voltage and current data. (V AND I printout is not available with ON FAILURE switch set to CONTINUE.)
- f. PRINTER switch . Printer becomes fully operational with switch set to ON position. Even with switch set to off position, printer will record the card-loading information.

Figure 3-4. Recessed Panel Controls



To reduce test times and prevent handling errors, the front panel controls should be set as follows:

- a. Set the START switch at to the MAN/HNDLR position.
- b. Set the ON FAILURE switch to the END position.
- c. Set the V AND I RESULTS switch to the off (down) position.
- d. Set the PRINTER switch to the OFF position.

NOTE

It is important to use the PASS/FAIL program card to reduce the test time.

Figure 3-5. Control Settings for Handler Use

3-13. SELF CHECK PROCEDURE

3-14. Each day, before testing begins, a self-check procedure may be run on the tester to ensure the machine is operating properly. This procedure puts the tester through a rigorous test to ensure proper operation. The test can be found in Section IV under Operational Verification.

3-15. LOADING THE IC

3-16. Select the test socket that is compatible with the IC to be tested. Ensure that pin 1 of the IC matches pin 1 of the test socket (marked on the housing). Raise the test socket's locking lever, place the IC into the socket, and secure the IC into place by lowering the lever to its horizontal position.

3-17. MULTIPLE TESTING OF A SINGLE IC

- 3-18. Multiple testing is the ability to perform repeated test sequences on a single IC and record any failures. The IC might fail only one test in a thousand, but the failure will not go undetected. The internal counter that records the number of passes and failures is reset when a program card is first loaded. This should be done if a record is to be kept.
- 3-19. Multiple testing is also a useful mode to use when manually testing a group of IC's (i.e., without a handler). This mode eliminates the operation of pressing the TEST button for each new IC. Good IC's are indicated by the PASS light coming on shortly after the socket lever is lowered. (Between tests the FAIL light will be on, since the tester is testing an empty socket.)

3-20. Multiple Test Setup

3-21. Multiple testing is available by placing the START switch in the AUTO position. Also, for fast operation, set the ON FAILURE switch to END, the VAND I RESULTS switch to off (down) and the PRINTER switch to OFF. The TEST light will stay lit while the other lights reflect the test results. This method of testing is totally automatic and should not be used when operating from a handler. The tester may be attempting to perform a check while the handler is shifting in a new IC.

3-22. RETRIEVING PASS/FAIL INFORMATION

- 3-23. The tester records the number of failures even though no printing occurred. To retrieve this information, it is necessary to induce a failure (or wait until the next failure). The following procedure will cause the tester to print the number of failures and passes.
 - a. Set the START switch to MAN/HNDLR.
 - b. ON FAILURE switch to END.
 - c. Set the PRINTER switch to ON.
 - d. Remove the IC from its test socket.
 - e. Push the TEST button, once.
- 3-24. The tester will now print the failure data. Of importance here is the number of recorded failures minus one: the one that was induced. In the example below, the IC passed 45 test sequences and failed once of its own accord. If the printer had recorded only one failure (the induced one), the IC tested good.

TEST: FAN OUT
FAIL 2PASS 45
CORRECT 1001001
PIN
STATE 1>1100010
FAIL PIN: 3

3-25. DUPLICATING MAGNETIC CARDS

3-26. The Digital IC Tester has the ability of duplicating magnetic cards. The tester does this by "learning" the information from a card containing program data (a source card) and transferring that data to a blank card.

NOTE

Cards missing their program protect tabs cannot be reprogrammed.

3-27. Duplicating Procedure

- 3-28. Use the following procedure when duplicating program cards.
 - a. Set the START switch to the MAN/HNDLR position.
 - b. Push the LOAD button and insert side 1 of the source card (the card already programmed) into the tester. If the LOAD light does not go off, insert side 2 of the source card. The printer will now printout the IC number and the type of test. This verifies that proper loading has occurred. The program stored in the tester can now be transferred to the blank card.
 - c. Push the WRITE button the LOAD light should come on.
 - d. Load side 1 of the blank card into the tester. Load side 2 if the LOAD light does not turn off. Any number of cards can be made in this manner without reloading the source card.
 - e. To verify for proper duplicating, see paragraph 3-31 below.

3-29. MAKING A ROM PROGRAM CARD

3-30. A feature of the tester is the ability to produce a program card for any ROM, regardless of the ROM's program. To do this, first load the PROGRAM/STIMULUS card for the type of ROM (or PROM) that you're going to test. Then insert and test a known good ROM that contains your own output pattern. The tester "learns" the ROM's program and stores that information in its memory. Next, push the WRITE button and load a blank card. The tester will write the ROM's stimulus sequence from the first card and the output pattern from the reference ROM onto the blank card. This newly programmed blank card now becomes the test card to which all subsequent ROM's with that pattern can be tested.

3-31. Verification

3-32. Once the newly programmed card contains the duplicated program information, a verification of the program should be made. Push the LOAD button and insert side 1 of the new card and then side 2, if necessary. The printer should list the test for the type of card entered.

RELOAD

7476 PASS/FAIL

7476 DIAGNOSTIC

3-33. The printer will print the word "RELOAD" if the card didn't accept all of the program information available to it. In such case, first try reloading the card, if this doesn't work reload the source card and the blank card, as described earlier.

3-34. CARD READER CLEANING CARD

- 3-35. The tester is supplied with a special card that cleans the head of the magnetic card reader. This card is abrasive to the head assembly, therefore use it only when necessary. For example, if the tester printed "RELOAD" after four different program cards were loaded, it would be an indication that the card reader may need cleaning. Load the card in the same manner as a regular program card. Additional instructions are given on the card.
- 3-36. Power must be turned off to terminate the cleaning operation.



CAUTION

EXCESSIVE USE OF THIS CARD WILL DAMAGE THE READ/WRITE HEAD.

3-9





SECTION IV PERFORMANCE TESTS

4-1. INTRODUCTION

4-2. The procedure described in this section tests the instruments electrical performance using the specifications listed in Table 1-2 as the performance standards.

4-3. EQUIPMENT REQUIRED

4-4. Equipment required for the performance tests is listed in the Recommended Test Equipment table in Section 1 (Table 1-3).

4-5. OPERATIONAL VERIFICATION AND PERFORMANCE TESTS

4-6. Two sets of tests are provided in the following paragraph. The Operational Verification test will indicate whether the instrument tested operates correctly in all modes. The Performance Test is more extensive and may be performed after the Operational Verification Test to measure the condition of the instrument tested with respect to the new instrument specifications. Both tests require the use of pre-programmed magnetic cards which are included as part of the Diagnostic Card Kit.

4-7. IN-CABINET PERFORMANCE TEST CARD

4-8. The Operational Verification Test Card, page 4-6a, is provided to allow results of the tests to be recorded. A series of these cards with data taken at periodic intervals can be used to show trends in performance.

Table 4-1. Operational Verification Test

- I. SELF CHECK 1, 2, and 3
- II. R-PACK TESTS (Precision Resistor Pack Tests)
 - a. V/I R-PACK
 - b. R-PACK C-Current Modes Check
 - c. R-PACK Failure Detect Check

4-9. Operational Verification Test

- 4-10. The Operational Verification Test for the 5045A IC Tester consists of several self check routines that quickly verify correct operation of the major testing modes of the instrument. This test may be run each day to verify correct operation. For a rigorous verification of all 5045A specifications, refer to the Performance Test Paragraph 4-35.
- 4-11. The Operational Verification Test is divided into two parts: Part I uses a dummy IC along with special program cards to check several programmed modes of voltages and currents. In these tests, pin drivers are used in pairs. One driver is used as a source and the other becomes a measuring device. In Part II, a special precision resistor pack is used to obtain information about individual pins and their parameters.

4-1



4-12. Part I: Self Checks 1, 2 and 3

a. Set the front panel switches as follows:

START — MAN/HNDLER
ON FAILURE — CONTINUE
V and I RESULTS — OFF (down)
PRINTER — ON

b. Install the Dummy IC in the test socket. For Option 024 (24-pin instruments), use the IC (HP P/N 0S04S-80020). The 16-pin IC should be used for standard 16-pin instruments (HP P/N 0S04S-60019). The 20-pin socket adapter (HP P/N 0S045-60032) must be used with 16-pin ICs.

4-13. Self Check 1

a. Load the correct "Self Check 1" program card for 16-pin or 24-pin instrument. The following printout will be produced:

> SELF CHECK 1 CPU RDR PRNTR OK

The printout indicates that the S045A's card reader, central processing unit, and printer are operating properly.

Press TEST. Verify that the PASS light illuminates. There should be no printer output.

4-14. Self Check 2

- a. Load the correct "Self Check 2" card for 16-pin or 24-pin instrument. This self check program is a test of relative accuracy for several modes of voltage and current setup conditions.
- b. Press TEST. Verify that the PASS light illuminates. There should be no printer output.

4-15. Self Check 3

Note: Self check 3 will not operate with instrument serial numbers 1620A001S5 and below.

- a. Load the correct "Self Check 3" card for 16-pin or 24-pin instruments. This self check program further exercises the pin driver voltage and current generators.
- b. Press TEST. Verify that the PASS light illuminates. There should be no printer output.

4-16. Part II: R-Pack Operational Verification Tests

a. The precision resistor pack (R-Pack HP P/N 0504S-60042) is used with special program cards to gain additional information about individual voltage and current parameters for each pin of the IC tester. The R-Pack loads each pin of the IC tester with a precision $1 \mathrm{K}\Omega$ resistor. The 24 resistors tie to a common ground point. When testing is performed, the R-Pack is inserted in the test socket and its ground lead is connected to A30TP2S (marked I). The R-Pack tests uses the voltage and current generator along with the V and I Results function to produce a printed output for each pin.

- 4-17. The R-Pack Operational Verification consists of the following tests:
 - a. V/I Performance

Analog Accuracy
V/I Results Function

- b. Pin Driver C-Current Modes Check
- c. Failure Detect Check

4-18. V/I Performance Check

- 4-19. This test verifies that the pin driver voltage and current generators along with the V and I Results function are working properly.
- 4-20. Remove the Test Head cover.
 - a. Set 5045A Front Panel switches to:

START — MAN/HNDLR ON FAILURE — HOLD V and I RESULTS — ON (UP) PRINTER — ON

Note: all of the tests for each program card may be executed automatically by setting ON FAIL-URE to CONTINUE.

- b. Turn on 5045A and load "V/I R-PACK 24-pin" or "V/I R-PACK 16-pin" for 24-pin or 16-pin instrument, respectively.
- c. Install R-PACK in Test Head socket.
- d. Connect R-PACK ground lead to A30TP25 (marked 1).
- 4-21. The V/I R-Pack check consists of four operational modes with a corresponding printout for each.

4-22. +7V, +7 mA Mode

- a. Press TEST.
- b. A printout similar to Figure 4-1 will be produced.
- c. All pins should be listed as failing.
- Note that each pin is listed twice. For example, observe the data for pin 24. The "L" in the printout denotes the programmed value of the voltage or current. The lower line denotes that 7 mA was forced (programmed) and the resultant voltage is 7.05V (1K Ω resistors are loading each pin). The upper line for pin 24 denotes that 7V was applied and the resultant current was 7.0 mA.
- e. In each printout line, the parameter of importance is the result of the forced current or applied voltage. Voltage printouts will always be on the left and current printouts on the right.
- f. For the 7V, 7 mA printout, make sure that voltage and current results for all pins are within the following limits.

7V, 7 mA 7V ±0.40V (6.60/7.40V) 7 mA ±0.40 mA (6.60/7.40 mA)

4-3

```
TEST:
       74,7MA
         SPASS
                   Ø
FAIL
                7 198
20
                7LMA
20
   7.05 V
             7.04 MA
       1 1
21
   7.02 V
                ZLMA
       71.7
                7 119
   7.04 V
                ZLMA
23
             7.08 MA
       747
                ZLMA
   6.98 V
       71.4
                7 114
                711
24 7.05 V
CORRECT 111111111111111
     10 11 12 13
      15 16 17 18
  14
     20 21 22 23
  24
```

Figure 4-1. Typical printout for R-Pack Test (partial printout)

4-23. 1V, 1 mA

- a. Press ADVANCE TO NEXT FAIL. The "1V, 1 mA" printout will be produced.
- b. Examine the voltage and current parameters as done in paragraph 4-22.
- c. Verify the following limits for all pins.

1V, 1 mA 1V ±60 mV (0.940/1.060V) 1 mA ±60 μ A (0.940/1.060 mA)

4-24. -7V, -7 mA

- a. Press ADVANCE TO NEXT FAIL. The "-7V, -7 mA" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22. Verify the following limits for all pins.
 - -7V, -7 mA -7V ±40 mV (-7.40/-6.60V) -7 mA ±40 μA (-7.40/6.60 mA)

4-25. -1V, -1 mA

- a. Press ADVANCE TO NEXT FAIL. The "-1V, -1 mA" printout will be produced.
- h. Examine the voltage and current parameters as in paragraph 4-22.

Model 5045A Performance Tests

c. Verify the following limits for all pins.

-1V, -1 mA -1V ±6 mV (-1.060/-.940V) -1 mA ±60 μA (-1.060/-.940 mA)

4-26. Pin Driver C-Current Modes Check

- 4-27. This test sets up the pin driver in typical continuous current modes. The continuous current function allows for current generators to be turned on independently of the logic state of the pin under test. In each of the tests, both the Logic 1 and Logic 0 current generators are turned on simultaneously. The resultant output current is the difference between the programmed Logic 1 and Logic 0 currents.
 - a. Load "R-Pack C-Current Modes 24-Pin" or "R-Pack C-Current Modes 16-Pin" for 24-pin or 16-pin instrument, respectively.

4-28. 7V, 7 mA +12, C-5

NOTE

+12, C-5 denotes that the Logic 1 and Logic 0 currents are +12mA and -5 mA, respectively. C-5 means that the Logic "0" source is turned on continuously for -5 mA.

- a. Press TEST. The "7V, 7 mA +12, C-5" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22. Verify the following limits for all pins.

7V ±1.1V (5.9/8.1V) 7 mA ±1.1 mA (5.9/8.1 mA)

4-29. 1V, 1 mA +2, C -1

Logic 1 Current Source: +2 mA

Logic 0 Current Source: -1 mA continuous

- a. Press ADVANCE TO NEXT FAIL. The "1V, 1 mA +2, C-1" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.
- c. Verify the following limits for all pins.

1V ±0.18V (0.82/1.18) 1 mA ±0.18 mA (0.82/1.18 mA)

4-30. -7V, -7 mA -12, C+5

Logic 1 Current Source: +5 mA Continuous
Logic 0 Current Source: -12 mA

- a. Press ADVANCE TO NEXT FAIL. The "-7V, -7 mA -12, C+5" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.
- c. Verify the following limits for all pins.
 - -7V ±1.1V (-8.1/5.9V) -7 mA·±1.1 mA (-8.1/-5.9) mA)

4-5

4-31. -1V, 1 mA -2, C+1

Logic 1 Current Source: +1 mA Continuous

Logic 0 Current Source: -2 mA

- a. Press ADVANCE TO NEXT FAIL. The "-1V, -1 mA -2, C+1" printout will be produced.
- b. Examine the voltage and current parameters as in paragraph 4-22.
- c. Verify the following limits for all pins.

-1V ±.18 (-1.18/-0.82V) -1 mA ±.18 (-1.18/-0.82 mA)

4-32. Failure Detection Circuitry Check

4-33. The failure detection circuitry check verifies that the tester can indicate failing conditions for IC's under test. Failing voltage and current conditions are set up with the R-Pack. Source and load parameters are tested for each pin. The four tests are as follows:

- Test 1 Even Pins "Source" Logic 1 Odd Pins "Load" Logic 0
- Test 2 Even Pins "Load" Logic 0
 Odd Pins "Source" Logic 1
- Test 3 Even Pins. "Load" Logic 1 Odd Pins "Source" Logic 0
- Test 4 Even Pins "Source" Logic 0 Odd Pins "Load" Logic 1
- a. Set S04SA front panel switches as in paragraph 4-20 except:

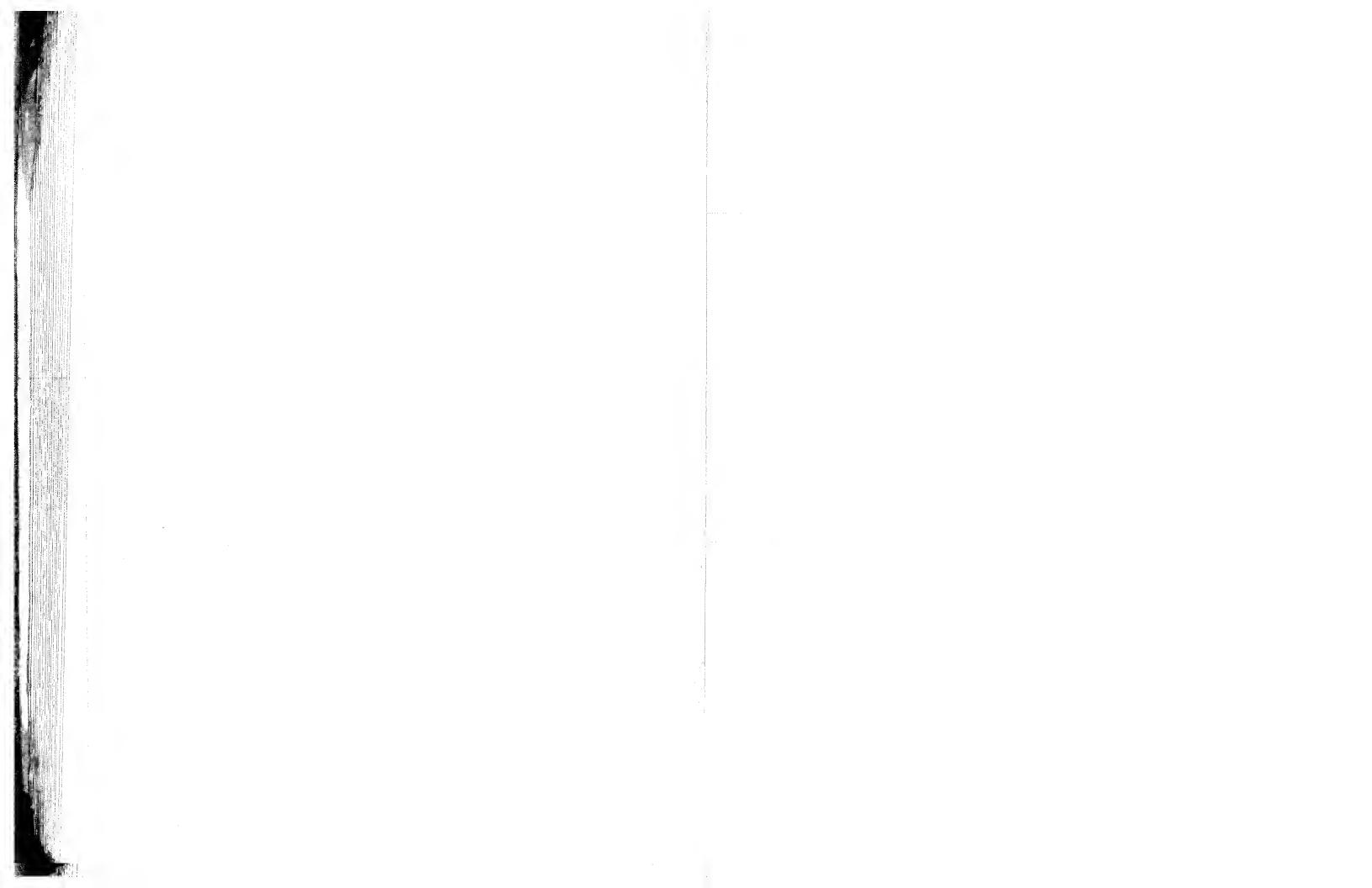
ON FAILURE — CONTINUE
V and I RESULTS — OFF (Down)

- b. Remove R-Pack from the test socket.
- c. Load "R-Pack Fail Detect Check 24-Pin" or "R-Pack Fail Detect Check 16-Pin" for 24-pin or 16-pin instrument.
- d. Press TEST. PASS light should illuminate and no printout will be produced.
- e. Install R-Pack in test socket and connect ground lead to A30TP25 (marked 1).
- f. Press TEST. Printout should begin. For all four tests, verify that every pin is listed in the FAIL PIN information. For 16-pin instruments, pins 1-16 should fail. For 24-pin instruments, pins 1-24 should fail. If any pin is not listed in any or all of the tests, then there may be a problem with the failure detect circuitry for that pin. If this occurs, reinsert the R-Pack and run the test again. If problem still occurs refer to Troubleshooting, Section VIII.
- 4-34. Successful completion of R-Pack Tests 1, 2, and 3 along with positive self check results indicates that with high probability the S045A Digital IC Tester is functioning properly. For a complete verification of all S04SA published specifications, the Performance Test must be executed.

Model 5045A Performance Tests

Operational Verification Test Card

	NLETT-PACKARD MODEL 5045A TESTER	Test Performed Date	
SER	IAL NO.		<u></u>
	DESCRIPTION		CHECK
1.	Self Check 1		
2.	Self Check 2		<u></u>
3.	Self Check 3		
4.	V/I R-Pack		
5.	R-Pack C-Current Modes	<u></u>	
6.	R-Pack Fail Detect Check	<u></u>	
jer Si			



4-35. PERFORMANCE TEST

4-36. The 5045A Performance Test, outlined in Table 4-2 is used to verify that all operational modes of the IC tester are functioning correctly. In addition, all voltage and current specifications are verified. This Performance Test may be used for incoming inspection, periodic certification, troubleshooting and post-repair verification.

Table 4-2. Performance Test Outline

1.	DAC Adjustment Check
	DAC Reference Level V Zero, V Gain I Zero, I Gain
11.	Analog Voltage Check
	Part I Hi, Lo Range Part II Logic Levels
	Analog Current Check
	Low Range 200 mA Range Continuous Current Modes
IV.	Cross Talk
	Part I, II
V.	Failure Detection Circuitry Check
V	V and I Results Check
	Voltage Current V/I Offset
VII	. Fast Edge Check
	Pos Rise Time Neg Rise Time
VII	I. Relays Check
lx ix	. Op Code Check
x	Printer Check
x	Automatic IC Handler Signals Check (Optional)

4-37. DAC ADJUSTMENT CHECK

- 4-38. The "DAC Adj Check" test verifies proper alignment of the A11 Reference Level Generator (DAC). This procedure may be deleted if an alignment has just been performed.
 - a. Remove test head cover. Tilt up the front portion of the cover (the cover hinges at the rear).
 - b. Attach DVM ground lead to A30 TP25 (marked 4). Remove R-Pack if installed.
 - c. Set front panel switches as follows:

START — MAN/HNDLR ON FAILURE — HOLD V and I RESULTS — DOWN PRINTER — ON

d. Load "DAC Adjust CHECK"

4-39. Test 1: DAC REF 7.5V

- 4-40. This test verifies that the DAC reference level is correct.
 - a. Press TEST. The "DAC REF 7.5V" printout will be produced.
 - b. Measure voltage on TP8.
 - c. Verify the following limits of 7.5V 55 mV.

+15

4-41. Test 2: -V Zero 2 0V

- 4-42. This test verifies correct zero offset for the -V Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "-V Zero 2 0V" printout will be produced.
 - b. Measure voltage on TP8.
 - c. Verify the following limits of $0.00V \pm 10 \text{ mV}$.

4-43. Test 3: +V Zero 2 0V

- 4-44. This test verifies correct zero offset for the +V Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The +V Zero 2 0V printout will be produced.
 - b. Measure voltage on TP8.
 - c. Verify the following limits of 0.00V ± 10 mV.

4-45. Test 4: "+6.5V Logic 1"

- 4-46. This test verifies the +6.5V Gain adjustment of the +V Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "+6.5V Logic 1" printout will be produced.

- b. Measure voltage on TP8.
- c. Verify the following limits of $\pm 6.5 \text{V} \pm 10 \text{ mV}$.

4-47. Test 5: "+6.5V Logic 0"

- 4-48. This test verifies the +6.5V Gain adjustment of the -V Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "+6.5V Logic 0" printout will be produced
 - b. Measure voltage on TP8.
 - c. Verify the following limits of $\pm 6.5 \text{V} \pm 10 \text{ mV}$.

4-49. Test 6: -6.5V Logic 1

- 4-50. This test verifies the -6.5V Gain adjustment of the +V Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "-6.5V Logic 1" printout will be produced.
 - b. Measure voltage on TP8.
 - c. Verify the following limits of -6.5V ± 10 mV.

4-51. Test 7: -6.5V Logic 0

- 4-52. This test verifies the -6.5V Gain adjustment of the -V Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "-6.5V Logic 0" printout will be produced.
 - b. Measure voltage on TP8.
 - c. Verify the following limits of -6.5V ± 10 mV.

4-53. Test 8: Current Gen, +10 mA

- 4-54. This test verifies proper gain for the +1 Level Generator. Switch meter to current mode.
 - a. Press ADVANCE TO NEXT FAIL. The "Current Gen. +10 mA" printout will be produced.
 - b. Measure current at TP8.
 - c. Verify the following limits of 10 mA \pm .6 mA.

4-55. Test 9: Current Gen, -10 mA

- 4-56. This test verifies proper gain for the -I Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "Current Gen. -10 mA" printout will be produced.
 - b. Measure current at TP8.
 - c. Verify the following limits of -10 mA \pm .6 mA.

- 4-57. Test 10: +1 Zero, +10 μ A
- 4-58. This test verifies proper zero offset for the +I Level Generator.
 - a. Press ADVANCE TO NEXT FAIL. The "I Zero $\pm 10~\mu A$ " printout will be produced.
 - b. Measure current at TP8.
 - c. Verify the following limits of $\pm 10 \, \mu A \pm 5 \, \mu A$.
- 4-59. Test 11: -l Zero, -10 μA
- 4-60. This test verifies proper zero offset for the -I Level Generator.
- a. Press ADVANCE TO NEXT FAIL. The "I Zero -10 μ A" printout will be produced.
- b. Measure current at TP8.
- c. Verify the following limits of -10 μ A \pm 5 μ A.

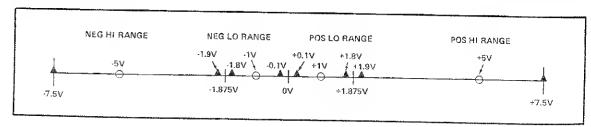
4-61. If all limits have been satisfied for all 11 tests then the A11 Reference Level Generator (DAC) is properly aligned. Perform the complete A11 adjustment procedure as described in Section V, if any of the tests failed.

4-62. Analog Voltage Check

4-63. The Analog Voltage Check is a verification of the accuracy of programmed voltage levels. The test is divided into two parts.

- a. Part I
 - +7.5V, Pos High Range High End Logic 1
 - +1.9V Pos High Range Low End Logic 1
 - +1.8V Pos Low Range High End Logic 1
 - +0.1V Pos Low Range Low End Logic 1
 - -7.5V Neg High Range High End Logic 0
 - -1.9V Neg High Range Low End Logic 0
 - -1.8V Neg Low Range High End Logic 0
 - -0.1V Neg Low Range Low End Logic 0
- b. Part II
 - +5V Logic 1
 - +5V Logic 0
 - -5V Logic 1
 - -5V Logic 0
 - +1V Logic 1
 - +1V Logic 0
 - -1V Logic 1
 - -1V Logic 0

4-64. The following graph shows the breakdown of the IC Tester's High and Low Voltage Ranges. The ▲ marks denote the voltages checked in Part I. "O" marks denote voltages checked in Part II.



4-65. Part l

- a. Set front panel switches as in paragraph 4-38.
- b. Load "Analog Voltage Check Part 1".
- c. Press TEST.

4-66. Test 1: +7.5V Pos High Range, High End

- a. Measure voltage on Test Points 1-24.
- b. Verify the following limits of $\pm 7.5V \pm 25$ mV for all pins.

4-67. Test 2: +1.9V Pos High Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- verify the following limits of $\pm 1.9 \text{V} \pm 25 \text{ mV}$ for all pins.

4-68. Test 3: +1.8V Pos Low Range High End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of $\pm 1.8 \text{V} \pm 15 \text{ mV}$ for all pins.

4-69. Test 4: +0.1V Pos Low Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of $\pm 0.1V \pm 15$ mV for all pins.

4-70. Test 5: -7.5V Neg High Range, High End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of $-7.5V \pm 25$ mV for all pins.

4-71. Test 6: -1.9V Neg High Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- Verify the following limits of -1.9V ± 25 mV for all pins.

4-72. Test 7: -1.8V Neg Low Range, High End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -1.8V ± 15 mV for all pins.

4-73. Test 8: -0.1V Neg Low Range, Low End

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -0.1V \pm 15 mV for all pins.

4-74. Part II

- 4-75. Voltage Limit Verification for Pos and Neg Logic Modes.
 - a. Load "Analog Voltage Check Part II",

4-76. Test 1: +5V Logic 1

- a. Press TEST.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of $\pm 5V \pm 25$ mV for all pins.

4-77. Test 2: +5V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of $\pm 5V \pm 25$ mV for all pins.

4-78. Test 3: -5V Logic 1

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage of Test Points 1-24.
- c. Verify the following limits of -5V ±25 mV for all pins.

4-79. Test 4: -5V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -5V ± 25 mV for all pins.

4-80. Test 5: +1V Logic 1

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of +1V ±15 mV for all pins.

4-81. Test 6: +1V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of $\pm 1V \pm 15$ mV for all pins.

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4-82. Test 7: -1V Logic 1

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -1V \pm 15 mV for all pins.

4-83. Test 8: -1V Logic 0

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure voltage on Test Points 1-24.
- c. Verify the following limits of -1V \pm 15 mV for all pins.

4-84. Analog Current Check

4-85. The Analog Current Check is a verification of the accuracy of programmed current levels. The test is divided into three parts.

4-86. Part I — Low Current Range

±20 mA

±2.6 mA

±2.4 mA

±10 μA

4-87. Part II — High Current Range

±200 mA

4-88. Part III

a. Continuous Current Modes

±100 mA

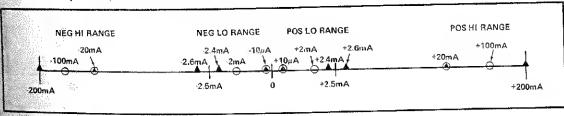
±20 mA

±2 mA

±10 μA

b. Voltage Verification for Current Modes

4-89. The following graph shows the breakdown of the IC Testers High and Low current ranges. The "A" marks denote the currents checked in parts 1 and 2. The "O" marks are for currents checked in part 3 (continuous modes).



4-90. Part I — Analog Current Check Low Range

- a. Set up DVM to measure DC current.
- **b.** Connect ground level to TP25 (marked 1).
- c. Load "Analog Current Check Low Range".

4-91. Test 1: +20 mA

- a. Press TEST.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 20 mA ± 1.2 mA for all pins.

4-92. Test 2: +2.6 mA

- Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 2.6 mA \pm 0.4 mA for all pins.

4-93. Test 3: +2.4 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 2.4 mA ± 0.14 mA for all pins.

4-94. Test 4: $\pm 10 \mu A$

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of 10 μ A \pm 10 μ A for all pins.

4-95. Test 5: -20 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -20 mA ± 1.2 mA for all pins.

4-96. Test 6: -2.6 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -2.6 mA ± 0.4 mA for all pins.

4-97. Test 7: -2.4 mA

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -2.4 mA \pm 0.14 mA for all pins.

4-98. Test 8: -10 μ A

- a. Press ADVANCE TO NEXT FAIL.
- b. Measure current on Test Points 1-24.
- c. Verify the following limits of -10 μ A \pm 10 μ A for all pins.

4-99. Analog Current Check 200 mA Range

4-100. The 200 mA ranges are checked with a separate test due to the maximum available current restrictions of the IC Tester. For any one pin setup condition, the total current from either positive or negative current generators may not exceed 600 mA. The test is organized so that only one pin is set up at any one time. The setup condition moves sequentially from pin 1 to 24 each time the ADVANCE TO NEXT FAIL button is pushed. Pin 1 is set up by pressing TEST.

- a. Load "Analog Current Check 200 mA Range".
- b. Press TEST.
- c. Measure current at TP1.
- d. Verify the following limits of ± 200 mA ± 12 mA on pin 1.
- e. Press ADVANCE TO NEXT FAIL to step test to pin 2. For each step, verify the following limits of ± 200 mA ± 12 mA.
- f. After TP24 has been checked, the -200 mA test begins with TP1. Again press ADVANCE TO NEXT FAIL to step through all 24-pins. The spec for the -200 mA test is -200 mA ±12 mA.

4-101. Continuous Current Modes

4-102. The continuous current function allows the current generators to be turned on independent of the logic state. In each of the tests, both the Logic 1 and Logic 0 current generators are turned on simultaneously. The resultant output appearing at the test points is the difference between the positive and negative programmed current levels. The tests are divided between three program cards as follows:

- a. Card 1 Pins 1-8
- b. Card 2 Pins 9-16
- Card 3 Pins 17-24

4-103. For any particular test checkpoint, the 8 pins will have different current setups. Refer to Table 4-3 for the expected outputs and limits.

NOTE

For 16-pin instruments, use the program for modes 1-8 and 17-24. Ignore references to pins 9-16.

4-104. Continuous Current Modes 1-8

a. Load "Pindriver C-Current Modes 1-8".

4-105. Test 1

- a. Press TEST.
- b. Measure current on Test Points 1-8.
- c. Verify currents according to Table 4-3 Test 1.

4106. Test 2

- Press ADVANCE TO NEXT FAIL.
- Measure current on Test Points 1-8.
- c. Verify currents according to Test 2.

4-107. Continue for remaining tests by pressing ADVANCE TO NEXT FAIL. For each test, verify the currents for Test Points 1-8 by referring to Table 4-3 and the appropriate test number.

4-108. Continuous Current Modes 9-16

- a. Load "Pindriver C-Current Modes 9-16".
- b. Proceed as in paragraph 4-104 above making reference to pins 9-16 in Table 4-3.

4-109. Continuous Current Modes 17-24

- a. Load "Pindriver C-Current Modes 17-24".
- p. Proceed as in paragraph 4-104 above making reference to pins 17-24 in Table 4-3.

4-110. Voltage Verification for Current Modes

4-111. This test is a verification of programmed voltage modes for continuous current pin driver setups.

4-112. Use the same procedure and equipment as outlined in paragraphs 4-104 through 4-109 except that voltages will be measured instead of currents. The approximate voltage magnitude is 7 volts. Refer to Table 4-4 for correct voltage levels. Note that for each program card, tests 1 through 4 are programmed for $\pm 7V \pm 25$ mV. For tests 5 through 8, the level is $\pm 7V \pm 25$ mV.

Table 4-3. Pindriver C-Current Modes (Current)

Pin	Numl	oer		Test Number						
Card 1-8	Card 9-16	Card 17-24	1	2	3	4	5	6	7	8
1,2	9,10	17,18	+100 mA +/-18 mA	+20 mA +/-3.6 mA	+2 mA +/52 mA	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20, +10 μA
3,4	11,12	19,20	+20 mA +/-3.6 mA	+20 mA +/52 mA	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20 +10 μA	+100 mA +/-18 mA
5,6	13,14	21,22	+2 mA +/52 mA	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20, ±10 μA	+100 mA +/-18 mA	+20 mA +/-3.6 mA
7,8	15,16	23,24	+10 μA +20, -10 μA	-100 mA +/-18 mA	-20 mA +/-3.6 mA	-2 mA +/52 mA	-10 μA -20, +10 μA	+100 mA +/-18 mA	+20 mA +/-3.6 mA	+2 mA +/52 mA

Table 4-4. Pindriver C-Current Modes (Voltages)

Pin	Numl	er				Test N	umber			
Card 1-8	Card 9-16	Card 17-24	1	2	3	4	5	6	7	8
1,2	9,10	17,18	+ 7 V	+7V	+7V	+7V	-7٧	-7V	-7V	-7V
3,4	11,12	19,20	+7V	+7V	.+7V	-7V	-7V	-7V	-7V	+7V
5,6	13,14	21,22	+7V	+7V	-7V	-7V	-7V	-7V	+7V	+7V
7,8	15,16	23,24	+7V	-7V	-7V	-7V	-7V	+7V	+7V	+7V

Note: +/-25 mV limits for all.

4-113. Cross Talk

4-114. The Cross Talk tests verify that the accuracy of programmed voltage and currents is within specification when cross talk conditions are set up on the Reference Level Generators and the individual pindrivers.

4-115. Cross Talk Part I

- a. Set front panel switches as in paragraph 4-38c.
- b. Connect DVM ground lead to TP25 (marked 1).
- c. Connect DVM Positive lead to TP7.
- d. Load "Cross Talk Part I".

4-116. Test 1: +V -I

- a. Press TEST.
- b. Verify the following limits of 7.5V ± 25 mV on TP7.

4-117. Test 2: +V -1

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 7.5V \pm 25 mV on TP7.

4-118. Test 3: +V +I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 7.5V \pm 25 mV on TP7.

4-119. Test 4: +V +I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 7.5V ±25 mV on TP7.

4-120. Test 5: -V +i

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -7.5V ± 25 mV on TP7.

4-121. Test 6: -V +1

- a. Press ADVANCE TO NEXT FAIL.
- **b.** Verify the following limits of -7.5V ± 25 mV on TP7.

4-122. Test 7: -V -I

- a. Press ADVANCE TO NEXT FAIL.
- **b.** Verify the following limits of $-7.5V \pm 25$ mV on TP7.

4-123. Test 8: -V -I

- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -7.5V ± 25 mV on TP7.
- 4-124. Set up DVM to measure current (approx. 2 mA).
 - a. Connect ammeter positive lead to TP7.
 - b. Ground lead remains on TP25 (marked 1).
- 4-125. Test 9: +I +V
 - a. Press ADVANCE TO NEXT FAIL.
 - b. Verify the following limits of 2 mA \pm 0.12 mA at TP7.
- 4-126. Test 10: +I +V
 - a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of 2 mA \pm 0.12 mA at TP7.
- 4-127. Test 11: +I -V
 - a. Press ADVANCE TO NEXT FAIL.
 - b. Verify the following limits of 2 mA \pm 0.12 mA at TP7.
- 4-128. Test 12: +I -V
 - a. Press ADVANCE TO NEXT FAIL.
 - b. Verify the following limits of 2 mA \pm 0.12 mA at TP7.
- 4-129. Test 13: -I -V
- a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA ± 0.12 mA at TP7.
- 4-130. Test 14: -I -V
 - a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA ± 0.12 mA at TP7.
- 4-131. Test 15: -I +V
 - a. Press ADVANCE TO NEXT FAIL.
 - b. Verify the following limits of -2 mA ± 0.12 mA at TP7.
- 4-132. Test 16:-I +V
 - a. Press ADVANCE TO NEXT FAIL.
- b. Verify the following limits of -2 mA ± 0.12 mA at TP7.

4-133. Cross Talk Part II

- a. Set DVM to measure voltage (approx. 7.5V). Connect DVM ground lead to TP25 (marked (1). Load "Cross Talk Part II".
- b. Press TEST. Printer output should be similar to that below:

- c. Measure voltage on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- d. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

TEST: 1-2
FAIL 2PASS 0
CORRECT 001001001001
FIN
STATE 1>100100100100100
FAIL PIN: 1 4 7
10 13 16 19 22

- e. Measure voltages on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- f. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

- **g** Measure voltage on indicated Fail Pins. Voltage should be $\pm 7.5 \text{V} \pm 25 \text{ mV}$.
- h. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

TEST: 2-3
FAIL 2PASS 0
CORRECT 010010010010
PIN
STATE 1>010010010010010
FAIL PIN: 2 5 8
11 14 17 20 23

- i. Measure voltage on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- . Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

- k. Measure voltage on indicated Fail Pins. Voltage should be +7.5V ±25 mV.
- I. Press ADVANCE TO NEXT FAIL. Printer output should be similar to that below:

TEST: 3-4
FAIL 2PASS 0
CORRECT 100100100100
PIN
STATE 1>001001001001
FAIL PIN: 3 6 9
12 15 18 21 24

m. Measure voltage on indicated Fail Pins. Voltage should be $\pm 7.5 \text{V} \pm 25 \text{ mV}$.

4-134. Failure Detection Circuitry Check

4-135. The Failure Detection Check verifies that a failing device under test can activate the 5045A's failure circuitry. The test uses a precision resistor package (HP P/N 05045-60042) to set up failing conditions for voltage and current. Source and load parameters are tested for each pin. The tests are as follows:

- Test 1 Even Pins "Source" Logic 1
 Odd Pins "Load" Logic 0

 Test 2 Even Pins "Load" Logic 0
 Odd Pins "Source" Logic 1

 Test 3 Even Pins "Load" Logic 1
 Odd Pins "Source" Logic 0

 Test 4 Even Pins "Source" Logic 0
 Odd Pins "Load" Logic 1
- a. Set 5045A front panel switches as in paragraph 4-38 c. except:

ON FAILURE — CONTINUE

b. Load "R-Pack Fail Detect Check 24" or "R-Pack Fail Detect Check 16" for 24-pin or 16-pin instrument. These programs are included in the Operational Verification Card Set. Press TEST. PASS light should illuminate and no printout will be produced. Note: R-Pack is not installed for this part of the test.

c. Now install R-Pack in test socket and connect ground lead to TP25 (marked \$\frac{1}{2}\$). Secure R-Pack with locking lever. Press TEST. Printout should begin. For all four tests, verify that every pin is listed in the FAIL PIN information. For 16-pin instruments, pins 1-16 should fail. For 24-pin instruments, pins 1-24 should fail. If any pin is not listed in any or all of the tests, then there may be a problem with the failure detect circuitry for that pin. If this occurs, reinsert the R-Pack and run the test again. If problem still occurs, refer to Trouble-shooting in Section VIII.

4-136. V AND I RESULTS — VOLTMETER/AMMETER PRINTOUT CHECK

4-137. This test verifies that the V and I RESULTS printout feature is working properly. The voltage specification is verified by applying an external voltage standard to each of the pins and observing the computed prinout. The current specifications check uses the Resistor Pack (also used in part V). A known current is produced by applying a specified voltage across each 1K resistor in the R-Pack. The resultant current is then computed and printed by the tester. The last part of the V/I check verifies that the voltmeter circuity has minimum offset.

CAUTION

Always adjust the power supply to the approximate test range before applying to the IC tester. Damage to the 5045A may result if voltage magnitudes exceeding 7V are applied to the Test Head.

4-138. Voltage Printout Feature

CAUTION AGAIN

Do not connect the power supply until the correct voltage is set up. Damage to the IC Tester may result if excessive voltage is applied to the Test Head pins.

- a. Turn on power supply and set voltage to $\pm 4.99V \pm 5$ mV. Connect negative (-) side to A30 TP25 (4).
- b. Install R-Pack in the 24 pin Test Head socket. Do not connect the black ground lead at this time.
- c. Set Front Panel Switches as follows:

START — MAN/HNDLR ON FAIL — Hold V and I RESULTS — OFF (DOWN) Printer — ON

- d. Load "V/I Results Voltage Check 16" or "V/I Results Voltage Check 24". Make sure that the correct program card is used (16-pin or 24-pin version).
- e. Press Test. The "+4.99 Setup" printout will be produced.
- f. Connect Power Supply Positive lead (+) to R-Pack black ground lead.
- 8. Measure Voltage on TP8 and adjust Power Supply as necessary to produce 5.000V ±5 mV.
- h. Set V and I RESULTS ON (switch UP).

4-139. V/I 5V Verification

a. Press ADVANCE TO NEXT FAIL.

b. A printout similar to the following will be produced (partial printout).

] a	4.5	įų i	VER	UF.	
FAI						
4 4 5					jį	
17	4.5				911	
15		SL.				
18	4 .				611	
19		ĒLŸ			31	
19	4.9				ail.	
28		ŠL.			äi.	
29	4.9				011	
21		ć. v			01	
	4,9				01 011	
22		šLV			01	
	4 1 m					
44 23		2 Y 6LV			01L	
					81	
	4.9				ØIL	
24					01	
24					811	
CORR		11	111	7	111	1 1
PIN						
STAT				Jennel.	111	1 4
	PI	1				3
H	i	1	5		7	8
9	10	j	11	1	2	13
14	4 1		16	4		18
19			21			23
24	*		· 1	3	Urant	~
I						

NOTE

Each pin number has two listings. Voltage levels are listed on the left side of the printout. All parameters containing "L" should be ignored. In this test, only the lower printout for each pin is of importance.

c. For each pin, verify that the printout reads:

4-140. V/I -5V Verification

- a. Disconnect Power Supply leads.
- b. Set:

- c. Press ADVANCE TO NEXT FAIL. The "-4.99V setup" printout will be produced.
- d. Connect Power Supply leads so that -4.99V is applied to the R-Pack black lead.
- e. Measure Voltage on TP24. If necessary, adjust Power Supply to produce -5.00V ±5 mV on TP8.
- f. Set:

V and I RESULTS — ON (UP)

- g. Press ADVANCE TO NEXT FAIL wait for printout.
- h. Observe voltage printout for each pin.
- i. For each pin, verify that the printout reads:
 .o4V (-4.96V) 5.04V)
 -5V ±.03V (-4.97V, -5.03V)

4-141. V/I +1V Verification

- a. Disconnect Power Supply leads.
- b. Set:

V AND I RESULTS - OFF (DOWN)

Printer - OFF O N

- c. Press ADVANCE TO NEXT FAIL. The "+0.99 Setup" printout will be produced.
- d. Connect Power Supply leads so that +0.99V is applied to the R-Pack black lead.
- e. Measure voltage on TP8. If necessary, adjust Power Supply to produce $\pm 1.00 \text{V} \pm 5 \text{ mV}$ on TP8.
- f. Set:

V AND I RESULTS - ON (UP)

- g. Press ADVANCE TO NEXT FAIL wait for printout.
- h. Observe voltage printout for each pin.
- i. For each pin, verify that the printout reads:

+1V ±.02V (+0.98, +1.02)

4-142. V/I - 1V Verification

- a. Disconnect Power Supply leads.
- b. Set:

V AND I RESULTS - OFF (DOWN)

Printer — OFF

- c. Press ADVANCE TO NEXT FAIL. The "-0.99 Setup" printout will be produced.
- d. Connect Power Supply leads so that -0.99V is applied to the R-Pack black lead.
- e. Measure voltage on TP8. If necessary, adjust Power Supply to produce $-1.00V \pm 5$ mV on TP8.
- f. Set:

V AND I RESULTS — ON (UP)

- 8. Press ADVANCE TO NEXT FAIL wait for printout.
- h. Observe voltage printout for each pin.
- For each pin, verify that the printout reads:

-1V ±.02V (-0.98, -1.02)

4-143. V/I Results Current Check

- a. Disconnect Power Supply from Test Head.
- b. Turn off 5045A.
- c. Leave R-Pack installed in test socket and connect R-Pack black lead to A30 TP25 (4).

4-144. V/I 7 mA Verification

- a. Turn on 5045A.
- b. Load "V/I Results Current Check 16" or "V/I Results Current Check 24". Make sure that the correct program card is used (16-pin or 24-pin version).
- c. Set:

- d. Press TEST.
- e. A printout similar to the following will be produced (partial printout).

TEST: +7MM VERIF.
(6.55/7.45) FAIL 2PASS 0
17 6.93 V 7kMA
18 7LV 7.08 MA
18 6.97 V 7LMA
19 7LV 7.04 MA 19 7.01 V 7LMA
19 7.01 V 7LMA
20 7LV 7.08 MA
20 7 V 7LMA
21 7LV 7.08 MA 21 6.95 V 7LMA
22 7LV 7.08 MA
22 6.98 V 7LMA
23 719 7,12 66
23 6.91 V 7LMA
24 7LV 7.04 MA
24 6.98 V 7LMA
CORRECT 11111111111111111
STATE 1>11111111111111111111111111111111111
9 10 11 12 13
14 15 16 17 18
19 20 21 22 23

Note

Each pin has two listings. The only parameter of interest is the top current printout (right column). Ignore the information in the left column. Also, ignore the right-column current containing the "L".

Verify that the current printout for each pin reads 7 mA ± 0.45 mA (6.55/7.45).

4-145. V/I -7 mA Verification

- a. Press ADVANCE TO NEXT FAIL.
- b. A printout similar to that obtained in paragraph 4-144e will be produced.
- c. Observe current printout for each pin (as in paragraph 4-144e).
- d. For each pin, verify that the printout leads -7 mA ± 0.45 mA (-6.55/-7.45).

4-146. V/I OFFSET CHECK

- a. Load "V/I OFFSET CHECK 16" or "V/I OFFSET CHECK 24". Make sure that the correct program card is used (16-pin or 24-pin version). **REMOVE R-PACK.**
- b. For 16-pin instruments, pins 6 and 7 should be shorted together with a short length of wire. The short may be mounted in the 24-pin test socket.

4-147. V/I Pos Offset

- a. Press TEST.
- b. A printout similar to that in paragraph 4-144e will be produced.
- c. Observe voltage (left column) for each failed pin (as in paragraph 4-144e).
- d. For each failed pin, verify that the voltage printout reads:

0.00V ±10 mV (-.01, .01)

4-148. V/I Neg Offset Check

- a. Press ADVANCE TO NEXT FAIL.
- b. Observe voltage (left column) printout for each failed pin (as in paragraph 4-144e).
- c. For each failed pin, verify that the voltage printout reads:

0.00 +10 mV (-.01, .01)

4-149. Fast Edge Check

4-150. The Fast Edge Check is a verification of positive and negative rise times for analog voltage levels being applied to the IC under test. If during the check, the FAIL lamp illuminates and a printout occurs, press TEST twice to continue. This is usually caused by shorting two pins together.

- a. Set the 5045A front panel switches as in paragraph 4-38c.
- b. Load "Pos Fast Edge Check".
- c. Insert R-Pack in test socket and connect ground lead to A30 TP25 (marked 1). Also connect scope ground to A30 TP25 (marked 1).

Oscilloscope Setup:

Single Trace: CH A Trigger Slope: POS

Vertical: 0.1V Div with 10X Probe

Horizontal: 0.1 µsec/div

Note

The display for this fast waveform will be easier to examine with the use of a viewing hood.

d. Connect scope probe to A30 TP1.

Press TEST. The TEST Light should illuminate and there should be no printer output.

Observe the scope display and compare to Figure 4-2.

Rise time: -2V to +2V; 120 nsec max

Overshoot: Less than 0.8V

Move the probe to TP2 and again observe the waveform. Repeat this for all pins. Note that on 16 pin instruments, TP9 through TP16 will have no output and should not be observed.

e. Load "Neg Fast Edge Check".

Change scope trigger to Neg slope.

f. Press TEST.

Observe the waveform as done in the Positive Fast Edge Check. Compare the scope displays to Figure 4-3.

Fall Time; +2V to -2V: 120 nsec max

Overshoot: less than 0.8V

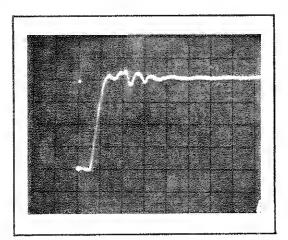


Figure 4-2. Fast Edge Check (Positive)

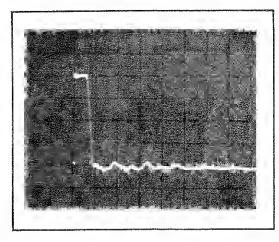


Figure 4-3. Fast Edge Check (Negative)

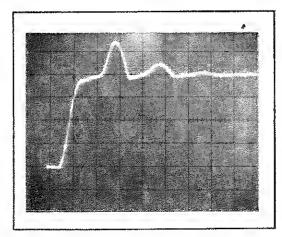


Figure 4-4. Positive Edge .1V Div/.1 μsec With Test Head Extender Cable

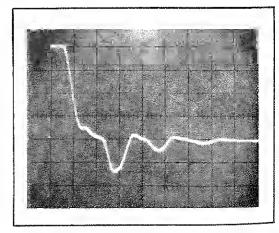


Figure 4-5. Negative Edge .1V Div/.1 µsec With Test Head Extender Cable

4-151. Fast Edge Signals for Extended Test Heads

4-152. The Fast Edge signals for test heads using the tongue extender cables are slightly altered. Figures 4-4 and 4-5 are typical waveforms expected after the positive and negative fast edge checks.

4-153. Relays Check

4-154. The Relays Check insures proper operation of the test head grounding and bypass capacitor relays.

- a. Set 5045A front panel switches as in paragraph 4-38c. Note: make sure that the ON FAIL-URE switch is in the "HOLD" position.
- b. Load appropriate "Relays Check" magnetic card; 16-PIN for a standard instrument or 24-PIN for an Option 024 instrument. Printer output should be one of the following:

RELAYS CHECK-16 PINS

RELAYS CHECK-24 PINS

c. Press TEST. Printer output should be as follows:

(16-pin)		(24-pin)		
TEST: KI OK FAIL 1PASS CORRECT 111111111 PIN STATE 1>111111111 FAIL PIN: 12	Ø	TEST: KI OK FAIL IPASS Ø CORRECT 111111111111111111111111111111111111		

d. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(16-pin)		(24-pin)
TEST: K2 OK FAIL 1PASS CORRECT 111111111 PIN STATE 1>11111111111111111111111111111111111	3	TEST: K2 OK FAIL 1PASS 0 CORRECT 111111111111111111111111111111111111

e. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

	(16-pin)		(24-pin)	
FAIL CORRECT FIM	K8 OK 1PASS 11111111 >11111111 N: 8	Î	TEST: K4 OK FAIL 1PASS 6 CORRECT 111111111111111111111111111111111111	

f. Press ADVANCE TO NEXT FAIL. Printout output should be as follows:

(16-pin)

(24-pin)

TEST:	K9 OK		TEST	K7 OK
FAIL	1 PA SS	A	FAIL	1PASS 0
, , ,	1111111	4	COBECT	111111111111
	1111111			خه عقد داده بطب باشت بای دار نشر بای وق _{مط} ر
PIN			PIH	
STATE 1	>11111111		STATE 1	>111111111111
FATI PT	N: 7		FAIL PI	4# 9

g. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(16-pin final check)

(24-pin)

TEST:	K11 OK		TEST:	K8 OK	
FAIL	1PA88	Ø	FAIL	1FA55	0
CORRECT	1111111		CORRECT	11111111	1111
PIN			PIH		
STATE 1	>11111111			>11111111	1111
FAIL PI			FAIL PI	4: 8	

h. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin)

i. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin)

i. Press ADVANCE TO NEXT FAIL. Printer output should be as follows:

(24-pin)

4-155. Op Code Check

- 4-156. The Op Code Check verifies program capabilities for logic and arithmetic functions within the Arithmetic Logic Unit of the 5045A's CPU.
 - a. Set front panel switches as in paragraph 4-38c.
 - b. Load "OP CODE CHECK".

Press TEST.

PASS light should illuminate and there should be no printer output.

4-157. Printer Check

- a. Set front panel switches as in paragraph 4-38c.
- b. Load "Printer Check".

Press TEST. The following printout will be produced:

c. Check vertical print spacing. Ideal spacing should be about 6 characters per inch. If adjustment is necessary, refer to printer adjustments (Paragraph 8-40i).

4-158. Automatic IC Handler Signals Check (Optional)

- 4-159. Control signals for automatic IC handlers are generated by circuitry within the 5045A IC Tester. The following procedure is a verification of the timing relationships for these signals.
- 4-160. The test requires the use of a known good TTL IC and its corresponding Pass/Fail Program Card. The 7400 Quad Nand gate is recommended. This IC is used to test the PASS, FAIL CONTINUITY, and FAIL FUNCTION signals.
- 4-161. In order to gain easy access to the signal lines, a test cable should be used. The test cable connector and pin-out is listed below.

4- 62. Cable

4-163. The test cable is made up of connector (HP Part Number 1251-0142) or Amphenol 5730140) with test wires connected as follows:

```
FAIL CONT — Pin 1

FAIL FUNCTION — Pin 11

PASS — Pin 9

GND — Pin 6, 13
```

4-164. Procedure

a. Hook up handler control test cable to rear of 5045A. Connect scope CH A to the EOT line. Set up scope as follows:

Trigger: CH A, Negative Slope

Vertical: - 2V/div

Horizontal:— 10 msec/div

Ground: Connect to pin 6 or 13 on J15 cable

b. Set 5045A Front Panel switches as follows:

START — AUTO
ON FAILURE — END
V and I RESULTS — OFF (DOWN)
PRINTER — OFF

- c. Turn on 5045A and install 7400 IC (or equivalent) in the test head socket. (The 20-pin adapter must be used.)
- d. Load the test program.
- e. Adjust scope trigger until the EOT signal stabilizes. Using the horizontal position control, move the signal so that beginning of trace is in a convenient location. Verify that the EOT signal is low for about 65 ms (see Figure 4-6).
- f. Connect the CHB probe to the PA55 line. Compare the signal to that shown in Figure 4 . Verify that the PA55 signal goes high after 30 ms ±5 msec (referenced to beginning of EOT trace).
- g. Lift the test IC so that the front panel "CONT" light flashes. (The "FAIL" light will also flash.)
- h. Connect the CH B Probe to the FAIL CONT line (pin 1 on the J5 cable). Compare the signal to that shown in Figure 4-6. Verify that the FAIL CONT signal goes high after 30 msec ±5 msec (referenced to beginning of EOT Trace).
- i. Reinsert the test IC in the test head socket. Connect the CH B Probe to the FAIL FCN line (pin 11 on the J5 cable). Use a screwdriver or similar tool to short pins 1 and 2 of the test IC together. Hold the short condition throughout this portion of the test. Verify that the "FAIL" light is flashing.
- j. Compare the signal displayed to that shown in Figure 4-6. Verify that the FAIL FCN signal goes high after 65 msec ±5 msec (referenced to beginning of EOT trace).

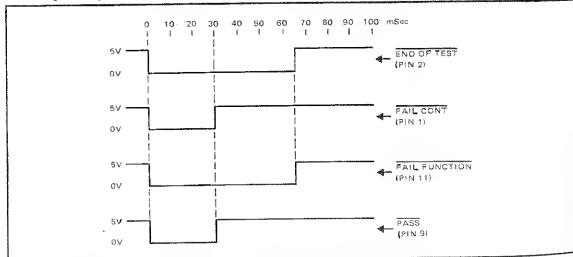


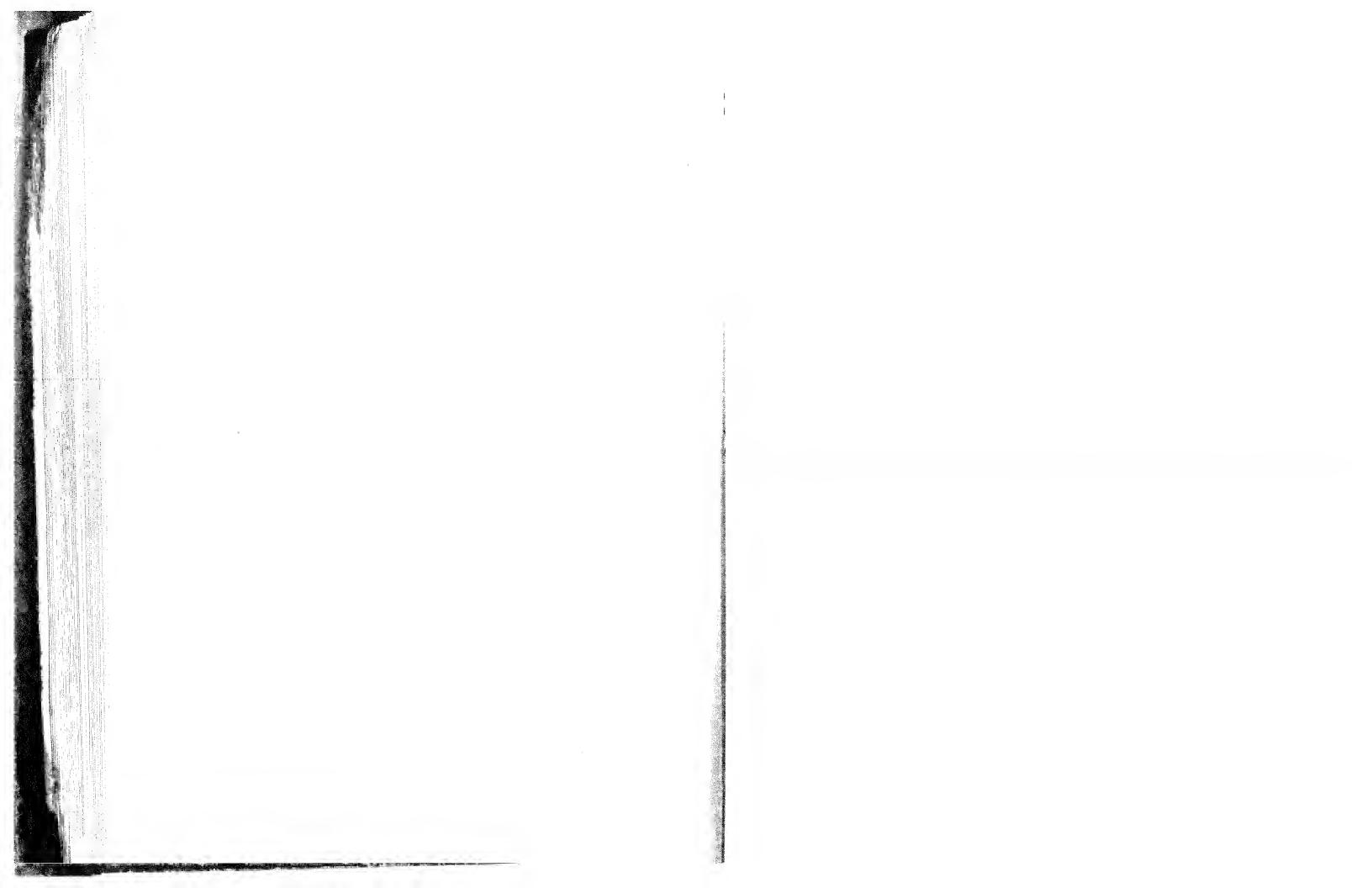
Figure 4-6. Automatic Handler Signal Timing

Performance Test Check Card

	VLETT-PACKARD MODEL 5045A TESTER	Test Performed Date		
SER	IAL NO.			
	DESCRIPTION		CHECK	
1.	Reference Level Generator Check (DAC)			
2.	Analog Voltage Check			
3.	Analog Current Check			
4.	Cross Talk			
5.	Failure Detect Check	energy de la constant	***	
6.	V and I Results Check	a		
z. 7.	Fast Edge Check			
8.	Relays Check	÷		
9.	Op Code Check			
10.	Printer Check			
11.	Automatic IC Handler Signals Check			
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SECTION V ADJUSTMENTS

5-1. INTRODUCTION

5-2. This section contains a list of test equipment required and adjustment procedures.

NOTE

All of the adjustments are written for 5045A's equipped with Option 024 (24-pin). For standard instruments, disregard any reference to test points 9 through 16.

5-3. TEST EQUIPMENT REQUIRED

5-4. Table 5-1 lists the equipment required for adjustments. See Table 1-3 for a complete listing of test equipment required for instrument maintenance.

Table 5-1. Required Test Equipment

Instrument Type	Required Characteristics	Recommended Model No.	
Oscilloscope	50 MHz	HP 1707B	
Vertical	50 mV/div sensitivity, >5 ns rise time		
Horizontal	10 ns/div bandwidth		
Voltmeter/Ammeter, Digital DC	Voltage: 20V max 1 mV Resolution on 6.5V level	HP 3465A *	
	Current: 10 μA, 20 mA 100 μA Resolution on 10 mA level .1 μA Resolution on 10 μA level		

5-5. ADJUSTMENTS

5-6. This section contains checkout and adjustment procedures for the power supplies, 4 MHz clock, printer group enable timing, and DAC alignment. These procedures should be performed in the order given, however the adjustments for the DAC should only be performed when there is an indication that an adjustment is necessary rather than on a periodic basis.

5-7. Standard Front Panel Switch Settings

Frior to performing adjustments or performance tests, set the front panel switches as blows:

START	MAN/HNDLR
ON FAILURE	HOLD
V AND I RESULTS	DOWN
PRINTER	ON

	.,,,		

5-9. POWER SUPPLY CHECK AND ADJUSTMENTS

5-10. There are four adjustable power supplies and seven supplies which are not adjustable. The supplies should be checked without a program loaded. To check and adjust the power supplies, proceed as follows:

WARNING

LOCATIONS AT LINE VOLTAGE ARE EXPOSED WHEN THE TOP COVER IS REMOVED AND POWER IS APPLIED. AVOID ELECTRICAL SHOCK. SERVICE AND ADJUSTMENTS SHOULD BE COMPLETED BY QUALIFIED SERVICE PERSONNEL.

- a. Disconnect primary power from the instrument. 5et the front panel switches as per paragraph 5-8.
- b. Remove top cover from IC tester.
- c. Remove power supply cover.
- d. Apply power to the 5045A. 8e sure the rear panel line selector settings matches the line voltage.
- e. Connect digital voltmeter and oscilloscope to each supply shown in the following table. 8 oard assembly numbers, test points and adjustment locations for the power supplies are marked on the power supply cover. Measure each supply using the chassis in the vicinity of power supply as ground. Adjust as required.
- f. Set front panel switch to MAN/HNDLR. Load any program card **BUT DO NOT PRESS**TEST
- g. Again measure the supplies and compare tolerances against the table shown below. When necessary, perform adjustments on the adjustable supplies.

Power Supply Voltages, Tolerances, and 120 Hz Ripple

Voltage		mbly and ustment	Tolerances	120 Hz Ripple	
+15	A1 None		±.75V	<100 mV	
-15	A1	None	±.5V	<100 mV	
+18	A1	None	±.9V	<100 mV	
-18	A1	R2	±.2V	<100 mV	
+8	A2	R2	±.2V	<100 mV	
-8	A2	R3	±.2V	<100 mV	
+12	A2		±.6V	<100 mV ·	
-12	A2		±.5V	<150 mV	
+5	A3	R3	±.05V	<200 mV	
-5	A3 A3		±.25V	<200 mV	
+18			±2V	<200 mV	

h. Using an oscilloscope, measure the ripple on each supply and verify that the tolerances are met.

NOTE

Re-install power supply cover before proceeding with other measurements.

5-11. A9 4 MHz CLOCK CHECK AND ADJUSTMENT

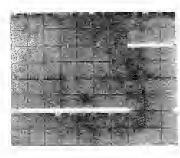
a. Connect frequency counter to A9TP4. Check that frequency is 4 MHz ±.01 MHz, if not adjust A9R4 for proper frequency.

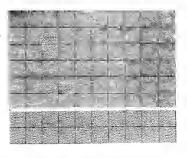
5-12. PRINTER GROUP ENABLE TIMING ADJUSTMENT

a. Set front-panel switches as follows:

START switch	 	 	AUTO
ON FAILURE switch	 	 	CONTINUE
PRINTER switch	 	 	ON

- b. Load "DAC REF CHECK" magnetic card.
- c. Using a 10:1 divider probe, connect oscilloscope to A26U2(7). Connect ground lead to A26U2(8).
- d. Set oscilloscope to .1 V/division and horizontal sweep to 1 msec/ division. Check that time between positive pulses (period) is 7 msec ±1 msec, if not, adjust A26R21 for proper period. See Figure A and B for proper waveform.





1 V/cm, 5 msec/div

1 V/cm, 1 msec/div

Figure A

Figure B

NOTE

The remaining adjustments should only be performed when there is an indication that adjusting is necessary rather than on a periodic basis.

5-13L A11 DAC VOLTAGE ADJUSTMENT

5-14 The A11 Adjustment Procedure requires the use of five pre-programmed magnetic test cards which are included in the Diagnostic Card Kit. These cards are:

"DAC REF CHECK"

"+/-V ZERO ADJUST"

"DAC V GAIN ADJUST"

"ERRENT GEN. PRESET ADJUST"

"+/- I ZERO 1-2 ADJUST"

- 5-15. Proper alignment of the A11 Reference Level Board depends on careful execution of the following procedure. During the adjustments, it will be necessary to record some measurements and make simple averaging calculations. A hand held calculator or scratch paper will be useful. This precise alignment technique is necessary to insure proper DAC offset and linearity. Note: Allow the 5045A to warm up for at least 20 minutes before making any A11 Reference Level Generator Adjustments.
- 5-16. The A11 Reference Level Generator (DAC) Adjustments are performed in 3 steps:
 - a. DAC Reference Adjustment
 - b. Voltage Generator Adjustment
 - c. Current Generator Adjustment

NOTE

All of the tests refer to 24-pin instruments. For 16-pin instruments, test points 9-16 will have no outputs and should not be measured.

5-17. DAC REF Adjustment

a. Set 5045A Front Panel 5witches:

```
START —— MAN/HNDLR
ON FAILURE —— HOLD
V and I RESULT5 —— DOWN
PRINTER —— ON
```

- b. Load "DAC REF CHECK"
- c. Remove Test Head Cover.
- d. Connect DVM ground lead on A30 TP25 (labeled 1).
- e. Center all pots on the A11 board.
- f. Press TEST. Measure voltage on A30 TP8. Adjust A11 "REF" pot for 7.5V ±5 mV.

5-18. Voltage Generator Adjustment

- 5-19. Note: Scratch paper or a Calculator will be useful. Some of the adjustments involve splitting voltage differences with the +V ZERO 1 and -V ZERO 1 pots (located on A11). Table 5-2 serves as an aid in recording measurements and calculating these differences. Make a copy of the table and fill it in as measurements are made. (Make a blank copy because the table may have to be used more than once.)
 - a. +V ZERO 2 Adjustment

Set Front Panel Switches as in paragraph 5-17 (a).

Load "+/-V ZERO 2 ADJUST."

Connect DVM ground lead to A30 TP25.

b. Press **TEST**. The following printout will be produced:

- c. Measure \pm V ZERO 2 pot to produce 0.00 \pm 5 mV on pin 8. Then verify that all other pins measure 0.00V \pm 10 mV.
- d. -V ZERO 2 Adjustment

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- e. Adjust -V ZERO 2 pot to produce 0.00 ± 5 mV on pin 8. Then verify that all other pins measure $0.00V \pm 10$ mV.
- f. +V GAIN (+6.5V) Adjustment
 Load "DAC V GAIN ADJUST"
- 8. Press TEST. The following printout will be produced:

- h. Adjust +V GAIN pot to produce 6.5V ±2 mV on pin 8.
- i. -V GAIN (-6.5V) Adjustment

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

j. Adjust -V GAIN pot to produce -6.5V ±2 mV on pin 8.

The following measurements involve splitting voltage differences. Use Table 5-2 as an aid in making calculations. Table 5-3 is an example of typical measurements. It will be helpful to study Table 5-3 before proceeding.

k. +V ZERO 1 (-6.5V)

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

La	4.	ZEE	0 1	
(-6.5V)) .	PASS		Ü
FAIL CORREC				
PIN				
STATE FAIL P	IN: Tart	1111	1. de de	ائىلىك ئار ئار
Light	5	6	1 1 1 1 1	(" 1 ₂₄
14	10 15	11	17	13
19	20	3.1	end the	fort to
Park Tollar				

I. Measure the voltage on pin 8 and record it under column A of Table 5-2 (line 1). Calculate the **DIFFERENCE** between -6.5V and the voltage recorded in A. For example (Table 5-3), if column A has -6.580, then the **DIFFERENCE** (.080V) is entered in column B. Next, enter 1/2 the difference in the "HALF DIFF" column. In the example this "HALF DIFF" is .040V. In the +V ZERO 1 Adjustment Column, enter the voltage from A plus the "HALF DIFFERENCE". In other words, split the difference between the voltage recorded in Column A and -6.5V by adjusting the +V ZERO 1 pot. In the example, -6.540V is entered. Note that the adjustment to +V ZERO 1 should always bring the output voltage closer to -6.5V level. If the adjustment moves the output further from -6.5V, then a sign error has been made in the calculations. Now that the desired +V ZERO 1 adjustment has been calculated, adjust the +V ZERO 1 pot for that voltage (pin 8).

m. -V ZERO 1 (+6.5V)

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- n. Measure voltage on pin 8 and record in Table 5-2 column A (line 2). Use the same procedure for calculating **DIFFERENCE**, **HALF DIFFERENCE**, and **-V ZERO** 1 level as was used in Paragraph 5-19 step (l). Note that in this test, the difference between the measured reading in column A and +6.5V must be calculated. After calculating the **-V ZERO** 1 level, adjust **-V ZERO** 1 pot for that voltage (pin 8).
- o. Now that +V ZERO 1 and -V ZERO 1 pots have been adjusted, it is necessary to trim the +V GAIN and -V GAIN levels. Press TEST twice. A "V GAIN (+6.5V)" printout will be produced. Measure the voltage on pin 8 and record in Table 5-2, column A (line 3). Calculate the "MAGNITUDE DIFFERENCE" and enter in column 8. In the "MAGNITUDE DIFFERENCE" column, note the two arrows, 1 and 1. Do not worry about the sign of the difference. Instead, use the arrows to indicate if the adjustment should increase (1) or decrease (1) the parameter in question. An example will help: for the +V GAIN (+6.5V) test, suppose a level of 6.542V is measured. This is recorded under column A. The "MAGNITUDE DIFFERENCE" is .042V and the adjustment direction is down (1). Under column 8, .042V is entered and the (1) arrow is circled. Make no adjustments at this time.
- p. Press ADVANCE TO FAIL. A "-V GAIN (-6.5V)" printout will be produced. Measure the voltage on pin 8 and record this level under column A of Table 5-2 (line 4). Determine the "MAGNITUDE DIFFERENCE" in the same manner as Paragraph 5-19 step (o). If -6.492V is measured, the "MAGNITUDE DIFFERENCE" is .008V. The direction for the "MAGNITUDE DIFFERENCE" is up (1), Therefore, .008V is recorded and the (1) arrow is circled in the "MAGNITUDE DIFFERENCE" column. Make no adjustments at this time.
- Press ADVANCE TO NEXT FAIL. A "+V ZERO 1 (-6.5V)" printout will be produced. Measure voltage on pin 8. Record level (line 5) and calculate "MAGNITUDE DIFFERENCE" as done in Paragraph 5-19 step (p). 8e sure to circle the appropriate arrow. Make no adjustments at this time.
- Press ADVANCE TO NEXT FAIL. A "-V ZERO 1 (+6.5V)" printout will be produced. Measure voltage on pin 8. Record level (line 6) and calculate "MAGNITUDE DIFFERENCE" as done in Paragraph 5-19 step (o). 8e sure to circle the appropriate arrow. Make no adjustments at this time.
- The four "MAGNITUDE DIFFERENCE" levels in Table 5-2 are labeled C, D, E, and F. It is now necessary to average these differences and calculate the adjustment required for trimming +V GAIN and -V GAIN.

t. ±V GAIN AVERAGE (line 7)

Take the two "MAGNITUDE DIFFERENCE" readings from C and E of Table 5-2 and add them. Take this sum and divide by 2 to find the "AVERAGE DIFFERENCE". Note that C and E should both have the same arrow direction († or ‡). The "AVERAGE DIFFERENCE" should also have the same arrow as C and E. Take the voltage recorded in column A (line 3) and add or subtract "AVERAGE DIFFERENCE" as necessary to bring this level closer to +6.5V. Press TEST twice. Measure voltage on pin 8 and adjust +V GAIN pot for the calculated level (should be close to +6.5V).

Use the following example for clarity. Refer to the sample chart, Table 5-3. Note that the "MAGNITUDE DIFFERENCES" for C and E are .042 \downarrow and .040 \downarrow respectively. The "AVERAGE DIFFERENCE" is .041V \downarrow . The +V GAIN (+6.5V) level recorded under column A (line 4) is +6.542V. The adjustment for +V gain is therefore 6.542V +.041V \downarrow = +6.501V (magnitude addition). In this example, after pressing TEST, the +V GAIN pot is adjusted to produce +6.501V on pin 8.

u. -V GAIN AVERAGE (line 8)

Press ADVANCE TO NEXT FAIL and adjust the -V GAIN pot for the correct level on pin 8.

Refer to the 5ample Test Record, Table 5-3 for an example. The "MAGNITUDE DIFFER-ENCE" is .009V \dagger . The -V GAIN (6.5V) level recorded under column A (line 4) is -6.492V. The adjustment for the -V GAIN pot is therefore $6.492 \pm .009 \pm -6.501$ V (magnitude addition).

v. It is now necessary to check all 4 levels to insure that the voltage generator is properly aligned. All measurements refer to pin 8.

Press TEST twice +GAIN (+6.5V) Measure +6.5V ±10 mV

Press ADVANCE TO NEXT FAIL -V GAIN (-6.5V)

Measure -6.5V ±10 mV

Press ADVANCE TO NEXT FAIL +V ZERO 1 (-6.5V)

Measure -6.5V \pm 10 mV

Press ADVANCE TO NEXT FAIL -V ZERO 1 (+6.5V)

Measure +6.5V ±10 mV

Note: Make no adjustments at this time.

w. +V ZERO 2 and -V ZERO 2 Check

Re-checking the $\pm V$ Zero 2 adjustments is necessary to insure that the voltage generator still has zero offset.

Repeat Paragraph 5-19 steps (a thru e) and readjust if necessary. If the $\pm V$ Zero 2 pots require adjustment, then, after adjusting, repeat step v above. Then proceed to step x.

x. If any of the limits measured in step v above could not be met, then a second pass at the voltage adjustments must be made. **DO NOT CENTER ANY OF THE POTS!** The second pass uses the same procedure and fine tunes the adjustments. Perform steps f through w under Paragraph 5-19 if a second pass is necessary. Use a new copy of Table 5-2 and proceed as before.

Verification of Voltage Adjustments

After all adjustments have been made, a verification of performance for all pins must be executed. Use the procedure in step v and w to verify voltage levels for all pins. Make measurements on A30 test points 1-24. If necessary, repeat second pass according to Paragraph 5-19 step x.

Final limits for all pins (Test Points 1-24).*

+V GAIN (+6.5V) +6.5V = 10 mV -V GAIN (-6.5V) -6.5V ±10 mV +V ZERO 1 (-6.5V) -6.5V ±10 mV -V ZERO 1 (+6.5V) +6.5V ±10 mV

5-20. Current Generator Adjustment

Equipment Required:

HP 3465A or equivalent 4-1/2 Digit Current Meter 10 μ A, 200 mA Ranges

- a. Set front panel switches according to Paragraph 5-17 step (a).
- b. Remove Test Gead cover (if not already done). Connect ammeter ground lead to A30TP25 (marked 4). Set ammeter to measure 10 mA level.
- c. Center ±1 ZERO 1 and ±1 ZERO 2 pots (if not already done).
- d. Load "CURRENT GEN. PRESET ADJUST". Press TEST. The following printout will be produced:

e. Measure current on pin 8. Adjust +1 ZERO 2 pot to produce 10 mA \pm 0.2 mA.

^{*}Note: For 16-pin instrument, test points 9-16 will have no outputs and should not be measured.

f. Press ADVANCE TO NEXT FAIL. The following printout will be produced:

```
TEST: ADJ.-I ZEROZ
FOR -10MA
FAIL
         1PASS
CORRECT 00000000000000
STATE 1>00000000000000
FAIL FIM: 1
              (m) (m)
     124.
1-1-1
                  (")
  4
          és.
  9 10 11 12 13
 14
     15 16 17 19
     20 21 25 23
 19
  24
```

- g. Measure current on pin 8. Adjust -1 ZERO 2 to produce -10 mA \pm 0.2 mA.
- h. Load "+/-I ZERO 1-2 ADJUST." Press TEST. The following printout will be produced:

- i. Measure current and adjust +I ZERO 1 pot to produce +10 μ A ±.1 μ A on pin 8. Then verify that all other pins measure +10 μ A ±5 μ A. If necessary, the spec on pin 8 maybe relaxed to +10 μ A ±5 μ A to meet tolerance on all other pins.
- j. Press ADVANCE TO NEXT FAIL. The following printout will be produced:

k. Measure current and adjust -I ZERO 1 pot to produce -10 μ A \pm .1 μ A on pin 8. Then verify that all other pins measure -10 μ A \pm 5 μ A. If necessary, the spec on pin 8 may be relaxed to -10 μ A \pm 5 μ A to meet tolerance on all pins.

Press ADVANCE TO NEXT FAIL. The following printout will be produced:

- m. Measure current and adjust ± 1 ZERO 2 pot to produce $\pm 10~\mu A \pm .1~\mu A$ on pin 8. Then verify that all other pins measure $\pm 10~\mu A \pm 2.5~\mu A$. If necessary, the spec on pin 8 may be relaxed to $\pm 10~\mu A \pm 2.5~\mu A$ to meet tolerance on all pins.
- n. Press ADVANCE TO NEXT FAIL. The following printout will be produced:

o. Measure current and adjust -1 ZERO 2 pot to produce -10 μ A \pm .1 on pin 8. Then verify that all other pins measure -10 μ A \pm 2.5 μ A. If necessary, the spec on pin 8 may be relaxed to -10 μ A \pm 2.5 μ A to meet tolerance on all pins.

P. VERIFICATION OF CURRENT ADJUSTMENTS

Verify that limits are met for all pins.

Note: This step may be deleted if all limits were met under steps h through j above.

Press **TEST** +1 **Zero** 1 +10 -A Verify: 10 μ A \pm 5 μ A

Press ADVANCE TO NEXT FAIL -I ZERO 1 -10 μ A Verify -10 μ A \pm 5 μ A for all pins.

p. VERIFICATION OF CURRENT ADJUSTMENTS (Continued)

Press ADVANCE TO NEXT FAIL +1 Zero 2 +10 μ A Verify +10 μ A ±2.5 μ A for all pins.

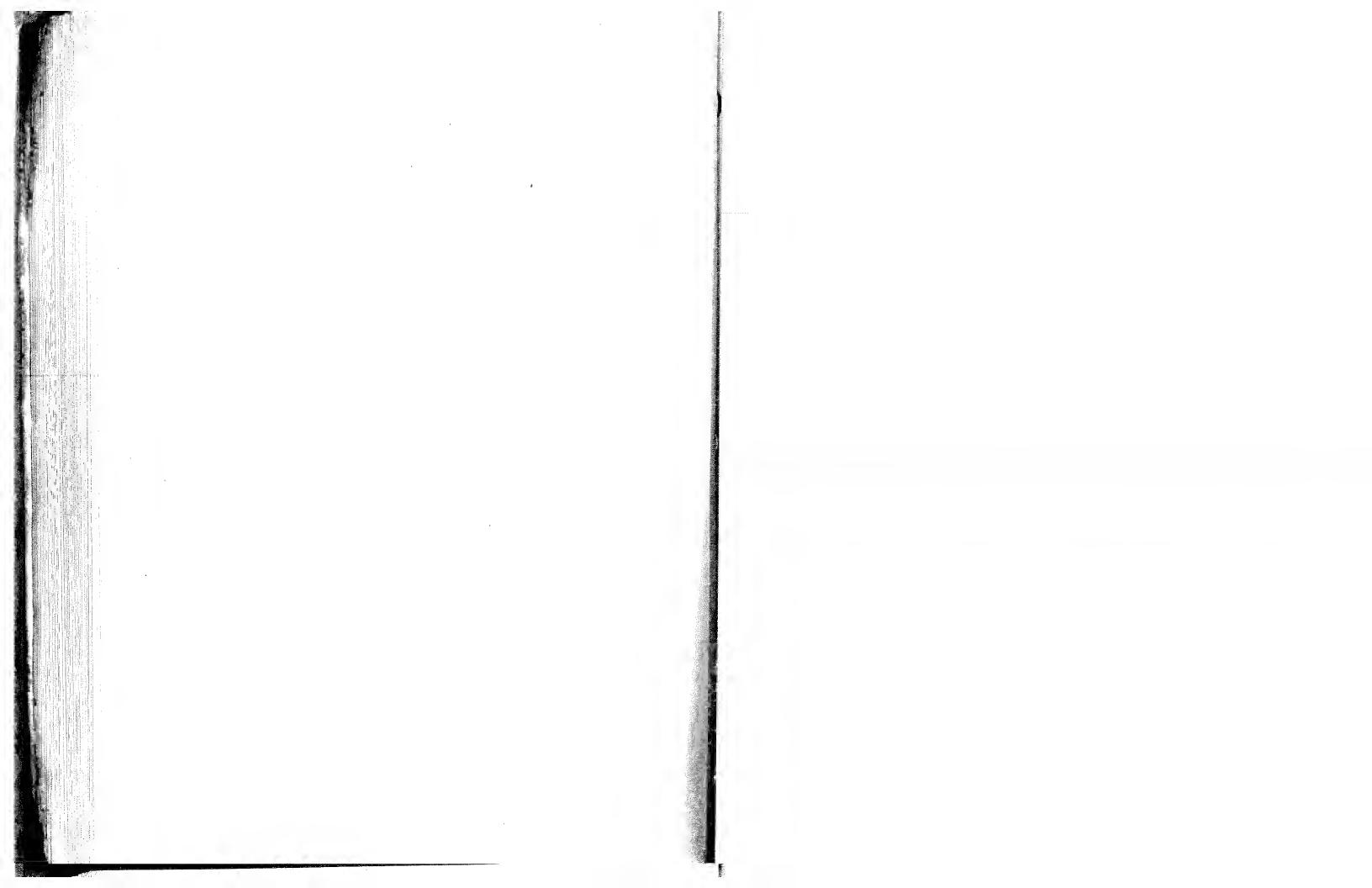
Press ADVANCE TO NEXT FAIL -1 ZERO 2 -10 μ A Verify -10 μ A ± 2.5 μ A for all pins.

If all limits cannot be met, then repeat steps h through p above as many times as necessary. DO NOT center the pots when making a second pass through the adjustments.

5-21. Successful completion of the DAC Reference Adjustment, Voltage Generator Adjustment, and Current Generator Adjustment results in proper calibration of the A11 Reference Level Generator (DAC). All Performance Tests should be run in order to verify instrument specs.

Tak	de	5-2	Blank	Test	Aid
111	11 -	3-2	Diam		

TEST SEQUENCE Press TEST. +V ZERO 1 (-6.5V)	MEASURED VOLTAGE	B DIFFERENCE (-6.5V -A)	HALF DIFFERENCE (B/2)	± V ZERO 1 AD USTMENT (A + B/2) Adj +V ZERO 1 to V.	
	>	(+6.5V -A)	(B/2)	(A + B/2) Adj -V ZERO 1 to V.	
ES D	>	C Magnitude Difference Magnitude Difference	NOTE: Circle the ap	NOTE: Circle the appropriate arrow (♠ or ♦)	Table 5-2
Line 4 -V GAIN (-6.5V) Press ADVANCE TO NEXT FAIL	>	E Magnitude Difference	to indicate li adjustment.	to indicate Increase (4) or Decrease (7) adjustment. See text.	Blank resi
Line 5 +V ZERO 1 (-6.5V) Press ADVANCE TO NEXT FAIL	> >	F Magnitude Difference			Ald
Line 7 +V GAIN AVERAGE	Average = $\frac{C + E}{2}$ Note: C and E s	= C + E Average V Adj + V GAIN to C and E should have same arrow direction.	SAIN to Irrow direction.	Press TEST. Measure V. increase ↓ or Decrease ▼ V. Output by Average.	
Line 8 -V GAIN AVERAGE	Average = $\frac{D+}{2}$ Note: D and F	Adj -V GAIN to F should have same arrow direction.	V ♠ ♥ SAIN to arrow direction.	Press ADVANCE TO NEXT FAIL. Measure V. Increase V. or Decrease V. Output by Average.	-



Nouei 3043/A Replaceable Parts

SECTION VI REPLACEABLE PARTS

6-1. INTRODUCTION

- 6-2. This section contains information for ordering replacement parts. Table 6-1 lists parts in alphanumerical order of their reference designators and indicates the description and HP Part Number of each part, together with any applicable notes. The table includes the following information.
 - a. Description of part (see abbreviations below).
 - b. Typical manufacturer of the part in a five-digit code; see list of manufacturers in Table 6-2.
 - c. Manufacturer's part number.
 - d. Total quantity used in the instrument (Qty column).

			REFERENCE D	ESIGNA	TIONS		
			= micellaneous electrical	MP	= miscellaneous	TP	= test point
ÂŦ	 assembly attenuator; isolator; 	E	part = micenarieous electricus		mechanical part	U	= Integrated circuit;
	termination	-	= fuse	. P	= electrical connector:		microcircult
8	= fan: motor	FL FL	= filter=:		(movable portion);	٧	= electron tube
er .	= battery	North Control	= hardware		plug	VR	= voitage regulator;
C.	# capacitor	HY	= circulator	Q	= transistor; SCR; triode		breakdown diode .
CP .	= coupler		= electrical connector	· .	thyristor	W	= cable; transmission
COR .	= diode; diode thyristor;	d	(stationary portion);	R .	= resistor:		path; wire
	varactor	55.5	lack	BT	= thermistor	X	= socket
DC	directional coupler			S	= switch	Υ	= crystal unit-plezo-
OL	* delay line	к	= relav	Ť	= transformer		electric
08	= annunciator; signaling		= coil: inductor	TB	= terminal board	Z.	= tuned cavity; tuned
T. Sec.	device (audible or	M	= meter	TG	= thermocouple		circuit
	visual); lamp; LED			-			
							*
			ABBREV	IATIONS			
	* ampere	8CD:	= binary coded decimal	COMP	= composition	«K	= degree Kelvln
	* alternating current	BD	= board	COMPL	= complete	DEFC	= deposited carbon
	* accessory	BE CU	= pervilium copper	CONN	= connector	DET	= detector
	* adjustment	BFO	= beat frequency	CP	≃ cadmium piate	diam	= diameter
	a analog-to-digital		oscillator	CRT	= cathode-ray tube	DIA - ΄,	= diameter (used In
****	# atudio frequency	вн 🗥 🖰	= binder head	CTL	= complementary tran-		parts::ilst)-
1	* automatic frequency	BKDN	- □ = breakdown		sistor logic	DIFF	
	control	BP .	= bandpass	CW	= continuous wave	AMPL	 differential amplifier
	* Automatic gain control	BPF	= bandpass filter	cw	 clockwise 	div.	= division
No.	* Wuminum	BAS 1	= brass	D/A	= digital-to-analog	DPDT	= double-pole, double-
	* #utomatic level control	BWO	= backward-wave	dB	= decibel "		throw
/m	* amplitude modulation		- n oscillator	dBm	= decibel referred to	DR	= drive
	* amplifier	CAL	= calibrate		-1 mW	DSB	= double sideband
	* * ** ** ** ** ** ** ** ** ** ** ** **	ECW	= counterclockwise:	dc:	= direct current	DTL	 diode transistor logic
	COntrol	CER	= ceramic	deg	= degree (temperature	DVM	= digital voltmeter
W. Williams	* Bosembly	CHAN	= channel	•	interval or difference)	EGL	= emitter coupled logic:
WAR IS	* auditry	cm	= centimeter	•	= degree (plane angle)	EMF	= electromotive force
- A	* average	CMO	= coaxial-	۰ċ	= degree Celsius	EDP	= electronic data
W. 74	* *** wire gauge	COEF	= coefficient-		(centrigrade)		processing
	*belance	COM	= common	٥F	= degree Fahrenheit	ELECT	= electrolytic

6-1

A ALMAI FOAFA

ABBREVIATIONS (CONTINUED)

			(6) = 0	PIV	= peak inverse voltage	TFT		ilm transi	stor
ENCAP	= encapsulated	Thirti	minute (time)		= peak	TGL	= toggi		
EXT	= external	***	minute (plane angle)		= phase lock	THD	= thread		
F	= larad	14114	= minizture = miltimeter	PLO	= phase lock oscillator	THRU	= throu	-	
FET	= field-effect transistor	111111		PM	= phase modulation	र।	≃ tifanit		
F/F	= flip-flop	14100	= modulafor		= positive-negative~	TOL	= tolera		
FH	= flaf head		= momentary = metal-oxide semi-		positive	TRIM	= trimm		
FOLH	= fillister head	MOS	conductor	P/O	= part of	TSTR	= Iransi		-1-4
FM	= frequency modulation		= millisecond	POLY	= polystyrene	TTL		stor-tran	sistor
FP	= tront panel	1110	= mounting	PORC	= porcelain		logic		
FREQ	= frequency	.,,,,	= mounting = meter (indicating	POS	= positive; position(s)	TV	= televi		· favanan
FXD	= fixed	MTR	device)		(used in parts list)	TVI		sion Inter	
g	= gram	-mld	= millivolt	POSN	= position	TWT		ing wave (10°°) (t	
GE	□ germanium	111.	= mittivolt, ac	POT	= potentiometer	U			2560 III
GHz	= gigahertz	1111444	= millivott, dc	p-p	= peak-to-peak		parfs		and In
GL	∞ glass	,,,,	= millivott, peak	PP	= peak-to-peak (used in	UF		ofarad (US	900 III
GND	= ground(ed)	1137 6.1	= millivolt, peak-to-peak		parts lisf)		parts	nigh fregi	Innev
H	= henry	mVp-p mVrms	= millivolt, rms	PPM	= pulse-position	UHF		gulafed	acticy
h	= hour		= milliwalt		modulation	UNREG	= volf	guiaieu	
HET	= heterodyne	mW MID	= multiplex	PREAMPL	= preamplifier	٧	= voita	mnara	
HEX	= hexagonal	MUX	= mylar	PRF	= pulse-repetition	AV	= voita		
HD	= head	MY	= microampere		frequency	Vac	= voits = varia		
HDW	= hardware	μA μ F	= microfarad	PRR	 pulse repetition rate 	VAR		une ge-contri	olled
HF	high frequency	-	= microhenry	ps	= picosecond	ACO	oscil		Olica
HG	= mercury	μH	= micromho	PT	= point	164-			
н	= hìgh	μmho	= microsecond	PTM	= pulse-time modulation	Vdc	= volts		ing (weed
HP	= Hewlett-Packard	μs	= microvolt	PWM	 pulse-width modulation 	VDCW		dc. work	ang tuseu
HPF	= high pass filter	μ ∨	= microvoit, ac	PWV	 peak working voltage 			irts list)	
ня	= hour (used in parts list)	μVac	= microvoit, dc	RC	= resistance capacitance	V(F)		, filtered	10001
HV	= high voltage	μVdc	= microvoit, geak	RECT	= rectifier	VFO		ible-frequ	Jency
Hz	= Hertz	μVok	= microvolt, peak-to-	REF	= reference			lator	
IC	= integrated circuit	µVp−p		REG		VHF		-high free	quency
ΙD	= inside diameter		peak	REPL	= replaceable	Vpk	= volts		
iF	= intermediate frequency	μ∨rms	= microvolt, rms	RF	= radio frequency	Vp~p		s peak-to	-реак
IMPG	= impregnated	μW	= microwatt	RFI	= radio frequency	Vrms	= volts		
in	= inch	nA	= nanoampere	* **	interference	VSWR		ige stand	ing wave
INCD	= incandescent	NC	= no connection	RH	= round head; right hand		ratio		
INCL	= include(s)	N/C	= normally closed	RLC	= resistance-inductance-	VTO			d oscillator
INP	= input	NE	= peon	rico	capacitance	VTVM		Jum-tube	
INS	= insulation	NEG	= negative	RMO	= rack mount only	V(X)	= volt:	s, switche	ed `
INT	= internal	nF	= nanofarad	rms	= root-mean-square	W	= wat	:	
8	= kilogram	Nf PL	= nickel plate	AND	= round	W/	≂ with		1.
kg kHz	= kilohertz	N/O	= normatly open	ROM	= read-only memory	WIV	= wor	king inve	rse voltage
kΩ	= kilohm	NOM	= nominal	R&P	= rack and panel	ww	= wire	wound	7
K7T	= kilovolt	NORM	= normal	RWV	= reverse working voltage	W/O	= with	out	
1	= pound	NPN	= negative-positive-	S	= scattering parameter	YIG	= yttr	ium-iron-	garnet 📜
lb .	= inductance-capacitance		negative		= second (time)	Zo	= cha	racteristic	3
LC LED	= light-emitting diade	NPO	= negative-positive zero	S	= second (plane angle)		imp	edance	4
	= low frequency		(zero temperature		= slow-blow (fuse (used				3
L.F	= long		coefficient)	S-B	in parts list)				
LG	= left hand	NRFR	= not recommended for	con	= silicon controlled				88
I LH	= fimit		field replacement	SCR	rectifier; screw		NO	TE	
LIM	= linear taper (used in	NSR	= not separately		= selenium			na in the p	arts list
LIN			replaceable	SE		Allab	Dreviatio	ng (n ure y	. 3
1	parts list) = iinear	กร	= nanosecond	SECT	= sections	WIIE	e in upp	o. ourse.	
IIn		nW	= nanowaif	SEMICON	 semiconductor superhigh frequency 				. 2
LK WAS	SH = lockwasher = tow; local oscillator	OBO	= order by description	SHF					
LO	= fow; local defination = logarithmic taper	00	outside dlamefer	SI	= silicon				
LOG	(used in parts list)	ОН	= oval head	SIL	= sijvsr				
		OP AMPL	. ≃ operatioπal amplifier	SL	= siide				
log	= logarithm(ic)	OPT	= option	SNR	= signal-to-noise ratio	A	AULT	IPLIE	нь 🦠
LPF	= low pass filter	osc	= oscillator	SPDT	= single-pole, double-	.,			· :
LV	= tow voltage	OX	= oxìde		throw				va diinia
§ m	= meter (distance)	oz	= ounce	SPG	= spring	Abbre	viation	Prefix	Multiple
mA	= milliampere	Ω	= ohm	SR	= split ring		•	tera	1012
MAX	= maximum	P	= peak (used in parts	SPST	= single-pole, single-		T G	giga	101
мΩ	= megohm	•	(ist)		throw			mega	10"
MEG	= meg (10°) (used in	PAM	= pulse-amplitude	SSB	» single sideband		VI.	kilo	109
1	parts list)	r varas	modulation	SST	= stainless steel		k	deka	10
MET F		PC	≥ printed circuit	STL	= steel		ia.	deci	10→
MET	OX = metal oxide	PCM	= pulse-code moudulation;	SQ	= square		d	centi	10-
MF	= medium frequency;	L CiAI	pulse-count modulation	SWR	= standing-wave ratio		c	milli	10-3
1	microfared (used in	10/1044	≈ oulse-duration	-SYNC	= synchronize		m	micro	10-6
	parts list)	PDM	modulation	T	= timed (slow-blow fuse)		μ	nano	10**
MFB	= manufacturer		= oicofarad	TA	= tantalum		n		10-12
mg	= milligram	pF	= phosphor bronze	TC	= temperature		p	pico temto	10-16
MHz	= megahertz	PH BRZ	= phospilor bronze = Phillips		compensating		f		10-18
mН	= millihenry	PHL	= Phillips = positive-instrinsic-	TD	= time delay		а	atto	N. A.
mho	= mino	PIN	negative	TERM	= terminal				, 163
MIN	= នារិតាំកាបកា		negative						

6-2



6-3. ORDERING INFORMATION

- 6-4. To obtain replacement parts, address order of inquiry to your local Hewlett-Packard Sales and Service Office (see lists at rear of this manual for addresses). Identify parts by their Hewlett-Packard part numbers.
 - a. Instrument model number.
 - b. Instrument serial number.
 - c. Description of the part.
 - d. Function and location of the part.

6-5. HP PART NUMBER ORGANIZATION

6-6. Following is a general description of the HP part number system.

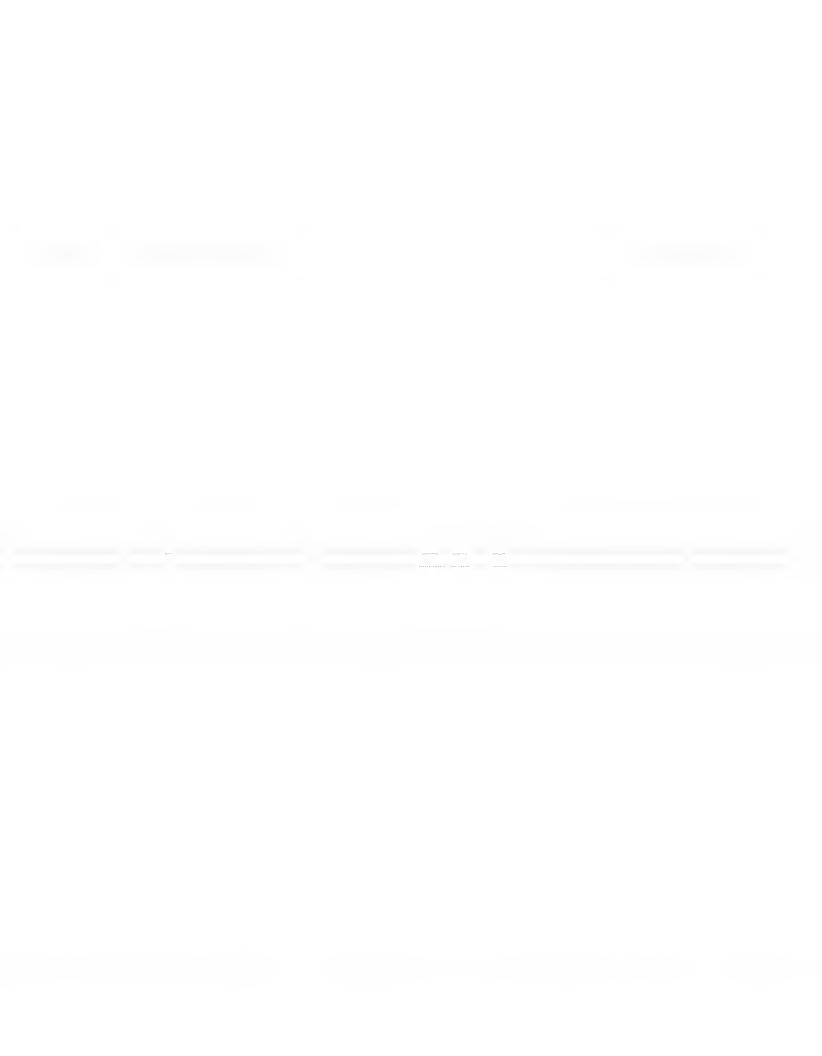
6-7. Component Parts and Materials

6-8. Generally, the prefix of HP part numbers identifies the type of device. Eight digit part numbers are used, where the four digit prefix identifies the type of component, part, or material and the four digit suffix indicates the specific type. Following is a list of some of the more commonly used prefixes for component parts. The list includes HP manufactured parts and purchased parts.

Prefix	Component/Part/Material
0121-	Capacitors, Variable (mechanical)
0122-	Capacitors, Voltage Variable (semiconductor)
0140-	Capacitors, Fixed
0150-	Capacitors, Fixed - Non-Electrolytic
0160-	Capacitors, Fixed
-0810	Capacitors, Fixed Electrolytic
0330-	Insulating Materials
0340-	Insulators, Formed
0370-	Knobs, Control
0380-	Spacers and Standoffs
0410-	Crystals
0470-	Adhesives
0490-	Relays
0510	Fasteners
0674- thru 0778-	Resistors, Fixed (non wire wound)
0811- thru 0831-	Resistors (wire wound)
1200-	Sockets for components
1205-	Heat Sinks
1250-	Connectors (RF and related parts)
1251-	Connectors (non RF and related parts)
1410-	Bearings and Bushings
1420-	Batteries
1820-	Monolithic Digital Integrated Circuits
1826-	Monolithic Linear Integrated Circuits
1850–	Transistors, Germanium PNP
1851–	Transistors, Germanium NPN
1853–	Transistors, Silicon PNP
1854–	Transistors, Silicon NPN
1855–	Field-Effect-Transistors
1900- thru 1912-	Diodes

6-3

A 4 . A.I MAGA



Prefix	Component/Part/Material
1920- thru 1952- 1990- 3100- thru 3106- 8120- 9100-	Vacuum Tubes Semiconductor Photosensitive and Light-Emitting Diodes Switches Cables Transformers, Coils, Chokes, Inductors, and Filters

6-9. For example, 1854-0037, 1854-0221, and 1851-0192 are all NPN transistors. The first two are silicon and the last is germanium.

6-10. General Usage Parts

6-11. The following list gives the prefixes for HP manufactured parts used in several instruments, e.g., side frames, feet, top and bottom covers, etc. These are eight-digit part numbers with the four-digit prefix identifying the type of parts as shown below:

Type of Part	Prefix
Sheet Metal	5000- to 5019-
Machined	5020- to 5039-
Molded	5040- to 5059-
Assemblies	5060- to 5079-
Components	5080- to 5099-

6-12. Specific Instrument Parts

6-13. These are HP manufactured parts for use in individual instruments or series of instruments. For these parts, the prefix indicates the instrument and the suffix indicates the type of part. For example, 05328-60001 is an assembly used in the 5328A. Following is a list of suffixes commonly used.

Type of Part	P/N Suffix
Sheet Metal	-00000 to -00499
Machined	-20000 to -20499
Molded	-40000 to -40499
Assembly	-60000 to -60499
Component	-80000 to -80299
Documentation	-90000 to -90249

Table 6-1. Replaceable Parts

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A 1	05045-60001	6	1	BOARD ASSEMBLY, -15V/18V REGULATOR (SERIES 1852)	26480	ŋ5g45=6gvij1
A 1 0 1 A 1 0 2 A 1 0 2 A 1 0 4 A 1 0 5	0180=0578 0159=0121 0180=1735 0189=0117 0180=0117	95322	1 11 4 2	CAPACITOR-FXD 750UF+75-10% 4690C AL CAPACITOR-FXD .10F +86-20% 5690C CER CAPACITOR-FXD .22UF+10% 3590C TA CAPACITOR-FXD 2.7UF+-10% 3590C TA CAPACITOR-FXD 2.7UF+-10% 3590C TA	56289 28460 56289 56289 56289	3907575444644 0150=0121 1500224494542 1500275X903582 1500275X903582
A506 A107 A108 A109	0160-0127 0180-1735 0180-0127 0180-0121	SERVE	29	CAPACITOR-FXD 1UF +=20% 25VDC CEP CAPACITOR-FXD 22UF+=1U% 35VDC TA CAPACITOR-FXD 1UF +=20% 25VDC CER CAPACITOR-FXD 1UF +80=20% 50VOC CER	59480 58480 58588 58480	0160=0127 \$500224x9035A2 v160=0127 0150=0121
A1CR1 A1CR2	1901=0638 1901=0638	3	3	DIODE-FW BRDG 100V 4A DIODE-FW BRDG 100V 4A	94713 94713	MUA=970+2 MUA=970+2
A1R1 A1R2	0698=0083 2100=1757	9	1 2	RESISTOR 1,96% 1% _125W F TC=0+=100 RESISTOR+TRMR 500 5% WW SIDE=60J 1-TRN	24546 28480	C4=1/8=10=1961=F 2109=1757
A17P1 A17P2 A17P3 A17P4	0360-1662 0360-1662 0360-1662 0360-1662	0 0 0	de disease	TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	28480 28480 28480	0500*1552 0560=1562 0560=1552
A1U1 A1U2 A1U3 A1U4	1826=0233 1826=0126 1826=0169 1826=0203	4 5 8	1 1 1	IC V RGLTR TO=3 IC 7818 V RGLTR TO=3 IC V RGLTR TO=3 IC 7815 V RGLTR TO=3	27014 04713 27014 47263	L™226K=15 ₩C7H18CK L™32BK=15 7815KC
	0340=0596 1205=0291 1480=0116 4040=0749	1 20 00 4	12 5 26 4	INSULATOR=XSTR SIL-RBR HEAT SINK ID-3-PKG PIN-GRV .062-IN-DIA .25-IN-LG SIL EXTR-PC BD BRN POLYC .062-BD-IHKNS	28480 28480 28480 28480	0340+0595 1205-0293 1480+0116 4640+0749
*5	05045-60002	7	í	BOARD ASSEMBLY, 7.5/12V REGULATOR (SERIES 1852)	28480	Q\$Q 4\$= 6V0V2
A2C1 A2C2 A2C3 A2C4 A2C4	0160w0127 0180w0197 0180w0197 0160w0127 0180w1735	20000	5	CAPACITOR=FXO 1UF +=20% 25VDC CER CAPACITOR=FXD 2,2UF+=1U% 20VDC TA CAPACITOR=FXD 2,2UF+=1U% 20VDC TA CAPACITOR=FXD 1UF +=20% 25VDC CER CAPACITOR=FXD ,22UF+=1U% 35VDC TA	28480 56269 56269 28480 56289	1500224x9030A2 1500225x9030A2 1500225x9030A2 1500224x9035A2
A2C6 A2C7 A2C8	0150=0121 0180=1735 0150=0121	5 2 5		CAPACITOR-FXD .1UF +80-20% 50VDC CER CAPACITOR-FXD .22UF+10% 35VDC TA CAPACITOR-FXD .1UF +80-20% 50VDC CER	28480 56289 28480	0150*0121 1500224x9035A2 0150*0121
A2CA1	1901=0638	3	•	DIODE-FW BRDG 100V 4A	64713	MDA+970=2
4281 4282 4283	0757-0284 2100-1755 2100-1755 0698-3443	7 0 0	2	RESISTOR 150 1% ,125w F TC=0+100 RESISTOR=1RMR 100 5% WW SIDE=ADJ 1+TRN RESISTOR=TRMR 100 5% RW SIDE=ADJ 1-TRN RESISTUR 287 1% ,125w F TC=U+-100	24546 28480 28480 24546	C0=1/8-T0=151=F 2100=1755 2100=1755 C4=1/8-T0=287<=F
AZIPA AZIPA AZIPA	0360-1682 0360-1682 0360-1682 0360-1682	0 0		TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	28480 28480 28480 58480	0569-1586 0569-1586 0560-1586 0560-1588
\$50# \$505 \$503 \$501	1826=0160 1826=0235 1826=0117 1826=0202	6 3 7	1	IC V RGLTR TO=3 IC V RGLTR TO=3 IC 7812 V RGLTR TO=3 IC V RGLTR TO=3	07263 27014 07263 27014	7896KC L*20X=12 7612KC L*320X=115
	0340=0596 1205=0290 1205=0291 1480=0116 4040=0750	17887		INSULATOR-XSTR SIL=RBR MEAT SINK TO-3-PKG HEAT SINK TO-3-PKG PIN-GRV _062-IN-DIA _25-IN-LG STL EXTR-PC 80 RED POLYC _062-RU-IMKVS	26480 26480 26480 26480	0349=0598 1205-0290 1205-0291 1480-0115 4040-0754
	1205=038;	7	1	HEAT SINK SGL TD=3-CS	30161	2n50
	05045=60003	A	5	BOARD ASSEMBLY, +5/18V REGULATOR (SERIES 1520)	56480	05045+60003
#103 #103 #103 #103 #103	0160-3456 0160-3679 0160-0127 0160-0155 0160-0574	67283	3	CAPACITOR-FXO 1000PF +-10X 1AVOC CER CAPACITOR-FXD ,81UF +-20X 100VDC CER CAPACITOR-FXD 1UF +-20X 25VDC CER CAPACITOR-FXD 2,20F+-20X 20VDC TA CAPACITOR+FXD ,025UF +-20X 100VDC CER	58480 58480 58480 58480	0160-3456 0160-127 1500225x0420A2 a160-0574
APCE SECT SECT.	0160-0127 0160-0116 0160-1912	2 1 7	4	CAPACITOP-FXD 1UF +-20% 25VDC CER CAPACITOR-FXD 6.8UF+-10% 35VDC 7A CAPACITOP-FXR 120UUF+75-10% bVDC AL	28460 56289 56289	39915×6000544 1500683×903585
		1	-			



Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part Number	C	Qty	,]	Description	Mfr Code	Mfr Part Number
Designation A3CR1 A3CR2 A3CR3 A3CR4	1901=0033 1902=3036 1902=3036 1902=0079 1901=0040	2338	1 2 1 9	IQ .	ODE-GEN PRP 180V Z00M4 U0-7 ODE-ZNR 3,16V 5% D0-7 PD=,4W TC=-,954% ODE-ZNR 3,16V 5% D0-7 PD=,4W TC=+,054% ODE-ZNR 20V 2% D0-14 PD=,4W TC=+,08% COE-SWITCHING 30V 50M4 2NS D0=35	\$8480 \$9480 \$9480 \$9480 \$8480	1901-0053 1902-3050 1902-3050 1902-0079 1901-0040
A3CR5 A3G1	1884=0217 1854=0671	6		1 TF	HYRISTOR-TRIAC PANSISTOR NPN 2N6282 SI TO-3 PD#160M	04713	MAC-10md 2N6282
A3G1 A3G2 A3R3 A3R3 A3R4	0757=0921 0757=0948 0757=0932 0757=0948 0757=0900	90204	1	2 RE 2 RE 2 RE 6 RE	ESISTOR 750 2% .125% F FCm0+m100 ESISTOR 10% 2% .125% F FCm0+-100 ESISTOR 2.2% 2% .125% F FCm0+-100 ESISTOR 10% 2% .125% F FCm0+-100 ESISTOR 100 2% .125% F FCm0+-100 ESISTOR 100 2% .125% F FCm0+-100	54249 54249 54249	C4=1/8=10=751=6 C4=1/6=10=1002=6 C4=1/8=10=201=6 C4=1/8=10=1002=6 C4=1/8=10=101=6 C4=1/8=10=471=6
A3R5 A3R5 A3R7 A3R8 A3R8	0757-0916 0757-0916 0811-3333 0757-0961 0811-3332	2 2 9 7 8		R R	ESISTOR 470 2% .125% F IC%0+-100 ESISTOR 470 2% .125% F IC=0+-100 ESISTOR .05 3% 2W PWW IC%0+-150 ESISTOR 36% 2% .125% F IC%0+-100 ESISTON .025 1% 5% PW IC%0+-150	24546 24546 28460 28460	C4-1/8-10-471-4 U811-333 C4-1/8-10-3-02-6 U811-3332
A3R11 A3R11 A3R12 A3R13 A3R14	0686=1005 0811=3333 2100=1757 0757=0913	2 5 5 1		1 R	ESISTOR 10 5% 5% CC TC=0+412 ESISTOR .05 3% 2W PWW TC=0+150 REBISTOR=TRWR 500 5% WW SIDE=ADJ 1=TRN RESISTOR 360 2% .125W F TC=0+-100	01121 28480 28480 24546	0611=333 2100=1757 C4=1/8=7U=351=G
A3TP1 A3TP2 A3TP3 A3TP4	0360=1682 0360=1682 0360=1682	0 0 0		1 1	TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG TERMINAL-STUD SGL-TUR PRESS-MTG	28480 28480 28480	0360*1682 0360*1682 0360*1682
43U1 43U2 43U3	1820-0439 1820-0216 1826-0202	0	. [1	IC Y RGLTR 14-D1P-P OP AMP GP 8-D1P-P IC V PGLTR 10-3	07263 28480 27014 28480	1820=0216 L4320K=05 0340=0596
	0340 m0596 1205 m0266 1205 m0291 1460 m0116 4640 m0751	16	3	1	INSULATOR=XSTR SIL-RBR HEAT SINK SGL TO=3-PKG HEAT SINK TO-1-PKG PIN=GRV .052-IN-DIA .25-IN-LG STL EXTR-PC BD URN POLYC .062-80-THKNS	28480 28480 28480 28480	1205-0200 1205-0291 1880-00160 4040-0751
Au	05045∞6001	4	•	1	BOARD ASSEMBLY, ARITHMETIC LOG (SERIES 1520)	28480 56289	05045-60004 1500335×0015A2
A4CI	0180-0210		6	10	CAPACITOR-FXD 3,3UF+=20% 15VDC TA	24546	Ca-1/8-10-5101-G
A4R2	0757=0981 0757=0941 0757=0941		3 3	30	RESISTOR 5.1K 2% .125% F TC#0+-100 RESISTOR 5.1K 2% .125% F TC#0+-100 RESISTOR 5.1K 2% .125% F TC#0+-100	24546 24546	C4=1/8=T0=5101=G C4=1/8=T0=5101=G
4473 44U3 44U3 44U4	1820-0374 1820-0368 1820-0368 1820-0368 1820-0328		2 4 4 6	18 8	IC FF ITL O-TYPE PDS-EDGE-TFIG CLEAR IC SHF-RGIR ITL R-S PRL-IN PRL-OUT 5-811 IC SHF-RGIR ITL R-S PRL-IN PRL-OUT 5-811 IC SHF-RGIR ITL PS PRL-IN PRL-OUT 5-811 IC GATE TTL NDR GUAD 2-INP	01295 01295	5N7474N SN7496N SN7496N SN7496N SN7402N
A4U6 A4U7 A4U8 A4U9	1820=054 1820=062 1820=060 1820=07 1820=078		0 3 2 6	1 2 1	IC CNIR TIL BIN UP/DOWN SYNCHRO IC FF TIL S J=K NEG=EDGE=TRIG IC ARIHH-LGC=UN TIL 3-BII IC FF TIL D=TYPE POS=CUGE=TRIG CLEAR IC GATE TIL NUR TPL 3-INP	01295 01295 01295 01295 01295	9M7474N 6N7427N
A4U10 A4U12 A4U13 A4U13	1820-030 1820-061 1820-017 1820-006	1 6 4 8	5	1 5 2 2	IC LCH TYL D-TYPE 4-817 IC MUXR/OATA-SEL TYL 2-TU-1-LINE GUAD IC INV TYL HEX IC GATE TYL NAMO TPL 3-INP IC MUXR/OATA-SEL TYL 16-TU-1-LINE 16-IN	01295 07263 01295 01295	E graphc
A4U16 A4U17 A4U18 A4U19	1820-009 1620-028 1820-068 1820-026 1820-076	1 5 2	5 0 6 7 6	7 2 6	IC GATE TIL NAND QUAD R-INP IC FF TIL J-K M/S PULSE CLEAR DUAL IC INV TIL S HEX S-INP IC BHF-MGTR TIL R-S PRE-IN SERIAL-OUT IC BATE TIL NOR TPL 3-1NP	01295 01295 01295 27016 01295	9N74107N 5N74504N 0M8590N 5N7427N
A4U21 A4U21 A4U22 A4U23	1820=06 1820=02 1820=04	20	1 9 6	1 2 1	IC MUXP/DATA-SEL TIL 4-TO-10-LINE DUAL 1C DCCR TIL 8CO-TO-DEC 4-TO-10-LINE IC DCDR TIL 4-TU-10-LINE 4-INP	0129 0129 0129	5 SN74153N 5 SN7442AN 5 SN74154N
	1480-01 4040-07		8 3	2	PIN-GRV .062-IN-DIA .25-IN-LG STL EXTR-PC BD BLK POLYC .062-BD-TMKNS	2#48	0 4949=0748
AS	05045=6	0005	0	1	ROARD ASSEMBLY, PROCESSOR MEMORY (SERIES 1520)	5948	0 05045-60005
ASR1	0757-09	1.7	3	15	RESISTOR 510 2% .125% F TC#0+#100	2454	6 C4-1/8-10-511-6
ASTP1 ASTP2	0360-16 0360-16	82	0		TERMINAL-STUD SGL-TUR PRESS-MIG TERMINAL-STUD SGL-TUR PRESS-MIG	5848	0560=1662

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
45U1 45U2 45U3 45U4 45U4	1820=0716 1820=0373 1820=0656 1820=0694 1820=0380	6 1 9 0	21	IC CNIR ITE BIN SYNCHRU POS-EOGE-TRIG IC GATE TIL H NAND DUAL 4-INP IC GATE TIL S AND TPL 3-IMP IC GATE TIL S EXCL-OR GUAD 2-INP IC GATE TIL H AND-OR-INV	01295 01295 01295 01295 01295	SN74161N SN74H20A SN74811N SN74818N SN74H53N
ASUB ASU7 ASUB ASU9 ASU10	1820=0693 1820=0894 1820=0328 1820=0716 1816=0598	\$2.50 G M	8	IC FF ITL 3 D-TYPE POS-EDGE-TRIG IC GATE TYL NANO GUAO 2-INP IC GATE TYL NOR GUAO 2-INP IC GATE TYL SIM SYNCHKU POS-EDGE-TRIG IC GATE TYL SIM SYNCHKU POS-EDGE-TRIG IC TYL 256-BIT RAM 3-3	01295 01295 01295 01295 01295	\$
ASU11 ASU12 ASU13 ASU14 ASU15	1816-0598 1820-0716 1820-0685 1820-1107 1820-0716	3 6 8 1 6	5	IC TIL 256-BIT RAM 3-8 IC CNTR TIL BIN SYNCHRU POS-EDGE-TRIG IC GATE TIL 3 NAND TPL 3-INP IC SHF-RGIR TIL 9-8 PRL-IN SERIAL-OUT IC CNTR TIL SIN SYNCHRU POS-EOGE-TRIG	01295 01295 01295 01295 01295	SN74820UN SN74161N SN74310N SN74166N SN74161N
A5U16 A5U17 A5U18 A5U19 A5U20	1820=0716 1820=0883 1820=0716 1820=0716 1820=0822	6 6 6 3	á	IC CNTR TIL BIN SYNCHRU POS-EDGE-TRIG IC INV TIL 3 MEX 1-INP IC CNTR TIL BIN SYNCHRU POS-EDGE-TRIG IC CNTR TIL BIN SYNCHRU POS-EDGE-TRIG IC MUXR/DATA-SEL TIL 8-T0-1-LINE 8-INP	01295 01295 01295 01295 01295	SM74151N BN74804N SN74161N SN74161N SN74151AN
	1480=0116 4040=0749	8		PIN-GRV .062-IN-0IA .25-IN-LG STL EXTR-PC BD BRN POLYC .062-80-THKNS	59490 59490	1480+0116 4040+0749
46	03045-60006	1	1	BOARD ASSEMBLY, MAIN MEMORY (SERIES (712)	28480	()5() #5 ≈ 6 € 0 0 0
A6C: A6C3 A6C3 A6C4	0160=0301 0180=0210 0180=0210 0180=0210 0160=3000	44448	1	CAPACITOR-FXD .012UF +-10X 200VDC POLYE CAPACITOR-FXD 3.3UF+-20X 15VDC TA CAPACITOR-FXD 3.3UF+-20X 15VDC TA CAPACITOR-FXD 3.3UF+-20X 15VDC TA CAPACITOR-FXD .1UF +-20X 25VDC CER	28480 56289 56289 56289 28480	0150=0301 1500335x6015A2 1500335x4015A2 1500335x4015A2 0160=3660
A6C6 A6C7 A6C8 A6C9 A6C10	0180~0210 0180~0210 0160~0165 0160~0165 0180~1746	មាខាធាទា	2	CAPACITOR-FXO 3.3UF+-20% 15V0C TA CAPACITOR-FXO 3.3UF+-20% 15V0C TA CAPACITOR-FXD .056UF +-10% 200V0C POLYE CAPACITOR-FXD .056UF +-10% 200V0C POLYE CAPACITOR-FXD 15UF+-10% 20V0C TA	56289 56289 28480 28480 56289	1500335x0015A2 1500335x0015A2 0160=0105 1500156X902082
A6C11	0180=1746 0180=1746	5		CAPACITOR-FXD 15UF+-10% 20VDC TA CAPACITOR-FXD 15UF+-10% 20VDC TA	56289 56289	1500156x902062 1500156x902062
AGR1 AGR2 AGR3 AGR4 AGR5	0757~0941 0757~0945 0757~0941	3	20	RESISTOR 5.1k 2% 125W F TC=0+-100 RESISTOR 51K 2% 125W F TC=0+-100 RESISTOR 51K 2% 125W F TC=0+-100 NOT ASSIGNED NOT ASSIGNED	20586 20546 24506	C#=1/8=10=5101=6 C#=1/8=10=5102=6 C#=1/8=10=5101=6
A6R6 A6R9 A8R10 A6R11 A6R12	0757~0941 1810~0041 1810~0041 1810~0041 1810~0041	5999	10	PESISTOR 5,1K 2X ,125W F TC=0+-100 NETWORK=955 9=PIN-SIP .15=PIN-3PCG NETWORK=85 9=PIN-SIP .15=PIN-3PCG NETWORK=85 9=PIN-SIP .15=PIN-3PCG NETWORK=85 9=PIN-SIP .15=PIN-3PCG	24546 28460 28480 28480 28480	C4-1/8-10-5101-G 1810-0041 1810-6041 1810-6041
A6R13 A6R14 A6R15 A6R16 A6R17	1810=0041 1810=0041 0698=3150 0696=3150 0696=8823	9 4 4 0	5	NETWORK-RES 9-PIN-SIP .15-PIN-SPCG NETWORK-RES 9-PIN-SIP .15-PIN-SPCG RESISTOR 2.37K 11 .125W F TC=0+-100 RESISTOR 2.37K 11 .125W F TC=0+-100 PESISTOR 8.25 11 .125W F TC=0+-100	28480 28480 24546 24546 28480	1810-0041 1810-0041 C4-1/8-10-2371-F C4-1/8-10-2371-F U598-8823
ALALIN	0698-8823	0		RESISTOR 8.25 1% ,125W F 1C=0+-100	28480	0698#8823
1401 1603 1608 1608	1820-0716 1820-0716 1820-0281 1820-081 1820-0693	66038	5	IC CNTR ITL BIN SYNCHRU POS-EDGE-TRIG IC CNTR ITL BIN SYNCHRU POS-EDGE-TRIG IC FF TIL 3-K M/S PULSE CLEAR DUAL IC GATE TIL 3 NAND QUAD 2-INP IC FF TIL 3 D-TYPE POS-EDGE-TRIG	01295 01295 01295 01295 01295	\$N74161N \$N74161N \$N74167N \$N74800N \$N74874N
4646 A647 A648 A648 A645 o	1820=1288 1820=0387 1820=0387 1820=0733 1820=0367	7 3 7 3	12	IC ORVE ITL CLOCK DEVE ITL-(G-MGS 1-IMP IC SHF-RGIR PMGS SERIAL-IN SERIAL-OUT IC SHF-RGIR TIL R-S PRL-10 PRL-OUT 4-BIT IC SHF-RGIR PMGS SERIAL-IN SERIAL-OUT IC SHF-RGIR TIL R-S PRL-10 PRL-OUT 4-BIT	2/014	MMH0026CL MM 1402AV 5N7495AN MM 1402AV SN7495AN
AGU11 AGU12 AGU13 AGU13	1820-0328 1820-0307 1820-0693 1820-0685 1820-0693	0000	1	IC GATE ITL NOR QUAD 2-INP IC MY TIL MONDSTBL RETHIS/PESET IC FF TIL S D-TYPE POS-EDGE-TRIG IC GATE ITL S NAMO TPL 3-IMP IC FF TIL S D-TYPE POS-EDGE-TRIG	01295 04713 01295 01295 01295	3N7492N MCB001P 3N74374N 3N74310N SN74374N
A6016 A6017 A6016 A6018 A6020	1820-0733 1820-0367 1820-0733 1820-0367 1820-054	7 3 7 3 5	;	IC SMF-RGTR PMOS SERIAL-IN SERIAL-OUT IC SMF-RGTR TIL R-5 PKL-IN PRL-OUT 4-BIT IC SMF-RGTR PMOS SERIAL-IN SERIAL-OUT IC SMF-RGTR TIL R-5 PRL-IN PRL-OUT 4-BIT IC GATE TIL NAND GUAD Z-INP	5/014	M41402AD SN7495AD M41402AD SN7495AN SN7400N
		MACCOLLEGE OF THE PARTY OF THE			- Andrews	



Table 6-1. Replaceable Parts (Cont'd)

Reference			Qty	Description	Mfr Code	Mfr Part Number
Reference Designation A6U21 AAU22 AAU23 AAU23 AAU25 AAU26 AAU27 AAU28 AAU28 AAU30 AAU31 AAU31 AAU31 AAU33 AAU33 AAU34 AAU35 AAU36 AAU37 AAU38 AAU39 A7 A7C1 A7C2 A7C3 A7C4 A7J1 A7R1 A7R2 A7R3 A7R4 A7R6 A7R7 A7S1 A7U1 A7U1 A7U1 A7U1 A7U1 A7U1 A7U1 A7U	Number 1 1820-0685 1820-0683 1820-1849 1820-0693 1820-0733	D 86467 37204 25557 3049 87 2 0055 1236 2573 61653 18168 93263 22361 128	1 2 1 1 1 2 1 1 1 2 1 1 1 1 1 1 1 1 1 1	IC GATE ITL S NANO IPL 3-INP IC INV ITL S HEX 1-INP IC GATE ITL S OR GUAD 3-INP IC GATE ITL S OF THE POSSEDGE-IRIG IC FF ITL S OFTYPE POSSEDGE-IRIG IC SHF-RGIR PMOS SERIAL-IN SERIAL-OUT IC SHF-RGIR ITL R-S PRL-IN PRL-OUT G-BIT IC FF ITL D-TYPE POSSEDGE-IRIG CLEAR IC FF ITL D-TYPE POSSEDGE-IRIG CLEAR IC FF ITL H D-TYPE POSSEDGE-IRIG IC GATE ITL S AND GUAD 2-INP IC GATE ITL S AND GUAD 2-INP IC GATE ITL S AND GUAD 2-INP IC MUXP/DATA-SEL ITL 2-IO-1-LINE GUAD IC MUXP/DATA-SEL ITL 2-IO-1-LINE GUAD IC MUXP/DATA-SEL ITL 2-IO-1-LINE GUAD IC SHF-RGIR PMOS SERIAL-IN SERIAL-OUT IC SHF-RGIR ITL R-S PRL-IN PRL-OUT G-BIT IC FF ITL S JAK NGG-EDGE-IRIG IC GATE ITL S NAND GUAD 2-INP IC GATE ITL AND GUAD 2-INP IN-GRY 062-IN-DIA .25-IN-LG SIL EXTR-PC BO RED POLYC .062-BD-IHKNS BOARO ASSEMBLY, I/O PPIB (SERIES 1852)	Code V1295 C1295	3N74510N 3N74304N 5N74374N M1402AD 3N7495AN SN74174N SN7474N SN7474N SN7474N SN74851N SN7486N 1480-0110 2040-0750 05645-60007 0160-0571 0160-057

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C	Qty	Description	Mfr Code	Mfr Part Number
7036	1820=1201 1820=1433	6	i 2	IC GATE TIL LS AND GUAD 2-INP IC SHF-RGIR TIL LS R+S SERIAL-IN PRL-DUT	01295 01295	5 % 7 4 L 5 0 8 W 5 % 7 4 L 5 1 6 4 W
17037 17038 17039 17040	1620-1433 1620-0681 1620-1470 1620-1194	1 5	1	IC GATE TIL S WAND QUAU 2-INP IC MUXR/DATA-SEL TIL LS 2-TO-1-LINE GUAD IC CHIR TIL LS BIN UP/DOWN SYNCHRO	01295 01295 01295	5N7450UN 5N74L5157N 5N74L5143N
17041	1820=0692 1820=1207 1820=0628	7 2 9	1 1	IC GATE TIL S AND OR-INV IC GATE TIL LS NAND 8-1NP IC ITL 64-91T PAM 60-NS 0-C	01295 01295 01295	5 N 7 4 5 6 5 N 3 N 7 4 L 8 5 U N 5 N 7 4 8 9 N
A7U43	0360=1682 4040=0731 1200=0521	0 8 7	37	TERMINAL-STUD SGL-TUR PRESS-MIG EXTR-PC BO GRN POLYC . Doz-BD-THKNS LOCK-DUAL INLINE PKG INLINE PKG	28480 28460 52072	0350+1502 4000-0751 CA±24-200-004
AB .	05045=60008	3	1	BOARD ASSEMBLY, ROM (SERIES 1520)	28489	แรงจุร⇒ธูกิจหล
ABRI ABRZ ABRI ABRI ABRS	0757=0941 0757=0924 1810=0030 1810=0030 0757=0907	52661	33 5	RESISTOR 5.1K 2X .12SW F IC=0++100 RESISTOR 1K 2X .12SW F IC=0++100 NETWORK=RES 8-PIN-SIP .125-PIN-5PCG NETWORK=RES 8-PIN-SIP .125-PIN-SPCG RESISTOR 200 2X .125W F IC=0++100	54246 59480 54246 54246	C4-1/8-10-201-0 1810-0050 C4-1/8-10-1001-G C4-1/8-10-2001-0
A8U1 A8U2 A8U3 A8U4	1818=2278 1818=2281 1818=2284 1820=1294	49270	1 1 3	IC,MOS ROM 512 x 8 IC,MOS ROM 512 x 8 IC,MOS ROM 512 x 8 IC MUXR/DATA-SEL 7TL 2-TU-1-LINE GUAD IC GATE TTL OR GUAD 2-INP	28480 28480 28480 27014 01295	1818-2276 1818-2284 1818-2284 5M8123N 3N74324
A8U6 A8U7 A8U8 A8U9 A8U9	1820=0661 1818+2277 1818-2280 1818-2283 1820-1294 1820-0077	38 172	***	IC,MOS ROM 512 X 8 IC,MOS ROM 512 X 8 IC,MOS ROM 512 X 8 IC MUXR/DATA-SEL TTL 2-Y0-1-LINE GUAD IC FF TTL 0-YPPE POS-EDGE-TRIG CLEAR	28480 28480 28480 27014 01295	1818-2277 1818-2243 1818-2283 DMB1257 8N74748
#8411 #6412 #8413 #8414	1818×2276 1818×2279 1818×2282 1820×1294 1820×0214	25079		IC,MOS ROM 512 X 8 IC MUXR/DATA-8EL TTL 2-TO-1-LINE QUAD IC OCOR TTL 8CD-T0-DEC 4-TD-10-LINE	28480 28480 28480 27014 01295	1618-2276 1618-2276 1618-2262 UM81234 5N79924N
	0360=1682 1480=0116 4040=0752	9	4	TERMINAL-SIUD SGL-TUR PRESS-MTG PIN-GRV .062-IN-DIA2.25.L-LG STL EXTR-PG BO YEL POLYC .08248D-THKNS	58480 58480 58480	0360×1682 1480×6115 4940×6752
49	05045=60009	Acceptance 44	1	BOARD ASSEMBLY, ADDRESS (SERIES 1852)	28480	@5045 ∞ 60009
A9C1 A9C2 A9C3 A9C4	0180=0106 0180=0210 0180=0210	6669		CAPACITOR-FXD 3.3UF+-20X 15VDC TA CAPACITOR-FXD 3.3UF+-20X 15VDC TA CAPACITOR-FXD 43PF +-5X 300VDC MICA CAPACITUR-FXD 60UF+-20X 5VDC TA	56289 56289 28480 56289	1500535×0×15A2 ±500335×0×15A2 0160×2200 1500606×0006d2
AACH1 AACH2	1902-0126	6	į	DIODE-2NR 2.61v 5x DO-7 POx.4w TCx=.072% DIODE-SWITCHING 30v 50MA 2NB DO-35	28480 28480	1902-0125 1901-0040
A##4	1854-0071	7	27	TRANSISTOR NPW SI PD#300MM FT#200MMZ	28486	1854-0071 (4-1/8-10-5101-6
高等所生 高等符名 高等符名 高等符名 高等符名	0757-0941 0757-0941 0757-0941 2100-2633 0757-0279	3550	3	RESISTOR 5.1K 2% .125W F TC=0++100 RESISTOR 5.1K 2% .125W F TC=0++100 RESISTOR 5.1K 2% .125W F TC=0++100 RESISTOR-TEMP 1K 10% C SIDE+A0J 1-TRN RESISTOR 3.16K 1% .125W F TC=0++100	24546 24546 34546 34546	C4-1/8-10-5101-6 C4-1/8-10-5101-6
A986 A987 A988 A989 A980	0757-0940 0757-0940 0757-0924 0757-0976 0757-0948	0 6 8 8 8	7	RESISTOR 4.7K 2% .125W F TC#0+-100 RESISTOR 4.7K 2% .125W F TC#0+-100 RESISTOR 1K 2% .125W F TC#0+-100 RESISTOR 150K 2% .125W F TC#0+-100 RESISTOR 150K 2% .125W F TC#0+-100	24546 24546 24546 24546	C4-1/8-10-4701-6 C4-1/8-10-4701-6 C4-1/8-10-1001-6 C4-1/8-10-1502-8 C4-1/8-10-1402-6
498 1 498 12 1901 3 1901 4	1810-0164 0757-0940 0757-0972 0757-0924	200	15	NETWORK-RES 9-PIN-SIP .15-PIN-SPCG RESISIOR 4,7K 2% .125w F TC#4+-100 RESISIOR 100K 2% .125w F TC#4+-100 RESISIOR 1K 2% .125w F TC#4+-100	24546 54546 54546	CH-1/8-10-1001-6 CH-1/8-F0-1002-6 CH-1/8-10-1001-6
A17P: A17P2 447P3 A17PA A1PA A1PA	0360=1682 0360=1682 0360=1682 0360=1682 0360=1682	0	,	TERMINAL-STUD SGL-TUR PRESS-MIG	28480 28480 28480 28480	#360-1602 #360-1602 #360-1602 #360-1602
Agus	0360=1682	1		TERMINAL-SUD SGE-TUR PRESS.	28480	11350-1562 Change
	1820+0511 1820-0661 1820-0697 1820-068 1820-0567		1	IC GATE TIL AND QUAD 2-INP IC GATE TIL OR QUAD 2-INP IC ORRY TIL S NAMD LINE OUAL 4-INP IC GATE TIL NAMD TPL 3-INP IC MY TIL DUAL	01295 01295 01295 01295 01795	5%743160% 5%743160% 5%7432%



Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	c	Qtγ		Description	Mfr Code	Mfr Part Number
Designation	Number	D 2	`1	īĊ	GATE YTL NOR DUAL 4-INP GATE TIL NAND DUAL 4-INP GATE TIL NAND DUAL 4-INP	01295 01295 01295	9N7425N 9N7420N 9N7474N
19U6 19U7 19U8 19U9	1820-0069 1820-0077 1820-0077 1820-0683	9 12 20 W	1	10	FF TTL 0-TYPE POS-EDGE-TRIG CLEAR FF TTL 0-TYPE POS-EDGE-TRIG CLEAR INV TTL 9 HEX 1-TRP	01295	8N7474N 8N74804N 8N74K53N
A9U10 A9U11 A9U12 A9U13	1820-0380 1820-0715 1820-1054	0.000	1 10	10	GATE TIL M AND-OR-INY COURT TIL BIN SYNCHED POS-EDGE-TRIG SWE-BGTR TIL SERIAL-IN PRL-OUT 8-BIT INV TIL HEX 1-1NP FF TIL S D-TYPE POS-EDGE-TRIG	01295 01295 01295 01295	5N74151N 5N74164N 5N7406N 3N74574N
A9U14 A9U15	1820-0471 1620-0693 1820-0077	8		I	FF TIL S DETTPE PUS-EDGE TRIG CLEAR FF TIL DETTPE PUS-EDGE TRIG C CNTR TIL BIN SYNGHRU PUS-EDGE TRIG C CNTR TIL BIN SYNGHRU PUS-TOTE PUFAR HEX	01295 01295 01295	SN7414N SN74161N SN74174N SN74174N
19017 19018 19019	1820+0716 1820-0786 1820-0716 1820-0716	9 9	5	1	C CATE ITE BEN SYNCHRU POS-EDGE-TRIG C CATE ITE BEN SYNCHRU POS-EDGE-TRIG C CATE ITE BEN SYNCHRU POS-EDGE-TRIG	01295 01295 01295	3N74161N SN74165N
A9U20	1620-1042	3	2	- 1	C SHF-PGTR TTL R-S PRL-IN SERIAL-OUT IN-GRV .062-ND-IN-LG STL INTR-PG 80 GRN POLYC .062-80-THKNS	28480 28480	1480-0115
	4040-0753	0 7	2	1.	ensen assembly. DAG	58480	05045-60010
A 1 0	05045-6001 0160-2055	4	15		(SERIES 1520) CAPACITOR-FXD .01UF +80-20% 100VDC CER	28480 28480 28480	0160-3450
A10C3 A10C3 A10C4	0100-2055 0100-3456 0100-3456 0150-0101	9		.	CAPACITOR-FXD 1000PF +=101 1K4DC CER CAPACITOR-FXD 3.3UF+=101 354DC TA CAPACITOR-FXD 3.3UF+=101 354DC TA	28480 00906 28480	711083355803589
A10C5 A10C6 A10C7 A10C8	0180=2055 0180=0181 0160=2055 0180=0161		9		CAPACITOR FXD .01UF +80=20% 100VDC CER CAPACITUR=FXD 3.3UF+=10% 35VDC TA CAPACITOR=FXD .01UF +80=20% 100VDC CER CAPACITOR=FXD 3.3UF+=10% 35VDC TA	00908 28480 00908	71108335N035AS 0160~2055 71108335N035AS
A10CP1 A10CR1 A10CR2 A10CR3	1902=3234 1902=3234 1901=0040 1901=0046		3	2	DIODE-ZNR 19.64 SX DO-7 PD#,4% [C#+.07] DIODE-SWITCHING 304 56MA 288 DD-35 DIODE-SWITCHING 304 56MA 288 DD-35 DIODE-SWITCHING 304 56MA 288 DD-35 DIODE-ZNR 7.54 5% DO-7 PD#,4% IC#+.05% DIODE-ZNR 19.64 5% DD-7 PD#,4% IC#+.07	5848 5848 5948	1901=004U 1901=0040 0 1902=0094 1902=5234
ALOCRA ALOCRA ALOCRA	1902-006	! i	3		DIODE-INF 7.5V 5% DO-7 PDB.4M IC84.05% DIODE-INF 7.5V 5% DO-7 PDB.4M IC84.05% DIODE-SWITCHING 30V 5UMA 2NS DO-35 DIODE-SWITCHING 30V 5UMA 2NS DO-35	1 5946	1902=000# 1901=00#0 1901=00#0
ALOCRS ALOCRS ALOCRIO	1901-004 1901-064	0	1		DIODE-SWITCHING SOV SOMA ZNS DO-35 DIODE-SWITCHING SOV SOMA ZNS DO-35	59#	001-0040
A10CRT1	1901-004 1854-007	1	7 4	56	TRANSISTOR NPN SI POMBOOMN FTM260MMZ TRANSISTOR PNP SI POMBOOMN FTM150MMZ	284 284 245	86 1853-0020
A10G2 A1CR1 A1CR2 A1GR3	0757-09 0757-09 0757-09	24 24	2 2 9 0		RESISTOR 1K 2% .125% F TC=0+=100 RESISTOR 1K 2% .125% F TC=0+=100 RESISTOR 750 2% .125% F TC=0+=100 RESISTOR 10K 2% .125% F TC=0+=100 RESISTOR 510 2% .125% F TC=0+=100	545 545 545	46 C4-1/8-10-101-6 46 C4-1/8-10-151-6 46 C4-1/8-10-100-6 47 C4-1/8-10-511-6
A10R4 A10R6 A10R6 A10R7	0757-09 0757-09 0757-09 0757-09	17 00 17	3 3 3		RESISTOR 100 2% .125% F TC#0+=100 RESISTOR 510 2% .125% F TC#0+=100 RESISTOR 510 2% .125% F TC#0+=100 RESISTOR 510 2% .125% F TC#0+=100	24 24	546 C4=1/8=70=101=6 546 C4=1/8=70=511=6 546 C4=1/8=70=511=6 546 C4=1/8=70=511=6 546 C4=1/8=70=101=6
AICRE AICR9 AICRIC	0757-09 0757-09	117 190 741	3 1	7	RESISTOR 100 2% .125W # TC=0++100 RESISTOR 2K 2% .125W # TC=0++100 RESISTOR 2K 2% .125W # TC=0++100	24	546
ALORIZ ALORIZ ALORIZ ALORIZ	0757=0 0757=0 0757=0 0757=0	924 941	3 3		RESISTOR IN 2% .125W F TCB0+=100 RESISTOR IN 2% .125W F TCB0+=100	2	1546 C4-1/8-10-1001-9 1546 C4-1/8-10-5001-9
A10R16 A10R17 A10R16	0757+0 0757+0 0757-0 0757+0	935 935 976	5 5 4 4	â	RESISTOR 3K 2% 125% F TC=0+-100 RESISTOR 3K 2% 125% F TC=0+-100	5 5	4546 C4-1/8-T0-3601-0 4546 C4-1/8-T0-3001-0 4546 C4-1/8-T0-3001-0
A10R29 A10R20 A10R21 A10R22 A10R23 A10R24	0757=0 0757=0 0757=0 0757=0 0751=0757=	935 935 935 935 935	5 55552		RESISTOR 3K 2% .125% F TC=0+-100 RESISTOR 1K 2% .125% F TC=0+-100		4546
A10R25 A10R26 A10R27 A10R26 A10R26 A10R30	0757- 0757- 0757- 0757- 0757-	0929 7070 4290 0976	2		RESISTOR 1K 2% 125% F TC=0+-100 RESISTOR 200 2% 125% F TC=0+-100 RESISTOR 1K 2% 125% F TC=0+-100 RESISTOR 150% 2% 125% F TC=0+-100 RESISTOR 300 2% 125% F TC=0+-100		24546

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A: GR31 A: GR32 A: GR33 A: GR34 A: GR35	0757-0924 0757-0941 0757-0911 0757-0948 0757-0958	2 3 7 0 2	3	RESISTOR 1K 2% 125% F TCM0+-100 RESISTOR 5,1K 2% .125% F TCM0+-100 RESISTOR 300 2% .125% F TCM0+-100 RESISTOR 10K 2% .125% F TCM0+-100 RESISTOR 2K .125% F TCM0+-100	24546 24246 24246 54246 54246	C4-1/8-10-1001-6 C4-1/8-10-5401-6 C4-1/8-10-541-6 C4-1/8-10-1012-6 C4-1/8-70-2702-6
A10R36 A10R37 A10R38 A10R39 A10R40	0757-0924 0757-0948 0757-0967 0757-0924 0757-0941	20 50 E	1	RESISTOR 1X 2X .125W F TCm0+-100 RESISTOR 10K 2Y .125W F TCm0+-100 RESISTOR 62K 2Y .125W F TCm0+-100 96515TOR 1K 2X .125W F TCm0+-100 RESISTOR 5.1K 2X .125W F TCm0+-100	24546 24546 24546 24546	C4-1/8-10-1001-6 C4-1/8-10-1002-6 C4-1/8-10-202-6 C4-1/8-10-1001-6 C4-1/8-10-5101-6
A\$ 0 R 4 \$ 1	0757=0972 0757=0948 0757=0958 0757=0924 0757=0924	RNNOO		RESISTOR 100% 2% .125% F IC=0+=100 RESISTOR 10% 2% .125% F IC=0+=100 RESISTOR 27% 2% .125% F IC=0+=100 RESISTOR 1% 2% .125% F IC=0+=100 RESISTOR 1% 2% .125% F IC=0+=100	24546 24546 24546 24546	C4-1/8-T0-1002-G C4-1/8-T0-102-G C4-1/8-T0-2702-G C4-1/8-T0-1001-G C4-1/8-F0-1001-G
A10847 A10848 A10849	0757-0958 0757-0948 0757-0924	202		RESISTOR 27K 2X .125% F TC=0+-100 RESISTOR 10K 2X .125% F TC=0+-100 RESISTOR 1K 2X .125% F TC=0+-100	24546 24546 24546	Cu-1/8-10-1002-G Cu-1/8-10-1002-G Cu-1/8-10-1001-G
A10U1 A10U2 A10U3 A10U4 A10U5	1820=0899 1820=0716 1820=0716 1820=0716 1820=0511	00000	1	IC CATE ITL DECD SYNCHRO PUS-EDGE-TRIG IC CATE TIL BIN SYNCHRO POS-EDGE-TRIG IC CATE TIL BIN SYNCHRO POS-EDGE-TRIG IC CATE TIL BIN SYNCHRO POS-EDGE-TRIG IC GATE ITL AND GUAD Z-INP	01295 01295 01295 01295 01295	5N74160N SN74161N SN74161N SN74161N SN7408N
A10U6 A10U7 A10UB A10U9 A10U10	1620-0733 1820-0693 1820-0677 1820-0054 1820-0077	7 8 2 5 2		IC SMF-RGIR PMOS SERIAL-IN SERIAL-DUT IC FF ITL S D-TYPE POS-EDGE-TRIG IC FF ITL D-TYPE POS-EDGL-TRIG CLEAR IC GATE TIL NAND QUAD 2-INP IC FF TYL D-TYPE POS-EDGL-TRIG CLEAR	27018 01295 01295 01295 01295	M
A10011 A10012 A10013 A10014 A10015	1820=0491 1820=0733 1820=0471 1820=1322 1820=0328	47026	į.	IC DCDR TIL BCD-TO=DEC 4-TD=10=LINE IC 3HF=RGTR PMOS SERTAL=IN SEPIAL=DUT IC INV TIL HEX 1=INP IC GATE TIL S NOR QUAD 2=INP IC GATE TIL NOR QUAD 2=INP	01295 27014 01295 01295 01295	SN74145N - MM_HOZAD SN7406N SN74802N SN74802N
A10U16 A10U17 A10U18 A10U19 A10U20	1820=0077 1820=0716 1820=0367 1820=0788 1820=0471	SENO		IC FF 1TL D-TYPE PDS-EDGE-TRIG CLEAR IC CNTR TTL BIN SYNCHRU POS-EDGE-TRIG IC SHE-RGIR TIL P-S PRILIN PRI-DUT 4-BIT IC FF TTL G-TYPE POS-EDGE-TRIG CLEAP MEX IC INV TTL MEX 1-INP	01295 01295 01295 01295 01295	5N7474N SN74161N SN74455AN SN7474N SN7406N
A10U21 A10U22 A10U23 A10U24 A10U28	1820=0054 1820=0328 1820=0377 1820=0788 1820=0471	5 6 5 2 0		IC GATE TIL NAND QUAD 2-INP IC GATE TIL NDR QUAD 2-INP IC GATE TIL HAND-OP-INV OUAL 2-INP IC FF TIL D-TYPE POS-EDGE-TRIG CLEAP HEX IC INV TIL HEX 1-INP	01295 01295 01295 01295 01295	SN7400N SN7402N SN74150M SN741740 SN7406N
	1450-0116 4040-0754	1	2	PIN-GRV .062-IN-DIA .25-IN-LG STL EXTR-PC 80 8LU POLYC .362-BD-THKNS	28480 28480	1480=0115 8040=0754
111	05045-60011	6	i	80ARD ASSEMBLY, REFERENCE LEVEL G (SERIES 1852)	59490	05g45-69011
A11C1 A11C2 A11C3 A11C4 A11C5	0160-4279 0160-4279 0160-4279 0140-0209 0150-0121	33395	5	CAPACITOR=FXD 470PF +=10% 200VDC PDLYP CAPACITOR=FXD 470PF +=10% 200VDC PDLYP CAPACITOR=FXD 470PF +=10% 200VDC PDLYP CAPACITOR=FXD 5PF +=10% 500VDC MICA CAPACITOR=FXD .1UF +80-20% 50VDC CER	71590 71590 71590 71590 72136 28489	CPP-471J CPP-471J DM15C050K050U0V1CR 0150-0121
A11C0 A11C7 A11C8 A11C9 A11C1g	0150-0121 0160-0181 0160-0181 0160-2218 0160-2055	5 8 6 9	3	CAPACITUR-FXO .1UF +80-20% 50VDC CER CAPACITUR-FXD 30PF +-5% 300VDC MICA CAPACITUR-FXD 30PF >-5% 300VDC MICA CAPACITUR-FXD 1000PF +-5% 300VDC MICA CAPACITUR-FXD .01UF +80-20% 100VDC CER	28480 28480 28480 28480	0150-0121 0160-0151 0160-0151 0160-2218 0160-2255
Alicia Alicia Alicia Alicia Alicia	0160+2197 0140+0209 0160+0181 0140=0184 0160+2055	9 9 9		CAPACITOR-FXD 19PF +-5% 300VDC MICA CAPACITOR-FXD 5PF +-10% 500VDC MICA CAPACITOR-FXD 30PF +-5% 300VDC MICA CAPACITOR-FXD 8200PF +-1% 100VDC MICA CAPACITOR-FXD 01UF +89-20% 100VDC CER	28480 72136 28480 72136 28480	0160=2197 DM15C050K0500*V1CH 0160=0181 D*20f822F010UHV1CK 0160=2055
A:1016 A:1017 A:1018 A:1019 A:1020	0160-2225 0140-0184 0160-2225 0160-2055 0160-2055	59599		CAPACITOR=FXD 2000PF +=5x 30000C MICA CAPACITOR=FXD 8200PF +=1x 1000DC MICA CAPACITOR=FXD 2000PF +=5x 3000DC MICA CAPACITOR=FXD .010F +80=20x 1000DC CER CAPACITOR=FXD .010F +80=20x 1000DC CER	28480 72136 28480 28480 28480	0160-2055 0160-2255 0160-2255 0160-2255
411523 411523 411524 411524 411525	0180-0161 0140-0151 0150-0121 0150-0121 0160-0362	60557		CAPACITOR-FXD 3.3UF+-10X 35VOC TA CAPACITOR-FXD 82NPF +-2X 300VOC **ICA CAPACITOR-FXD .1UF +80-20X 50VOC CER CAPACITOR-FXD .1UF +80-20X 50VOC CER CAPACITOR-FXD 510PF +-5X 3800VC **ICA	00908 72136 28480 28480 28480 28480	71108335x03543 Dm15F82160300nV1CK 0150-0141 0150-0141 0150-0161
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See introduction to this section for ordering information *Indicates factory selected value

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Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	C	Qty	Description	Mfr Code	Mfr Part Number
Designation	Number 0160-0362 0180-0116 0180-0116 0180-0218	7		CAPACITOR=FXD 510PF +=5% 30UVDC MICA CAPACITOR=FXD 6.8UF++10% 35V0C TA CAPACITOR=FXD 6.8UF++10% 35V0C TA CAPACITOR=FXD 1000PF +=5% 300VDC MICA CAPACITOR=FXD 820PF +=2% 300VDC MICA	28480 56289 56289 28480 72136	0160-0362 1500685x903582 1500685x903582 0160-2216 DM15F821G05uUnv1CR
A11029 A11030 A11032 A11033 A11033 A11034	0140=0151 0160=1746 0150=0121 0160=2240 0160=0161	0 55365	1	CAPACITOR=FXO 15UF+=10% 20VOC TA CAPACITOR=FXO .1UF +8U-20% 5UVOC CER CAPACITOR=FXO 2PF += .25PF 500VOC CER CAPACITOR=FXO 3, 3UF+=10% 35VOC TA CAPACITOR=FXO 15UF+=10% 20VOC TA	\$6289 28480 28480 00908 56289	1500156X902082 0150+0121 0150+2240 11108335K035AS 1500156X902082 11108313K035AS
A11035	0180-1746	6	}	CAPACITOR=FXD 3.3UF+=10% 35VDC TA	00908	1901-0040
A;1C36 A;1CR1 A;1CR2 A;1CR3	0180=0161 1901=0040 1901=0040 1901=0040	1 1 1		DIODE-SWITCHING BOV SOMA 2NS 00-35 DIODE-SWITCHING BOV SOMA 2NS 00-35	56480 56480 56480 56480	1901-0040 1901-0040 1901-0040 1901-0040
ALICRE ALICRE ALICRE ALICRE	1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1 1		OIODE-SWITCHING 30V 50MA 2MS 00=35 DIODE-SWITCHING 30V 50MA 2MS 00=35 DIODE-SWITCHING 30V 50MA 2MS 00=35 DIODE-SWITCHING 30V 50MA 2MS 00=35	28480 28480 28480	1901=0040 1901=0040 1901=0040 1901=0040
ALICAS ALICAS	1901-0040 1901-0040 1901-0040	Î	1	I STODE SWITCHING SHE	28480	1902=0071
ATICRIO ATICRII	1902-0071	1	, ,	and speny ast GaNOM	28480	9140=0144 9140=0144
ALIUMII	9140-0144		13	COIL-MED 4. FOR IVA	28480	205245
111.2 111.2 211.4 211.4 211.4	9140-0144 1855-0051 1853-0020 1854-0071 1853-0020	Annual School of the Party of t		TRANSISTOR J=FET N=CHAN D=MODE 31 TRANSISTOR PNP 31 P0=300% FT=150MHZ TRANSISTOR NRN 31 PD=300% FT=150MHZ TRANSISTOR PNP 31 PD=306% FT=150MHZ TRANSISTOR PNP 31 PD=306% FT=150MHZ TRANSISTOR J=FET N=CHAN D=MODE 31	28480 28480 28480 28480	1853-0040 1854-0071 1853-0020
A1104 A1105	1855=0081		1	and the property of the state o	01295	1854=00/1
A1196 A1197 A1198 A1199	1855-0081 1854-0071 1854-0071 1854-0071		1 7 7 7 7 7	TRANSISTOR MPN SI PDEBOGMM FIRZOOMMZ TRANSISTOR MPN SI PDEBOGMM FIRZOOMMZ TRANSISTOR MPN SI PDEBOGMM FIRZOOMMZ TRANSISTOR MPN SI PDEBOGMM FIRZOOMMZ	28480 28480 28480 28480	1854-0071 1854-0071
AiiGio	1854-0071		a	TRANSISTOR PNP SI PDE300MW FTE150MHZ TRANSISTOR PNP SI PDE300MW FTE150MHZ TRANSISTOR PNP SI PDE300MW FTE150MHZ	58490	1853=0020
A11011 A11012 A11013	1853-0020 1853-0020	0	4	TRANSISTOR PRO DI	24546	G4=1/8=T0=101=G G4=1/8=T0=101=G
A11R1 A11R2 A11R3	0757=090 0757=090 0757=094 0757=090	Q 4	4 6 4	RESISTOR 100 2X .125W F TC=0+=100 RESISTOR 000 2X .125W F TC=0+=100 RESISTOR 0.8K 2% .125W F TC=0+=100 RESISTOR 100 2X .125W F TC=0+=100 RESISTOR 100 2X .125W F TC=0+=100	2454 2454 2454	6 C4=1/8=10=101=6 C4=1/8=10=601=6
Alira Alira Alira Alira	0757-090 0757-094 0757-094	0 15 16 14	7 0	RESISTOR 7.5K 2% 125m F 1C=0+=100 RESISTOR 10K 2% 125m F 1C=0+=100 RESISTOR 6.8K 2% 125m F 1C=0+=100 RESISTOR 6.8K 2% 125m F 1C=0+=100	2454 2454 2454 2454 2454	6 C4=1/8=10=501=6 C4=1/8=10=501=6
A11R8 A11R9 A11R10	0757-095	11	3	RESISTOR ISK SA F TCEO+=100	245	1 cu_(/A=10a10UEPY
A11R11 A11R12 A11R13	0757-09 0757-09 0757-09 0757-09	60 44 49	9 0 6	15 RESISTOR 20K 2% 125% F TC80+-104 RESISTOR 6.8K 2% 125% F TC80+-100 RESISTOR 6.8K 2% 125% F TC80+-100 RESISTOR 100 2% 125% F TC80+-100 RESISTOR 5.1K 2% 125% F TC80+-100	245 245 245	46 C4-1/8-10-601-6 46 C4-1/8-10-101-6 46 C4-1/8-10-5101-6
ATTRIA ATTRIS	0757-09	41	3	RESISTOR 100 2% .125W F TC=0+-100	245 245	46 C4-1/8-10-101-6
A11R16 A11R17 A11R18 A11R19	0757-09 0757-09 0757-09 0757-09	100 100 100	4 4	RESISTOR 100 2% .125% F ICE0+-100		46 C4-1/6-10-101-6 46 C4-1/6-10-101-6 546 C4-1/8-10-10-6
A11R20 A11R21 A11R22 A11R23	0757-0 0757-0 0757-0 0757-0	972 931 952	0 1 6	RESISTOR 100K 2% .125W F TC=0+=100 RESISTOR 2K 2% .125W F TC=0+=100 RESISTOR 15K 2% .125W F TC=0+=100 RESISTOR 6.6K 2% .125W F TC=0+=100 RESISTOR 5tK 2% .125W F TC=0+=100	24	546 C#=1/8=10=2001=6 546 C#=1/8=10=1502=6 546 C#=1/8=10=5001=6 546 C#=1/8=10=5102=6
A11R24 A11R25 A11R26	0757+0	965	3 2	RESISTOR 2.4K 2% .125W F TC#0+=100 RESISTOR 1K 2% .125W F TC#0+=100 RESISTOR 1K 2% .125W F TC#0+=100	28	546
A11827 A11828 A11829 A11830	0757=0 0698=3 0757=0 0757=0	252	6	RESISTOR 15K 2% 125% # TC=0+=100	24	546 C4-1/8-10-1002-6
A11R31 A11R32 A11R33 A11R34 A11R35	0757- 0757- 0757- 0757- 0757-	0748 0924 0900	2 2	RESISTOR 20% 2% .125% F TC#0+-109 RESISTOR 16% 2% .125% F TC#0+-109 RESISTOR 16 2% .125% F TC#0+-109 RESISTOR 100 2% .125% F TC#0+-109 RESISTOR 100% 2% .125% F TC#0+-109	51	1546 546 546 546 64-1/8-10-1002-6 64-1/8-10-1002-6
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Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part Number	C	Qty	Description	Mfr Code	Mfr Part Number
Designation AttR37 AttR38 AttR39 AttR40	0757-0940 0757-0957 0757-0394 0757-0416 0757-0957	2 1 0 7 1	2 N N	RESISTOR 4.7K 2% .125W F TC=0+=10U RESISTOR 24K 2% .125W F TC=0+=100 RESISTOR 511 1% .125W F TC=0+=100 RESISTOR 511 1% .125W F TC=0+=100 RESISTOR 52K 2% .125W F TC=0+=100	24546 24546 24546 24546 24546	C4-1/8-[0-4701-G C4-1/8-10-2402-G C4-1/8-10-51k1-F C4-1/8-10-51k4-F C4-1/8-10-2402-G
A11R41 A11R42 A11R43 A11R44 A11R45	0757-0911 0757-0924 0757-0965 0757-0953 0757-0957	7 2 1 3		RESISTOR 300 2% .125% F TC#0+=100 RESISTOR 1K 2% .125% F TC#0+=100 RESISTOR 51% 2% .125% F TC#0+=100 RESISTOR 2.6% 2% .125% F TC#0+=100 RESISTOR 24% 2% .125% F TC#0+=100	54249 54249 54249 54249	C4=1/8=70=501=G C4=1/8=10=1001=G C4=1/8=10=2001=G C4=1/8=10=2401=G C4=1/8=10=2402=G
A11R#6 A11R#7 A11R#8 A11R#9 A11R50	0698=3252 0757=0957 0757=0416 0757=0965 0757=0394	9 1 7 1 0		PESISTOR 450 1% .125% F TC=0+=50 RESISTOR 24% 2% .125% F TC=0+=100 RESISTOR 511 1% .125% F TC=0+=100 RESISTOR 51% 2% .125% F TC=0+=100 RESISTOR 51% 1 1% .125% F TC=0+=100	54240 54240 54240 54240 54240 58480	0698-3232 Ca=1/8-TU-2u02=G C4=1/8-TU-511%=F C4=1/8-TU-5102=G C4=1/8-TU-5181=F
A11851 A11852 A11853 A11854 A11855	0757=0965 0757=0965 0757=0965 0757=0965 0757=0965	111111		RESISTOR 51K 2X ,125M F 1C=0+-100	24249 24249 24249 24249	C4=1/8=10-5102=G C4=1/8=10-5102=G C4=1/8-10-5102=G C4=1/8-10-5102=G C4=1/8-70-5102=G
A11R56 A11R57 A11R58 A11R59 A11R60	0757=0941 0757=0941 0757=0941 0757=0941 0757=0941	33343		RESISTOR 5.1k 2x .125w F TC=0+-100 RESISTOR 5.1k 2x .125m F TC=0+-100 RESISTOR 5.1k 2x .125m F TC=0+-100 RESISTOR 3k 2x .125m F TC=0+-100 RESISTOR 3k 2x .125m F TC=0+-100	24546 24546 24546 24546 24546	C4-1/8-10-5101-G C4-1/8-10-5101-G C4-1/8-10-5101-G C4-1/8-10-5101-G C4-1/8-10-5101-G
A11861 A11862 A11863 A11864 A11865	0757=0941 0757*0920 0757=0941 0757*0911 0698*6977	3055-4	1	RESISTOR 5.1K 2% .125W F IC=0+-100 RESISTOR 680 2% .125W F IC=0+-100 RESISTOR 5.1K 2% .125W F IC=0+-100 RESISTOR 300 2% .125W F IC=0+-100 RESISTOR 30K .1% .125W F IC=0+-25	24546 24546 24546 24546 28489	CR=1/B=10=5101=G CB=1/B=10=501=G C4=1/B=1(H=5101=G C4=1/B=10=501=G 0698=6977
A11R66 A11R67 A11R68 A11R69 A11R70	0757#0945 0598=6977 0757#0945 0698#6360 0698=6360	7 17 6 6	2	RESISTOR 7.5K 2% .125W F TC%0+=100 RESISTOR 30K .1% .125W F TC%0+=25 RESISTOR 7.5K 2% .125W F TC%0+=100 RESISTOR 10K .1% .125W F TC%0+=25 RESISTOR 10K .1% .125W F TC%0+=25	24546 28480 24546 28480 28480	C4=1/8=70-/501=G 0698=6977 < C4=1/8=10=/501=G 0698=6360 0698=6360
A11R71 A11R72 A11R73 A11R74 A11R75	0757=0915 0757=0915 0757=0915 0757=0915 0757=0907	1 1 1 1	a	RESISTOR 430 2% .125M F 1C=0+-160 RESISTOR 430 2% .125M F 1C=0+-100 RESISTOR 430 2% .125M F 1C=0+-100 RESISTOR 430 2% .125M F 1C=0+-100 RESISTOR 200 2% .125M F 1C=0+-100	24546 24546 24546 24546 24546	C4-1/8-10-431-6 C4-1/8-10-431-6 C4-1/8-10-431-6 C4-1/8-10-431-6 C4-1/8-10-201-0
A11876 A11877 A11878 A11879 A11880	1810*0202 0757*0972 0757*0944 0757*0926 2100*2632	4 0 6 4 4	1 2	NETWORK-RESISTOR 12 BIT BIN LADDER NTMK RESISTOR 100K 2% .125W F TCm0+-100 RESISTOR 6.8K 2% .125W F TCm0+-100 RESISTOR 1.2K 2% .125W F TCm0+-100 RESISTOR-TRMR 100 10% C SIDE-AOJ 1-TRN	73138 24546 24546 24546 30983	812-411-R50k C4-1/8-T0-1002-G C4-1/8-T0-080t-G C4-1/8-T0-120t-G ET50x101
A11R81 A11R82 A11R83 A11R84 A11R85	2100-2514 2100-2632 2100-2514 2100-2514 2100-2522	1 1	4	RESISTOR-TRMR 20K 10X C SIDE-ADJ 1-TRN RESISTOR-TRMR 100 10X C SIDE-ADJ 1-TRN RESISTOR-TRMR 20K 10X C SIDE-ADJ 1-TRN RESISTOR-TRMR 20K 10X C SIDE-ADJ 1-TRN RESISTOR-TRMR 10K 10X C SIDE-ADJ 1-TRN RESISTOR-TRMR 10K 10X C SIDE-ADJ 1-TRN	30983 30983 30983 30983 30983	ET50x203 ET50x101 ET50x203 ET50x203 ET50x103
A11R86 A11R87 A11R88 A11R89 A11R90	2100-2514 2100-2522 2100-2633 2100-2489 2100-2489	1595	1	RESISTOR-TRMR 20% 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 10% 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 1% 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 5% 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 1% 10% C SIDE-ADJ 1-TRN RESISTOR-TRMR 1% 10% C SIDE-ADJ 1-TRN	30983 30983 30983 34983	ET50×205 ET50×102 ET50×502 ET50×102
FILEGI	0757-0924	5		RESISTOR 14 2x .125W F TC=0+=100	24546	C4=1/8=T0=1001=6
A::TP: A::U:	1326=0205 1326=0205 1326=0207 1326=0207 1326=0207	0 33222	11	TERMINAL-STUD SGL-TUR PRESS-MTG OP AMP GP 8-CIP-P OP AMP M8 8-CIP-P OP AMP W8 8-CIP-P DP AMP W8 8-CIP-P OP AMP W8 8-CIP-P	28480 27014 27014 27014 27014	LW310W LW310W LW310W LW310W
AITUE AITUF AITUE AITUEO	1820=0493 1826=0208 1826=0208 1820=1938 1820=1617	6 22 0 0	8 5	OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P IC CMOS GUAD BILATERAL SWITCH IC CMOS DUAL D F-F POS EDSE CLOCK	27014 27014 27014 24480 94713	LM307N LM310N LM310N 1820-1936 MC14U138CP
41013 41013 41013 41014	1826=0208 1826=0208 1826=0208 1826=0208 1820=1938	3 3 3 6		OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OF AMP GP 8-DIP-P IC CMOS QUAD BILATERAL SWITCH	27014 27014 27014 27014 28480	LM310N LM310N LM310N LM310N
\$11016 \$17017 \$17019 \$17019 \$17019 \$11029	1820 = 1617 1820 = 1936 1826 = 6208 1820 = 1617 1826 = 6208	8 6 3 8 3		IC CMOS OUAL D F=F POS ÉDGE CLOCK IC CMOS QUAD SILATERAL SWITCH QP AMP GP 8-DIP=P IC CMOS DUAL D F=F POS EDGE CLOCK OP AMP GP 8-DIP=P	04713 28480 27914 04713 27014	MC14013MCP 1020-1938 MC14013MCP LMS10N



Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	c	Ωty	Description	Mfr Code	Mfr Part Number
Designation	Number	D 683	1	IC CMOS QUAO SILATERAL SWITCH IC CMOS DUAL D F-F POS EOGE CLOCK IC OFF CMOS QUAO	28480 04713 01925 28480	1820-1936 MC140138CP C04041At 1820-1622 1820-1622
A11U22 A11U23 A11U24 A11U25	1850=1955 1850=1955 1850=0458	5 5 5	4	IC SHF-RGTR CMOS DUAL 4-BIT	28480 27014 28480	LM310N 1820-1622
A11U26 A11U27 A11U28	1826=0208 1820=1622 1820=0471 1820=0980	3506	,	OP AMP GP 3-01FA ON OUAL 4-817 IC SHF-RGTR CMOS DUAL 4-817 IC 1NV 1TL HEX 1-1NP IC 8FR CMOS MEX 1-1NP IC 8HF-RGTR CMOS OUAL 4-817	01295 01928 26480	9074060 CD4010AF 1820=1622
A11U20	1820-1622	8 2		PIN-GRV .062-IN-DIA .25-IN-LG STL EXTR-PC 80 VIO POLYC .062-80-THKNS	28480 28480	1480-0110-
	4040=0755 05045=6001		1	BOARO ASSEMBLY, PIN ORIVE C (SERIES 1520)	28480	05045~60412
A12C1 A12C2 A12C3	0160=3456 0160=3456 0160=3456 0160=3456			CAPACITOR-FXO 1000PF +-10% 1KVDC CER CAPACITOR-FXD 1000PF +-10% 1KVDC CER CAPACITOR-FXD 1000PF +-10% 1KVDC CER CAPACITOR-FXO 1000PF +-10% 1KVDC CER CAPACITOR-FXO 1000PF +-10% 1KVDC CER	59490 59490 59490 59490 59490	0160-3456 0160-3456 0160-3456
A12C4 A12C5 A12C6 A12C6	0160=3456 0160=3456 0160=2055 0160=2055	And the second s	699	CAPACITOR=FXD 1000PF +*10% 1KVDC CER CAPACITOR=FXD .01UF +89=20% 100VDC CER CAPACITOR=FXD .01UF +89=20% 100VDC CER	59490 59490 59490 59490	
A12C8 A12C9 A12C10 A12C11 A12C12	0160-2055 0160-2055 0160-2055 0160-2201 0160-2201		9 9 7 1	CAPACITOR=FXD .01UF +80=20% 100VOC CER CAPACITOR=FXD .01UF +80=20% 100VOC MICA CAPACITOR=FXD 51PF +-5% 300VOC MICA CAPACITOR=FXD 51PF +-5% 300VOC MICA	28480 28480 28480 28480 28480	0160=2055 0160=2201 0160=2201
A12C13 A12C14 A12C15	0150=2201 0150=2201 0150=2201 0160=2201		7 7 7 7 7	CAPACITOR=FXU 51PF +=5% 300VDC MICA CAPACITOR=FXU 51PF +=5% 300VDC MICA CAPACITOR=FXD 51PF +=5% 300VDC MICA	2848 2848 2848 2848	0 0160-2201
A:2C:7 A:2C:6 A:2C:9 A:2C20	0160-220 0160-220 0150-012	1	7 5	CAPACITOR=FXD 51PF +=5% 300VDC MICA CAPACITOR=FXD 51PF +=5% 300VDC MICA CAPACITOR=FXD .1UF +80=20% 50VDC CER CAPACITOR=FXD .1UF +80=20% 50VDC CER	2848	0 0150=0121
412E1	0150-012 0757-089 0757-095	3	5	7 RESISTOR 51 2% .125% F TC#04-100 RESISTOR 2K 2% .125% F TC#04-100	2454 2454 2454 2454	16
A 1 2 R 2 A 1 2 R 3 A 1 2 R 4 A 1 2 R 5	0757-093 0757-089 0757-093	11	1	RESISTOR ZK ZX .125% F IC=0+=100	245 245 245	46 C4-1/8-10-1002-G
A12R6 A12R7 A12R8 A12R8	0757-09' 0757-09' 0757-09'	72 72 72	0	RESISTOR 100% 21 125W F 10=00+=100 RESISTOR 100% 21 125W F 10=0+=100 RESISTOR 100% 21 125W F 10=0+=100 RESISTOR 100% 21 125W F 10=0+=100	245 245 245	46 C4-1/8-70-1002-6 46 C4-1/8-70-1002-6 46 C4-1/8-70-1002-6
A12R10 A12R11 A12R12 A12R13	0757=09 0757=09 1810=00 0757=08 0757=08	72 41 193	0 9 4	RESISTOR 100K 2X .125W F TC#0+-100 NETWORK=RES 9-PIN-SIP .15-PIN-SPCG RESISTOR 51 2X .125W F TC#0+-100 RESISTOR 51 2X .125W F TC#0+-100 RESISTOR 51 2X .125W F TC#0+-100	285 245 245	1810+0041 546 546 546 546 546 64-1/8-10-5180-6 64-1/8-10-5180-6
A12R14 A12R15 A12R16 A12R17	0757-06 0757-0 0757-0 0757-0	814 814 972 818	9 9 0	4 RESISTOR 511 1% .5% F TC=0+=100 RESISTOR 100% 2% .125% F TC=0+=100 RESISTOR 511 1% .5% F TC=0+=100	26 26 24	480 0757=0814 546 0757=0814 546 04=1/8=10=1002=6 546 04=1/8=10=1002=6 546 04=1/8=10=101=6
A12R19 A12R10 A12R20 A12R21 A12R22	0757-0 0757-0 0757-0 0757-0	900 814 972	9	RESISTOR 100 - 2	26	0757=0814 1546 1
A12R23 A12R24 A12R25	0757=0 0757=0 0757=0 0757=0) 972) 955 0917	3	RESISTOR 100 2 .125 F TCB0+-100 RESISTOR 510 2 .125 F TCB0+-100 RESISTOR 50 2 .125 F TCB0+-100 RESISTOR 20K 2 .125 F TCB0+-100	5 5	4546
A12R27 A12R29 A12R29 A12R30	0757- 0757-	0955 0941 0941	3 3	RESISTOR 5.1K 2X .125W F TCEU+=100 RESISTOR 5.1K 2X .125W F TCEU+=100 RESISTOR 20K 2X .125W F TCEU+=100	} a	4546
A12R31 A12R32 A12R33 A12R34	0757- 0757- 0757- 0757- 0757-	094	3 3	RESISTOR 5.1K 2% .125W F TC=0+-100		24546
A12R36 A12R36 A12R37 A12R39 A12R39 A12R39	0757- 0757- 0757- 0757- 0757- 0757	-095 -095 -095 -095	5 9 5 9 5 9	RESISTOR 20K 2X .125% F ICE0++100 RESISTOR 3.6K 2X .125% F ICE0++100		24546

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A12R41 A12R42 A12R43 A12R44 A12R45	0757~0924 0757~0937 0757~0924 0757~0955 0757~0931	27291		RESISTOR 1K 2X ,125W F 15x0+-100 RESISTOR 3,6K 2% ,125W F 1C=0+-100 RESISTOR 1K 2X ,125W F 1C=0+-100 RESISTOR 20K 2X ,125W F TC=0+-100 RESISTOR 20K 2X ,125W F TC=0+-100	24546 24546 24546 24546 24546	C4-1/8-10-1001-6 C4-1/8-10-3641-6 C4-1/8-10-3641-6 C4-1/8-10-2002-6 C4-1/8-10-2001-6
A12U1 A12U2 A12U3 A12U4 A12U4	1820+0616 1820+1028 1820+0519 1820+0471 1820+0819	55100	1 1	IC MUXR/DATA+SEL TTL 2=TD=1=LINE GUAO IC (MISC ITEM) IC SFR TTL NAND GUAD 2=INP IC INV TTL HEX !=INP IC FF TTL D=TYPE POS=EDGE+TRIG CLEAR	07263 01295 01295 01295 01295	9322PC 9N7489N 8N7437N SN745N SN745N
A1206 A1207 A1208 A1209 A12010	1820=0716 1820=0716 1820=0782 1820=0683 1820=0693	00000		IC CNTR TTL 8IN SYNCHRU FOS-EDGE-TRIG IC CNTR TTL BIN SYNCHRO FOS-EDGE-TRIG IC GATE TTL NOR TPL 3-INP IC INV ITL S HEX 1-INP IC FF TTL S D-TYPE POS-EDGE-TRIG	01295 01295 01295 01295 01295	8N74161N SN74161N SN7427N SN74866N SN74874N
A:2011 A:2012 A:2013 A:2014 A:2015	1820=0367 1820=1184 1820=0669 1820=0328 1826=0055	M4000	\$	IC SMF-RGTR TTL R-S PRL-IN PRL-DUT 4-81T IC 6FR TTL NOR QUAD 2-INP IC GATE TTL NOR QUAD TPL 3-INP IC GATE TTL NOR QUAD 2-INP COMPARATOR GP DUAL 14-DIP-C	01295 01295 01295 01295 01295	3774 95 AN 577 A 28 N 577 A 28 I ON 574 O 2 N 7 I 1 O C
A12U16 A12U17 A12U18 A12U19 A12U20	1826-0955 1820-1615 1820-0468 1826-0955 1826-0955	01 6 55 6) E	1	COMPARATOR GP DUAL 19-DIP-C IC DCDR TTL BCO+TO=DEC 4-TO=10-LINE IC DCDRARATOR GP DUAL 14-DIP-C COMPARATOR GP DUAL 14-DIP-C	07263 04713 01295 07263 07263	711DC %C 4049%CP \$47445N 711DC 711DC
(2) (4)	1250-1368 1480-0116 4040-0747	7 8 2	6 2	CONNECTUR-RF \$M8 M PC 50=0HM PIN-GRV _062=IN-DIA _25=IN-LG STL EXTR=PC BO GRA POLYC _062=80+THKNS	59490 58490 59490	1250=13c8 1480=011c 4046=0747
A11	05045=60013	9	1	BOARD ASSEMBLY, PIN DRIVER (SERIES 1916)	28480	@\$\#5≂6UV1å
413C1 413C2 413C3 413C4 413C5	0180=2201 0170=0094 0170=0094 0160=2201 0160=3456	7 3 3 7 6	8	CAPACITOR-FXD 51FF +-5% 300V0C MICA CAPACITOR-FXD 0047UF +-20% 50V0C POLYE CAPACITOR-FXD 047UF +-20% 50VDC POLYE CAPACITOR-FXD 1000FF +-10% 1KVDC CER	28480 84411 84411 28480 28480	0160-2201 602-473085%2 602-473085%2 0160-2201 0160-3056
Å13C6 Å13C7 Å13C8 Å13C9 Å13C10	0160~3456 0160~3456 0160~3456 0160~3456 0160~3201	6 6 6 7		CAPACITOR-FXD 1000FF +=10% 1KVDC CER CAPACITOR-FXD 1000FF +=10% 1KVDC CER CAPACITOR-FXD 1000FF +=10% 1KVDC CER CAPACITOR-FXD 1000FF +=10% 1KVDC CER CAPACITOR-FXD 51FF +=5% 300VDC MICA	28480 28480 28480 28480 28480	0160-3456 0160-3456 0160-3456 0160-3456 0160-2291
413C11 413C12 413C13 413C14 #13C15	0170*0094 0170=0094 0160*2201 0160*3456 0160*3456	3 7 6 6		CAPACITOR-FXD .047UF +=20% 50VDC PDLYE CAPACITOR-FXD .047UF +=20% 50VDC PDLYE CAPACITOR-FXD 51PF +=5% 30VDC MICA. CAPACITOR-FXD 1000PF +=10% 1KVDC CER CAPACITOR-FXD 1000PF +=10% 1KVDC CER	84911 84411 28480 28480 28480	602=4730R5A2 602=4730R5W2 0160=2201 0160=3456 0160=3456
At3C16 A13C17 A13C16 A13C19 A13C20	0160=3456 0160=3456 0160=3456 0160=2204 0160=3454	6 6 0 4	10	CAPACITOR-FXD 1000PF +-10% 1KVOC CER CAPACITOR-FXD 1000PF +-10% 1KVDC CER CAPACITOR-FXD 1000PF +-10% 1KVDC CER CAPACITOR-FXD 1000PF +-10% 1KVDC MICA CAPACITOR-FXD 220PF +-10% 1KVOC CER	28480 28480 28480 28480 28480	3160=3456 4160=3456 4160=3456 0160=2204 0160=3454
413C22 413C23 413C23 413C23	0160-3454 0160-3454 0160-2204 0150-0071 0160-3454	4044	4	CAPACITUR-FXO 220PF +-10X 1KVOC CER CAPACITOR-FXO 220PF +-10X 1KVOC CER CAPACITOR-FXD 100PF +-5X 1KVOC CER CAPACITOR-FXD 400PF +-5X 1KVOC CER CAPACITOR-FXD 220PF +-10X 1KVOC CER	26460 26460 26460 26460 26460	0150-1454 0150-3454 0150-2204 0150-0071 0150-3454
A11026 A11027 A12028 A13029 A13030	0150+3455 0150+3455 0150+3456 0150+3456 0160+2199	20002	8	CAPACITOR=FXD 1000PF +=19X 1KVOC CER CAPACITOR=FXD 1000PF +=10X 1KVOC CER CAPACITOR=FXD 1000PF +=10X 1KVOC CER CAPACITOR=FXD 1000PF +=10X 1KVOC CER CAPACITOR=FXD 30PF +=5X 100VOC MICA	\$8480 \$8480 \$6480 \$8480 \$480	0100 * 3456 0160 = 3456 0160 = 3456 0160 = 3456 0160 = 2149
A13C11 A13C12 A13C14 A13C14 A13C35	0160-2199 4052-6610 4052-6610 9052-6610	2005	,	CAPACITOR-FXD 30FF +-5X 300V0C MICA CAPACITOR-FXD 100FF +-5X 300V0C MICA CAPACITOR-FXD 100FF +-5X 300V0C MICA CAPACITOR-FXD 30FF +-5X 300V0C MICA CAPACITOR-FXD 30FF +-5X 300V0C MICA	58480 58480 58480 58480	0160-2149 0160-2204 0160-2204 0160-2149 0160+2149
A13C17 A13C17 A13C18 A14C19 A13C48	0170-0094 0170-0094 0160-2199 0160-2199 0170-0094	33223		CAPACITOR-FXO .047UF ++20X 50VOC POLYE CAPACITOR-FXO .047UF ++20X 50VOC POLYE CAPACITOR-FXO 30PF ++5X 300VOC MICA CAPACITOR-FXO 30PF ++5X 500VOC MICA CAPACITOR-FXO _047UF ++20X 50VOC POLYE	84411 84411 28480 28480 34411	502-4730K5N2 502-4730K5N2 0150-2149 0150-2149 002-4730R5N2
Allen Allen Allen Allen Allen Allen	0170-0094 0150-0071 0150-0071 0150-0071 0160-2204	3 4 4 0	- Avenue and a second	CAPACITOR=FXD .047UF +=20% 50VDC PDLYE CAPACITOR=FXD 400RF +=5% 1KVDC CER CAPACITOR=FXD 400PF +=5% 1KVDC CER CAPACITOR=FXD 400PF +=5% 1KVDC CER CAPACITOR=FXD 100PF +=5% 300VDC MICA	84411 28460 28460 26460 26460	602-4730K5%2 0150-0071 0150-0071 0150-0071 0160-2204



Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	C	Qty	Description	Mfr Code	Mfr Part Number
Designation	Number 0160-2199	5 5		CAPACITOR-FKD 30PF +-5% 360VDC MICA CAPACITOR-FKD 30PF +-5% 300VDC MICA	28480 28480 28480	0160-2199 0160-2199 0160-2204
A13047 A13048 A130R1	0160-2199 0160-2204 1901-0040	0		DIDDE-SWITCHING 30V SOMA 2NS DO-35	26460 26460 26460	1901-0040 1901-0040 1901-0040
A13CRA A13CRA A13CR4 A13CR4	1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		DIODE-SWITCHING 30V 50M4 2NS 00-35 DIODE-SWITCHING 30V 50M4 2NS 00-35 DICDE-SWITCHING 30V 50M4 2NS 00-35	28480 28480 28480	1901-0040 1901-0040 1901-0040
AIBCR6 AIBCR7 AIBCR8 AIBCR9 AIBCR10	1901-0040 1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1		DIDDE-SWITCHING 30V SQMA 2NS D0-35 DIDDE-SWITCHING 30V SQMA 2NS D0-35 DIDDE-SWITCHING 30V SQMA 2NS D0-35 DIDDE-SWITCHING 30V SQMA 2NS D0-35 OIDDE-SWITCHING 30V SQMA 2NS D0-35	28480 28480 28480 28480	1901=0040 1901=0040 1901=0040 1901=0040
A13CR11 A13CR12 A13CR13 A13CR14 A13CR15	1902-3193 1902-3193 1902-3193 1902-3193 1901-0040	3 3 3 3		OIODE-ZNR 13.3V 5% DG-7 PDE,4W 7C*+,059% DIODE-ZNR 13.3V 5% DG-7 PDE,4W 7C*+,059% OIODE-ZNR 13.3V 5% DG-7 PDE,4W 7C*+,059% DIODE-ZNR 13.3V 5% DG-7 PDE,4W 7C*+,059% DIODE-ZNR 13.3V 5% DG-7 PDE,4W 7C*+,059% DIODE-SWITCHING 36V 50MA 2NS DG-35	28480 28480 28480 28480	1902-3193 1902-3193 1902-3193 1901-0040
A13CR16 A13CR17 A13CR19 A13CR20	1901=0040 1901=0518 1901=0518 1901=0040 1910=0034	8 8 1	6	DIDDE-SHITCHING 30V 50MA 2NS DO-15 DIQDE-SCHOTTKY DIODE-SCHOTTKY DIODE-SHITCHING 30V 50MA 2NS DO-35 DIQDE-SE 30V 60MA 6NS DO-7	28480 28480 28480 28480	1901-0518 1901-0518 1901-0518 1910-0040 1910-0054
A13CR21 A13CR22 A13CR23 A13CR24 A13CR25	1901-0040 1901-0050 1901-0050 1901-0050	10 miles	108	DIODE-SWITCHING 30V 58MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-35 DIODE-SWITCHING 80V 200MA 2NS 00-55 DIODE-SWITCHING 80V 200MA 2NS DU-35 DIODE-SWITCHING 80V 200MA 2NS 00-35	28480 28480 28480 28480 28480	1901-0050 1901-0050 1901-0050 1901-0050
A13CR26 A13CR27 A13CR28 A13CR29 A13CR30	1901-0050 1901-0050 1901-0050 1901-0050 1910-0034		3 3 3 2	DIODE-SWITCHING BOV 200MA 2NS 00-35 DIODE-SWITCHING BOV 200MA 2NS 00-35 DIODE-SWITCHING BOV 200MA 2NS 00-35 DIODE-SWITCHING BOV 200MA 2NS 00-35 DIODE-SWITCHING BOV 200MA 2NS 00-35 DIODE-GE 10V 80MA 8NS 00-7	28480 28480 28460 28460 28480	1901=0050 1901=0050 1901=0050 1910=0054
A13CR31 A13CR32 A13CR33 A13CR34 A13CR35	1910-0034 1901-0518 1901-0518 1901-0518		288888	DIODE-SCHOTIKY DIODE-SCHOTIKY DIODE-SCHOTIKY DIODE-SCHOTIKY DIODE-SCHOTIKY	28480 28480 28480 28480	1901-0518 1901-0518 1901-0518 1901-0518
A13CR36 A13Q1 A13Q2 A13Q3 A13Q4	1854-0071 1854-0634 1854-0071 1854-0071		7 8 7 7	TRANSISTOR NPN SI PORJOOMN FTE2COMHZ TRANSISTOR NPN SI PORJOOMN FTE2COMMZ	28480 04713 28480 28480 28480	1854-0071 MP3-U01 1854-0071 1854-0071 1854-0071
A1305 A1306 A1307 A1308 A1309	1854-0634 1854-0634 1854-0071 1853-0020		7 8 7 3	TRANSISTOR NPN SI PD#300MW FT#200MHZ TRANSISTDR NPN SI PD#1W FT#50MHZ TRANSISTOR NPN SI PD#300MW FT#200MHZ TRANSISTOR PNP SI PD#300MW FT#150MHZ TRANSISTOR PNP SI PD#1W FT#50MHZ	28480 04713 28480 28480 04713	1853-0020 MPS-U51
A13010 A13011 A13012 A13013 A13014	1853-0020 1853-0020 1853-0020 1853-0320)) b	4 4 3	TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#30 FT#50MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ TRANSISTOR PNP SI PD#300MW FT#150MMZ	28480 28480 28480 04711 26480	1853-0020 1853-0020 MPS-U51 1853-0020
A13015 A13016 A13017 A13018 A13019	1853-002 1854-067 1854-007 1854-067	0 0 1	2 7 2 7	IRANSISTOR PNP SI POE300MM FTE150MMZ TRANSISTOR NPN SI DARL POE50M TRANSISTOR NPN SI POE300MM FTE200MMZ TRANSISTOR NPN SI DARL PUE50M TRANSISTOR NPN SI POE300MM FTE200MMZ	2848 0129 2648 0129 2848	5 TIP110 1854-0071 11P110 0 1854-0071
A13Q20 A13Q21 A13Q22 A13Q23	1853-002 1853-037 1853-037 1853-002	7	4 4	TRANSISTOR PNP SI PD#300MW FT#150MMZ PANSISTOR PNP SI DARL PD#50W TRANSISTOR PNP SI DARL PD#50W TRANSISTOR PNP SI PD#300MW FT#150MMZ	2848 0129 0129 2848	5 71P 115 1853-0020
A13024 A13R1 A13R2 A13R3 A13R4	0757-090 0757-090 0757-090 0757-028	9 9 9 9 8 3	3 3 1 6	2 RESISTOR 240 2X .125W F IC=0++100 RESISTOR 240 2X .125W F IC=0++100 RESISTOR 200 2X .125W F IC=u++100 RESISTOR 2X 125W F IC=u++100 RESISTOR 2X 1X .125W F IC=u++100 RESISTOR 25 1X 3W PW IC=u+20	5 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	6 C4-1/8-T0-2411-6 C4-1/8-T0-2001-F OBLI-3453
A13R5 A13R6 A13R7 A13R8 A13R9	0757=02/ 0757=09/ 0811=34/ 0757=09/ 0757=09/	83 70 53 74	6 2 4 2 4	RESISTOR 2K 1% 125 FTL =0+-100 RESISTOR 120% 2% 125 FTC=0+-100 RESISTOR 25 1% 12 PT TC=0+-100 RESISTOR 120% 2% 125 FTC=0+-100 RESISTOR 120% 2% 125 FTC=0+-100	2454 2454 245 245	46
A13R10 A13R11 A13R12 A13R13 A13R15	0757=09 0757=09 0757=09 0757=09 0757=09	65 18 65	the second	RESISTOR 51K 2X .125% F TC=0+-100 RESISTOR 560 2X .125% F TC=0+-100 RESISTOR 51K 2X .125% F TC=0+-100 RESISTOR 200 2X .125% F TC=0+-100 RESISTOR 120K 2X .125% F TC=0+-100	245	46

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A13R16 A13R17 A13R18 A13R18 A13R20	0757-0974 0811-3453 0757-0283 0757-0283 0611-3453	Na o o a		RESISTOR 120K 2% 125W F TC=0+-100 RESISTOR 25 1% 3M PM TC=0+-20 RESISTOR 2K 1% 125W F TC=0+-100 RESISTOR 2K 1% 125W F TC=0+-100 RESISTOR 2K 1% 125W F TC=0+-20	24546 28680 24546 24546 26480	C4-1/8-f0-3-02-6 0811-3453 C4-1/8-10-2001-F C4-1/8-10-2001-F 0811-5453
A13R21 A13R22 A13R23 A13R24 A13R25	0757-0918 0757-0965 0757-0965 0757-0918 0757-0948	4 1 1 0		RESISTOR 560 2x .125% F TC=0+-100 RESISTOR 51% 2x .125% F TC=0+-100 RESISTOR 51% 2x .125% F TC=0+-100 RESISTOR 560 2x .125% F TC=0+-100 RESISTOR 10% 2x .125% F TC=0+-100	24546 24546 24546 24546	C4-1/8-70-561-G C4-1/8-70-5102-G C4-1/8-70-5102-G C4-1/8-70-511-G C4-1/8-70-1002-5
A:1826 A:1827 A:1828 A:1829 A:1820	0757-0948 0757-0948 0757-0948 0757-0937 0757-0923	0 0 7	q	RESISTOR 10% 2% .125% F TC=0+-100 RESISTOR 10% 2% .125% F TC=0+-100 RESISTOR 10% 2% .125% F TC=0+-100 RESISTOR 3,6% 2% .125% F TC=0+-100 RESISTOR 910 2% .125% F TC=0+-100	24546 24546 24546 24546 24546	C4-1/8-10-1002-6 C4-1/8-10-1002-6 C4-1/8-70-1002-6 C4-1/8-70-3601-6 C4-1/8-70-911-6
A13R31 A13R32 A13R33 A13R34 A13R35	0757-0923 0757-0923 0757-0263 0757-0955 0757-0976	1 5 9 4		RESISTOR 910 2x .125% F TC=0++100 RESISTOR 910 2x .125% F TC=0+-100 RESISTOR 2k 1% .125% F TC=0+-100 RESISTOR 20k 2x .125% F TC=0+-100 RESISTOR 150k 2x .125% F TC=0+-100	24546 24546 24546 24546	C4-1/8-70-91:-G C4-1/8-70-911-G C4-1/8-70-2001-P C4-1/8-70-2002-G C4-1/8-70-1502-G
A:3R36 A:3R37 A:3R36 A:3R39 A:3R40	0757-0924 0757-0976 0757-0955 0757-0283 0757-0911	24967		RESISTOR 1K 2% 125W F TC=0+-100 RESISTOR 150K 2% 125W F TC=6+-100 RESISTOR 20K 2% 125W F TC=0+-100 RESISTOR 2K 1% 125W F TC=0+-100 RESISTOR 300 2% 125W F TC=0+-100	24546 24546 24546 24546 24546	C4-1/8-f0-1001-G C4-1/8-f0-1502-G C4-1/8-10-2002-G C4-1/8-10-201-F C4-1/8-10-301-G
At3R41 A13R42 A13R43 At3R44 At3R45	0757+0937 0757-0924 0698-3457 0757-0976 0698-3457	7 2 5 4 6	4	RESISTOR 3,6K 2% ,125W F TC=0+-100 RESISTOR 1K 2% ,125M F TC=0+-100 RESISTOR 316K 1% ,125W F TC=0+-100 RESISTOR 150K 2% ,125W F TC=0+-100 RESISTOR 316K 1% ,125W F TC=0+-106	24546 24546 28480 24546 28480	C4=1/8=10=3601=G C4=1/8=10=1001=G 0598=3457 C4=1/8=10=1502+G 0594=3457
A13846 A13847 A13848 A13849 A13850	0757-0937 0757-0924 0757-0924 0757-0976 0757-0937	7 2 2 4 7		RESISTOR 3.6K 2% .125W F 7Cm0+-100 RESISTOR 1K 2% .125W F 7Cm0+-100 RESISTOR 1K 2% .125W F 7Cm0+-100 RESISTOR 150K 2% .125W F 7Cm0++100 RESISTOR 3.6K 2% .125W F 7Cm0+-100	24546 24546 24546 24546 24546	C4-1/8-10-3501-G C4-1/8-10-1001-G C4-1/8-10-1001-G C4-1/8-10-1502-G C4-1/8-10-3501-G
A13R51 A13R52 A13R53 A13R54 A13R55	0757-0911 0757-0911 0757-0923 0757-0924 0698-3457	7 7 1 2 6		RESISTOR 300 2% .125W F fC=0+-100 RESISTOR 300 2% .125W F fC=0+-100 RESISTOR 910 2% .125W F fC=0+-100 RESISTOR 1K 2% .125W F fC=0+-100 RESISTOR 1K 2% .125W F fC=0+-100	24546 24546 24546 24546 28480	C4-1/8-10-301-6 C4-1/8-10-301-6 C4-1/8-10-911-6 C4-1/8-10-1001-6 0698-3457
A:3856 A:3857 A:3856 A:3856 A:3850	0757-0924 0698-3457 0757-0911 0757-0955 0757-0955	26799		RESISTOR 1K 2% ,125W F TC=0+-100 RESISTOR 316K 1% ,125W F TC=0+-100 RESISTOR 3100 2% ,125W F TC=0+-100 RESISTOR 20K 2% ,125W F TC=0+-100 RESISTOR 20K 2% ,125W F TC=0+-100	24546 24546 24546 24546	C4-1/8-10-2032-G C4-1/8-10-2032-G C4-1/8-10-301-G C4-1/8-10-1001-G
A13R61 A13R62	0757-0283 0757-0283	5.6		RESISTOR 2K 1% .125% F TC=0+=100 RESISTOR 2K 1% .125% F TC=0+=100	2#5#6 245#6	C4-1/8-10-2001-F C4-1/8-10-2001-F
A13U1 A13U2 A13U3 A13U4 A13U5	1826 = 0311 1820 = 1619 1826 = 0311 1820 = 1618 1820 = 1620	9 0 9 3	8 2 2 3	OP AMP GP 8-01P-P IC GATÉ CHOS EXCL-UR/NUR TPL 3-INP OP AMP GP 8-01P-P IC GATE CMOS NAND TPL 3-INP IC GATE CMOS NOR QUAD 2-INP	04713 04713 04713 94713 04713	MC!4091NRCH MC!4053NRCH MC!4053NRCH MC!4055UBCH MC!405UBCH MCM20!4P1
A13U6 A13U7 A13U8 A13U8 A13U10	1820-4621 1826-0311 1826-0311 1826-0311	4999	1	IC GATE CMOS NAMO GUAD 2-IMP OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P OP AMP GP 8-DIP-P	04713 04713 04713 04713 04713	MC10201AP1 MLM201AP1 MLM201AP1 MLM201AP1
413011 413012 413013 413014 413015	1826-0311 1820-1619 1826-0311 1820-1618 1820-1620	9 0 9 3		OP AMP GP 8-DIP-P IT GATE CMOS EXCL-OR/NOR TPL 3-INP OP AMP GP 8-DIP-P IT GATE TMOS NAND TPL 3-INP IT GATE CMOS NOR GUAD 2-INP	04713 04713 04713 04713 04713	#C { 4 4 6 1 4 4 1 4 1 4 1 4 1 4 1 4 1 4 1 4
Af3016 Af3017 Af3018 Af3019 Af3020	1820-1938 1820-1938 1820-1614 1820-1614 1820-1620	66553	5	IC IC, CMOS, 40168 AD IC, CMOS, 40168 AD IC GATE CMOS NOR QUAD 2-1%P	20480 26480 26480 28480 94713	#C140017#C5 1850#1914 1850#1914 1850#1919 1850#1938
Atauss Atauss Atauss Atauss Atauss	1520-1614 1820-1617 1820-1614 1820-1614 1820-1936	5 8 5 6		IC, CMOS, 40168 40 IC CMOS DUAL D F-F POS EDGE CLOCK IC, CMOS, 40168 40 IC, CMOS, 40168 40 IC	28480 28480 28480 28480	1820-1614 *C14013#CP 1#20-1614 1#20-1614 1#20-193#
A13U26	1620-1938	6		IC	\$6498	1550-1950



	Tal		Mfr	Mfr Part Number
Reference Designation A14 A15 A16 A17 A16 A19 A20 A21 A22 A23 A24 A25 A25C1 A25C2 A25C3 A25C3 A25C4 A25C3 A25C4	HP Part C Qty 0340-0579 0 1 0340-162 0 0570-0125 9 14040-0710 9 2 2360-0055 05045-20202 5 1	Description INSULATOR RUBBER RED TERMINAL-STUD SCL-TUR PRESS-MTG TERMINAL-STUD SCL-TUR PRESS-MTG SCREW-MACH 4-40 .188-IN-LG 80G-MO-SLT PIN-GRV .062-IN-01A .25-IN-LG STL EXTR-PC 8D BLK POLYC .07-80-THKS SCREW-MACH 6-3? .188-IN-LG 80G-MO-SLT MEAT SINK SAME AS A13, USE PREFIX A14 SAME AS A13, USE PREFIX A15 SAME AS A13, USE PREFIX A15 SAME AS A13, USE PREFIX A16 SAME AS A13, USE PREFIX A26 SAME AS A13, USE PREFIX A26(OPTION OR SAME AS A13, USE PREFIX A20(OPTION OR SAME AS A13, USE PREFIX A20(OPTION OR SAME AS A13, USE PREFIX A22 SAME AS A13, USE PREFIX A21 SAME AS A13, USE PREFIX A22 CARD READER INTERFACE ASSEMBLY THE CARD READER INTERFACE AND TH SENSOR ASSEMBLY ANE AN EXCHANGE ORDERED SY PART NUMBER 98819-679 THE REPLACEMENT PARTS ARE LISTED THE REPLACEMENT PARTS ARE LISTED CAPACITOR-FXD 22UF+-10X 15VDC TA CAPACITOR-FXD 21UF +80-20X 100VDC CAPACITOR-FXD 21UF +80-20X 100VDC	Code 28480 28480 28480 28480 28480 28480 28480	Mfr Part Number 0340-0579 0360-1682 0RDER BY DESCRIPTION 1460-0116 4040-0710 ORDER BY DESCRIPTION 05045-20202 1500226×901582
452CS	0180-0228 0160-0128 0160-0128 0160-0128 0160-0138 0150-0084 0150-0084 0150-0084 0160-2204 0160-2001 0160-2204 0160-2001 0160-2001 0160-2001 0160-2001	2 CAPACITOR=FXD 2_2UF +20X 25V0C CAPACITOR=FXD 4UF +80=20X 100 V0C CAPACITOR=FXD 1UF +80=20X 100 V0C CAPACITOR=FXD 1UF +80=20X 100 V0C CAPACITOR=FXD 01UF +100=0X 50V CAPACITOR=FXD 20UF+-10X 15V0C TAPACITOR=FXD 20UF+-10X 15V0C CAPACITOR=FXD 01UF+100=0X 50V CAPACITOR=FXD 100 PF +-5X 300 V0C CAPACITOR=FXD 100 PF +-5X 300 V0C CAPACITOR=FXD 20UF+-10X 15V0C CAPACITOR=FXD 50 PF +-1X 500 V0C CAPACITOR=FXD 50 PF +	CERRECER CCER CCER CCER CCER CCER MICA MICA MICA MICA MICA MICA MICA MICA	28480 0150-0084 0150-0084 0150-0084 0150-0084 0150-0084 0150-0084 0150-0084 0160-3847 1500226×901582 0160-2001 0160-

introduction to this section for ordering information

eference	HP Part	C D	Qty		Description	Mfr Code	M	fr Part Number	_
Designation SCR43 SCR100 SCR101 SCR101	1901-0040 1901-0040 1901-0040 1902-0041 1902-0041	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	и	0100 0100 0100	SWITCHING 30V 50MA 2NS DD-35 SWITCHING 30V 50MA 2NS DD-35 SWITCHING 30V 50MA 2NS DO-35 SWITCHING 30V 50MA 2NS DD-35 E-SWITCHING 30V 50MA 2NS DD-35	28480 28480 28480 28480 28480	1901=0 1901=0 1901=0 1902=0 1901=0	ስተር ዕቴ7 የተር	
5CR102 SCR103 SCR105 SCR104	1901=0040 1901=0040 1901=0040 1901=0040	1 1 1		0100	E-SWITCHING 30V 50MA 2NS DD-35 E-SWITCHING 30V 50MA 2NS DD-35 E-SWITCHING 30V 50MA 2NS DD-35 E-SWITCHING 30V 50MA 2NS DD-39 E-INR 5,11V 5% DD-7 PD=,4W TC=-,009%	26480 26480 26480 26480	1901=0 1901=0 1902=0	1047 4040 4040 4040	
25CR201 25CR201 25CR202 25CR203 25CR203 25CR204	1902=0041 1901=0040 1901=0040 1901=0040	1 1 1 1		0100	DE-SWITCHING BOV SOMA 2NS DO+35 DE-SWITCHING BOV SOMA 2NS DO-35 DE-SWITCHING BOV SOMA 2NS DO-35 DE-SWITCHING BOV SOMA 2NS DD-35 DE-2NR 5.11V 5X DO-7 PDE. GW TCE009X	\$8480 \$8480 \$8480 \$8460 \$8480		4040 004a 604a	
25CR300 25CR301 25CR302 25CR303 25CR303	1902=0041 1901=0040 1901=0040 1901=0040	4		010	DE-SWITCHING 30V SOMA 2NS DO-35 DE-SWITCHING 30V SOMA 2NS CO-35 DE-ZNR 5.11V 5% DO-7 PDS.4W TCS-009%	59480 58480 58880	1901= 1901=	.0040 .0040	
125CR400 125CR401 125CR402 125CR403	1901-0040 1902-0041 1901-0040 1901-0040 1901-0040	1 1 1		010	DE-SWITCHING 30V 50MA 2NS 00-35 DE-SWITCHING 30V 50MA 2NS 00-35 DDE-SWITCHING 30V 50MA 2NS 00-35 DDE-SWITCHING 30V 50MA 2NS 00-35 DDE-SWITCHING 30V 56MA 2NS 00-35	58486 58486 58486	1901 1901 1901	-0040 -0040 -0040	
A25CR405 A25CR406 A25G: A25G: A25G2	1854-0404 1853-0010 1854-0404	0	1	TR TR TR	ANSISTOR NPN SI TD=16 PD=366MM ANBISTOR PNP SI TD=18 PD=366MM ANSISTOR NPN SI TD=18 PD=366MM ANSISTOR NPN SI TD=18 PD=366MM	28485 2845 28485 28485 28485	0 1853 0 1854 0 1859	-0404 -9010 -0404 -0404 -0404	
A25011 A25021 A25022 A25023	1854-0404 1854-0404 1853-0010 1854-0404 1854-0404	0 0 0 0 0		TR TR	ANSISTOR NPN SI TO-18 PD=3-00MM ANSISTOR NPN SI TO-18 PD=3-60MM RANSISTOR NPN SI TO-18 PD=3-60MM RANSISTOR NPN SI TO-18 PD=3-60MM RANSISTOR NPN SI TO-18 PD=3-60MM	594 594 594 594 594 594	00 185 50 185 80 185 80 185	4-0404 4-040n 4-040n 4-040n	
A25041 A25041 A25042 A25001 A25044	1854-040 1853-040 1853-040 1853-040	4 0 0	2	1	RANSISTOR NPN SI TO-18 PD=360M# RANSISTOR PNP SI TO-18 PD=360M# RANSISTOR PNP SI TO-18 PD=360M# RANSISTOR NPN SI TO-18 PD=360M# RANSISTOR NPN SI TO-18 PD=360M# RANSISTOR PNP SI TO-18 PD=360M#	284 284 284 284 284	80 185 80 185 80 185 80 185	4-9404 3-0010 3-0010 4-0404 3-0010	
A25045 A250101 A250103 A250105 A250105	1853-001 1854-040 1854-040 1854-040 1853-000	0 4 04	2000	T	RANSISTOR NPN SI TO-18 PD=360MM PANSISTOR NPN SI TO-18 PD=360MM PANSISTOR NPN SI TO-18 PD=360MM PANSISTOR NPN SI TO-18 PD=360MM PRANSISTOR NPN SI TO-18 PD=360MM PRANSISTOR NPN SI TO-18 PD=360MM		180 181 180 18 180 18	4 - 6404 54 - 0404 55 - 0404 54 - 0404	
A250107 A250201 A250203 A250204 A250205	1854=04 1853=00 1854=04 1854=04	10 04 04	2000		TRANSISTOR PNP SI TO-18 PD=360MW TRANSISTOR NPN SI TO-18 PD=360MW TRANSISTOR NPN SI TO-18 PD=360MW TRANSISTOR NPN SI TO-18 PD=360MW TRANSISTOR PNP SI TO-18 PD=360MW TRANSISTOR PNP SI TO-18 PD=360MW	28 28 28	080 18 480 18 080 18	53-0010 54-0404 54-0404 54-0404	
4250204 4250207 4250301 4250303 4250303	1853=60 1854=6 1853=00 1854=0	464 464	8 0 2 0 0		TRANSISTOR NPN SI TG-18 PO=3609W TRANSISTOR PNP SI TO-16 PO=3609W TRANSISTOR NPN SI TG-18 PO=3609W TRANSISTOR NPN SI TG-18 PO=3609W TRANSISTOR NPN SI TO-18 PO=3609W	21	1480 1 1480 1 1480 1 1480 1	554-0484 553-0010 554-0404 554-0404	
A250305 A250300 A250300 A250401 A250403	1854-0 1854-0 1854-0 1854-0	010 404 010	0 0 0 0		TRANSISTOR PNP SI TO-18 PDE3604W TRANSISTOR NPN SI TO-18 PDE3604W TRANSISTOR PNP SI TO-18 PDE3604W TRANSISTOR NPN SI TO-18 PDE3604W TRANSISTOR NPN SI TO-18 PDE3604W TRANSISTOR NPN SI TO-18 PDE3604W	2	8480 1 8480 8480 1 8480	853-0010 851-0404 853-0010 854-0404	
1250404 1250404 1250404	1650×0 1654×0 1855×0 1654×0	3404	0 2 0		TRANSISTOR NPN SI TO-18 PUB360MM TRANSISTOR PNP SI TU-18 PDB360MM TRANSISTOR NPN SI TO-18 PDB360MM		8480 8480	CR1031 82=-0004 82=-0010 824-0404	
Agent Agens Agens Agens	0084- 0094- 1084- 0084-	1031 1021 1031	7 0 8	16 7 1	RESISTOR 10K 10X .25% FC TCB=400/+? RESISTOR 1K 10X .25% FC TCB=400/+60 RESISTOR 470 10X .25% FC TCB=400/+66 RESISTOR 1K 10X .25% FC TCB=400/+66	0 0	01121 26460 01121	CR105/ CR411; CR411; CR105;	
A2507 A2505 A25010 A25011 A25012 A25013	9664- 0684- 9698- 0684- 0684-	2231 -5101 -2241 -1031	7 3 5 9 2	5 4	RESISTOR 22K 10% .25W FC TC%-400/+8 RESISTOR 33 10% .25W FC TC%-400/+8 RESISTOR 220K 10% .25W FC TC%-800/+1 RESISTOR 10K 10% .25W FC TC%-400/+1 RESISTOR 47K 10% .25W FC TC%-400/+1	10 19 1900	01121 01121 01121 01121 01121	CR4731 CR4731 CR4731	
	0698 0684 0684	-4731 -5101 -2241 -1031 -4731	5	7 8	RESISTOR 33 10% .25% FC TC=-800/+51 RESISTOR 220K fc x.25% FC TC=-800/ RESISTOR 10K 10% .25% FC TC=-400/+ RESISTOR 47K 10% .25% FC TC=-400/+ RESISTOR 100K 10% .25% FC TC=-400/	00 +900 709 800	01121 01121 01121 01121	C#3301 C#2241 C#1031 C#4731 C#1041	



Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	C	Oty		Description	Mfr Code	Mfr Part Number
Designation A25R25 A25R30 A25R31 A25R32	Number 0684-1031 0698-5101 0684-2241 0684-1031	9 15 9		R	ESISTOR 16K 10% -25% FC TC%-400/+700 ESISTOR 33 10% ,25% FC TC%-400/+500 ESISTOR 220K 10% ,25% FC TC%-800/+900 ESISTOR 10% 10% ,25% FC TC%-000/+700 ESISTOR 47K 10% ,25% FC TC%-000/+800	01121 12110 12110 12110 12110	CB1031 CB5301 CB2241 CB1031 CB4731
#25R33 A25R33 A25R41 A25R41 A25R42 A25R443 A25R44	0684-4731 0698-5101 0684-2241 0684-1031 0684-1731 0694-1041	2 15025		8	ESISTOR 33 10% .25% FC TC==400/+500 ESISTOR 220% 10% .25% FC TC==400/+900 ESISTOR 10% 10% .25% FC TC==400/+700 ESISTOR 47% 10% .25% FC TC==400/+800 ESISTOR 490K 10% .25% FC TC==400/+800	01121 01121 01121 01121 01121	CH3501 CH2241 CB1031 CH4731 CB1041
A25R45 A25R46 A25R47 A25R48	0684-1031 0684-1331 0684-2231 0684-1031 0684-2231	9 6 3 9 3	1		RESISTOR 10K 10X .25W FC ICE-400/+700 RESISTOR 33K 10X .25W FC ICE-400/+800 RESISTOR 22K 10X .25W FC ICE-400/+800 RESISTOR 10K 10X .25W FC ICE-400/+700 RESISTOR 22K 10X .25W FC ICE-400/+800 RESISTOR 22K 10X .25W FC ICE-400/+800	01121 01121 01121 01121 01121	CB3331 CB2231 CB1031 CB2231
A25R49 A25R50 A25R101 A25R102 A25R103 A25R104	0684-4721 0684-1031 0684-1031 0684-2721 0684-1221	09969	1	- i	RESISTOR 4.7K 10% .25m FC TC==400/+700 RESISTOR 10% 10% .25m FC TC==400/+700 RESISTOR 10% 10% .25m FC TC==400/+700 RESISTOR 2.7K 10% .25m FC TC==400/+700 RESISTOR 1.2K 10% .25m FC TC==400/+700 RESISTOR 1.2K 10% .25m FC TC==400/+700	01121 01121 01121 01121	CH1031 CH1031 CH2721 CH1221 CA-1/8-TU-1001-F
\$25R105 \$25R105 \$25R107 \$25R108 \$25R109	0757+0280 0757+0280 0698-4519 0698-4500 0757+0250			9	RESISTOR 1K 1% .125W F TC=0++100 RESISTOR 1K 1% .125W F TC=0+-100 RESISTOR 140K 1% .125W F TC=0+-100 RESISTOR 57, ok 1% .125W F TC=0+-100 RESISTOR 1K 1% .125W F TC=0+-100	24546 24546 24546 24546	C4=1/8=(U=1001=F C4=1/8=(U=1403=F C4=1/8=(U=5702=F C4=1/8=(U=1001=F C4=1/8=(U=3012=F
A25R111 A25R112 A25R113 A25R114	0757-0453 0757-0280 0684-1051 0698-#211 0684-1041	Appendix of the second	3	7 0	RESISTOR 30.1% 1X .125m F TC#0+-100 RESISTOR 1M 1X .125m F TC#0+-100 RESISTOR 1M 10X .25m FC TC#=800/+900 RESISTOR 158M 1X .125m F TC#0+-100 RESISTOR 100M 10X .25m FC TC#=400/+800 RESISTOR 100M 10X .25m FC TC#=400/+800	24545 01121 24545 01121	C4-1/8-(0-1901-F C51051 C4-1/8-(0-1563-F C51041 C4-1/8-(0-6062-F
A25R115 A25R116 A25R117 A25R118 A25R119	0698-4509 0698-4505 0664-1651 0664-2231 0684-4731			4	RESISTOR 80.6K 1% .125M F 7Cm0+-100 RESISTOR 71.5K 1% .125M F 7Cm0+-100 RESISTOR 1M 10% .25M FC 7Cm-801/+700 RESISTOR 22K 10% .25M FC 7Cm-401/+800 RESISTOR 47K 10% .25M FC 7Cm-401/+800	24546 01121 01121 01121	C4-1/8-TU-/192-F C61051 CB2231 C84731
A 2 5 R 1 2 1 A 2 5 R 1 2 1 A 2 5 R 2 0 1 A 2 5 R 2 0 0 2	0684-4721 0684-1021 0684-1031 0684-1031 0684-2721		0 7 9		RESISTOR 4.7K 10% .25% FC TC=+490/+700 RESISTOR 1K 10% .25% FC TC=+400/+600 RESISTOR 10K 10% .25% FC TC=+400/+700 RESISTOR 10K 10% .25% FC TC=+400/+700 RESISTOR 2.7K 10% .25%	15:10 15:10 15:10 15:10 15:10	CB1031 CB1031 CB2721
A 25R203 A 25R204 A 25R206 A 25R207 A 25R208	0684-1221 0757-0286 0757-0286 0757-0286 0698-451))	3 3 3 3 3		RESISTOR 1.2K 10% .25% FC TCM-400/+700 RESISTOR 1K 1% .125% F TCM0+-100 RESISTOR 1K 1% .125% F TCM0+-100 RESISTOR 140K 1% .125% F TCM0+-100 RESISTOR 57.6K 1% .125% F TCM0+-100 RESISTOR 57.6K 1% .125% F TCM0+-100	2454 2454 2454 2454	C4-1/8-TU-1001-F C4-1/8-TU-1001-F C4-1/8-TU-1001-F C4-1/8-TU-1001-F C4-1/8-TU-1001-F
A25R210 A25R210 A25R211 A25R212 A25R213	0757-028 0757-045 0757-028 064-105 0698-421	0 3 0	32333		RESISTOR 1K 1X .125% F TC=0+-100 RESISTOR 30.1K 1X .125% F TC=0+-100 RESISTOR 1K 1X .125% F TC=0+-100 RESISTOR 1M 10X .25% FC TC=0+-100 RESISTOR 156% 1X .125% F TC=0+-100	2454 0115 2454	C4=1/8=10=5012=F C4=1/8=10=1001=F CB1051 C4=1/8=10=1583=F
A25R214 A25R215 A25R216 A25R217 A25R216	0698-450 0698-450 0698-450 0684-103	19 19 15	1 7 3 3		RESISTOR 100K 10% .25% FC TC=-400/+800 RESISTOR 80.5K 1% .125% F TC#0+=100 RESISTOR 71.5K 1% .125% F TC#0+=100 RESISTOR 71.5K 1% .25% FC TC#-800/+900 RESISTOR 22K 10% .25% FC TC#-440/+800	0112 2454 2454 0116	6 C4-1/8-10-8082-F C4-1/8-10-7152-F C81051 C82231
#25R219 #25R220 #25R221 #25R223 #25R301	74-22- 74-4-40 74-40-40 01-4-60 01-4-60 01-4-60	31 21 21 31	2 0 7 9		RESISTOR 47K 10% 25M FC TCE=400/+800 RESISTOR 4.7K 10% 25M FC TCE=400/+700 RESISTOR 10K 10% 25M FC TCE=400/+700 RESISTOR 10K 10% 25M FC TCE=400/+700 RESISTOR 10K 10% 25M FC TCE=400/+700	011	CH4721 CH1021 CH1031 CH1031 CH1031
A25R302 A25R304 A25R306 A25R307	0584-10 0584-27 0584-12 0757-02 0598-45	21 21 80	6 9 3 3		RESISTOR 2.7K 10% .25W FC TC=-400/+700 RESISTOR 1.2K 10% .25W FC TC=-400/+700 RESISTOR 1K 1% .125W F TC=0+100 RESISTOR 1K 1% .125W F TC=0+100 RESISTOR 140K 1% .125W F TC=0+100	54 d 54 d	21 CW1221 46 C4=1/8=TU=1001=F 46 C4=1/8=TU=1001=F 46 C4=1/8=TU=103=F
A25R308 A25R309 A25R310 A25R311 A25R312	0698-45 0757-03 0757-03 0757-03	500 280 280 280	3 2 3 3		RESISTOR 57.5% 1% 125% F TC=0+-100 RESISTOR 1% 1% ,125% F TC=0+-100 RESISTOR 30.1% 1% ,125% F TC=0+-100 RESISTOR 1% 11% ,125% F TC=0+-100 RESISTOR 1% 11% ,125% F TC=0+-100 RESISTOR 1% 10% ,25% FC TC=-800/+900	54°	46 C4-1/8-70-1001-F 46 C4-1/8-70-1001-F 64 C3-1/8-70-1001-F C3-1051 C3-1051-F
A25R313 A25R314 A25R316 A25R316 A25R317 A25R318	0 9 8 4 - 1 0 9 9 8 - 1 0 9 9 8 - 1 0 9 9 8 - 1	211 041 509 505	2 2 1 4 7 3		RESISTOR 158K 1X .125W F TC±0+-100 RESISTOR 100K 16X .25M FC TC=-400/+61 RESISTOR 80,6K 1X .125W F TC±0+-100 RESISTOR 87 .5K 1X .125W F TC±0+-100 RESISTOR 1M 10X .25W F TC±0+-100	10 01 24	546 C4-1/8-10-1303-F 546 C4-1/8-10-3002-F 546 C4-1/8-70-7)52-F C51051

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A2%R319 A2%R320 A2%R321 A2%R323 A2%R401	0684=2231 0684=4731 0684=4721 0684=1021 0684=1031	32079		RESISTOR 22k 10% ,25% FC TCm-480/+800 RESISTOR 47k 10% ,25% FC TCm-400/+800 RESISTOR 4,7k 10% ,25% FC TCm-400/+700 RESISTOR 10k 10% ,25% FC TCm-400/+000 RESISTOR 10k 10% ,25% FC TCm-400/+700	01121 01121 01121 01121 01121	C#2231 C#4731 C#1031 C#1031
A25R402 A25R403 A25R404 A25R406 A25R407	0684-1031 0684-2721 0684-1221 0757-0260 0757-0260	9 6 9 3 3		RESISTOR 10K 10X .25W FC TC=-400/+700 RESISTOR 2,7K 10X .25W FC TC=-400/+700 RESISTOR 1.2K 10X .25W FC TC=-400/+700 RESISTOR 1K 1X .125W F TC=0+-100 RESISTOR 1K 1X .125W F TC=0+-100	01121 01121 01121 24546 24546	CB1031 CB2721 CB1223 CH-1/8-fU-1001-F C4-1/8-FU-1001-F
A25R408 A25R409 A25R410 A25R411 A25R412	0698-4519 0698-4519 0757-0280 0757-0280 0757-0280	32323		RESISTOR 140K 1% ,125w F TC#0+-100 RESISTOR 57.6K 1% ,125w F TC#0+-100 RESISTOR 1K 1% ,125w F TC#0+-100 RESISTOR 30.1K 1% ,125w F TC#0+-100 RESISTOR 1K 1% ,125w F TC#0+-100	24546 24546 24546 24546	C4-1/8-10-1405-F C4-1/8-10-5702-F C4-1/8-10-1001-F C4-1/8-10-5012-F C4-1/8-10-1001-F
A25R414 A25R415 A25R416 A25R416 A25R418 A25R418	0698-4211 0684-1041 0698-4505 0684-1031 0684-1051	1 7 9 3		RESISTOR 158% 1% .125% F TC=0+-100 RESISTOR 100% 10% .25% FC TC=-400/+800 RESISTOR 50,6% 1% .125% F TC=0+-100 RESISTOR 71.5% 1% .125% F TC=0+-100 RESISTOR 10% 10% .25% FC TC=-400/+700 RESISTOR 1M 10% .25% FC TC=-400/+900	24546 01121 24546 01121 01121	C4-[/8=[0-158]-P C51041 C4-[/8+[0-6002-F C4-[/8-60-7152-F C4103] C61031
A25R419 A25R420 A25R421 A25R422 A25R423	0684-1041 0684-1021 0684-1041 0684-1031 0684-1021	1 7 1 9 7		RESISTOR 100K 10% ,25w FC TC=-400/+800 RESISTOR 1K 10% ,25w FC TC=-400/+800 RESISTOR 10K 10% ,25w FC TC=-400/+800 RESISTOR 10K 10% ,25w FC TC=-400/+700 RESISTOR 1K 10% ,25w FC TC=-400/+600	15110 15110 15110 15110 15110	C41051 C#1031 C#1041 C#1051 C#1041
A25U5 A25U2 A25U3 A25U4	1820+0077 1820+0077 1520+0471 1520+0077 1820+0175	2 0 2 1	1	IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR IC INV TTL HEX 1=INP IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR IC INV TTL HEX 1-INP	01295 01295 01295 01295 01295	8 17 17 17 18 8 17 17 17 18 8 17 17 17 18 8 17 17 18 8 17 17 18
A2506 A2507 A250100 A250200 A250300	1820-0077 1820-0077 1820-0203 1820-0203 1820-0203	00000	Œ	IC FF TTL 0-TYPE PUS-EDGE-TRIG CLEAR IC FF TTL D-TYPE POS-EDGE-TRIG CLEAR OP AMP GP TO-99 OP AMP GP TO-99 OP AMP GP TO-99	01295 01295 01928 01928 01928	847474N 847474N CA741CT CA741CT CA781CT
. A25U400	1820=0203	6		OP AMP GP TO=99	01925	CA741CT
A2524	1251-1636 4040-0750 09820-24761	4 7 6	1	MISCELLAMEOUS PARTS CONNECTOR-SGL CONT SKT _04-IM-BSC-3Z RND EXTR-PC 8D RED POLYC _062-RO-THKNS SPACER, CAPTIVE	28480 28480 28480	1251-1636 4048-0750 99820-84761
A26	05045=60015	2		CARD READER/PRINTER INTERFACE ASSEMBLY (SERIES 1852)	28486	u5045=60015
A26C1 A26C2 A26C3 A26C4 A26C5	0180=0291 0180=0373 0180=0210 0180=0195 0180=0195	2000	1 1	CAPACITOR-FXD 1UF+-10X 35VDC TA CAPACITOR-FXD .68UF+-10X 35VDC TA CAPACITOR-FXD 3-3UF+-20X 15VDC TA CAPACITOR-FXD .33UF+-20X 35VDC TA CAPACITOR-FXD .33UF+-20X 35VDC TA	56289 56289 56289 56289 56289	1500165×9935A2 1500884×9935A2 1500335xuu15A2 1500334xu035A2 1500334xu035A2
A26C6 A26C7	0180+0195 0180-0210	6		CAPACITOR=FX0 _33UF+=ZUX 35V0C TA CAPACITOR=FX0 3_3UF+=ZUX 15V0C TA	56269 5626 9	1500335×0015A2
AZOCRI AZOCRZ AZOCRZ AZOCRA AZOCRA AZOCRA AZOCRA	1901=0040 1901=0040 1901=0029 1901=0040 1901=0040 1901=0040 1902=0644	1 6 1 1 3	1	DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-PWR RECT 500V 750MA 00-29 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-ZWITCHING 30V 50MA 2NS 00-35 DIODE-ZWITCHING 30V 50MA 2NS 00-35 DIODE-ZWITCHING 30V 50MA 2NS 00-35	28450 28450 28450 28450 28450 28460 28460	1901-0040 1901-0040 1901-0049 1901-0040 1901-0040 1901-0040 1902-0044
A26-51	1251=3025	9	1	CONNECTOR 34-PIN M RECTANGULAR	28480	1251=3025
42602 42602 42603 42604 42605	1853-0318 1854-0449 1853-0058 1853-0058	3 8 8 8	1 1 4	TRANSISTOR PNP SI PD#500M# FT#50MHZ TRANSISTOR NPN SI TD#30 PD#50 FT##MHZ TRANSISTOR PNP SI PD#300M# FT#200MHZ TRANSISTOR PNP SI PD#300M# FT#200MHZ TRANSISTOR PNP SI PD#300M# FT#200MHZ	04713 28480 07263 07263 07263	\$52245 \$32245 \$654-0449 \$655245
45006	1853-0058	8		TRANSISTOR PNP SI POZZUOMA FIZZONMIZ	07263	\$32248
AZBAT AZBAT AZBAT AZBAT AZBAT AZBATA	0757-0941 1810-0041 0757-0970 0757-0960	3 0 8 6	1 1	RESISTOR 5,1K 2% .125W F 1Cm0+-100 NETWORK-RES 9-07N-31P .15-PIN-9PCG RESISTOR 82% 2% .125W F TCm0+-100 RESISTOR 33% 2% .125W F TCm0+-100 NOT ASSIGNED	\$4549 \$4649 \$4549	C4-1/8-10-5101-G 18t0-0941 C4-1/8-10-5302-S C4-1/8-10-5302-G
Alery Aleny Aleny Aleny Aleny Aleny	1510=0041 1810=0041 9757=0897 0757=0900 0811=2822	9 8 4 9	1	NETWORK-RES 9-PIN-SIP ,15-PIN-SPCG NETWORK-RES 9-PIN-SIR ,15-PIN-SPCG RESISTOR 15 2% ,125 F T (C**+100 RESISTOR 100 2% ,125 F T (C**+100 RESISTOR 5.8 5% ,75 W PM TC**0+-50	28460 28460 24546 24546 91637	:810-0041 1810-0041 C4-17=:0-75=0 C4-18-:101-0 P5172-T2-080-J



Table 6-1. Replaceable Parts (Cont'd)

Poference	HP Part	С	Otv		Description	Mfr Code		Mfr Part Number
Reference Designation A26R11 A26R13 A26R13 A26R14 A26R15 A26R15 A26R16 A26R17 A26R16 A26R17 A26R16 A26R22 A26R22 A26R22 A26R22 A26R23 A26R23 A26R24 A26R25 A26R25 A26R26 A26R26 A26R26 A26R27 A26R26	HP Part Number 0757-0893 0757-0924 0757-0930 0757-0930 0686-2015 0686-2015 0757-0930 0757-0930 0757-0930 0757-0930 0757-0930 0757-0930 0757-0930 0757-0932 0757-0932 0757-0932 0757-0932 0757-0932	D 42025 55502 42002 1 31		RESSOS SOSSES BIGERE E CO IIII	ISTOR 51 2% .125W F TCm0+=100 ISTOR 1K 2% .125W F TCm0+=100 ISTOR 1, 8% 2% .125W F TCm0+=100 ISTOR 1, 8% 2% .125W F TCm0+=100 ISTOR 1, 8% 2% .125W F TCm0+=100 ISTOR 200 5% .5W CC TCm0+529 ISTOR 1, 8% 2% .125W F TCm0+=100 ISTOR 2, 2% 2% .125W F TCm0+=100 ISTOR 2, 2% 2% .125W F TCm0+=100 ISTOR 31 2% .125W F TCm0+=100 INNECTOR=3GL CONT PIN .04=1N-85C-3Z RND INNECTOR=3GL CONT PIN .	24546 24546 24546 24546 01122 01122 01122 2454 2454 2454 2454 2454 2454 2454	C44-2 C44-2 E5 B282 C44-2 E5 B282 C44-2 C4	1/8-10-5180-6 1/8-10-1001-6 1/8-10-1001-6 1/8-10-1001-5 0015 0015 0015 0015 0015 0015
A20U3 A26U4 A26U4 A26U7 A26U8 A26U9 A26U10 A26U11 A26U12 A26U13 A26U14 A26U15 A26U17 A26U17 A26U17 A26U19 A26U19 A26U19	1818-2103 1820-0368 1820-0716 1820-0730 1820-077 1820-0077 1820-1017 1820-1017 1820-1017 1820-066		2542 NAGOS 74054 089		C SHF-RGTR TIL P-S PRL-IN PRL-OUT 5-81 C CNTR ITL SIN SYNCHRU POS-EGGE-TRIG C MY TIL MONOSTEL RETRIG/RESEI DUAL C SHF-RGTR TIL SERIAL-IN PRL-OUT 8-81 C SHF-RGTR TIL R-S PRL-IN PRL-OUT 9-81 C FF TIL D-TYPE POS-EUGE-TRIG CLEAR IC FF TIL D-TYPE POS-EUGE-TRIG CLEAR IC DCDR TIL L 2-TO-ALINE DUAL 2-INP IC SHF-RGTR TIL R-S PRL-IN RRL-OUT 5-8: IC GATE TIL NON-INV MEX 1-INP IC SHF-RGTR TIL R-S PRL-IN PRL-OUT 5-8: IC INV TIL HEX IC SHF-RGTR TIL R-S PRL-IN PRL-OUT 5-8: HEAT SINK TO-5/TO-19-CS PIN-SRV .062-IN-DIA .25-IN-LG SIL EXTR-PC BD YEL POLYC .062-8D-THKNS	01; 07; 07; 07; 01; 01; 01; 01; 01; 01; 01; 01; 01; 01	295 263 263 263 265 265 265 265 265 265 265 265 265 265	10741610 10102DC 1144PC 141
A 27 CC 2 A 27 CC 3 A 27 CC 3 A 27 CC 4 A 27 CC 4 A 27 CC 6 A 27 CC 6 A 27 CC 7 R 2 27 R 2 4 27 R 2 2 2 2	05045=6 0160=01 0160=01 0160=01 0160=01 0160=01 0160=0 0180=0 0757=0 07	646117 7776 55555 24156411 676	8 9 7 8 0 8	2 52 31	SWITCH-IGL SUBMIN SPOT UZA 20VAC/C	E PC	284480 55289 2849 2849 2849 2849 2849 2849 2849 2	3101-0647 3101-1916 3101-1915 3101-1916 3101-0647 3101-1916 3101-1917

Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C	Qty	Description	Mfr Code	Mfr Part Number
	3101-1916	8	Ť	SWITCH-PR SPOT MOM .14	28480	3101-1910
27811		9	3	IC MV TTL MONDSTAL RETRIG DUAL	01295	9H74123N
27U1 27U2	1820=0579 1820=0579	9		IC MY TTL MONDSTBL RETRIG DUAL IC INV TTL HEX 1-INP	01295	3N7496N
2703	1820-0471	9		TTI MONDSTAL MEINIO COME	01295	5 N 7 G 1 2 3 N 5 N 7 G U 8 N
27U4 27U3	1520-0511	9		IC CATE TIL AND GUAD SALAR	01295	8474L874N
	1820=1112	В		IC FF TIL LS Daivre PDS-EDGE-TRIG IC SCHMITT-IRIG TIL MANO GUAD Z-INP	01295	5×74132N
12746 12747	1820=1056	9 6	1		01295	8N74U2N 8N74L5164N
127U8 127U9	1820-1433	6		IC GATE TIL NON GUAD ZERIAL-IN PRL-DUT IC GATE TIL NANO GUAD Z-INP	01295	8N7400N
A27U10	1820-0054	5			01295	5 N 7 4 1 6 5 N 5 N 7 # L 3 7 4 N
A27U11	1820=1042	3 8		IC FF TIL LS D-TYPE PDS-EDGE-TRIG	01295	847478144
A27U12 A27U13	1820-1112	8			28460	0380=9771
-	0580-0771	8	ц	STANDOFF-RVT-DN .625-IN-LG 6+32THD		
		1		SOARD ASSEMBLY, SOCKET DRIVER	52490	05045-6041 7
428	05045=60017	4	1	(SERIES 1916)		
			3.4	WYD H705 +-201 200VOC CER	28480	0160-3876 0160-0579
42801	0160-3876	4	24 25	CAPACITOR-FXD .047UP +=20x 200VDC CER	28480 28480	0160-3676
458C2 458C3	0160-3875	4 4		- 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1	58480 58480	0160-0575 G160-3870
428C4 428C5	0160-0575	4		CAPACITOR-FXD 47PF +-201 200.00	1 -	0160-0575
	0160-0575	4		CAPACITOR-FXD .047UF +=20% 50VOC CER CAPACITOR-FXD 47PF +=20% 200VOC CER	58480 58480	0168=3876
428C6 428C7	0160-3876	4			58#80 58#80	0160-0575
428C8 428C9	0160-0575	4		CAPACITOR=FXD 47PF +-20% 200VDC CER CAPACITOR=FXD .047UF +-20% 50VDC CER	28489	0160-05/5
458C10	0160-0575	4		SVO SESS SOUNDE CER	28480	0160=3676
12854	0160-3876	4			28480 28480	0160-0575
128C12 128C13	0160=0575	14]	CAPACITOR-FXD 479F +-20% 2000DC CER	28459	0160=0575
428014	0160=0575	4		CAPACITOR-FXD 47PF +-20% 200VDC CER	28489	0160=3670
A28C15		4		CAPACITOR-FXD .047UF 4-ZOX 50VOC CEH	08489	0150-0575
A26C16 A26C17	0160=0575 0160=3676	4		CAPACITOR OF A APPER += 20% SOVOE CER	24480	0160=0575 0160=3876
81365¥	0160=0575	4		CAPACITUREFXD 47PF 1-20% 200VDC CER	28480 28480	0160=0575
W56C50 W56C16	0160-0575	4			28480	0160-3676
456CS1	0160=3876	4		CAPACITOR-FXD 47PF +-20% 200VDC CER CAPACITOR-FXD .047UF +-20% 50VDC CER	58480	0160×0575 0160×3876
428C22 428C23	0160-0575	4		CAPACITOR=FXD 47PF +=20% 200VDC CER CAPACITOR=FXD 47PF +=20% 200VDC CER CARACITOR=FXD .047UF +=20% 200VDC CER	59480 58480	0160=0575
A28C24	0100-0575 0160-3876	4		CAPACITOR-FXD 47PF +-20% 200VDC CER	58480	V160-3876
159052		4		CAPACITOR-FXD . 047UF 1-20% 50VDC CER	28480 28480	0168-0575 0169-3676
A28C25	0160+0575 0160+3676	4		CAPACITOR-FXD 47PF 4-201 50VDC CER	28480	0160=05/5
428C29	0160-0575 0160-1676	4			28460 26460	0160-3876 0160-0575
ASSC30	0160-0575	4		CAPACITURE XD 4047UF +=20% 50VDC CER CAPACITURE XD .047UF +=20% 50VDC CER CAPACITURE XD .047UF +=20% 50VDC CER	28480	6169-0575
420C30	0160-0575	1		THE THE TWO STOR LOW SHOVE CER	28480	
1 428C32	0160-3876		4	CARACITURATAD SUITE AND AND COM	28480 28480	0160=3875
A28633 A2863a	0160-3876	1	4	■ A 1 = 1 ← 1 ← 2 ← 2 ← 2 ← 2 ← 2 ← 2 ← 2 ← 2 ←	28480 28480	
159532	0160+3675			CAPACITOR-FXD 47PF +=20x 290408 0F.	28480	
Y50C70	0160=0575		4	CAPACITOR-FXD .007UF +-20% 50VDC CER CAPACITOR-FXD 47PF +-20% 200VDC CER	28480	U160=3676
A28C37 A28C38	0160-3676		4		28480	U160=1875
Azecia Azecao	0160=3876		4	CAPACITOR=FXD 47PF +=20% 200VDC CEP CAPACITOR=FXD 47PF +=20% 50VDC CEP CAPACITOR=FXD 4047UF +=20% 50VDC CER	28480	0160-9575
	0160-0575	·	1	240.0170E EVD 8795 4-201 200VDC CER	28480	
#28C#1 #28C#2	0160+3876	i	4 4	CAPACITOR-FXD .047UF ++20% 30VDC CER	2848(2848)	0160-3876
159C43	0160=367	b [4		26486	
A28C45	0160+367		4	CAPACITOR-FXU 47PF +=201 200102 000	2848	
428C46 428C47	0160=057		4	CAPACITOR=FXD .047UF +=20% 30VDC CER CAPACITOR=FXD 07PF +=20% 20UVDC CER	2848	0 0164-3676
128518	0160-387 0160-057		4	CAPACITOR-FXD .047UF +-20% 50VDC CER	2848	E
Azecai	1901-004	1		SECOND SILVER TO SOME SANS DO-35	2848	
428CR2 1426CR2	1901-004	0	1	DIDDE-SWITCHING 30V 50MA 2NS DO-35	2848	e 1901-00AU
ASSCR4 ASSCRS	1901-004	0	1		5849 5848	
A TOTAL	1901-004		i	DIDDE-SWITCHING BOY SOMA 2NS DO-35		
7						
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See introduction to this section for ordering information *Indicates factory selected value

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Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	C	<u>O</u>	ty	Description	Mfr Code	Mfr Part Number
Designation	1901-0040 1901-0040 1901-0040 1901-0040	1 1 1			DIGGE-SWITCHING 30V 50MA 2NS DG-35 DIGGE-SWITCHING 30V 50MA 2NS DG-35 DIGGE-SWITCHING 30V 50MA 2NS DG-35 DIGGE-SWITCHING 30V 50MA 2NS DG-35 DIGGE-SWITCHING 30V 50MA 2NS DG-35	28480 28480 28480 28480	1901-0040 1901-0040 1903-0040 1901-0040 1901-0040
A28CR10 A28CR11 A28CR12 A28CR13 A28CR14	1901-0040 1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1 1 1 1			OIODE-SWITCHING 30V 50MA 2NS 00-35 DIDDE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 OIODE-SWITCHING 30V 50MA 2NS 00-35 OIODE-SWITCHING 30V 50MA 2NS 00-35	28480 28480 28480 28480 28480	1901-0040 1901-0040 1901-0040 1901-0040 1901-0040
A28CR15 A28CR16 A28CR17 A28CR18 A28CR19	1901-0040 1901-0040 1901-0040 1901-0040 1901-0040	1 1 1 1 1 1			OIODE-SWITCHING 30V 50MA 2NS 00-35 OIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35 DIODE-SWITCHING 30V 50MA 2NS 00-35	28480 28480 28480	1901-0040 1901-0040 1901-0040 1901-0040 1901-0040
A28CR21 A28CR21 A28CR22 A28CR23 A28CR23	1901-0040 1901-0040 1901-0040 1901-0040	1 1 1			DIODE-SWITCHING 30V 50MA 2NS 00-35 0100E-SWITCHING 30V 50MA 2NS 00-35 0100E-SWITCHING 30V 50MA 2NS 00-35	28480 58480 58480 58480	1901-0040 1901-0040 1901-0040
A2811 A2812 A2813 A2814 A2819	9100-2247 9140-0144 9140-0144 9140-0144 9140-0144	0000		1	COIL-MLD 100NH 10% G234 .0950%.25LG-NOM COIL-MLD 4,70H 10% G245 .0950%.25LG-NOM COIL-MLO 4,70H 10% G245 .0950%.25LG-NOM COIL-M	28480 28480 28480 28480	9340-0144 9140-0144 9140-0144 9140-0144
A28L6 A28L7 A28L8 A28L9 A28L10	9140-0144 9140-0144 9140-0144 9140-0144 9140-0144	0			COIL-MLD 4.70H 10% Q=45 .0950%.25[G=NOM COIL-MLD 4.70H 10% Q=45 .0950%.25[G=NOM COIL-MLD 4.70H 10% Q=45 .0950%.25LG=NOM COIL-MLD 4.70H 10% Q=45 .0050%.25LG=NOM COIL-MLD 4.70H 10% Q=45 .0050%.25LG=NOM COIL-M	28480 28480 28480 28480 28480	3140-0144 3140-0144 3140-0144 3140-0144
A28L11 A28L12	9140+0144 9140+0144				COIL-MED 4.70H 10% Q#45 .0950%.25LG-MOM COIL-MED 4.70H 10% Q#45 .0950%.25LG-MOM	59490 59490	9140-0144
428P2 428P4	1251+3283 1251+0101		1	2	CONNECTOR 24-P1% F MICHORIBBON CONNECTOR 50-PIN F MICHORIBBON	28480	1251-0101
A28G1 A28G3 A28G4	1853-0820 1854-0071 1853-0020 1854-0071 1853-0020		7 4 7		TRANSISTOR PNP SI PDW300MM PTW150MMZ TRANSISTOR NPN SI PDW300MM FTW200MMZ TRANSISTOR PNP SI POW300MM FTW150MMZ TRANSISTOR NPN SI PDW300MM FTW200MMZ TRANSISTOR PNP SI PDW300MM FTW200MMZ TRANSISTOR PNP SI PDW300MM FTW150MMZ	28480 28480 28480 28480	1854-0071 1853-0020 1854-0071 1851-0020
42805 A2806 A2807 A2808 A2809	1853-0020 1853-0020 1853-0020 1853-0020 1854-0071		74747		TRANSISTOR NPN SI PO#300MM FT#200MMZ TRANSISTOR PNP SI PO#300MM FT#1200MMZ TRANSISTOR NPN SI PO#300MM FT#150MMZ TRANSISTOR NPN SI PO#300MM FT#150MMZ TRANSISTOR NPN SI PO#300MM FT#150MMZ TRANSISTOR NPN SI PO#300MM FT#260MMZ	28480 28480 28480 28480 28480	1854-0071 1853-0020 1854-0071 1853-0020 1854-0071
A 28G10 A 28G12 A 28G13 A 28G14	1853-0020 1854-0071 1853-0071 1853-0020		4 7 4 7 4		TRANSISTOR PNP SI PDEJUOMW FTE150MHZ TRANSISTOR NPN SI PDEJUOMW FTE150MHZ TRANSISTOR PNP SI PDEJUOMW FTE150MHZ TRANSISTOR PNP SI PDEJUOMW FTE200MHZ TRANSISTOR PNP SI PDEJUOMW FTE150MHZ TRANSISTOR PNP SI PDEJUOMW FTE150MHZ	28480 28480 28480 28480	1854-0071 1853-0020 1854-0071 1853-0020
A 28915 A 28916 A 28917 A 28918 A 28919	1854-0071 1853-0020 1854-0071 1853-0020	i } !	7 4 7 4 7		TRANSISTOR NPN SI PD=300MM FT=200MMZ TRANSISTOR PNP SI PD=300MM FT=150MMZ TRANSISTOR NPN SI PD=300MM FT=200MMZ TRANSISTOR PNP SI PD=300MM FT=150MMZ TRANSISTOR NPN SI PD=300MM FT=200MMZ TRANSISTOR NPN SI PD=300MM FT=200MMZ	58480 58480 58480 58480	1853-0020 1854-00/1 1853-0020 1854-0071
A28920 A28921 A28922 A28923 A26924	1853-002 1854-007 1853-002 1854-007	0 1 0	4 7 4 7		TRANSISTOR PNP SI PORTUGYM FIRISOMMZ TRANSISTOR NPN SI PORTUGWM FIRISOMMZ TRANSISTOR PNP SI PORTUGWM FIRISOMMZ TRANSISTOR NPN SI PORTUGWM FIRISOMMZ	28486 28486 28486	1854-0071 1853-0020 1854-0071
A 2 4 R 1 A 2 5 R 2 A 2 5 R 3 A 2 5 R 4	0683-105 0683-105 0757-091 0653-105 0683-105	5	55355	24	RESISTOR im 5x .25% FC TC==800/+900 RESISTOR 1M 5x .25% FC TC==000/+900 RESISTOR 510 2% .125% FC TC==800/+900 RESISTOR 1M 5x .25% FC TC==800/+900 RESISTOR 1M 5x .25% FC TC==800/+900	0112 2454 0112 0112	1
A2885 A2886 A2887 A2888 A2889 A28810	0757-091 0683-105 0683-105 0757-091 0683-105	7 5 5 7	35555		RESISTOR 510 2X .1250 F TCM9+-100 RESISTOR 1M 5X .250 FC TCM-800/+900 PESISTOR 1M 5X .250 FC TCM-800/+900 RESISTOR 510 2X .1250 F 1CM0+-160 RESISTOR 1M 5X .250 FC TCM-800/+900	2454 0112 0112 2454	1 C81055 1 C81055 6 C4-1/6-10-5:1-6 1 C81055
A26R11 A26R11 A26R13 A26R13 A26R14 A26R15	0883-109 0757-09 0683-10 0683-10 0683-10	55 17 55	5 5 5 5		RESISTOR 14 5% .25% FC TC*-800/+900 RESISTOR 16 5% .25% FC TC*-800/+900	0112 0113 0113 0114	6 C=1/8-TC-511-0 C=1055 11 C=1055 11 C=1055
A 28R16 A 28R17 A 28R18 A 28R19 A 28R20	0683-10 0757-07 0757-09 0757-09 0683-10	17 17 55	5 3 5 5		RESISTOR 1M S% ,25M FC TC=860/+900 R&SISTOR 510 2% ,125M F TC=100 RESISTOR 510 2% ,125M FC TC=800/+900 RESISTOR 1M 5% ,25M FC TC=800/+900 RESISTOR 1M 5% ,25M FC TC=800/+900	011 545 545	57 CR1622 66 C4=1/8=10=211=6 C4=1/8=10=211=6

Table 6-1. Replaceable Parts (Cont'd)

Reference	HP Part	С	Qty	Description	Mfr Code	Mfr Part Number
Designation	Number 0757-0917	D 3		ofeterna 510 ≥r .125% F TC#0+~100	24546 01121	C4=1/8+10=511=6 CB1055
A26R32 A26R32 A26R24 A26R25	0683=1055 0663=1055 0757=0917 0683=1055	5 5 5 5		RESISTOR 1M 5% 25W FC TC==800/+900 RESISTOR 1M 5% 25W FC TC==800/+900 RESISTOR 510 2% 125W FC TC==400/+900 RESISTOR 1M 5% 25W FC TC==400/+900	01121 24546 01121	C41/8-10-511-6 C4-1/8-10-511-6
428F25 A28F27 A28F28 A28F29 A28F30	0683-1055 0757-0917 0683-1055 0663-1055 0757-0917	53553		RESISTOR 1M 5% .25% FC TCa+800/+900 RESISTOR 510 2% .125% F TCa0++100 RESISTOR 1M 5% .25% FC TCa+800/+900 RESISTOR 1M 5% .25% FC TCa+800/+900 RESISTOR 510 2% .125% F TC#0++100	01121 24546 01121 01121 24546	C81055 C0=1/8=70=511=6 C81055 C81055 C8=1/8=70=511=6
A26R31 A26R32 A26R33 A26R34 A26R35	0483-1055 0683-1055 0683-1055 0683-1055 1810-0020	D-M-GRUND		RESISTOR 1M 5% .25M FC TC#=800/+900 NETWORK=RES 6=PIM=SIP .125=PIM=SPCG	01121 01121 01121 01121 28480	C81055 C81055 C81055 C81055 1810+0030
A28R36 A28R37 A28R38 A28R39 A28R40	0683+5125 0683+5125 0683+5125 0757-0917 0757-0917	88833	t 2	RESISTOR 5.1K 5% .25% FC TC==400/+709 RESISTOR 5.1K 5% .25% FC TC==400/+700 RESISTOR 5.1K 5% .25% FC TC==400/+700 RESISTOR 5.10 2% .125% F TC=0+-100 RESISTOR 5.10 2% .125% F TC=0+-100	01121 01121 01121 24546 24546	C85125 C85125 C85125 C4-178-10-511-5 C4-178-10-511-6
A 26 R 4 E	0663-5125 0663-5125 0683-5125 1810-0030 0683-5125	8 5 6 6 8		RESISTOR 5.1K SX .25W FC TC==400/+700 RESISTOR 5.1K SX .25W FC TC==400/+700 RESISTOR 5.1K SX .25W FC TC==400/+700 NETWORK=RES &=FIN=5IP .125=PIN=5PC RESISTOR 5.1K SX .25W FC TCX=400/+700	01121 01121 01121 28480 01121	C85125 C85125 1810=0050 C85125
A28R46 A28R47 A28R48 A28R49 A28R50	0683-5125 0683-5125 0683-5125 0683-5125 0683-5125	8 8 8 8		RESISTOR 5.1K 5% .25W FC TCx=400/+700	01121 01121 01121 01121 01121	CH5125 CH5125 CH5125 CH5125 CH5125
426R51	0757-0924	2		RESISTOR 1K 2% _125% F TC#0+=100	24546	CE=1/6=10=1001=6
128U1 128U2 128U3 128U3 128U9	1820-0367 1820-0471 1820-0471 1820-0788 1820-0788	30022	The state of the s	IC SHF-RGTR TIL R-8 PRL-IN PRL-OUT 4+81T IC INV TTL HEX 1=INP IC INV TTL HEX 1-INP IC FF TTL D-TYRE POS-EDGE-TRIG CLEAR HEX IC FF TTL D-TYPE PUS-EDGE-TRIG CLEAR HEX	01295 01295 01295 01295 01295	5N7495AN 5N744DN 5N74106N 5N74174N SN74174N
A28U6 A28U7 A28U8	1820=0367 1820=0903 1820=0903	3 33	5	IC SHPORGIR ITL ROS PRLOIN PRLOUT 4-817 IC SHPORGIR ITL L POS SERIAL-IN PRLOUT IC SHPORGIR ITL L ROS SERIAL-IN PRLOUT	01295 01295 01295	587295AN 9874L1648 5874L1648
450	- Constitution of the Cons			SAME AS A28, USE PREFIX A29		
430	05045-60619	6	1	BOARO ASSEMBLY, SOCKET (SERIES 1520)	28480	G5045→60019
A30C1 A30C3 A30C3 A30C4 A30C8	0160=3877 0160=3877 0160=3877 0160=3877 0160=3877	55555		CAPACITOR=FX0 100PF +=20X 200VDC CER CAPACITOR=FX0 100PF +=20X 200VDC CER CAPACITOR=FX0 100PF +=20X 200VDC CER CAPACITOR=FXD 100PF +=20X 200VDC CER CAPACITOR=FXD 100PF +=20X 200VDC CER	28480 28480 28480 28480 28480	0160-3977 0160-3877 0160-3877 0160-3877 0160-3877 0160-3877
A30CA A30C7 A30C8 A30C9 A30C10	0160=3877 0160=3877 0160=3877 0160=3877 0160=3877	55555		CARACITOR-FXD 100PF +-20X 200VDC CER CAPACITOR-FXD 100PF +-20X 200VDC CER CAPACITOR-FXD 100PF +-20X 200VDC CER CAPACITOR-FXD 100PF +-20X 200VDC CER CARACITOR-FXD 100PF +-20X 200VDC CER	28480 28480 28480 28480	0 t 60 = 3877 0 1 60 = 3677 0 1 60 = 3677 0 1 60 = 3877 0 1 60 = 3877
A30011 A30013 A30014 A30015	0160-3677 0160-3677 0160-3677 0160-3677 0160-3677	W 10 10 10		CAPACITOR-FXO 100PF +-20% 200VOC CER CAPACITOR-FXO 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER CAPACITOR-FXD 100PF +-20% 200VOC CER	59480 59480 59480 58480 58480	0160-38/7 0160-38/7 0160-38/7 0160-38/7 0160-38/7
A30c16 A30c17 A30c18 A30c14 A30c20	0160-3877 0160-3877 0160-3877 0160-3877 0160-3877	2000		CAPACITOR-FXD 100PF +=20X 200V0C CER	58480 58480 59480 59480 58480	0160-3677 0160-3677 0160-3877 0160-3877 0160-3877
#30C21 #30C22 #30C23 #30C24 #30C25	0160-3877 0160-3877 0160-3877 0160-3877 0160-0127	01.51.01		CAPACITOR-FXD 100PF +=20% 200VOC CER CAPACITOR-FXD 100PF +=20% 200VOC CER CAPACITOR-FXD 100PF +=20% 200VOC CER CAPACITOR-FXD 100RF +=20% 200VOC CER CAPACITOP-FXD 1UF +=20% 200VOC CER	\$8480 \$8480 \$8480 \$8480	0150-3877 0150-3877 0150-3877 0160-3877 0160-9127
A30C26 A30C27 A30C28	0160-3879 0160-0127 0160-0127			CAPACITOR-FXD .01UF +-20X 10UVQC CER CAPACITOR-FXD 1UF +-20X 25VOC CER CAPACITOR-FXO 1UF +-20X 25VOC CER	26480 28480	0100+3879 (100+0127 (100+012) (100+012)

See introduction to this section for ordering information *Indicates factory selected value

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Table 6-1. Replaceable Parts (Cont'd)

1891 1200-015 5 1	Reference Designation	HP Part Number	CD	Qty	Description	Mfr Code	Mfr Part Number
Section Sect		1200=0610			SOCKET IC-TS 24-CONT (BASE) DIP-SLDR SOCKET, TEST 24-PIN		1200-0850
Section Sect	130KB 130K3 730KS	0490=1079 0490=1079 0490=1079 0490=1079	4 4 0	•	RELAY=REED 1A 500MA 100VOC 5VDC=COIL	26480 26480 26480 28480	0490=1079 0440=1079 0490=1079 0490=1079
### ASON 12	A30K6 A30K7 A30K8 A30K9	0490=1079 0490=1079 0490=1079 0490=1079	4		RELAY=REED 1A 500MA 100VDC 5VDC=COIL RELAY=REED 1A 500MA 100VDC 5VDC=COIL RELAY=REED 1A 500MA 100VDC 5VDC=COIL RELAY=REED 1A 500MA 100VDC 5VDC=COIL	25450 25450 25450 25450	0490=1079 0490=1079 0490=1079 0490=1079
A SOLID	A30K11	0490=1079			RELAY-REED 14 500MR 1004DC 348CE	28480	0490-1079
A36L0 9100-1791 1 COIL 290HH 201 230.2351.0-NOM 2840 9100-1791 1 COIL 290HH 201 2300.2351.0-NOM 2840 9100-1791 1	A30L1 A30L2 A30L3 A30L#	9100=1791 9100=1791 9100=1791 9100=1791	1 1		COIL 290NH 20% ,23D%,375LG=NOM COIL 290NH 20% ,23D%,375LG=NOM COIL 290NH 20% ,23D%,375LG=NOM	28480 28480 28480 28480	9100=1791 9100=1791 9100=1791 9100=1791
A30.11 9100-1791 1 COIL 290NH 20X -23DX_375LG-NOM 20X 00-1791 2000-1791 1 COIL 290NH 20X -23DX_375LG-NOM 20X 00-1791 1 COIL 290NH 20X 00	A3016 A3017 A3018 A3019	9100=1791 9100=1791 9100=1791	1		COIL 290NH 20% 23D% 375LG=NOM	28480 28480 28480 28480	9100-1791 9100-1791 9100-1791 9100-1791
300.16	A30111 A39112 A30113 A30114	9100=1791 9100=1791 9100=1791 9100=1791	1		COIT 540MH 50% *53DX*312PG=40W COIT 540MH 50% *53DX*312PG=40W COIT 540MH 50% *53DX*312PG=40W	58480 59480 59480 58480	9100=1791 9100=1791 9100=1791 9100=1791
A30 21	A30,16 A30,17 A30,18 A30,18	9100 × 1791 9100 × 1791 9100 × 1791 9100 × 1791			COIL 290NH 20% _23D%_375LG=NOM COIL 290NH 20% _23D%_375LG=NOM COIL 290NH 20% _23D%_375LG=NOM	28480 26480 26480 28480	9100=1791 9100=1791 9100=1791 9100=1791
A30R1 0698-8369 9 0688-8369 9	A30L23 A30L23	9100=1791 9100=1791	A Participated in the Part	1	COIL SAONH SOR "SIDX"112FG-NDW COIL SAONH SOR "SIDX"112FG-NDW	28480 28480 28480	9100=1791 9100=1791 9100=1791
A307P1	AZORZ	0598-8369	- 1	9	RESISTOR 2.7 5% 125% CC TC=-120/+400	01121	B827G5
A30TP1	A307P1 A307P2 A307P3 A307P4	0360=0077 0360=0077 0360=0077 0360=0077		5 5	TERMINAL-STUD SGL-TUR SWGFRM-MTS TERMINAL-STUD SGL-TUR SWGFRM-MTS	28480 28480 28480 28480	0360=0077 0360=0077 0560=0077 0360=0077
A30TP12	A307P6 A307P7 A307P8 A307P9	0360=0077 0360=0077 0360=0077 0360=0077		5 5 5	TERMINAL-STUD SGL-TUR SWEERM-MTG	28480 28480 28480	0360=0077 0360=0077 0360=0077 0360=0077
A30TP15 A30TP16 A30TP17 A30TP17 A30TP17 A30TP18 A30TP19 A30TP20 A30TP21 A30TP22 A30TP22 A30TP23 A30TP24 A30TP25 A30TP25 A30TP25 A30TP26 A30TP27 A30TP27 A30TP28 A30TP28 A30TP29 A30	A307P11 A307P12 A307P13 A307P14	0360-0077 0360-0077 0360-0077	; ; ;	5	TERMINAL-STUD SGL-TUR SWGFRM-MTG	28480 28480 28480	0360-0077 0360-0077 0360-0077 0360-0077
A30TP21	A307P16 A307P17 A307P18 A307P19	0360=007 0360=007 0360=007 0360=007	7 7 7 7	5 5 5 5 5 5	TERMINAL-STUD SGL-TUR SWGFRH-MTG TERMINAL-STUD SGL-TUR SWGFRH-MTG TERMINAL-STUD SGL-TUR SWGFRH-MTG TERMINAL-STUD SGL-TUR SWGFRM-MTG	5849 5849 5849	0360=0077 0360=0077 0360=0077 0360=0077
1	4307P21 4307P22 4307P23 4307P24	0360=007 0360=007 0360=007 0360=007	7 7 7 7	5 5	TERMINAL STUD SGL TUR SWEFRMENTG	5848 5848 5848	0 0360 × 0077 0 0360 × 0077 0 0360 × 0077 0 0360 × 0077
	4501765				4 STANDOFF-RVI-ON -187-IN-LG 5-32THO	0000	ט טאטאט אז טביייייייייייייייייייייייייייייייייייי

Replaceable Parts

Table 6-1. Replaceable Parts (Cont'd)

leference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
						n5n45 ⇔ 6n02t
i	05045∞60020	9	1	BOARD ASSEMBLY, TEST HD INT	28480	
1 X A 2 8	1251-1365	5		CONNECTOR-PC EDGE 22-CONT/RDW 2-ROWS CONNECTOR-PC EDGE 22-CONT/RDW 2-ROWS	28480 28480	1251=1365 1251=1365
PSARI Aogasi	1251-1345	6	1	CONNECTOR-PC EDGE 6-CONT/ROW 2-ROWS	28480	1251-0472
20,000				BOARO ASSEMBLY, MOINER INTERFACE	28480	05045=60016
32	05045-60016	3	1		56289	1500226X0035H2
3261	0180-0160	5	1	CAPACITOR=FXO 22UF+=20% 35VOC TA	24546	C4=1/8=10=5101=G
1281	0757=0941	3		RESISTOR 5,1K 2% .125W F 1Cmo+=100	28480	1251-2045
SZXAZ5 SZXAZ6	1251-2035	6	1	CONNECTOR=PC EDGE 15-CUNT/ROW 2-ROWS CONNECTOR=PC EDGE 22-CUNT/ROW 2-ROWS	28480	ê û E Î - Î Ê S Î
A53	05045-60014	1	1	BOARD ABSEMBLY, MAIN MOTHER (SERIES 1628)	28480	05045×60014
1 = 2 = 1	0180-0151	6		CAPACITOR=FXD 3,3UF+=10x 39VDC TA	00908 28480	71108335K035A8 0160-0127
433C5 433C1	0160=0127	St. Ct.		CAPACITOR-FXD 1UF +=20% 25VDC CER	58480 59480	0150-0127 T1108335K03548
A33C3 A33C4	0180=0161 0180=1746	6		CAPACITOR-FXO 3.3UF+-10% 35VDC TA CAPACITOR-FXO 15UF+-10% 20VDC TA	59589	1200129×6050q5
A3365				PARACTERIAL FEO & REFERENCE ASSETS	00908	T110B335K035A8
A33C6 A33C7	0180=0161 0180=0161	5		CAPACITOR=FXD 3.3UF+=10% 35VUL TA	80900 56289	110435503548 1500156x902082
A3308	0180=1746 0160=0127	5 20		CAPACITOR=FXD 1UF +=20% 25VDC CER CAPACITOR=FXD 1UF +=20% 25VDC CER	28480 28480	0160×0127 0160=0127
A33010	0160-0127	2		CARACTTOR-EVO THE ++201 25VOC CER	28480	0160-0147
A33C11 A33C12	0160-0127	2		CAPACITOR-FXD 3.3UF+=10% 35VDC 1A	0090B	71106335KB35AS 0160=0127
A33C13 A33C14	0160=0127	5		CAPACITOR=FXD 1UF +=20% 25VOC CER CAPACITOR=FXD 1UF +=20% 25VOC CER	2848n	0160-0127
A33C15	0160-0127	5		CARLESTON AND THE +=20% 25VDC CER	28480 28480	0160-0127 0160-0127
A33C17	0160-0127	2		CAPACITUR-FXD 1UF +-20% 25VDC CER	24546	Cu=1/8=10=10R0=F
ASSRI	G757±0346	5	1	RESISTER 10 1% ,125W F 7C=0++100	28480	1251-1365
AJZKA4 AZZKAS	1251-1365	6		CONNECTOR-PC EDGE 22-CUNT/RDW 2-ROWS CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28480	1251-1365 1251-1365
433x46	1251-1365	8		CONNECTOR-PC 2DGE 22-CONT/ROW 2-ROWS	28480	1251=1365
433x47 433x48	1251-1365	ě		CONNECTOR-DC EDGE SS-CONT/ROW S-MOMB	28480	
433XA9	1251=1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28480 28480	1251=1365
ASSXA10 ASSXA11	1251=1365 1251=1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	58480 58480	1251-1305
433×412	1251=1365 1251=1365	6		COMMECTOR-SC EDGE SS-COMINGO S-MAND	28480	1251-1305
A33X414	1251-1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28480 28480	1251=1365
A33×A15 A33×A16	1251-1345 1251-1345	0		CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS	28480 28460	1251=1365
*33x417 433x418	1251-1365 1251-1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-ROWS	28460	1251-1365
433XA19	1251-1365	6		CONNECTOR-PC EDGE 22-CONT/ROW 2-RDWS	26480 26480	1251=1305
OSAXEIA !SAXEEA	1251-1365	6		CONNECTOR-PC EDGE ESPECIALIZADA Z-ROMS	28480 28480	1251-1305
Y23XTS5	1251-1365	6		CONNECTOR-PC EDGE 22-CUNT/ROW 2-ROWS	28480	1251-1305
ASSKAZO	1251-1365			CONNECTOR-PC EDGE 22-CONT/ROW 2-RDWS	56480	1251-1305
	1251-1115	4	1	TARE FOUR	28480	1251-1115
A34	05150=6001	1 6	1	PRINTER MECHANICAL ASSEMBLY	28480	#5150=60VII
45441	5080-9051	ā	1 1	PRINT HEAD	59490	5080-9051
k34L1	9100=3515	1	. 1		26480	9100-3515
435	09810-6796	2 1	1	SENSOR ASSEMBLY (ORDERED AS PART OF A25)	28480	(19810=67962
435CR1000	1901-0050		5	DIGOE-SWITCHING BOY 200MA 2NS 00-35	ខ្នួនជនប	1901-0050
Alloan	2140-0892	1		LAMP-INCANO 685 SVDC 60MA T-1-8ULB	L0000	683 TIP END
A350821 A350831	2140=0092 2140=0092		3	LAMP-INCAND 685 5VDC 60M4 T-1-RULE LAMP-INCAND 685 5VDC 60M4 T-1-RULE	10000 10000 10000	685 TIP END
4350841	2140-0092		ō	LAMP-INCAND 665 SVDC 50MA T-1-8DL6	0.00.03	W42 14: 2:0
		Same of the same o				
	1		1	1	1	1

See introduction to this section for ordering information *Indicates factory selected value

Model 5045A

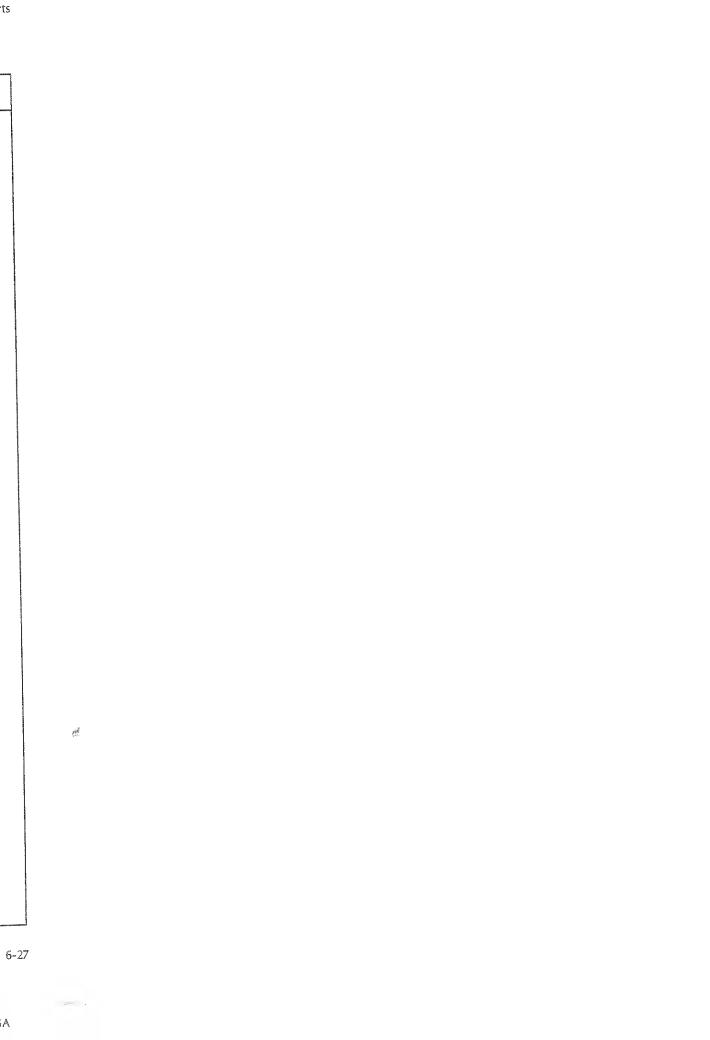


Table 6-1. Replaceable Parts (Cont'd)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A35M1	09820-29761	6	٠, ١	MOTOR ASSEMBLY	28480	09820-29761
A35010 A35020 A35030 A35040	1990+0306 1990+0306 1990+0306 1990+0306	9	ŧ	PHOTOTRANSISTOR VAXE40V IOR100NA PHOTOTRANSISTOR VAXE40V IOR100NA PHOTOTRANSISTOR VAXE40V IOR100NA PHOTOTRANSISTOR VAXE40V IOR100NA	28480 28480 28480 28480	1990-0306 1990-0306 1990-0306 1990-0306
	1450-0153 09610-23301 09610-25791 09810-26564	0.040	1 1 1	MISCELLANEOUS PARTS LAMPHOLDER MOGT-SC-FLG+SKI TUR-TERM LAMP, RETAINER NUT, RETAINING PC BOARD, SENSOR MOUNTING	28480 28480 28480	1450=0153 09810=23301 09810=25701 09810=26564
A3b	05045+60041	4	1	BOARD ASSEMBLY, ONE SHUT (SERIES 1748)	28480	ტუც 45∞ გე0 41
436C1 436C2	0169-3762	7	2	CAPACITOR-FXD .68UF +-5% SOVOC MET-POLYC CAPACITOR-FXD .68UF +-5% 50VDC MET-POLYC	58780 58480	0160-3762 0160-3762
A36J1	1200-0559	6	1	SOCKET TEST 20-PIN	25480	1200-0851
A36P1 A36P2	1200+0557 1251-4259	9	1	SOCKETIC 20-CONT DIP DIPSLOW (BASE) CONNECTOR-SGL CONT PIN .031-IN-BSC-SZ	19613 28480	220-0334+00-0502 1251-4259
436R1 A36R2	0757=0449 0757=0449	6	5	RESISTOR 20K 1% .125W F TC=0++100 RESISTOR 20K 1% .125W F TC=0++100	24546 24546	C4-1/8-10-2002-F C4-1/8-10-2002-F
A3681 A3682 A3683 A3684	3101-1660 3101-1641 3101-1841 3101-1841	1. 5 83 85	3	SWITCH-SL S-1A DIP-SLIDE-ASSY .1A 50VDC SWITCH-SL 4-1A DIP-SLIDE-ASSY .1A 50VDC SWITCH-SL G-1A DIP-SLIDE-ASSY .1A 50VDC SWITCH-SL 4-1A DIP+SLIDE-ASSY .1A 50VDC	28480 28480 28480 28480	3101-1600 3101-1841 3101-1841 5101-1841
A37	05045+60043	6	1	STATIC PROTECTION BOARD (SERIES 1916)	28484	05045-60043
A37C1 A37C2 A37C3 A37C4	0160-4557 0160-4557 0160-0228 0180-0228	0 0 6	2	CAPACITOR-FXD .10F +-20% 50VDC CER CAPACITOR-FXD .10F +-20% 50VDC CER CAPACITOR-FXD 22UF+-10% 15VDC TA CAPACITOR-FXD 22UF+-10% 15VDC TA	28480 28480 56289 56289	0160-4557 0160-4557 1500226x901582 1500226x901582
A37CR1+ A37CR192	1901=0050	3		DIODE-SWITCHING 86V 200MA 2NS 00-35	28480	1901-0050
A37P1	1251-2656	2	:	CONNECTOR=PC EDGE S0+CUNT/ROW 2-ROWS	28480	1251-2658
A 38	05045-60037	8	1	BOARD ASSEMBLY, HP-IB INTERPACE (SERIES 1712)	28480	05045-60037
A38CR1	1901-0040	1		DIDDE-SWITCHING BOV SUMA 2NS DD-35	28480	1901-0040
l loea Elsea	1200±0433 1251=3263	0		SOCKET-IC 24-CONT CONNECTOR 24-PIN F MICROMIBBON	58480 58480	1200-0453 1251-3283
A38R1 A36R2	1510=0136 1610=0136	3		NETWORK-RES 10-PIN-SIP ,1-PIN-SPCG NETWORK-RES 10-PIN-SIP ,1-PIN-SPCG	28480 28480	1810-0156 1810-0156
	0698-6362 1251-4364 1400-0995	24 2 1	: [PRECISION RESISTOR PACK BOARD (05045-60042) RESISTOR 1K 0.1% .125W CONNECTOR 12-PIN HEADER CABLE GRABBER		0698-6362 1251-4364 1400-0995
		the state of the s				

See introduction to this section for ordering information *Indicates factory selected value

Model 5045A Replaceable Parts

Table 6-1. Replaceable Parts (Cont'd)

-	Table 6-1. Replaceable Parts (Colfi d)					
Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A1				CHASSIS PARTS	28480	3160=0267
81 82	3160+0287 3160+9287	8	5	FAN=TBAX 45=CFM 115V 50/60=H2 1.5=THK FAN=TBAX 45=CFM 115V 50/60=H2 1.5=THK	28480	3160-0287
C1 C1	0150+0119 0180+2179	1 0	1	CAPACITOR=FXD 1010F7.010F +=20% CAPACITOR=FXD 4600UF+75=10% 1590C 46 (PART OF J1)	26480 00853	0150=0119 5004620015AA2A
C2 C3	0180-0580 0180-0580	2 2	s	CAPACITOR=FXO .04F+75=10% 15VOC AL CAPACITOR=FXO .04F+75=10% 15VOC AL	56289 56289	6020403G015Ht24
C4 C5 C6 C7 C8	0180+2277 0180+2277 0180+0579 0180+0579 0180+0577	9 9 0 4 8	2 2 1	CAPACITOR=FXO 8200UF+75=10% 25VOC AL CAPACITOR=FXO 8200UF+75=10% 25VOC AL CAPACITOR=FXO 7200UF+75=10% 30VDC AL CAPACITOR=FXO 7200UF+75=10% 30VDC AL CAPACITOR=FXO .028F+75=10% 40VDC AL	56269 56269 00853 00853 00853	3608226025AC2A 3608226025AC2A 5667224036AD2A 5007224030AD2A 5002834046Ck2A
C9 C10 C11 C12 C13	0160=3094 0160=3094 0160=3094 0160=0127	8 8 8 8 8 2	Ú	CAPACITOR=FXO ,1UF +-10X 100XPC CER CAPACITOR=FXO ,1UF +0UR 100XPC CER CAPACITOR=FXO ,1UF +0X 100XPC CER CAPACITOR=FXD 1UF +0X 100XPC CER CAPACITOR=FXD 1UF +0X 25X0C CER	28480 28480 28480 28480 28480	0160=3094 0160=3094 0160=3094 0160=3094 0160=0127
CR1 CR2 CR3	1906-0058 1902-0986 1902-0986		5	DIGOE-FW BRDG 100V 30A VF DIFF=1.14V . DIGOE-ZNR 9.1V 5% PO=1# IR=1UA DIGOE-ZNR 9.1V 5% PD@1W IR=1UA	04713 04713 04713	MUA990=2 1 1 1 5 6 3 2 A F 1 1 1 1 6 6 7 2 A F 1
Da1 Da2 Da3 Os4 Da5	2140+0025 2140+0025 2140+0025 2140+0025 2140+0025	99999	5	LAMP-INCAND 327 284DC 40MA T-1-3/4-8UL8 LAMP-INCAND 327 284DC 40MA T-1-3/4-8UL8 LAMP-INCAND 327 284DC 40MA T-1-3/4-8UL8 LAMP-INCAND 327 284DC 40MA T-1-3/4-8UL8 LAMP-INCAND 327 284DC 40MA T-1-3/4-8UL8	28480 28480 28480 28480	2140=0025 2140=0025 2140=5025 2140=9025 2140=0025
Fi	2110=0381	7	1.	FUSE 3A 250V SLO-BLO 1.25%.25 UL (PART OF J1)	28480	2110-0181
F1	2110-0304	4	1	FUSE 1.54 250V SLO-BLO 1.29X.25 UL (PART OF J1)	26480	2110-0304
F2	2110-0054	1	5	FUSE 154 250V MOM-8LO 1.25X.25 UL	28486	2110-0954
F3	2110-0054	1		FUSE 15A 250V MDM-BLD 1.29x.25 UL	28489	2110=0054
Ji	0960-0444	ê	1	POWER MODULE, UNFILTERED	06985	4900 = 0.444
L1 L2	9140-0136 9140-0136	0	3	COIL-MLD 281H 10% Q#50 .281H%.938LG-NOM (PART OF J1) COIL-MLO 28UH 10% Q#50 .261D%,938LG-NOM (PART OF J1)	28480 28480	3740 = 913¢ 6140 = 613¢
4P1 4B2 MP3 MP4 MP5	5040-7219 5040-7220 5060-9805 05045-00023 5040-7201	8 1 4 6 8	P N N N N	STRAP, HANDLE, CAP-FRONT STRAP, HANDLE, CAP-REAH COVER, SIDE FOOT(STANDARD)	25480 26480 28480 28480 28480	5040-7219 5040-7220 5060-9605 05045-00023 5040-7201
MP6 MP7 MP6 MP9 MP10	5001=0440 5040=7202 5040=9848 5060=9836 05045=20201	- 9 B 1 4	44 44 44	TRIM, SIDE TRIM, TOP PANEL, FRONT EXTRACTOR	58480 58480 58480 58480 58480	1949 - 1946 2057 - 1960 8489 - 1960 2587 - 1960 1960 - 2050
MP11 MP12 MP13 MP15	3131=0367 3131=0369 3131=0370 3131=0371 3131=0368	4 69 05	4 d q d	CAP, SWITCH, LOAD CAP, SMITCH, PABS CAP, SMITCH, CONT CAP, SMITCH, FAIL CAP, SWITCH, FEST	28480 28480 28480 28480 28480	3131=0357 3131=0359 3131=0370 3131=0371 3131=0356
MP16 MP17 MP16 MP10 MP20	05045+00016 05045+60112 05045+20205 05045+60111 05045+20206	9	1	SUB-PANEL, CONTHOLS ODDR 453Y, PRINTER PIN, HINGE C.D. DOOR 453Y, CONTROL PIN, HINGE, P.O.	28480 58490 58480 58480 58480	05045+00016 05045+601112 05045-20205 05045-60111 05045-20206
#P21 KP23 MP24 MP25 MP26	05045-20203 05045-40003		1	AXLE, PAPER ROLL NOT ASSIGNED COVER, TEST MEAD NOT ASSIGNED NOT ASSIGNED	28480 28480	05045-20203
MP27 MP28 MP29 MP31 MP32	05045-20204 05045-00027 05045-00021 05045-40001 05045-40002	4	1	SCREM, TONGUE GUIDE, BOARD, SOCKET ORIVE TRAY, TEST MEAD GUIDE, MAG CARD, BOTTOM GUIDE, MAG, CARD, TOP	28460 28460 28460 28460 28460	05045-20204 05045-00027 05045-00021 05045-40002
#931 #918 #919 #936 #937	0403=0150 05045=00004 5020=8805 05045=00014 05045=00015	5	1	GUIDE-PC BD GRA POLYC .062-30-TMKNS COVER, FOWER SUPPLY FRAME, FRONT SUPPORT, CARD READER BRACKET, CARD READER	58441) 54441 54441 54481	0403=0150 05045=00004 5020=8805 05045=00014 05045=00015
	1		1		1	

See introduction to this section for ordering information *Indicates factory selected value

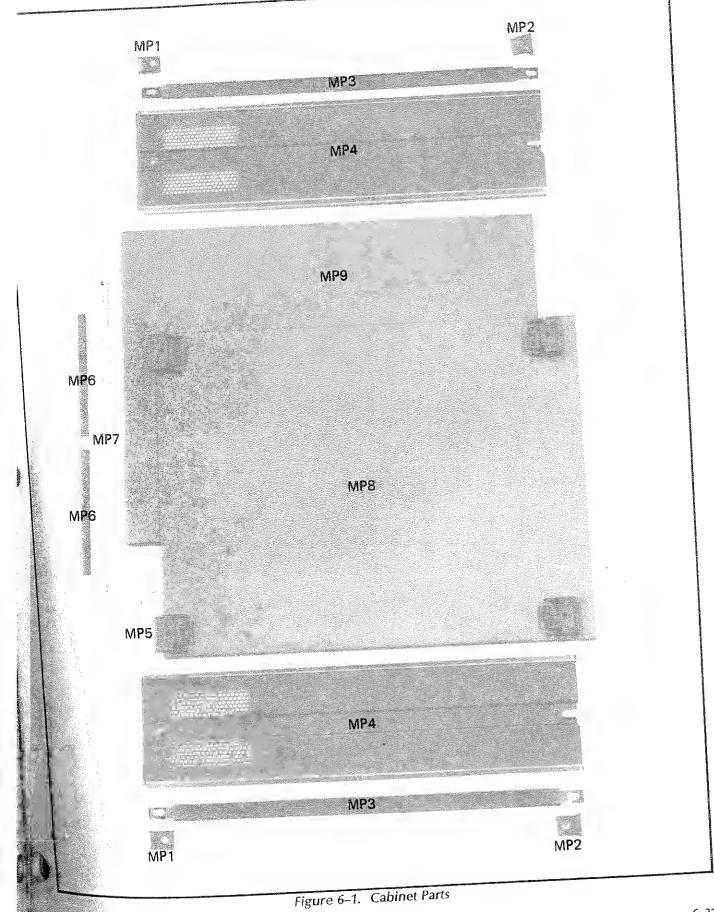
6-29



Table 6-1. Replaceable Parts (Cont'd)

D-forence	HP Part	С	Otv	Descri	ption	Mfr Code	Mfr Part Number
Reference Designation MP36 MP40 MP41 MP42 MP43 MP44 MP45 MP45 MP46 MP47 MP48 MP48 MP47 MP48 MP48 MP49 MP50 MP48 MP49 MP49 MP48 MP48 MP49 MP48 MP49 MP48 MP49 MP48 MP49 MP48 MP49 MP48 MP48 MP48 MP48 MP48 MP48 MP48 MP48	1-P Part Number 05045-00013 05045-00010 05045-00016 5020-8838 05045-00007 05045-00006 5020-8838 05045-00006 5020-8838 05045-00006 5020-8836 05045-00016 1854-0671 1854-0671 0511-2640 9100-3044 05045-6010 05045-6010 05045-6010 05045-6010 05045-6010 05045-6010 05045-6010 05045-6010	D 41277 86459 203 33 9 1 65332 2 1	Oty 1211111111111111111111111111111111111	SUPRORT, INTERFACE TO GIODE, BOARD, LEFT GUIDE, BOARD, RIGHT BULKHEAD, FRONT STIFFENER, BLOCK ME BULKHEAD, REAR GUIDE, BOARD, FRONT GUIDE, BOARD, REAR, FRAME, REAR SUPRORT, R.S. COVER PAPER, ROLL BRACKET, MOTHER BO TRANSISTOR NPN 2ND RESISTOR 220 1% 3W TRANSFOHMER-POWER CABLE ASSY, BM AIN IN CABLE ASSY, FRONT CABLE ASSY, FRONT CABLE ASSY, TRANSCABLE ASSY, TRANSCABLE ASSY, TRANSCABLE ASSY, TRANSCABLE ASSY, TRANSCABLE ASSY, AS PO CABLE ASSY	ption 3.8. AO , p.s. p.s. P.S. 282 SI TO-3 PD=1AOW 282 SI TO-3 PD=1AOW 282 SI TO-3 PD=1AOW PW TC=0+=20 PRIL 115/230V: W/LOOV IOTHER SM PANEL CONTROL OOLH OOLH SM PANEL CONTROL OOLH OOLH SM PANEL CONTROL OOLH OOLH OOLH SM PANEL CONTROL OOLH OO	Mfr Code 26460 26	0340=0570 505=,196
	05045 05045 05045	19 22676 17 39 58821 84973 00000 0000000 0000000 0000000 0000000 0000	55 92297 09 34 49212 21527 51257 128350	TERMINAL SALDR LOV SPACER-RNO .502- SPACER-RNO .502- SPACER-RNO .502- TASTENER-LATCH A O-RING .200-IN-I SOCKET-XSTR 2-CE SOCKET TEST 20-PIN HEAT SINK TO-3-F SOCKET, IC 20-CONT CHART OF SOCK CLAMP-CAR 1.375 CONNECTOR-PC DOLARIZING KEY- PUSEHOLDER-BLOC CAMP-CAP 2.5-D SCREWMACH 10-1 CAMP-LAP 2.5-D SCREWMACH 10-1 LABEL-INFORMAT PLATE-SERIAL . FOOT PANEL, REAR PAN, FLOOR COVER, RECEPT, SHIELD, PROCE BOARD ASSEMBL DUMMY IC, 18-	IN-LG , IN-IN-ID 125-IN-LG 6-32THO OJ PAWL SRIP RANGE 440-THD , 25-WD SPR-STL D, 87-IN-XSECT-DIA NIRI NY 10-3 XXG DIP TEST 20-PIN (BASE) ET ADAPTER) -DIA STL GE 15-CGNT/ROW 2-ROWS RC EOGE CONN K 15A 250V 1-FU 1A 8TL 12 , 375-IN-LG 100 DEG BLACK; , 375-IN DIA 4 X 2" 1N-WD , 54-IN-LG AL IN-WD , 54-IN-LG AL IN-WD , 54-IN-LG AL IN-WD , 54-IN-LG AL IN-WD 1, 25-IN-LG AL IN-WD 1, 25-IN-	00000000000000000000000000000000000000	ORDER BY DESCRIPTION OSTO-0182 ORDER BY DESCRIPTION OFFICE OF DESCRIPTION OFFICE OF DESCRIPTION OFFICE OFFICE OFFI 1205-0293 220-0334-00-0502 1210-0013 1251-0159 1251-0159 1251-115 1400-0598 1400-0598 1400-0598 1400-0598 1500-0172 3101-1671 080 7120-1254 7120-4289

See introduction to this section for ordering information *Indicates factory selected value



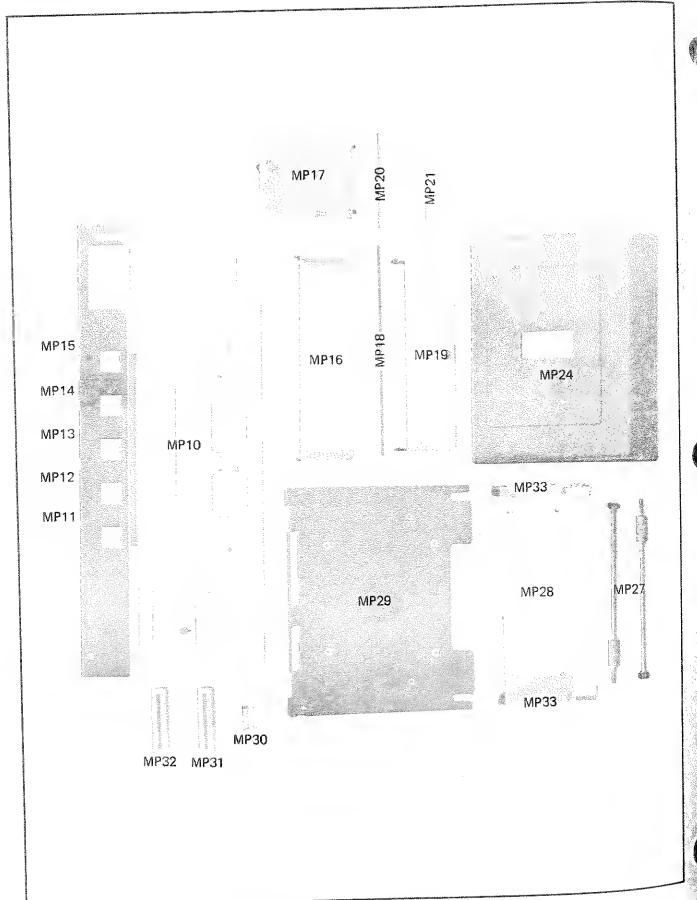
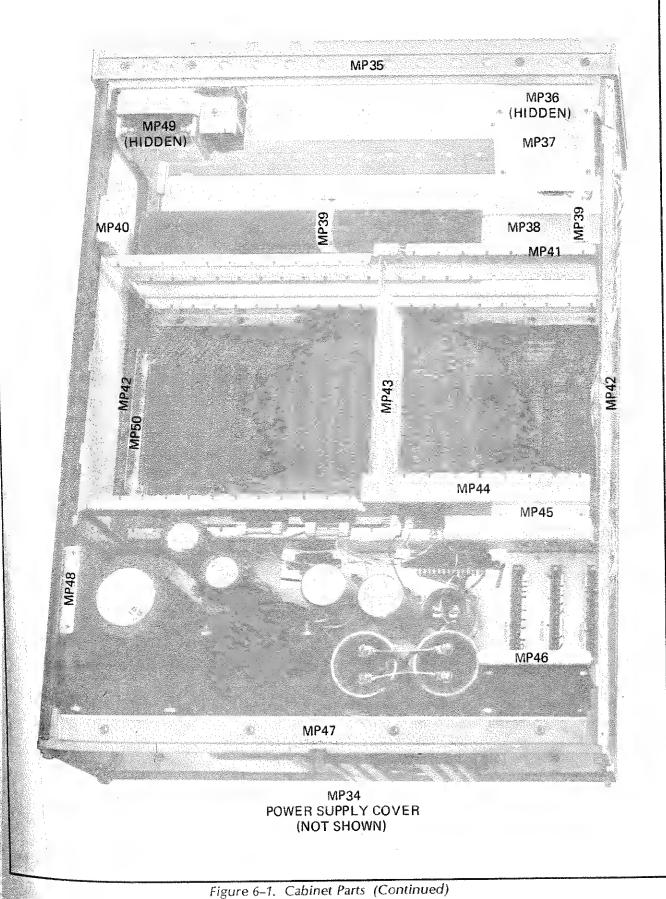


Figure 6-1. Cabinet Parts (Continued)



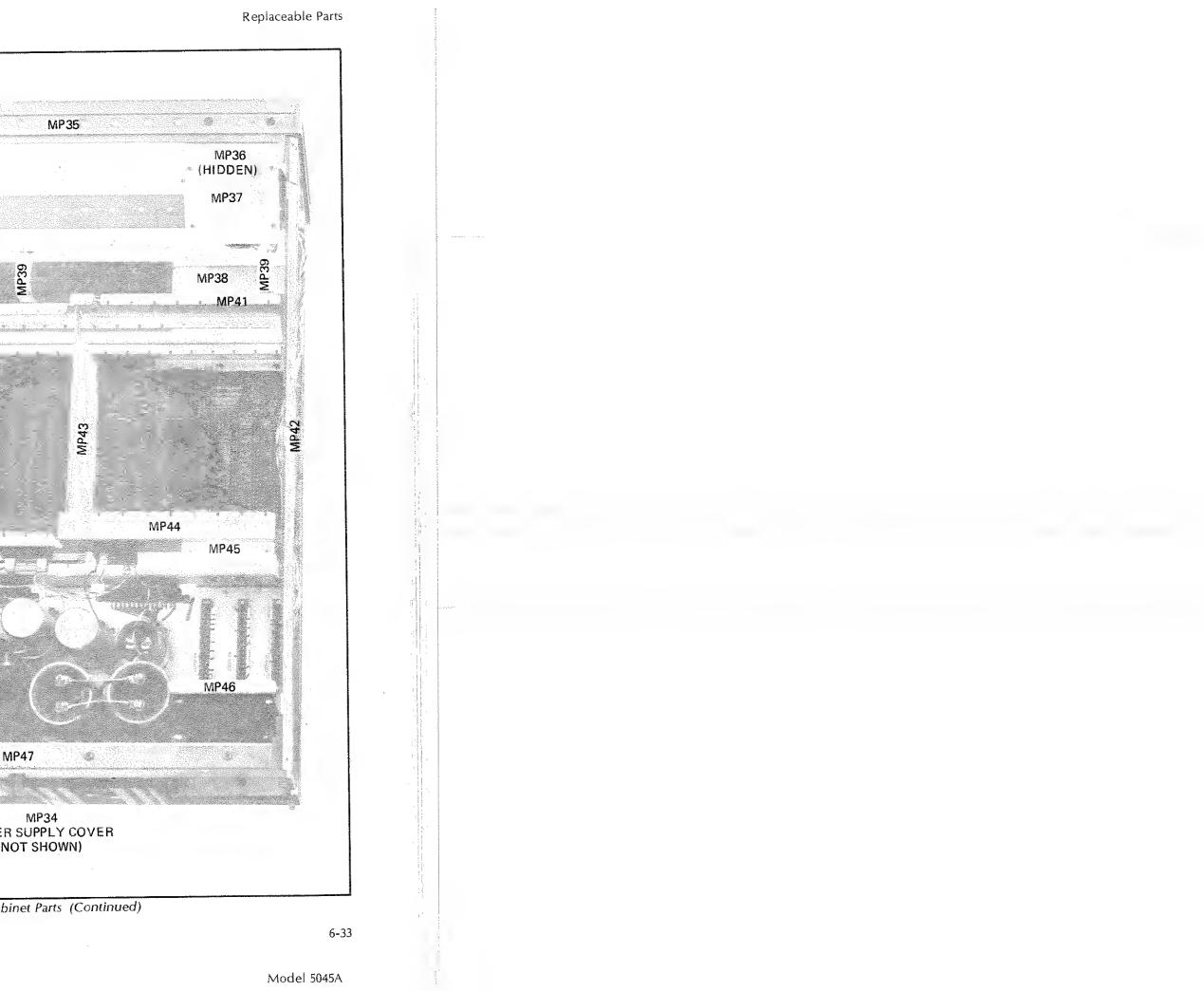


Table 6-2. Manufacturers Code List

		Table 0 2.	1.1.1	Zip Code
Mfr	No.	Manufacturer Name	Address	03244
00	[00]	GTE Sylvania Miniature LT Prod	Hillsboro, NH	03244
00	000	Any Satisfactory Supplier		29671
00	8S3	Sangamo Elec Co S. Carolina Div	Pickens. SC	2907 1
00	90B	Kemet		53204
01	1121	Allen-Bradley Co	Milwaukee, WI	75222
01	1295	Texas Instr Inc Semicond Cmpnt Div	Dallas, TX	
0	1928	RCA Corp Solid State Div	Somerville, NJ	08876
1	4713	Motorola Semiconductor Products	Phoenix, AZ	85062
	7263	Fairchild Semiconductor Div	Mountain View, CA	94042
	9613	Textool Products Inc	trving, TX	75060
	1	Corning Glass Works (Bradford)	Bradford, PA	16701
	4546	National Semiconductor Corp	Santa Clara, CA	95 051
	7014	Hewlett-Packard Co Corporte HQ	Palo Alto, CA	94304
	28480		Laconia, NH	03246
3	30161	Aavid Engineering Inc	San Diego, CA	92121
	30983	Mepco/Electra Corp	Costa Mesa, CA	92626
	52072	Circuit Assembly Corp	North Adams, MA	01247
	56289	Sprague Electric Co		50501
	71590	Centralab Elek Div Globe-Union Inc	Milwaukee, WI	06226
	72136	Electro Motive Corp Sub IEC	Willimantic, CT	
	73138	Beckman Instruments Inc Helipot Div	Fullerton, CA	92634
	79963	Zierick Mfg Co	Mt Kisco, NY	10549
	84411	TRW Capacitors Div	Ogallala, NE	69153
		Dale Electronics Inc	Colümbus, NE	68601
	91637	Date decisions		

SECTION VII MANUAL CHANGES

7-1. INTRODUCTION

7-2. This section contains information necessary to adapt this manual to older instruments. This manual applies directly to 5045A instruments having serial prefix 1932A.

7-3. NEWER INSTRUMENTS

7-4. As changes are made, newer instruments may have a serial prefix not listed in this manual. Manuals for these instruments are supplied with a manual change sheet, containing the required information. Contact the nearest Hewlett-Packard Sales and Service Office for information if this sheet is missing.

7-5. OLDER INSTRUMENTS

7-6. To adapt this manual to instruments having a serial prefix prior to 1932A, perform the backdating that applies to your instrument's serial prefix as listed in Table 7-1 below.

Table	e 7-1.	Manual	Backdatin
Table	e /-1.	Manuai	расхолог

If Your Instrument has Serial or Serial Number Below	Make the Following Changes to Your Manua
	1
1916	1,2
1852	1,2,3
1712A	1,2,3,4
1704A	
1628A176 thru 185	1,2,3,4,5
1628A156 thru 175	1,2,3,4,5,6
	1,2,3,4,5,6,7
1620A	1,2,3,4,5,6,7,8

CHANGE 1

Page 6-23, Table 6-1, A28 Replaceable Parts:

Change A28 from Series 1916 to 1520A.

Page 8-147, Figure 8-31, A28 Schematic Diagram:

Change A28 Series from 1916 to 1516 and 1520.

Delete a connection between the shell and pin 17 (circuit common) of 24-pin dual inline connector P2 and connection between shell and pin 36 (circuit common) of 50-pin dual inline connector P4.

Page 6-15, Table 6-1, A13 (05045-60013) Replaceable Parts:

Change A13 Series from 1916 to 1712.

Change HP Part Numbers for A13U16, 17, 25 and U26 from 1820-1938 to 1820-1614.

Page 8-135, Figure 8-27 (Sheet 1 of 2), A13-A24 Schematic Diagram:

Change A13-A24 from Series 1916 to 1712.

Page 6-29, Table 6-1, Replaceable Parts:

Delete CR3 1902-0986.

Page 8-113, Figure 8-17, A2 Schematic Diagram:

Delete 9.1V breakdown diode (CR3) between terminal 15 and terminals 11, 11.

Page 6-29, Replaceable Parts:

Delete complete A37 parts list.



SECTION VIII MAINTENANCE AND TROUBLESHOOTING

8-1. INTRODUCTION

8-2. This section contains maintenance, troubleshooting, theory of operation, component locators and schematic diagrams. The maintenance information includes a table for identification of assemblies and a table of test equipment required. Removal and disassembly procedures, in addition to repair and cleaning procedures, are included. Troubleshooting covers the CPU, the pin drivers and self check. A troubleshooting flow chart, and operation flow chart and a ROM listing are included.

8-3. ASSEMBLY IDENTIFICATION

8-4. Table 8-1 lists the designations, name and Hewlett-Packard part number of the assemblies that comprise the 5045A.

Table 8-1. Assembly Identification

Assembly	Description	HP Part No.
A1	±15V and ±18V Regulator	05045-60001
A2	±8V and ±12V Regulator	05045-60002
A3	±5V and +18V Regulator	05045-60003
A4	Arithmetic Logic Unit	05045-60004
A5	Processor Memory	05045-60005
A6	Main Memory	05045-60006
A7	I/O Board (HP-IB)	05045-60007
A8	ROM	05045-60008
A9	Address	05045-60009
A10	D/A Control	05045-60010
A11	Reference Level Generator	05045-60011
A12	Pin Driver Control	05045-60012
A13 thru A24	Pin Driver	05045-60013
,	(A17 thru A20 comprise Option 024)	
A25	Card Reader Interface Assembly	09810-66562
A26	Card Reader/Printer Interface	05045-60015
A27	Front Panel Switch Board	05045-60021
A28 or A29	Socket Driver	05045-60017
A30	Socket Assembly	05045-60019
A31	Test Head Interconnect	05045-60020
A32	Interface Motherboard	05045-60016
A33	Main Motherboard	05045-60014
A34	Thermal Printer	05150-60011
A35	Magnetic Card Reader	09810-67962
A36	One-Shot Multivibrator	05045-60041
A37	Static Protection	05045-60043
A38	HP-IB Interface	05045-60037

8- i



8-17. Card Reader Removal

- a. Disconnect power from 5045A.
- b. Remove top cover of 5045A by loosening screw on rear of cover.
- c. Remove top trim strip using flat-blade screwdriver inserted into slots in strip to lift strip
- d. Remove A25 Card Reader Interface board by lifting board up until it is out of connector, then push board down and to the rear of the connector until the left end of the board passes through the board guide. Pull left side of board forward, sliding the board under the guide. When clear of the guide lift the board up until the side edge connector can be removed. Remove the connector in the center of the board, making sure not to bend the pins. Remove board from instrument.
- e. Turn 5045 on its side and remove bottom cover by loosening the screw at rear of cover.
- f. Remove the screw second in from left end of the instrument on the front flange (bottom portion). (A nut on the inside of the instrument on this screw must be held to allow removal of the screw.)
- g. Remove the two screws on the left top of the front flange. This will allow the card reader assembly to be removed.
- h. Reverse the preceding procedure to reinstall the card reader assembly. The nut and screw attaching the lower bracket and lower front flange should be loosened and the lower portion of the card reader moved if the card does not feed smoothly into and out of the reader. The nut and screw should then be retightened.

8-18. Cleaning Solvents

8-19. Recommended freon cleaning solvents listed below can be used for the card driving wheels and the commutator contacts.

CAUTION Do not use freon on Magnetic Read/Write head.

Manufacturer's Name	Manufacturer's Part No.	HP Part No.
Sprayon Products	#2002	8500-0232
Miller-Stephenson	MS-180	
jesta	TFA 1135	
CRC Chemicals	2016	

CAUTION

Do not use solvents which are not recommended. Some solvents will leave a harmful residue which will seriously affect the operation of the card reader.

8-20. Cleaning the Card Driving Wheels

8-21. The magnetic card reader must be removed as described above. Remake the electrical circuit connections to the card reader and start the card reader running. Spray a moderate amount of solvent on a kimwipe and wipe the driving surface of the two drive wheels which are shown in Figure 8-1. Repeat this procedure until no more dirt can be removed from the drive wheels.

CAUTION

Do not spray solvent directly onto the drive wheels. Solvent will destroy adjacent plastic parts.

8-22. Cleaning the Motor Commutator Contacts

8-23. The magnetic card reader must be removed as described above. Loosen the two hex headed screws which fasten the end cap to the motor shown in Figure 8-1. Pull the end cap back to expose the commutator contacts. Remake the electrical circuit connections to the card reader and start the card reader running. Spray moderate amounts of solvent directly on the commutator contacts, until the motor runs smoothly at the normal speed. Do not wipe the commutator contacts with a cloth or tissue.

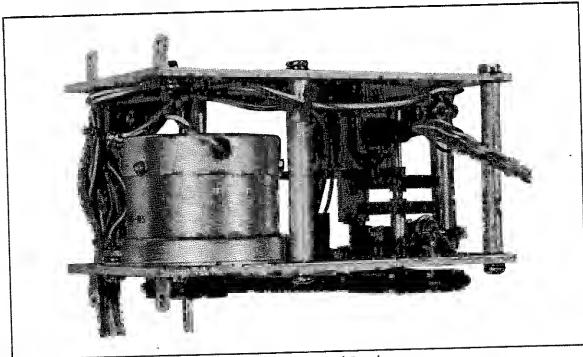


Figure 8-1. A35 Card Reader

8-24. Cleaning the Read/Write Head

8-25. Clean the card reader Read/Write head with cleaning card, HP Part Number 8660-0463. Instructions for use of this cleaning card are listed in the following paragraph. Cards are available from HP Customer Service Center, in Mountain View, California and Parts Center Europe, Boeblingen, Germany.

CAUTION

See warning on card.

8-26. Use of Cleaning Card for Magnetic Card Reader

8-27. This card should be used only as often as is necessary. Use when the reader gives erratic results, such as when loading a program card results in a "RELOAD" being printed by the thermal printer. It should also be used after approximately every 750 program card loadings or every 2 months, whichever comes first. If the reader continues to give erratic results after two passes of the cleaner card and these results are not restricted to a few cards, the problem may be in another part of the tester. Maintenance procedure for cleaning the card drive wheels (paragraph 8-20) should be performed if the card seems to be slipping.

Model 3043/A



8-28. Lamp Replacement

- 8-29. To replace a defective lamp in the card reader, proceed as follows:
 - a. Remove the card reader as described above.
 - b. Remove the lamp assembly by pulling it out with a pair of pliers.
 - c. Loosen brass nut on the front (Lamp) end of the assembly with a 3/16" wrench. (See Figure 8-2.)
 - d. Remove the brass nut and lamp holder.
 - e. Replace the defective lamp, HP Part Number 2140-0092.
 - f. Screw the lamp holder back into place and replace the $^3\!/_{16}$ " brass nut.
 - g. Press the lamp assembly into the assembly holder.
 - h. Check to assure that the magnetic card reader is performing properly by loading a known good program from a magnetic card into the tester and verify that the program in memory and the program on the card are identical.

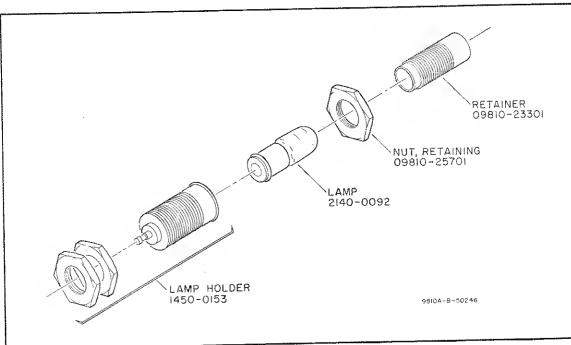


Figure 8-2. Lamp Replacement

- 8-30. If the card reader still malfunctions after performing the above cleaning and lamp replacement procedures, exchange it via your HP Service Office (listed at the rear of this manual).
- 8-31. There are two versions of magnetic card readers, as follows:

Version A:

This has a teflon guide on the motor shaft. The motor mounting nuts are the aircraft type with rubber inserts. The motor is purposefully left loose on its mounting bolts.

CAUTION

Do not tighten the motor mounting nuts. To do so will bind the motor shaft.

Version B:

This version does not have a teflon guide on the motor shaft. The motor mounting nuts have lock washers and hold the motor tight against its mounting surface.

CAUTION

Do not loosen the motor mounting nuts. To do so will cause the card reader to malfunction.

8-32. A34 THERMAL PRINTER MAINTENANCE

8-33. The following procedures are provided for maintenance of the thermal printer. To insure that the print head is not damaged by a possibly defective A26 Card Reader/Printer Interface board, the board should be checked per paragraph 8-40.

8-34. Printer Removal and Disassembly

- 8-35. Remove the printer as follows:
 - a. Disconnect gray cable and the red and blue wires from control board.
 - b. Remove A26 Card Reader/Printer Interface board.
 - c. Remove print mechanism by removing front casting top trim strip. Remove two top screws and mechanism will be loose and can be removed. Note that lower lip of paper guide overhangs the front panel and the upper paper guide is free to move and does not touch panel.
 - d. Remove mounting bracket by removing only the four screws on the rear of the assembly that hold the bracket to the side plates.
 - e. Remove the spring clip that holds the head in place by pressing down and sliding it towards the left side of the mechanism, then up and out.
 - f. Loosen the cam hold screws at rear of heat sink. Head and heat sink are ready to be removed. Note that there is a spring between the upper plastic paper guide and the heat sink. Remove heat sink by pressing the rear down and back.
- 8-36. PRINT HEAD REPLACEMENT. Remove the head from the heat sink by pressing a blunt tool through hole in the heat sink. There should be enough heat sink compound in heat sink to hold the new head in place. Install the new head in the heat sink.
- 8-37. ROLLER REPLACEMENT. Remove the thumbwheel. Then remove the right side plate on ly. Do not loosen any screws on the solenoid side of the mechanism other than the two on the mounting bracket. This will insure some mechanical alignment.
- 8-38. Remove the retaining ring holding the armature onto the shaft. Slide the armature/clutch assembly off the roller shaft. Slide the roller shaft out of the left side plate.
- 8-39. Install the new roller shaft and reassemble the mechanism. Do not oil the armature or side plate bearings. The right side plate should be adjusted so that the bearing drag is minimized.

8-40. A26 Card Reader/Printer Interface Board Checkout

- a. Check all power supplies. (Refer to paragraph 5-9.)
- b. Load card in (card title should print), place AUTO/MAN switch to MAN.
- c. Check current drawn by A 26U5, U9, U13, U17 and U20 in the following manner: Connect a $\frac{1}{4}$ Watt 200 Ω resistor between ± 5 volts and:

U5 — pin 10,11,13,14,15

U9 — pin 10,11,13,14,15

U13 — pin 10,11,13,14,15

U17 — pin 10,11,13,14,15

U20 — pin 10,11,13,14,15

Measured voltage at each indicated pin should be less than 0.4V with load resistor applied.

d. Check the Group Enable lines (pins 19,33,16,32 of gray connector on the A26 board). Connect $\frac{1}{2}$ Watt 200 Ω resistor from ground to each pin and measure voltage.

pin 19 -- >+9.5V

pin 33 -- >+9.5V

pin 16 - ~0V

pin 32 — ~0V

- e. Check the voltage at U12A pins 4,5,6,7. Voltage should be greater than 2.4V.
- f. Reinstall mechanism into the instrument and connect the gray cable, the red and blue wires to the A26 board. Mechanism should be positioned, using four screws on mounting bracket so that lip on lower paper guide rests on front panel and upper guide is free.
- Check "Printer Group Enable Timing" per paragraph 5-12. Make adjustments as necessary.
- h. Run "Printer Check" per paragraph 4-157.
- Print spacing is controlled by an adjustable stop screw located between the solenoid and armature. The hex end is 3/16 inch. To reduce print spacing, turn the screw clockwise. To increase spacing, turn the screw counter-clockwise. Vertical spacing should be approximately 6 characters per inch.
- Press STEP button to obtain a printout and repeat measurement and adjustment as necessary.

8-41. PC Boards Requiring Special Handling and Cleaning

- 8-42. The following PC boards require special handling and cleaning.
 - A11 Reference Level Generator, Part No. 05045-60011
 - A13-A24 Pin Driver, Part No. 05045-60013
 - A33 Main Motherboard, Part No. 05045-60014
 - A28 or A29 Scoket Driver, Part No. 05045-60017
 - A30 Socket Assembly, Part No. 05045-60019
 - A31 Test Head Interface, Part No. 05045-60020

CAUTION

The A11 DAC and A13 thru A24 pin driver boards contain CMOS circuits which are highly susceptible to static discharge damage. Handle these boards only by the large black heat sink or the board extractor.

8-43. HANDLING. The boards listed above should be handled only by the edges. Finger prints on the board surface may cause high resistance leakage and degrade instrument performance.

8-44. CLEANING. After repairs are made on the boards listed above, the contaminated areas should be washed with a special detergent such as Alcohol. The areas should be dried and sprayed with a coating (approximately 0.001 inch) of GE Dri-Film (or equivalent). Old film can be stripped from the board when necessary by using freon.

8-45. REPAIR

8-46. Printed Circuit Component Replacement

8-47. Component lead holes in the circuit boards have plated-through walls to ensure good electrical contact between conductors on opposite sides of the board. To prevent damage to the plating and the replacement component, apply heat sparingly, and work carefully.

8-48. Replacing Integrated Circuits

- 8-49. Following are two recommended methods of replacing integrated circuits:
 - a. SOLDER GOBBLER. This is the best method. Solder is removed from board by a soldering iron with a hollow tip connected to a vacuum source. MUST NOT PRODUCE STATIC CHARGES WHEN OPERATING!
 - b. CLIP-OUT. This method should be used as a last resort only. Clip the leads as close to the base as possible. With a soldering iron and long nose pliers, carefully remove the wires from each hole. Then clean the holes.

8-50. TROUBLESHOOTING

- 8-51. Troubleshooting the 5045A is divided into two sections: (1) the CPU and its peripherals, and (2) Pin Drivers and associated circuitry.
- 8-52. CPU troubleshooting covers the following circuits:
 - a. A35 Card Reader and interface
 - b. A34 Printer and interface
 - c. A4 Arithmetic Logic Unit (ALU)
 - d, A5 Processor Memory Board
 - e. A6 Main Memory Board
 - f. A8 ROM Board
 - g. A9 ROM Address Board
- 8-53. Pin Driver troubleshooting covers the following circuits:
 - a. A13-A24 Pin Drivers Boards
 - b. A28, A29 Socket Driver Boards (Fast Edge circuits)
 - c. A10 D/A and A12 Pin Driver Control Logic
 - d. A11 Reference Level Generators
 - e. A12 Pin Driver Control
 - f. A30 Socket Board
 - g. Relays

- 8-54. Troubleshooting the 5045A requires an understanding of the sequence of operation within the instrument. This sequence is divided into three levels of documentation: (1) general overall operations; (2) Firmware flow diagram; (3) ROM listing (mnemonic and hexcode).
- 8-55. The overall operational flow of information is as follows:
 - a. Power on.
 - b. Wait for LOAD button to be pressed.
 - c. Turn card reader and LOAD light on.
 - d. Read information from card.
 - e. Turn card reader motor and LOAD light off.
 - f. Perform checksum on data read in from card versus information stored on the card.
 - g. If checksum error, then print "RELOAD" and return to step b. If checksum is correct, print IC Type information.
 - h. Press TEST button (TEST light comes on).
 - Test Circuit (PASS, FAIL, or CONT light comes on).
 - j. Press LOAD button (go back to step c).
 - k. Press TEST (In MAN/HANDLR mode).
 - l. TEST light goes out.
- 8-56. Figure 8-4 is a troubleshooting flow diagram showing areas of concern when a particular step is not executed correctly. This is based on the use of the Self Check 1 & 2 Programs covered in paragraphs 4-13 and 4-14.

CAUTION

NEVER operate the 5045 with any of the Pin Driver boards (A13 to A24) installed while A10 or A11 or A12 are removed. It is all right to operate the 5045A with A13 to A24 removed if A10 or A11 or A12 are installed. A11 will not operate without A10 while A12 will operate independently of A10 and A11.

NOTE

Before proceeding further, perform clock adjustment per paragraph 5-11a.

8-57. CPU Troubleshooting

- 8-58. Check the symptoms listed and perform the appropriate procedure:
 - a. Instrument will not operate when LOAD button is pressed.
 - 1. Remove boards A10 through A24.
 - Check power supplies per paragraph 5-9.
 - Check clock per paragraph 5-11a.
 - 4. Check program flow in operational flow diagram, Figure 8-3.
 - 5. Connect 1601L and 10250A per Table 8-3 and perform the following steps.

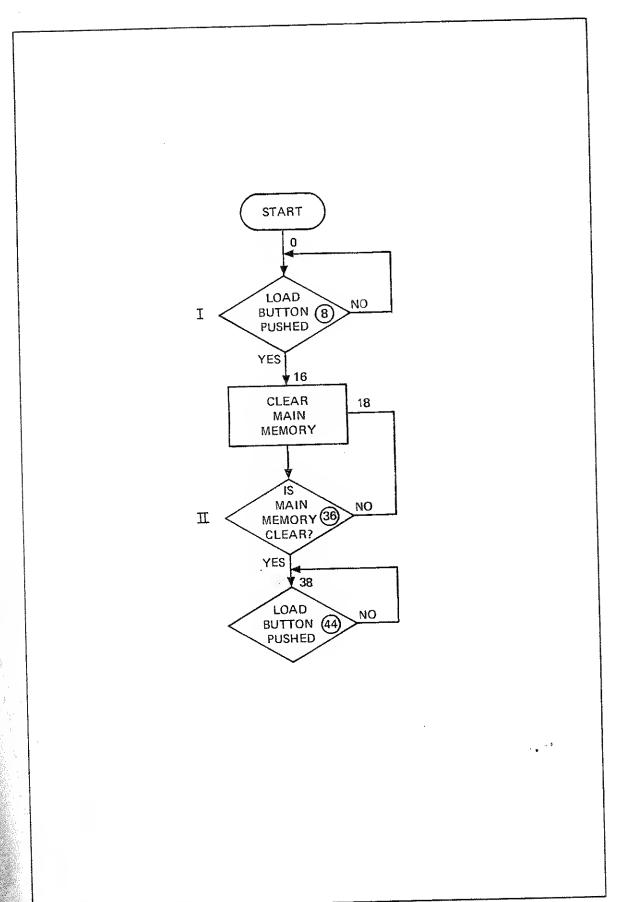
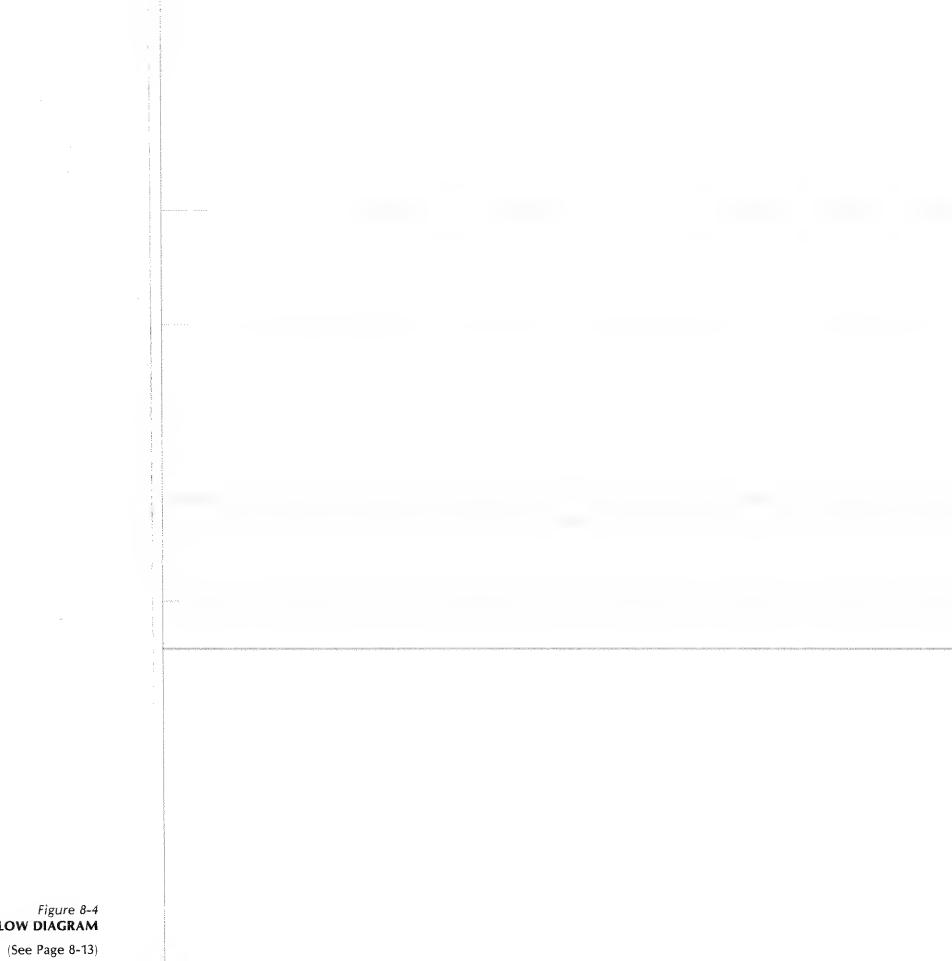
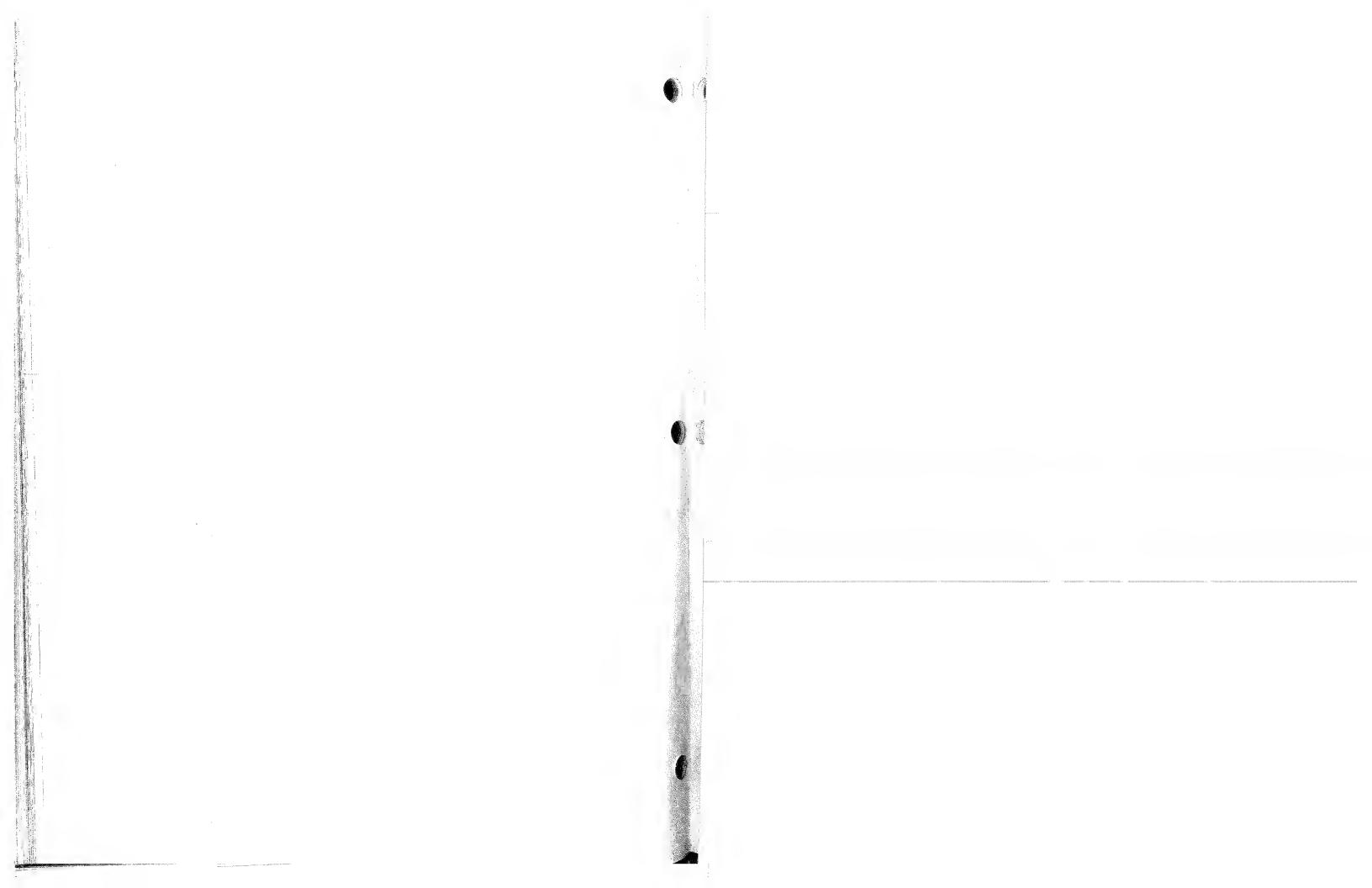


Figure 8-3. Operational Flow Diagram (First 44 Addresses)

Table 8-3. HP 1601L and HP 10250A Connections

		Table 8-3. HP 1601L and HP 10250/A Connections				
	Connect	To 5045A				
	1601L Data Inputs	Test Points				
	Data IIIpus					
	0	A8TP1				
	7	A8TP2				
	2	A8TP3				
	3	A8TP4				
	4	A8TP5				
	5	A8TP6				
	6	A8TP7				
	7	A8TP8 A8TP9				
	8 9	A8TP10				
	10	Connect to 10250A output				
	11	A9TP3 (serial data)				
	Clock	A9TP1				
	GND	Chassis				
	Connect	To 5045A				
	10250A	Test Points				
	1	A8TP11				
	2	A8TP12				
	3	A9TP6 A8TP13 (if 5045A is equipped with 05045-60030 connect to A9U2(12))				
	4 +5∨	A5TP1				
	GND	Chassis				
	Trigger switch se	ettings for 1601L and 10250A (Positive True Logic):				
	10250A:					
		ar address to be checked				
		er address to be checked				
	3 HI					
-	4 HI					
	1601L:					
	0-9 per	address to be checked				
	10 HI					
	11 OFF					
	LOGIC	— PO5				
	DISPLAY MARK — ON					
	BYTE — 3 Bit (OCT)					
		K — /				
		HOLD — TTL				
		LE MODE — REPEAT				
		SER MODE — START DISPLAY				
	DELAY 5ET — ØØØØØ					





- 6. Set the 1601L and 10250A TRIGGER switches as follows:
 - 0-9 on 1601A and 1-2 on 10250A for Address 1. (All address related switches LO except 0 on 1601L to HI.)
- 7. Display should be as shown in Figure 8-6. (See explanation of how to read the ROM listing and flow diagrams, paragraph 8-71.)
- 8. Using the flow diagram and listing determine if the flow is correct. If not, determine where it starts to deviate.

NOTE

The basic operation of the CPU is best checked using the first 8 addresses. Check that this loop is correct before proceeding further. Boards included in this basic operation are the Power Supplies, A1, A2 and A3, A4 ALU, A5 Processor Memory, A6 Main Memory, A8 PROM and A9 Address, Front Panel.

- b. Instrument operates properly until LOAD button is pressed.
 - 1. Check the power supply while the unit is inoperative after LOAD button is pressed. If the power supplies are being loaded it is an indication that the pin driver boards may be loading the power supplies. Turn the power off and remove the pin driver boards. Repeat the test without pin driver boards. The instrument will operate without the pin drivers although failure will be registered.
 - 2. Check that LOAD button data is being transfered from the A27 Front Panel board to A5U20 when the front panel transfer line is LOW as follows: sync scope of A27U11(1) (+ edge). On the first clock pulse (positive edge) after U11(1) goes high, a low should be shifted out, check that on A5U20(6) a high is also clocked out on the first clock pulse. Keep scope triggered on U11(1).
 - 3. Check that the Main Memory is cleared *prior* to data loading by triggering on the Refresh line A6U27(5). Press the LOAD button but don't load the card. Check that the outputs of U36, U26, U19, U10, U8 and U17 are low for all 256 memory locations.
 - 4. To check that the information is being loaded into the memory from the mag card, sync the scope on A6U20(3). Check that the data input at the following points A6U31(13 & 9) and check that U31 (1, 10) are alternately high. If there is no data at A6U31(9) the shift register may not be working properly.
- 5. Check that Data is also shifted out on $A6(\overline{3})$ during the load operation.
- 6. Check that data is being shifted from the memories to the parallel/serial input shift register and back to the memory. Check all 24 outputs of U36, U26, U19, U10, U8 and U17.
- 7. Check the Main Memory to insure that the program is being stored. While waiting for the TEST button to be pressed the Main Memory should be periodically refreshed. Trigger scope off the Refresh line A6U27(5). Check that there is one Clock 2 for each of the two Ø clocks.
- 8. Use 1601L to check that the ROM address is cycling through addresses 464 to 584 prior to the TEST button being pressed. If not, check the CPU flow using the flow diagram.
- 9. Check that when A6(4) goes low, A6U28(5) also goes low. (This condition indicates that the ROM program has reached the logic model execution state and the main memory is the program source.) If in refresh mode, A26U28(5) will remain high until completion of refresh cycle.

8-59. Non-sequential Troubleshooting Hints for 5045A That Fails After TEST Button is Pressed.

8-60. With A12(4) shorted to the chassis all programs should be executed with no failure (except Self Check 1). This allows checking the Main Memory Program and ROM program flow. All controls should operate properly. In AUTO START mode the PASS and TEST lights should stay on or may flash. While in MAN START mode the tester should cycle once each time the TEST button is pressed. Pressing the TEST button while the program is being executed should stop execution and the TEST button light should turn off. If not, check the A21 Front Panel board and the ROM program flow.

8-61. To check the parameter storage on the A10 board, remove A11-A24 and load the Self Check 1 Card.

a. Set front panel switches as follows:

START — MAN/HANDLR ON FAILURE — HOLD V AND I RESULTS — ON PRINTER — ON

The printout should be as follows (see page 8-17).

Maintenance and Troubleshooting

TEST: 1-1	TEST: 1-2
TEST: 1-1 FALL 1988 - 0	TEST: 1-2 FAIL (PASS 0
1 /7.5 V -15LMA	
2 -514 <-269 MA	10LMA
2 >7.5 V -15LMA	4 -519 -191HA
3 -517 <-200 MA	
3 -519 <-200 MA 3 >7.5 Y -151MA	
	Z ASTA ATRIBA
4 >7.5 V -15LMA	a STU STOLMA
	a ETV LIGIMA
5 >7.5 9 -151119	1A -FIV -181MA
	11
6 >7.5 V -15LMA 7 -5LV <-200 MA 7 >7.5 V -15LMA	to LEIU AIRINA
7 -517 (-200 119	to Sir Maria
7 >7 5 7 - 15 17	
S -5LY <-200 MA	ia siú saama
8	
1	is sla 2900 na
9 77.5 V -15LMA	18 (-7.5 V 15LNA 14 5LV 2200 MA 14 (-7.5 V 15LNA 15 5LV 2200 NA 15 5LV 2200 NA
10 -5LY <-200 MA 10 >7.5 Y15LMA	16 51V 1200 MA
10 >7.5 V -15LMA	16 K-7.5 V 15LMA
11 -5LV <-200 MA 11 >7.5 V -15LMA .	17 5LV 2200 HA
11 >7.5 V -15LMA . 12 -5LV <-200 MA 12 >7.5 V -15LMA	16 5LV 200 MA 16 (-7.5 V 15LMA 17 5LV 200 MA 17 (-7.5 V 15LMA 18 5LV 200 MA 18 5LV 200 MA 18 5LV 200 MA
12 -5L% (-200 MA	18 5LV >200 MA
12 27.5 V - 15LMA	18 (-7.5 % 151)
13 5LV 16LMA	19 5LV >200 MA 19 <-7.5 V 15LMA 20 5LV >200 MA
14 51Y 10LMA 15 5LY 10LMA	19 (-7.5 Y 15LMA
15 5LV 10LMA 16 5LV 10LMA 17 5LV 10LMA	20 SLV >200 MA
TO SEVEN TOURS	zy kaza kanalitan
18: 51.4 10LMA	21 5 k V 200 MA
19 5LV 10LMA	- 91 747 F N 15 MA
20 SLV 10LMA	22 5LV >200 MA 22 K-7.5 V 15LMA 23 5LV >200 MA 23 K-7.5 V 15LMA 24 5LV >200 MA
20 SLV 10LMA 21 SLV 10LMA	22 K-7.5 V 15LNA
21 560 1 06 0 22 560 1 060 23 560 1 060	29 51/2 200 119
23 SLV (OLMA	23 K-7.5 V 15LMA
	24 5LV >200 MA
CORRECT 111111111111	E E E E E E E E E E E E E E E E E E E
FIN	CORRECT 111111111111111111111111111111111111
STATE 1>000000000000	
FRIL PIN: 1 2 3 4 5 6 7 8	STATE 1296462646969
4 5 6 7 8 9 10 11 12	FRIL PIM: 18 14 15
P AC AA AC	16 17 18 19 20 21 22 23 24
SELF CHECK 1	
CPU RIR PRNTE OK	

8-17

- b. If overall printout is incorrect, in format and/or wording, the problem is either in the printer interface or A8 ROM.
- c. If limits are incorrect (i.e., 5LV, 10 LMA), problem is on A10 or A5, A6 boards. Check the A10 2K storage element and the output on A10(17) (serial data out to RAM). If limits are correct but non L values are incorrect then problem is in the A8 ROM (A11 and A12 must be installed and A12(4) shorted).

8-62. To check the A11 Reference Level Generator operation use V/I R-Pack Program Card. Figure 8-5 shows a typical waveform for A11TP1 triggered by A11U25(13).

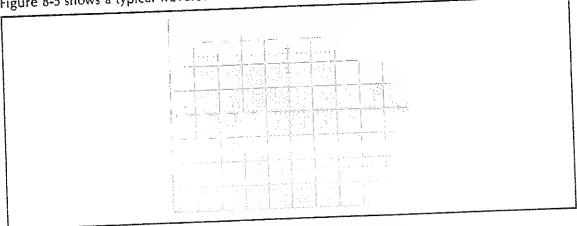


Figure 8-5. Typical Waveform for A11TP1

- a. Check that the four reference output voltages at A11(11, 12, 13, 14) agree with the programmed voltages and currents as shown in Table 8-4, and current equations described in paragraph 8-131.
- b. If the V and I printout is correct from the previous step but waveform or output voltages are incorrect, then the problem is on the A11 DAC converter or the A11 Sample and Hold circuit.

A11 Output	A13 Waveform
A11(8)	A13TP1
A11(12)	A13U24(8)
A11(13)	A13U24(4)
A11(11)	A13U18(11)
A11(14)	A13U19(11)

- c. Check that A11U25 outputs 15, 13, 12, 11, 2, 5, 4, 3 and 10 and U24 outputs 5, 7, 3, 10 are sequentially shifting a low pulse out.
- 8-63. Failure pin grouping may be used to troubleshoot as follows:
 - a. 1 or 2 adjacent pins failed means that pin driver or socket driver board is bad.
 - b. Failure of every fourth pin is seven pin groups starting with pin 1 on test socket means A12 board or one of the pin drivers in the group is bad.
 - c. If a group of four pins fail, then set 5045A front panel to:

START Auto
ON FAILURE — Continue
V/I RESULTS — OFF (down)
PRINTER — Off
Load "Self Check 2" card.

Then using an oscilloscope (this may require the use of a viewing hood) check for series of pulse at A12 U17 pins 2, 4, 6, 10, 12, 15.

8-64. Printer Problems

- 8-65. Check the symptoms listed and perform the appropriate procedure:
 - a. Paper advances but no printing.
 - 1. Check the A26 interface board group enable (paragraph 5-12).
 - 2. Check A26 character storage register clock.
 - 3. Check A26 print data register.
 - b. If printer prints but does not advance paper, check A26 paper advance circuit.
 - c. If overall printout format is incorrect but characters printed and spacing is correct, the problem is with the A8 ROM board.
 - d. If characters are not printed correctly but overall format spacing is correct, problem is on A26 board.

8-66. Card Reader Problems

- 8-67. Check the symptoms listed and perform the appropriate procedure:
 - a. LOAD button pushed and light comes on but reader motor does not come on.
 - 1. With instrument power off, remove A 26 board from its socket and turn the power on. The reader motor should come on. If not, check A 25 card reader interface and A 35 card reader assembly.
 - b. With LOAD button pushed, LOAD light on, card runs through but "RELOAD" printed.
 - 1. Check for TTL data streams at A26U19(2,3,4), A26U1(13), U19(10,11,12) (while U19(6) is low) and U1(9).
 - 2. Use head cleaner card if the operation seems intermittent (paragraph 8-26).
 - 3. If activity is correct at above points the problem is associated with the A5 processor memory board.

8-68. Troubleshooting Using Flow Diagram and ROM Listing

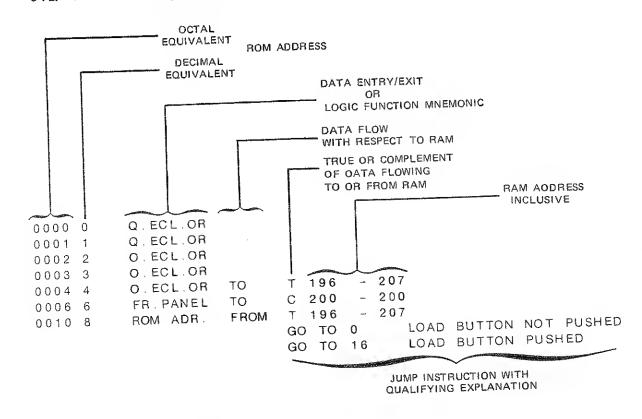
- 8-69. Troubleshooting using flow diagram (Figure 8-4) and firmware (ROM) listing (paragraph 8-149) is performed as follows:
 - a. Connect 1601L/10250A per Table 8-3.
 - b. 5et address of first decision point (i.e., address 8) and check that the instrument cycles through address 8 until the LOAD button is pressed.
 - c. Repeat step (b) using further check points designated by roman numerals on flow diagram. (Decimal numbers indicate ROM addresses.) When it is found that a check point has not been reached the previous check point should be checked and then the ROM listing used to step sequentially through the intervening program flow. Check that the program reaches each of the designated "GO TO" addresses until a deviation from normal flow is encountered. The test program may have to be reloaded several times to accomplish this isolation procedure. Turn power off then ON or momentarily ground A4(5) to regain control. Then use the normal card loading procedure to load the card.

8-19

8-70. Example of How to Interpret 1601L versus ROM Listing

8-71. Figure 8-6 shows the ROM addresses being incremented, starting at ROM address 1. Note that the address holds at address 5 for 12 clock cycles. This corresponds to the implementation of ROM Address 1-5 as shown in Figure 8-6. Figure 8-7 corresponds to the implementation of the last clock of Address 5 and address 6-9 and ending with address 0. This operation is shown in flow diagram, Figure 8-3.

8-72. The ROM Listings (paragraph 8-149) are read as follows:



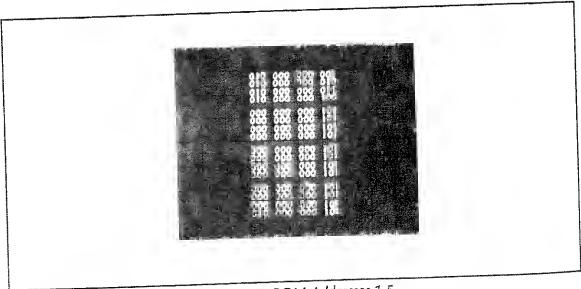


Figure 8-6. ROM Addresses 1-5

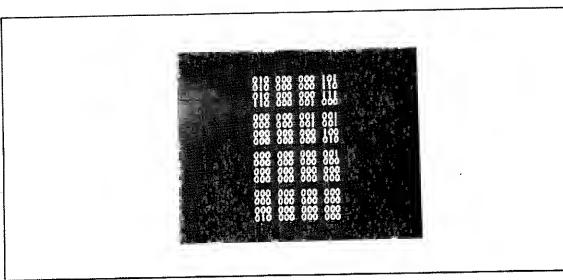


Figure 8-7. ROM Addresses 6-9

8-73. Figure 8-8 shows the implementation of ROM Address 8 and 9 when the LOAD button was pressed.

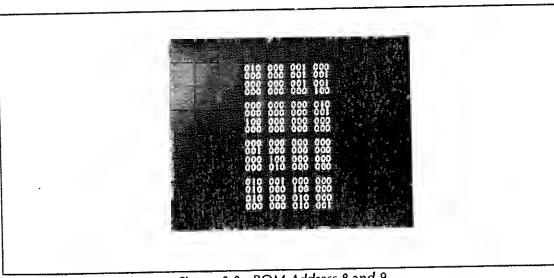


Figure 8-8. ROM Address 8 and 9

8-74. Note that in all cases the leftmost bit displayed is the serial data being transmitted to or from the RAM.

NOTE

Momentarily shorting A9(6) should cause the reset on pin 5 of A4, A5, A6, A8 and A9 to go low for approximately 3 seconds. Check that this resets the RAM and ROM address registers on the A5 and A9 boards to Ø. This can also be used to reset the ROM program if it jumps the loop. The logic element used is the quad exclusive OR (op code 038) on the A4 board. This should be checked to insure that it is decoded at the ALU as 11₈ at U8 S₀₋₃. Check that data transfered from the front panel is high until the LOAD button is pushed and then one low bit is transfered via A5U20.

8-21

8-75. ROM Contents Allocation

8-76. Content allocation for the ROM and PROM boards is described in the following paragraphs:

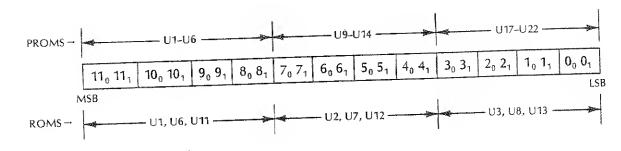
a. PROM boards (05045-60030) are sectioned as follows:

Address	IC No.
0-511	U1,9,17
S12-1023	U2, 10,1 8
1024-1535	U3,11,19
1536-2047	U4,12,20
2048-2559	∪5,13,21
2560-3071	∪6,14,22

b. ROM boards (05045-60008) are sectioned as follows:

Address	IC No.
0-1023	U1, 6, 1 1
1024-2047	U2, 7, 12
2048-3071	U3, 8, 13

c. Within each group of 3 PROMs or ROMs the bits are allocated as follows:



8-77. SELF CHECK TROUBLESHOOTING PROCEDURES

8-78. The operating procedures for performing the Self Check are described in Section III. the following paragraphs provide troubleshooting procedures to use when a failure occurs during the Self Check. The three-part Self Check (Self Check 1, 2 and 3) is described for both the standard 5045A (up to 16-pin ICs) and for Option 024 (up to 24-pin ICs).

8-79. Self Check 1 (Standard 5045A)

8-80. Self Check 1 (16 Program) has four tests which verify the ability to detect and register a failure on each of the pins.

- a. Test 1-1: Checks pins 9-16 in the '1' state.
- b. Test 1-2: Checks pins 1-8 in the '0' state.
- c. Test 1-3: Checks pins 1-8 in the '1' state.
- d. Test 1-4: Checks pins 9-16 in the '0' state.

8-81. If the failure detect circuitry is operating properly, the tester should register a pass each time, the four tests are performed, and the data is being set properly.

- 8-82. The program requires that the 16 pin Dummy IC (05045-80019) be installed in the 20 pin test socket. In the case of a handler, the IC should be in the handler test socket.
- 8-83. The switch settings recommended for running the Self Check 1 program are:

AUTO/MAN/HANDLR — Either position ON FAILURE — HOLD V AND I — Off (down) PRINTER — ON

8-84. TROUBLESHOOTING. When a failure is printed, the two interconnected pins may both be printed as failed pins. The failure may be on either of the two pin driver boards and therefore further tests should be run to isolate the failed pin.

8-85. The general procedure for isolating a failure is listed below:

CAUTION

Turn off power before removing or installing printed-circuit boards. The A11 DAC and A13 thru A24 pin driver boards contain CMOS circuits which are highly susceptible to static discharge damage. Handle these boards only by the large black heat sink or the board extractor.

- a. Interchange the pin driver boards associated with the failed pin with a pin driver board that did not register a failure, one board at a time. Rerun the program and see if the failure is registered on the same pin or has moved to the pin where the suspect board was moved to. If the failure has moved, then the problem is associated with the moved board and the troubles hooting procedure in paragraph 8-118 should be used.
- b. If the failure has not moved, then the fault may be associated with the driver interconnected to the failed pin, the fast edge circuitry, or the control circuitry on A10, A11, or A12.
- c. Interchanging boards should be used where possible to isolate the failure. This can be done on the pin driver and socket driver boards.
- d. Where more than one group of pins is registered as failed and the grouping is every fourth pin (i.e., 1,5,9, etc.) the failure is probably associated with the failure detect circuitry on the A12 board or one of the pin driver boards listed as failed.

8-98. TROUBLESHOOTING. The tests in this program complements the tests in Self Check 2 and they are configured in such a way that they exercise the overall pin driver section of the tester in all modes. This program or the programs listed in paragraph 4-12 may be used to isolate the failure to the board and component. See paragraph 8-92 for a general procedure to isolate a failure.

8-99. Self Check 1 (Option 024)

8-100. Self Check 1 (24 Program) has four tests which verify the ability to detect and register a failure on each of the pins.

- a. Test 1-1: Checks pins 13-24 in the '1' state.
- b. Test 1-2: Checks pins 1-12 in the '0' state.
- c. Test 1-3: Checks pins 1-12 in the '1' state.
- d. Test 1-4: Checks pins 13-24 in the '0' state.

8-101. If the failure detect circuitry is operating properly, the tester should register a pass each time the four tests are performed.

8-102. The program requires that the 24-pin dummy IC (05045-80020) be installed in the 24-pin test socket. In the case of a handler, the IC should be installed in the handler test socket. The switch setting recommended for running the Self Check 1 program are:

AUTO — MAN/HNDLR — Either position ON FAILURE — HOLD V AND I — Off (down) PRINTER — ON

8-103. TROUBLESHOOTING. When a failure is printed, the two interconnected pins may both be printed as failed pins. The failure may be on either of the two pin driver boards and therefore further tests should be run to isolate the failed pin.

8-104. The general procedure for isolating a failure is listed below:

- a. Interchange the pin driver boards associated with the failed pin with a pin driver board that did not register a failure, one board at a time. Rerun the program and see if the failure is registered on the same pin or if it has moved to the pin where the suspect board was moved to. If the failure has moved, then the problem is associated with the moved board and the troubleshooting procedure in paragraph 8-118 should be used.
- b. If the failure has not moved, then the fault may be associated with the driver interconnected to the failed pin, the fast edge circuitry, or the control circuitry on A10, A11 or A12.
- c. Interchanging boards should be used where possible to isolate the failure. This can be done on the pin driver and socket driver boards.
- d. Where more than 1 group of pins is registered as failed and the grouping is every fourth pin (i.e., 1,5,9, etc.), the failure is probably associated with the failure detect circuitry on the A12 board or one of the pin driver boards listed as failed.

8-105. Self Check 2 (Option 024)

8-106. Self Check 2 (pin drivers 24 program) contains ten tests that test the overall operation of the pin driver boards, the reference generator, the sample and hold circuits, and related circuitry.

- 8-107. A description of each test is as follows:
 - a. Test 2-1: Checks all pin drivers at the maximum voltages (7.5V) and at the crossover point on the low current range (250 μ A). Pins 13-24 monitor and load pins 1-12. '0' and '1' states are exercised.
 - b. Test 2-2: Checks all pin drivers at maximum voltages (7.5V) and at the crossover point on the low current range. Pins 1-12 monitor and load pins 13-24. '0' and '1' states are exercised.
 - c. Test 2-3: Checks all pin drivers at the voltage crossover point (1.875V) and at the crossover point between Hi and Lo current ranges (2.5 mA). Pins 13-24 monitor and load pins 1-12. '0' and '1' states are exercised.
 - d. Test 2-4: Checks all pin drivers at the voltage crossover point (1.875V) and at the crossover point betwene Hi and Lo current ranges (2.5 mA). Pins 1-12 monitor and load pins 13-24. '0' and '1' states are exercised.
 - e. Test 2-5: Checks continuous current control on pin drivers 13-24. Pins 1-12 monitor pins 13-24. '0' and '1' states are exercised.
 - f. Test 2-6: Checks continuous current control on pin drivers 1-12. Pins 13-24 monitor pins 1-12. '0' and '1' states are exercised.
 - g. Test 2-7: Checks all pin drivers at the maximum voltage (7.5V) and maximum current (200 mA). Pins 13-24 monitor and load pins 1-12. Each pin combination (e.g., 1 and 24) is separately checked.
 - h. Test 2-8: Checks all pin drivers at the maximum voltage (7.5V) and maximum current (200 mA). Pins 1012 monitor and load pins 13-24. Each pin combination (e.g., 1 and 24) is separately checked.
 - i. Test 2-9: Checks all pin drivers at the maximum voltage (7.5V) and low current (20 μ A). Pins 1-12 monitor and load pins 13-24. '0' and '1' states are exercised.
 - j. Test 2-10: Checks all pin drivers at the maximum voltage (7.5V) and low current (20μ A). Pins 13-24 monitor and load pins 1-12. '0' and '1' states are exercised.
- 8-108. When the pin driver circuitry is operating properly, the tester should cycle and register a pass each time the ten tests are performed.
- 8-109. The test program requires the 24-pin dummy IC (05045-80020) to be installed in the test socket (in the case of a handler, the IC should be installed in the handler test socket).
- 8-110. TROUBLESHOOTING. The tests in this program are configured in such a way that they exercise the overall pin driver section of the tester in all modes. This program or the programs listed in paragraph 4-12 may be used to isolate the failure to the board and component.
- 8-111. The general procedure for isolating a failure is listed below:
 - a. Interchange the pin driver board associated with the failed pin with a pin driver board that did not register a failure. Rerun the program and see if the failure is registered on the same pin or if it has moved to the pin to where the suspect board was moved.
 - b. If the failure has moved then the problem is associated with the moved board and the troubleshooting procedure in paragraph 8-118 should be used.
 - c. If the failure has not moved then the faulty circuit may be associated with the driver interconnected to the failed pin driver, the fast edge circuitry or the control circuitry on A10, A11 or A12. Interchanging boards should be used where possible to isolate the failure. This can be done on the pin driver and socket driver boards.

8-126. For all tests in both the V/I R-Pack and the R-Pack C-Current Modes program, the odd and even pins for any pin driver board are set up with the same parameters. Comparison trouble-shooting may be done with these programs.

8-127. Failing pins should be isolated by running the R-Pack Tests described in paragraph 4-16. Also, with the R-Pack removed from the test socket, actual programmed voltages and currents may be measured by probing the test points on the Test Head. Scopes, DVMs or other test equipment must be grounded to A30 TP25. The tolerances for voltages and currents when measured with the DVM is listed in Table 8-4.

Table 8-4. Tolerances for R-Pack Parameters

V/I R-Pack		R-Pack C-Current Modes	
Test 1	7V +/- 25 mV 7 mA +/42 mA	Test 1	7V +/- 25 mV 7 mA +/- 1.12 mA
Test 2	1V +/- 15 mV 1 mA +/06 mA	Test 2	1V +/- 15 mV 1 mA +/18 mA
Test 3	-7V +/- 25 mV -7 mA +/42 mA	Test 3	-7V +/- 25 mV -7 mA +/- 1.12 mA
Test 4	-1V +/- 15 mV -1 mA +/06 mA	Test 4	-1V +/- 15 mA -1 mA +/18 mA

Measurements made on A30 test points with DVM.

8-128. Current Source Troubleshooting

NOTE

All circuits on the pin driver boards are suspectible to loading and therefore high input impedance ($10\,\mathrm{M}\Omega$) oscilloscopes and DVMs should be used to monitor this circuitry. A large portion of the circuitry on the pin driver boards is CMOS with very high input impedances and low output driver currents. The operational amplifiers are also high input impedance devices.

Leads which are strobed onto pin driver boards via bilateral switches should be measured using an oscilloscope unless otherwise specified. These levels should be measured during valid strobe in intervals only. Bilateral switches turn on when U20 pin 3 is high for odd pins and when U20 pin 11 is high for even pins. The high state is approximately +8V.

8-129. The correct (+) op amp voltage for current sources may be calculated by using the formulas below.

Positive Current Sources (+) inputs Odd U13(16) Even U3(6) Negative Current Sources (+) inputs Odd U11(6)

Even U1(6)

8-130. Each current source has a high and low range. For each test, refer to Table 8-5 for this information.

8-131. Calculation of (+) op amp voltage.

I is programmed level in mA.

+I Hi Range V(+) = 15 - .025I

-I Lo Range V(+) = 15 - 2.025I)

-I Hi Range V(+) = -[15 - .025I]

-I Lo Range V(+) = -|15 - 2.025I|

Note: |a| = absolute value of "a".

(see Figure 8-9)

Example:

A programmed current level of +7 mA is set up. 7 mA is in the Hi range; therefore the +I Hi Range equation is used.

The expected (+) op amp voltage is then:

$$15 - .025 \times 7 = 14.83V$$

8-132. When the current source is operating properly the (-) op amp voltage (pin 2) should be within 20 mV of the (+) input (pin 3). The output of the op amp (pin 6) should be approximately two diode drops above or below the (+) input depending on the polarity of the current source.

8-133. When troubleshooting a current source, also check the following:

- a. Make sure that only 1 of the 3 gates in the current source is ON. The "A" gates are for the low current range and the "B" gates are for the high range. For positive current sources, the "ON" gates output voltage is within a few millivolts of the Vss pin (pin 7). The other two gate outputs should be near +18V. For negative current sources, the "ON" gate's output voltage is within a few millivolts of the VDD pin (pin 14). The two other negative current source gates should have outputs near -18V.
- b. The continuous current bit is set high or low depending on the programmed mode. When continuous current is specified, a current source will produce current independent of the logic state. These levels should be measured with an oscilloscope only. The levels are strobed onto the pin driver boards via bilateral switches. Bilateral switches turn on when U20 pin 3 is in the high state (approximately 8V) for odd pins and U20 pin 11 for even pins. Measure the continuous bit voltage level during the valid strobe period. The expected logic states for the Resistor Pack programs are listed in Table 8-5.

+ Continuous 1 U23(2) Odd Pins U23(3) Even Pins

-Continuous I U23(10) Odd Pins

U23(9) Even Pins

Logic H Level 2.5 to 5V (approx.) Logic L Level -2.5 to -5V (approx.)

c. The logic state for a pin is determined by the "Odd Pin Test Pattern Setup" or the "Even Pin Test Pattern Setup" control lines.

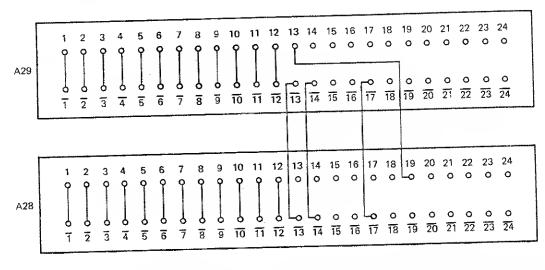
The logic levels should be measured on U22(12) for odd pins and U22(2) for even pins. Refer to Table 8-5 for expected levels.

Logic H Level +8V (approx.)
Logic L Level -8V (approx.)

- d. Turn on the 5045A and load Self Check 2. Do not use dummy IC.
- e. The PASS light should flash at a consistent rate. This indicates that the processor and memory are functioning correctly.
- f. If the FAIL light flashes then the processor or memory and associated control has a malfunction. Refer to processor troubleshooting paragraph 8-57.
- g. If the pass light flashes then one of the pindriver boards is bad.
- h. Turn the power off, Set "START" to "MAN/HANDLR."
- i. Insert one pindriver board and load Self Check 3. DO NOT USE THE DUMMY IC. Press TEST. Pass light should illuminate. Verify front panel operation by pressing TEST several times and then try to reload the card. If these front panel controls function correctly then turn off the 5045A and insert another pindriver board. Again verify correct operation. Continue this procedure until the bad board is found. When the bad pindriver is isolated, remove all of the others. Remove the ground jumper from A12 and troubleshoot the bad board by using the Current Source Troubleshooting procedure.

8-145. Troubleshooting the Fast Edge (Socket Driver) Circuitry

8-146. Positive and negative fast edge magnetic card program (05045-18009) and the procedure listed in paragraph 5-9 should be used to check each circuit.



8-147. To gain access to the failed board use above procedure and isolate the failed pin. Interchange the boards if necessary to place the failed board in the A29 position (upper board). Remove the A30 Socket board and the A31 Interconnect board. Connect the A28 and 29 boards together using two 24-pin connectors wired as follows:

- 8-148. Checks to be performed on the failed board using the fast edge program cards:
 - a. Check that data is shifted into circuits U7 and U8.
 - b. The control and generation of information to the fast edge circuitry is controlled by the A12 Pin Driver Control U1-U3, U6-U9. Information designating which pin drivers are driving inputs and which are monitoring outputs is contained in U2. This information is ANDed with the next logic state information in U3D. This information is fed to the A28 and A29 socket driver (fast edge) boards via U3(11) and connector J6. This data is fed in parallel to both boards. Data is clocked onto the A28 board using the output of U3(8) via connector J4 and to the A29 board using the U3(6) via connector J5 output.

- c. Check that the data is transfered from U7 and U8 to U4 and U5.
- d. The transfer from A 28/A 29 U7 and U8 to U4 and U5 is controlled by the signal generated at U3(3) and output via connector J5.
- e. Check that the transistors are turned on for at least 3 μ s.
- f. Check that the '1' state storage capacitor for each fast edge circuit is charged to the '1' state level while the test socket pin is in the '0' state and the '0' state storage capacitor is charged to the '0' state level while the test socket pin is in the '1' state. These capacitors are charged from the voltage source on the corresponding pin driver circuit.

8-149. A8 ROM LISTINGS

8-150. The ROM listing in connection with the ROM flow chart and an HP 1601 Logic State Analyzer can be used to verify the information flow in the instrument.

```
-(0-8) INITIAL
         -WAIT FOR LOAD BUTTON TO BE PRESSED
0000 0
        O, ECL, OR
        Q,ECL.OR
0001 1
0002 2 O.ECL.OR
0003 3
       O, ECL, OR
       O.ECL.OR TO
                      T 196 - 207
0004 4
                      C 200 - 200
        FR. PANEL TO
0006 6
        ROM ADR. FROM T 196 - 207
0010 8
                       GO TO 0 LOAD BUTTON NOT PUSHED
                       GO TO 16 LOAD BUTTON PUSHED
         -(16-36) CLEAR MM
         -LOOP 255 TIMES
0020 16 O.ECL.OR TO T 187 ~ 199
0022 18 A-ONE
                 FROM C 187 - 190
                 TO C 187 - 190
                                   , C 195
0024 20 A-ONE
                 FROM C 191 - 195
0027 23 A-ONE
                 TO C 191 - 194 ,C 198
0031 25 A-ONE
0034 28 COPY
                 FROM C 198 - 198 , T 198
                 TO T 200 - 225 ,C 197
0037 31 COPY
0042 34 M.MEM.
                 FROM T 202 - 225
0044 36 ROM ADR. FROM T 196 - 207
                       GO TO 18 MAIN MEM CLEAR LOOP LESS THAN 255
                       GO TO 38 MAIN MEM CLEAR LOOP FINISHED
         -(38-44) WAIT FOR LOAD BUTTON
        FR PANEL TO
                     C 199 - 199
0046 38
                      T 33 - 60 , C 56 , T 2
0050 40
        O.ECL.OR TO
        ROM ADR. FROM T 196 - 207
0054 44
                       GO TO 38 LOAD BUTTON NOT PUSHED
                       GO TO 46 LOAD BUTTON PUSHED
        ROM ADR. TO
                      T 499 - 510 , STORE ROM ADR: 47
0056 46
        ROM ADR. FROM T 49 - 60
0060 48
                       GO TO 128 RTN 50 GO TO MAG CARD SUB
         -(50-90) INITIAL D/A SET UP
0062 50 CONSTANT TO T 285 - 286
         ( 33 ) TO T 287 - 294
         ( 30 ) TO T 295 - 302
         ( 277 ) TO T 303 - 310
         ( 11 ) TO T 311 - 318
         ( 200 ) TO T 319 - 326
         ( 4 ) TO T.327 - 334
         ( 10 ) TO T 335 - 342
         ( 0 ) TO T 343 - 350
0074 60 A-ONE
               TO T 404 - 408 , T 404
0077 63 O.ECL.OR TO
                      T 212 - 223 ,C 221
0102 66 DECODER TO
                      T 375 - 391
0104 68 ROM ADR. TO
                      T 499 - 510 , STORE ROM ADR: 69
                FROM T 380 - 391
0106 70 ROM ADR.
                       GO TO 2048 RTN 72 GO TO D/A IN/OUT SUB
                TO
                      T 302 - 311 ,C 289 ,T 329
0110 72 DECODER
                      T 499 - 510 , STORE ROM ADR: 77
       ROM ADR. TO
0114 76
0116 78 ROM ADR. FROM T 315 - 326
                       GO TO 2048 RTN 80 GO TO D/A IN OUT SUB
```

```
0120 80 A-ONE
                  FROM C 289 - 289
0122 82 A-ONE
                  TO C 289 - 289 ,T 294
0125 85 A-ONE
                  FROM C 290 - 294
0127 87 A-ONE
                  TO C 290 - 293 ,C 300
0132 90 ROM ADR. FROM T 296 - 307
                       GO TO 76 PIN SET-UP NOT FINISHED
                       GO TO 92 FINISHED '0' ING PIN SET-UP
         -(94-100) CHECK SUM COMPARE 4LSB
0134 92 M.M. ADV FROM T 343 - 350
         COPY FROM T 128 - 131
0136 94
0140 98
         COPY
                  TO T 94 - 98
         COMPARE FROM T 94 - 102
0142 98
0144 100 COMPARE TO T 94 - 94
0148 102 COPY FROM T 132 - 135
0150 104 COPY
               TO T 98 - 102
0152 106 CONSTANT TO T 382 - 383
        ( 50 ) TO T 384 - 391
         ( 2 ) TO T 392 - 399
         ( 164 ) TO T 400 - 407
         ( 100 ) TO T 408 - 415
         ( 11 ) TO T 416 - 423
         ( 0 ) TO T 424 - 431
        ( 245 ) TO T 432 - 439
         ( 44 ) TO T 440 - 447
         ( 142 ) TO T 448 - 455
        ( 1 ) TO T 456 - 463
        ( 22 ) TO T 464 - 471
        ( 2 ) TO T 472 - 479
        ( 200 ) TO T 480 - 487
        ( 167 ) TO T 488 - 495
        ( 140 ) TO T 496 - 503
        ( 12 ) TO T 504 - 511
0174 124 M.MEM. FROM T 28 - 51
0176 126 ROM ADR. FROM T 464 - 475
                   GO TO 530 RTN 336 GO TO TITLE SEARCH SUB IN MM
         -(128-335) CARD READER SUBROUTINE
0200 128 O.ECL.OR TO T 96 - 122
0202 130 O.ECL.OR TO T 128 - 156
0204 132 COPY
                FROM T 500 - 509
0206 134 COPY
                 TO C 214 - 243
0210 136 ROM ADR. TO T 499 - 510 ,STORE ROM ADR: 137
0212 138 A-ONE TO C 499 - 503
0214 140 DECODER TO T 3 - 32 ,C 18 ,C 19
0220 144 EXT.CONT FROM T 2 - 9
0222 146 EXT. CONT TO C 502 - 502
        -WAIT FOR CARD IN
0224 148 CARD RDR FROM C 4 - 7
0226 150 ROM ADR. FROM T 499 - 510
                     GO TO 144 CARD NOT IN
                      GO TO 152 CARD IN
        -(152-166) SET UP FOR TIME DELAY
        -16MS DELAY
0230 152 O ECL.OR TO C 26 - 28
0232 154 ROM ADR. FROM T 9 - 20
                     GO TO 1536 RTN 156 8 MSEC DELAY
```

```
FROM C 2 - 2
                     C 504 - 506 ,T 507 ,T 500 ,T 503
0234 156 A-ONE
                TO
0236 158 A-ONE
T 505 ,T 501 ,T 511
0246 166 ROM ADR. FROM T 9 - 20
                      GO TO 1536 RTN 174 DO 8 MSEC DELAY THEN READ
                                        CARD SUB
                                     268 RTN TO WRITE CARD SUB
0250 168 CARD RDR TO T 95 - 98
0252 170 ROM ADR. FROM T 21 - 32
                      GO TO 224 RTN 172 24 BIT WORD FROM CRD RDR
                                         COMPLETE
                                      174 24 BIT WORD FROM CRD RDR
                                         NOT COMPLETE
        -(174) READ CARD SUBROUTINE
                FROM T 99 - 122
0254 172 M.MEM.
0256 174 CARD RDR FROM C 4 - 7
                     T 500 - 501
0260 176 O.ECL.OR TO
0262 178 EXT. CONT TO C 504 - 505
0264 180 OUAD OR FROM C 504 - 505 ,C 504 ,C 505 ,C 504
                      C 502 - 502 ,T 503 ,T 505
0271 185 OUAD OR TO
         -WAIT FOR MFL
0275 189 ROM ADR. FROM T 499 - 510
                       GO TO 176 NO CLOCK
                       GO TO 168 CARD AND CLOCK
                       GO TO 208 END OF CARD
                      T 501 - 501
 0300 192 EXT.CONT TO
0302 194 ROM ADR. FROM T 499 - 510
                       GO TO 192 CARD NOT IN
                       GO TO 196 CARD IN
 0304 196 M.M. ADV FROM T 9 - 16
                  FROM T 154 - 154
 0306 198 COPY
                      Т 90 - 90
 0310 202 ROM ADR. TO T 499 - 510 ,STORE ROM ADR: 203
 0314 204 ROM ADR. FROM T 9 - 20
                       GO TO 1536 RTN 206 DO 8 MSEC DELAY
 0316 206 ROM ADR. FROM T 9 - 20
                       GO TO 1536 RTN 210 DO 8 MSEC DELAY
 0320 208 NOP
 0321 209 NOP
                  FROM C 214 - 223
 0322 210 COPY
                  TO T 500 - 510
 0324 212 COPY
                  FROM C 90 - 90
 0326 214 A-ONE
                  TO T 233 - 233 ,C 231 ,C 226
 0334 220 EXT.CONT FROM T 9 - 16
 0330 216 A-ONE
 0336 222 ROM ADR. FROM T 224 - 235
                       GO TO 132 NO END CODE FOUND
```

GO TO 512 END CODE FOUND

```
-(224-235) CALCULATE CHECK SUM
        -(237-239 + 258-264) CHECK FOR END CODE
                FROM T 128 - 131 , T 511 , T 120 , T 121
0340 224 A+B
T 122
                 TO T 128 - 131 ,T 136
0346 230 A+B
                 FROM T 132 - 136
0351 233 A+B
                 TO T 132 - 135
0353 235 A+B
                 FROM C 120 - 122
0355 237 OR
                 TO C 140 - 140
0357 239 OR
0361 241 COPY
                 FROM T 110 - 119
                 TO T 113 - 122
0363 243 COPY
0365 245 COPY
                 FROM T 100 - 109
                 TO T 103 - 112
0367 247 COPY
                 FROM T 96 - 99
0371 249 CDPY
0373 251 COPY
                 TO T 99 - 102
0375 253 A-ONE
                 FROM C 137 - 139
0377 255 A-ONE
                 TO C 137 - 139 ,C 500
                 FROM T 140 - 149
0402 258 COPY
0404 260 COPY
                 TO T 141 - 150
        -CHECK IF 1 IN S.R. - END CODE FOUND
                 FROM C 141 - 148
0406 262 OR
                 TO C 90 - 90
0410 264 OR
0412 266 ROM ADR. FROM T 224 - 235
                      GO TO 512
        -(268-335) WRITE SUBROUTINE
0414 268 CARD RDR FROM C 4 - 7
0416 270 ROM ADR. FROM T 9 - 20
                       GO TO 1536 DO 8 MSEC DELAY RTN 272
0420 272 M.MEM.
                 TO T 99 - 122
0422 274 ROM ADR.
                 FROM T 9 - 20
                       GO TO 1536 DO 8 MSEC DELAY RTN 276
0424 276 CARD RDR FROM C 4 - 7
0426 278 CARD RDR FROM T 120 - 123
                      T 236 - 243 ,C 240 ,C 240
                 TO
0430 280 O.ECL.OR
                      T 499 - 510 , STORE ROM ADR: 285
0434 284 ROM ADR.
                 TO
                 FROM T 9 - 20
0436 286 ROM ADR.
                       GO TO 1536 DO 8 MSEC DELAY RTN 288
0440 288 CARD RDR FROM T 120 - 123
0442 290 ROM ADR. FROM T 21 - 32
                       GO TO 224 RTN 292 GET NEW WORD FROM MAIN MEM
                                        IF FINISHED OLD WORD
                                     294 STILL PROCESSING OLD WORD
0444 292 M.MEM.
                 TO
                      T 99 - 122
0446 294 OUAD OR FROM T 500 - 500 ,C 90 ,C 500
0452 298 OUAD OR
                 TO
                      T 502 - 502 ,T 155
0455 301 Q.ECL.OR TO
                      T 238 - 243
0457 303 O.ECL.OR TO
                      T 500 - 501
0482 306 ROM ADR. FROM T 9 - 20
                       GO TO 1536 RTN 308 HAVE END CODE
```

316 NO END CODE

```
0742 482 EXT.CONT FROM C 492 - 499
0744 484 A-ONE FROM C 192 - 192
                 TO C 456 - 456 , C 464
0746 486 A-ONE
0751 489 ROM ADR. FROM T 455 - 466
                       GO TO 530 RTN 492 TEST BUTTON PRESSED
                                     494 WRITE BUTTON PRESSED
                       GO TO 16 LOAD BUTTON PRESSED
0754 492 ROM ADR. FROM 'T 461 - 472
                       GO TO 1352 GO TO TEST PROG PREPERATION SUB
0756 494 O.ECL.OR TO T 467 - 484
0760 496 ROM ADR. FROM T 455 - 466
                       GO TO 530 RTN 498 LOOK FOR TITLE CODE FFFBEF
0762 498 DECODER FROM T 193 - 193
0764 500 DECODER TO C 219 - 219 ,C 221 ,C 2 ,T 204
0771 505 M.M. ADV FROM T 464 - 471
0773 507 A-ONE
                 TO T 499 - 504 , T 500
0776 510 ROM ADR. FROM T 212 - 223
                       GO TO 512 RTN SUB
                       GO TO 128 RTN 464 WRITE MAG CARD SUB
        -(512-528) RETURN SUBROUTINE
1000 512 A-ONE
               FROM C 501 - 502
1002 514 A-ONE
                 TO C 501 - 502 , T 511
1005 517 A÷B
                 FROM T 503 - 506 , T 511
1010 520 A+B
                 TO T 503 - 506 , T 511
1013 523 A+B
                 FROM T 507 - 511
                 TO T 507 - 511 , T 499
1015 525 A+B
1020 528 ROM ADR. FROM T 499 - 510
                      GO TO RETURN ADDRESS
        -(530-584) TITLE SEARCH SUBROUTINE
1022 530 O.EGL.OR TO T 212 - 223 ,C 221 ,C 485
1026 534 M.MEM.
                 TO T 256 - 279
1030 536 COMPARE FROM T 256 - 259 ,T 511 ,T 487 ,T 488
T 489 T 490
1037 543 COMPARE TO T 280 - 280
1041 545 COMPARE FROM T 260 - 263 T 511 T 491 T 492
T 493 T 494
1050 552 COMPARE
                 TO T 263 - 263
1052 554 OR
                 FROM C 271 - 277
1054 556 OR
                 TO C 266 - 266
                 FROM C 263 - 270
1056 558 OR
1060 560 OR
                 TO C 277 - 277
                 FROM C 477 - 480 , T 485
1062 562 A-ONE
                 TO C 477 - 480 ,C 485
1065 565 A-ONE
                 FROM C 481 - 485
1070 568 A-ONE
1072 570 A-ONE
                 TO C 481 - 485
1074 572 OR
                 FROM C 277 - 280
1076 574 OR
                 TO C 486 - 486
                 FROM T 485 - 486 ,T 485 ,T 486
1100 576 OUAD OR
1104 580 OUAD OR
                 TO
                      C 215 - 216
1106 582 M.MEM.
                      T 256 - 279
                 TO
1110 584 ROM ADR, FROM T 212 - 223
                      GO TO 536 TITLE CODE NOT FOUND
                      GO TO 512 TITLE CODE FOUND, GOTO RTN ADDRESS
                                 OR LOOPED 256 TIMES
```

```
-BLANK LOADER FOR PRINTER SUBROUTINE
1112 586 O.ECL.OR TO T 212 - 223
1114 588 Q.ECL.OR TO C 217 - 218 ,C 215 ,C 222
1120 592 CONSTANT TO T 228 - 229
         ( 40 ) TO T 230 - 237
         ( 10 ) TO T 238 - 245
         ( 202 ) TO T 246 - 253
         ( 40 ) TO T 254 - 261
               ) TO T 262 - 269
         ( 10
              ) TO T 270 - 277
         ( 202
               ) TO T 278 - 285
         ( 40
               ) TO T 286 - 293
         ( 10
              ) TO T 294 - 301
         ( 202
         (40 ) TO T 302 - 309
         ( 10
               ) TO T 310 - 317
         ( 202 ) TO T 318 - 325
         ( 40 ) TO T 326 - 333
         ( 10 ) TO T 334 - 341
         ( 202 ) TO T 342 - 349
1141609 ROM ADR. FROM T 212 - 223
                       GO TO 1128 IF STARTED 586
                       GO TO RETURN ADDRESS IF STARTED 592
         -(612-744) REFERENCE GENERATOR
         -SET UP SUBROUTINE
1144 612 M.MEM.
               TO T 280 - 303
1146 614 A-ONE
                TO T 438 - 443
                TO T 410 - 433
1150 616 M.MEM.
1152 618 COPY
                 FROM C 266 - 267 , C 416 , C 290 , T 291
1157 623 COPY
                 TO C 404 - 431 , T 286 , T 267 , T 290
.C 291
1165 629 CONSTANT TO T 500 - 501
         ( 116 ) TO T 502 - 509
1170 632 COPY
                  FROM T 303 - 303
1172 634 COPY
                  TO T 491 - 493 ,T 489 ,C 494
1176 638 ROM ADR. FROM T 487 - 498
                       GO TO 640 NEED TO DO '1' COMPLEMENT OF SETUP
                       GO TO 656 '1' COMPLEMENT NOT NEEDED
1200 640 A-ONE
                 FROM T 293 ~ 294
1202 642 A-ONE
                 TO C 293 - 294 ,T 350
1205 645 A-ONE
                  FROM T 295 - 298 ,C 350
                 TO C 295 - 298 ,T 350
1210 648 A-ONE
1213 651 A-ONE
                 FROM T 299 - 302 ,T 350
1216 654 A-ONE
                 TO C 299 - 303
1220 656 A-ONE
                  FROM T 427 - 428
1222 658 A-ONE
                 TO T 427 - 438
1224 660 COPY
                  FROM T 303 - 303 , T 302 , T 301 , T 300
T 299
T 298 T 297 T 296 T 295 T 294
1237 671 COPY
               TO T 296 - 305
1241 673 COPY
                 FROM T 293 ~ 293 ,T 292
1244 676 COPY
                 TO T 306 - 307
                 FROM C 431 - 431
1246 678 A-ONE
                 TO C 501 - 502 ,T 503 ,T 505 ,T 508
1250 680 A-ONE
, C 501
1256 686 ROM ADR, FROM T 432 - 443
                       GO TO 896 RTN 632 DATA RFG FROM MM TO D/A NOT
                                         FINISHED
                                  688 DATA RFG FINISHED
```

```
1260 688 M.M. ADV FROM T 212 - 219
                 TO T 232 - 255
1262 690 M.MEM.
                      T 375 - 391
1264 692 DECODER
                 TO
                 TO T 256 - 279
1266 694 M.MEM.
                 FROM C 232 - 239
1270 696 COPY
                 TO T 288 - 295 , T 287
1272 698 COPY
                 FROM C 236 - 237
1275 701 OR
1277 703 OR
                 TO T 494 - 494
1301 705 A-ONE
                 FROM C 494 - 494
                      C 435 - 435 ,T 433
1303 707 A-ONE
                 TO
                      T 499 - 510 , STORE ROM ADR: 711
1306 710 ROM ADR. TO
1310 712 ROM ADR. FROM C 424 - 435
                       GO TO 2048 PARAMETRIC INFO IN MM SENT TO/
                                  FROM D/A
                       GO TO 512 RTN 714 TRANSFER COMPLETED
1312 714 A-ONE
                 FROM C 375 - 376
                 TO C 375 - 377
1314 716 A-ONE
1316 718 DECODER FROM C 239 - 239 ,T 494
1321 21 DECODER TO C 492 - 492 ,T 493
                FROM C 493 - 493 ,C 493 ,C 494 ,C 377
1324 724 OUAD OR
,C 494
                 TO C 489 - 491
1332 730 OUAD OR
                 FROM T 241 - 250
1334 732 COPY
                 TO T 233 - 242
1336 734 COPY
                 FROM T 251 - 255
1340 736 COPY
                 TO T 243 - 255
1342 738 COPY
1344 740 CONSTANT TO C 500 - 501
         ( 121 ) TO C 502 - 509
1347 743 ROM ADR, FROM T 487 - 498
                       GO TO 696 END LIST OF PIN NO. NOT REACHED
                       GO TO 688 NEED TO INPUT ANOTHER WORD FROM MM
                       GO TO 612 SET-UP DATA FOR NEW PARAMETRIC INFO
                       GO TO 512 END OF PAMETRIC INFO SET-UP
         -(746-821) SUBROUTINE
         -(A+-B)A
         -AB
         -(A++1)B
         -AB)
         -(A+-16)B
         -(B-A)
         -BB
                     T 409 - 413 , T 415
1352 746 O.ECL.OR TO
1355 749 O.ECL.OR TO T 421 - 429
                 FROM T 417 - 418
1357 751 COPY
                      C 430 - 430 ,C 425
1361 753 COPY
                 TO
1364 756 OUAD OR FROM C 410 - 410 ,C 412 ,T 420 ,C 402
T 4021372 762 OUAD OR TO T 214 - 214 ,C 431 ,T 432
               FROM C 409 - 412
1376 766 A-ONE
                      C 409 - 412
                 TO
1400 768 A-ONE
1402 770 COMPARE FROM T 409 - 416
1404 772 COMPARE TO T 426 - 426
1406 774 O ECL.OR FROM C 426 - 426 ,T 418 ,T 417 ,C 431
T 288 T 419
1415 781 O.ECL.OR TO T 426 - 426 ,T 431 ,T 421
               FROM T 278 - 287
1421 785 COPY
                 TO
                      T 279 - 288
1423 787 COPY
```

```
FROM T 421 - 426
1425 789 A+B
                 TO T 426 - 426 , T 425
1427 791 A+B
                 FROM T 426 - 431
1432 794 A+B
                 TO T 426 - 426 , T 430
1434 796 A+B
                                   ,C 433 ,T 426
                 FROM T 432
                             - 433
1437 799 AND OR
                      T 278
                             - 278
1443 803 AND OR
                 TO
                  FROM T 392
                             - 401
1445 805 COPY
                       T 393
                             - 402
1447 807 COPY
                                   T 426 ,T 434 ,T 432
                 FROM C 434
                             - 434
1451 809 AND OR
1456 814 AND OR
                       T 392
                             - 392
                 TO
                 FROM C 214 - 214
1460 816 A-ONE
                      T 216 - 219
                 TO
1462 818 A-ONE
1464 820 ROM ADR. FROM T 212 - 223
                       GO TO 756 TRANSFER DATA NOT COMPLETED
                       GO TO 512 TRANSFER DATA COMPLETED
         -PASS/FAIL ANALYSIS
         -RETURN FROM MM LOGIC PROGRAM SOURCE
1466 822 PIN DRV FROM T 1 - 30
1470 824 M.M. ADV FROM C 272 - 279
                       C 457 - 462 ,T 202 ,C 461
1472 826 FR. PANEL TO
                  FROM T 447 - 447 ,C 460 ,C 203
1476 830 OR
                       C 275 - 275
                  TO
1502 834 OR
                  FROM T 457 - 459
1504 836 OR
                      C 508 - 508
                  TO
1506 838 OR
                                    T 511 , T 508
1510 840 COPY
                  FROM
                      T 507 - 511
1514 844 COPY
                  TO
                       C 500 - 506
                                    ,C 508
                FROM T 449 - 449
1516 846 DECODER
1521 849 DECODER TO
                      T 503 - 504
1523 851 CONSTANT TO
                     T 303 - 304
         ( 271 ) TO T 305 - 312
         ( 201 ) TO T 313 - 320
         ( 11 ) TO T 321 - 328
         ( 132 ) TO T 329 - 336
1531 857 ROM ADR. FROM T 325 - 336
                       GO TO 1440 RTN 464 LOAD, WRITE OR TEST
                                           BUTTON PUSHED
                                       860 LOAD, WRITE OR TEST BUTTON
                                           NOT PUSHED AND STOP ON FAIL
                                       876 CONTINUE ON FAIL
1534 860 PIN DRV TO T 241 - 271
                  FROM T 248 - 255
1536 862 OR
                  TO T 272 - 272
1540 864 OR
                  FROM T 256 - 263
1542 866 OR
                  TO T 273 - 273
1544 868 OR
                  FROM T 264 - 271
1546 870 OR
                  TO T 274 - 274
1550 872 OR
                  FROM T 272 - 275
1552 874 OR
                  TO T 307 - 307
1554 876 OR
1556 878 ROM ADR. FROM T 304 - 315
                       GO TO 882 CONTINUE TESTING
                        GO TO 890 FAILURE OCCURED
1560 880 M.M. ADV FROM T 477 - 484
1562 882 CONSTANT TO
                     T 497 - 498
         ( 66 ) TO T 499 - 506
1565 885 ROM ADR. FROM T 436 - 447
                        GO TO 1470 (NEXT TEST) MAIN MEM AS PROG SOURCE
```

```
1570 888 M.M. ADV FROM C 272 - 279
1572 890 O.ECL.OR TO
                      C 203 - 204 , T 206 , T 458
1576 894 ROM ADR. FROM T 314 - 325
                       GO TO 1216 FAILURE OCCURED
         -(896-958) 6 BIT PER PASS
         -RIGHT SHIFT SUBROUTINE UP TO
         -16 PASSES PROGRAMMABLE
                  FROM T 344 - 349
1600 896 COPY
                  TO T 224 - 229
1602 898 COPY
                  FROM T 334 - 343
1604 900 COPY
                  TO T 340 - 349
1606 902 COPY
                  FROM T 324 - 333
1610 904 COPY
                  TO T 330 - 339
1612 906 COPY
                  FROM T 314 - 323
1614 908 COPY
                  TO T 320 - 329
1616 910 COPY
1620 912 COPY
                  FROM T 304 - 313
                  TO T 310 - 319
1622 914 COPY
1624 916 COPY
                  FROM T 294 - 303
                  TO T 300 - 309
1626 918 COPY
                  FROM T 284 - 293
1630 920 COPY
                  TO T 290 - 299
1632 922 COPY
                  FROM T 274 - 283
1634 924 COPY
                  TO T 280 - 289
1636 926 COPY
                  FROM T 264 - 273
1640 928 COPY
                  TO T 270 - 279
1642 930 COPY
                  FROM T 254 - 263
1644 932 COPY
                  TO T 260 - 269
1646 934 COPY
                  FROM T 244 - 253
1650 936 COPY
                  TO T 290 - 2990
1632 922 COPY
                  FROM T 274 - 283
1634 924 COPY
                  TO T 280 - 289
1636 926 COPY
                  FROM T 264 - 273
1640 928 COPY
                  TO T 270 - 279
1642 930 COPY
                  FROM T 254 - 263
1644 932 COPY
1646 934 COPY
                  TO T 260 - 269
                  FROM T 244 - 253
1650 936 COPY
                  TO T 250 - 259
1652 938 COPY
                  FROM T 234 - 243
1654 940 COPY
                  TO T 240 - 249
1656 942 COPY
                  FROM T 224 - 233
1660 944 COPY
1662 946 COPY
                  TO T 230 - 239
1664 948 A-ONE
                  FROM T 431 - 434
1666 950 A-ONE
                  TO T 431 - 434 , T 219
                  FROM T 219 - 219
1671 953 COPY
                  TO T 220 - 220
1673 955 COPY
1675 957 ROM ADR. FROM T 212 - 223
                       GO TO 896 ROTATE DATA
                       GO TO 512 END ROTATION OF DATA
         -(960-1099) FAILURE PRINTOUT FORMATTERO BE
         -(208-211) NUMBER OF PIN IN IC
         -STORED IN NODES
1700 960 A-ONE TO C 441 - 446 ,T 241
1703 963 A-B-ONE FROM T 208 - 213 ,C 511
                  TO T 494 - 510
1706 966 A-B-ONE
1710 968 FR. PANEL FROM T 204 - 207
1712 970 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 971
```

```
1714 972 COPY
                  FROM T 366 - 375
1716 974 COPY
                  TO T 367 - 375 , T 351
                  FROM T 356 - 365
1721 977 COPY
                  TO T 357 - 366
1723 979 COPY
                  FROM T 350 - 355
1725 981 COPY
1727 983 COPY
                  TO T 351 - 356
1731 985 A-B-ONE
                  FROM T 494 - 498 , T 441
1734 988 A-B-ONE
                  TO T 494 - 510 , C 509
                  FROM T 442 - 446
1737 991 DECODER
                  TO T 422 - 427 ,C 500
1741 993 DECODER
                  FROM T 441 - 442
1744 996 A-ONE
                  TO T 441 ~ 442 ,T 350
1746 998 A-ONE
                     FROM T 443 - 446 ,C 350
1751 1001
            A -ONE
                     TO T 443 - 446 , T 350
1754 1004
            A -ONE
                     FROM C 350 - 350 ,C 352
1757 1007
            OUAD OR
                     TO T 492 - 493
1762 1010
            QUAD OR
                     FROM T 493 - 497
1764 1012
            COPY
                     TO T 410 - 440
1766 1014
            COPY
                     FROM T 414 - 414 , T 414
1770 1016
            COPY
1773 1019
            COPY
                     TO T 382 - 404 , T 448
            ROM ADR, FROM T 499 - 510
1776 1022
                        GO TO 1024 DETERMINATION OF OF PINS NOT
                                    FINISHED
                        GO TO 1026 DETERMINATION FINISHED
            A -ONE
                     TO T 493 - 498
2000 1024
                     FROM T 444 - 446
2002 1026
            AND OR
                                       ,T 446
                          C 503 - 503
2005 1029
            AND OR
                     TO
2007 1031
            DECODER
                     FROM T 492 - 492
                                       , C 351
                          C 500 - 500
            DECODER
                     TO
                                       , T 502
2012 1034
2015 1037
            QUAD OR
                     FROM C 502 - 503
            QUAD OR
                     TO
                          T 501 - 501
                                       ,C 503 ,C 387
2017 1039
            CONSTANT TO
                          C 430 - 431
2023 1043
         ( 317 ) TO C 432 - 439
            ROM ADR. FROM T 429 - 440
2026 1046
                        GO TO 390 RTN 1048 NO FAILURE
                                       1050 NO MORE INFO FOR PRINTER
                                       1054 FULL LINE READY TO BE
                                           PRINTED
                                       1058 FAILURE INFO
2030 1048
            ROM ADR. FROM T 448 - 459
                        GO TO 970 NO FAILURE
2032 1050
                     TO T 483 - 465
            DECODER
2034 1052
            ROM ADR. FROM T 462 - 473
                       GO TO 1746 NO MORE INFO FOR PRINTER
2036 1054
            COPY
                     FROM T 382 - 387 , C 337 , C 441
2042 1058
            COPY
                     TO T 327 - 329 , T 332 , T 333 , T 330
T 214 ,T 326
2051 1065
            OUAD OR
                     FROM T 332 - 333 ,T 337 ,T 214 ,T 214
2056 1070
                     TO
                          T 336 - 337 ,T 215
            OUAD OR
2061 1073
                     FROM C 346 - 350 ,T 501 ,T 501 ,C 350
            OUAD OR
2066 1078
                          T 431 - 434
            OUAD OR
                     TO
2070 1080
            A -ONE
                     FROM C 214 - 214
2072 1082
            A-ONE
                     TO
                          C 219 - 221 ,T 222 ,C 218
2076 1086
            A-ONE
                     TO
                          C 501 - 505
2100 1088
            ROM ADR. TO
                          T 448 - 459 , STORE ROM ADR: 1089
2102 1090
            ROM ADR. FROM T 212 - 223
                        GO TO 896 RTN 1094
                        GO TO 1100 RTR 1092
```

```
TO T 415 - 424
2427 1303
           COPY
                    FROM T 429 - 433
           COPY
2431 1305
                    TO T 425 - 433
           COPY
2433 1307
                    FROM T 401 - 409
           A + B
2435 1309
                    TO T 401 - 409
           A +B
2437 1311
                                      T 472 T 472
                    FROM T 402 - 406
           A + B
2441 1313
                     TO T 402 - 404 , T 473
           A + B
2445 1317
                    FROM T 402 - 405 ,C 511 ,C 473 ,C 473
           A-B-ONE
2450 1320
                    TO T 402 - 405
           A-B-ONE
2455 1325
                     FROM T 464 - 466
           A -ONE
2457 1327
                     TO T 464 - 466 ,C 222
           A-ONE
2461 1329
                     FROM T 472 - 473
           OR
2464 1332
                     TO T 221 - 221
           OR
2466 1334
                    FROM T 221 - 222
           DECODER
2470 1336
                    TO T 213 - 213 , T 221
           DECODER
2472 1338
                    FROM T 213 - 213 , T 213 , T 213 , T 511
            COPY
2475 1341
, C 221
                     TO T 216 - 220
2503 1347
            COPY
            ROM ADR. FROM T 212 - 223
2505 1349
                       GO TO 1280 LOOP OP NOT FINISHED
                       GO TO 512 LOOP OP FINISHED
                       GO TO 372 DECIMAL SUBSTRACT OP
         -(1352-1487) START OF TEST PROGRAM
         -START HERE WHEN TEST BUTTON PUSHED
         -INITIALIZE TO TEST
2510 1352 O.ECL.OR TO T 481 - 498
           O.ECL.OR TO T 204 - 207 ,C 206
2512 1354
            RELAYS FROM C 256 - 275
2515 1357
           NOP
2517 1359
            CONSTANT TO T 466 - 467
2520 1360
         ( 11 ) TO T 468 - 475
         ( 1 ) TO T 476 - 483
            ROM ADR. TO T 499 - 510 , STORE ROM ADR: 1365
2524 1364
            ROM ADR. FROM T 467 - 478
2526 1366
                       GO TO 530 RTN 1368 TITLE SEARCH SUB
                     FROM T 502 - 508 , T 485 , T 485
            A + B
2530 1368
                     TO T 502 - 506
            A +B
2534 1372
            ROM ADR. FROM T 499 - 510
2536 1374
                        GO TO 1376 LAST TEST OF PROGRAM NOT COMPLETED
                        GO TO 1472 LAST TEST OF PROGRAM COMPLETED
                     FROM T 487 - 490
            COPY
2540 1376
                     TO T 448 - 451
            COPY
2542 1378
                     FROM T 256 - 263
            COPY
2544 1380
                     TO T 487 - 494
            COPY
 2546 1382
                     FROM T 268 - 275
            COPY
 2550 1384
                     TO T 452 - 459
            COPY
 2552 1386
                         T 477 - 484
            O.ECL.OR TO
 2554 1388
            ROM ADR. TO T 499 - 510 , STORE ROM ADR: 1391
 2556 1390
            ROM ADR. FROM T 467 - 478
 2560 1392
                        GO TO 530 TITLE SEARCH SUB
            CONSTANT TO T 485 - 486
 2562 1394
          ( 144 ) TO T 487 - 494
          ( 302 ) TO T 495 - 502
```

```
O.ECL.OR TO C 309 - 309
2566 1398
            ROM ADR. FROM T 487 - 498
2570 1400
                       GO TO 612 REF GEN SET-UP SUB
                         T 465 - 484 ,C 466 ,C 469 ,C 474
           O.ECL.OR TO
2572 1402
T 203
                     FROM T 452 - 459
2600 1408
            COPY
                         T 487 - 494
                     TO
            COPY
2602 1410
                                       ,STORE ROM ADR: 1413
            ROM ADR. TO
                         T 499 - 510
2604 1412
            ROM ADR. FROM T 465 - 476
2606 1414
                        GO TO 530 RTN 1416 TITLE SEARCH SUB
            O. ECL. OR TO T 155 - 185
2610 1416
           M.M. ADV FROM T 155 - 162
2612 1418
                         T 0 - 30
            O.ECL.OR
                    TO
2614 1420
            O.ECL.OR TO
                         T 31 - 61
2616 1422
            Q.ECL.OR TO
                         T 62 - 92
2620 1424
            O.ECL.OR TO
                         T 93 - 123
2622 1426
            O.ECL.OR TO
                         T 124 - 154
2624 1428
            PIN DRV FROM T 1 - 30
2626 1430
                     FROM T 448 - 451
2630 1432
            COPY
                          T 487 - 494
                                        ,C 180
            COPY
                     TO
2632 1434
                          C 498 - 499
            CONSTANT TO
2635 1437
         ( 54 ) TO C 500 - 507
           Q.ECL.OR TO T 224 - 239
2640 1440
                           C 233 - 234
            O.ECL.OR TO
2642 1442
                     FROM C 498 - 498
2644 1444
            A -ONE
                     TO T 240 - 243
            A-ONE
2646 1446
            ROM ADR. FROM T 224 - 235
2650 1448
                        GO TO 1536 IF ENTERED FROM 858 RTN 860 LOAD,
                                   WRITE OR TEST BUTTON NOT PUSHED,
                                   STOP ON FAIL
                                   876 CONTINUE ON FAIL
                                   464 LOAD, WRITE OR TEST BUTTON PUSHED
                                   IF ENTERED FROM 1448 RTN 1450
            EXT.CONT FROM T 177 - 184
 2652 1450
                           T 180 - 199 ,T 205
            O.ECL.OR TO
 2654 1452
                           T 434 - 435
            CONSTANT TO
 2657 1455
         ( 276 ) TO T 436 - 443
         ( 5 ) TO T 444 - 451
                          C 350 - 375
            O. ECL.OR TO
 2663 1459
                          C 500 - 501
            CONSTANT TO
 2.665 1461
         ( 231 ) TO C 502 - 509
 2670 1464 FR. PANEL FROM C 437 - 440
            ROM ADR. FROM C 437 - 448
 2672 1466
                        GO TO MAIN MEMORY AS PROGRAM SOURCE
                      FROM C 487 - 490
 2676 1470
            A -ONE
                           C 487 - 490 ,T 509 ,T 484
 2700 1472
            A ~ONE
                      TO
                          T 499 - 500
 2704 1476
            CONSTANT TO
          ( 124 ) TO T 501 - 508
                      FROM C 509 - 509
 2707 1479
            A -ONE
                           C 504 - 506
                                        T 505
 2711 1481
                      TO
            A-ONE
 2714 1484
            EXT.CONT FROM T 499 - 502
 2716 1486 ' ROM ADR. FROM T 499 - 510
                        GO TO 432 ALL TESTS COMPLETED
                        GO TO 1360 MORE TESTS TO BE DONE
```

```
-(1488-1533) WALKING '1' AND '0'
2720 1488 CONSTANT TO T 218 - 219
        ( 342 ) TO T 220 - 227
        ( 137 ) TO T 228 - 235
         ( 24 ) TO T 236 - 243
                    FROM T 31 - 32
           COPY
2725 1493
                    TO C 291 - 291 ,C 32
           COPY
2727 1495
                    FROM C 33
                               - 36
                                      T 32
           A-ONE
2732 1498
                    TO C 33
                               - 37
           A -ONE
2735 1501
                   FROM T 32
                               - 36
           DECODER
2737 1503
                   TO T 0
                               - 15
           DECODER
2741 1505
                   FROM T 32 - 35
                                      , C 36
           DECODER
2743 1507
                    TO T 16 - 31
           DECODER
2746 1510
                    TO C 280 - 285 , T 501 , C 447
           A -ONE
2750 1512
                    TO T 304 - 327
           M.MEM.
2754 1516
           ROM ADR. FROM T 280 - 291
2756 1518
                       GO TO MAIN MEMORY AS PROGRAM SOURCE
                       GO TO 1520 CONTINUE
           DECODER FROM T 32 - 36
2760 1520
                    TO C 0 - 15
2762 1522
           DECODER
                    FROM T 32 - 35 ,C 36
2764 1524
           DECODER
                    TO C 16 - 24 ,C 447 ,C 31 ,C 291
2767 1527
           DECODER
                   FROM T 280 - 291
            ROM ADR
2774 1532
                       GO TO MAIN MEMORY AS PROGRAM SOURCE
         -(1536-1551) TIME DELAY SUBROUTINE
         -MAX 8MS 30MS PER LOOP MAX 256 LOOPS
2776 1534 PIN DRV FROM T 1 - 30
           Q. ECL.OR TO T 224 - 235
3000 1536
                    FROM T 236 - 239
           A -ONE
3002 1538
                     TO T 236 - 239 , T 233
           A -ONE
3004 1540
                     FROM T 240 - 243 ,T 233
           A -ON E
 3007 1543
                     TO T 240 - 243 ,T 234 ,C 233
            A -ONE
 3012 1546
            ROM ADR FROM T 224 - 235
 3016 1550
                       GO TO 512 END OF DELAY SUB
                       GO TO 1536 8MSEC DELAY SUB
         -(1552-1745) TRUTH TABLE AND TRUTH TABLE
          -MEMORY SUBROUTINE
 3020 1552 CONSTANT TO T 314 - 315
         ( 0 ) TO T 316 - 323
         ( 140 ) TO T 324 - 331
           M.MEM. TO T 296 - 319
 3024 1556
            M.M. ADV FROM C 121 - 128
 3026 1558
                     FROM C 199 - 199 ,T 199
            COPY
 3030 1560
                     TO T 325 - 326
            COPY
 3033 1563
            DECODER FROM C 102 - 102 , C 325
 3035 1565
            DECODER TO T 323 - 324
 3040 1568
            O ECL.OR TO C 283 - 284 ,C 287
 3042 1570
            ROM ADR. FROM T 320 - 331
 3045 1573
                        GO TO 1576
                        GO TO 1584
                        GO TO 1600
            O ECL.OR TO T 325 - 330
 3050 1576
            M.M. ADV FROM T 323 - 330
 3052 1578
            M.MEM. FROM T 129 - 152
 3054 1580
```

Model 5045A Maintenance and Troubleshooting

3060 3062 3064 3067 3072 3100 3100 3110 3110 3111 3121 3125 3127 3127 3131 3133 3135 3141 3143 3146 3151 3154 3161 3164 3167	1584 1584 1588 1599 1600 1600 1600 1600 1613 1613 1617 1613 1623 1623 1623 1633 1633 1633 1633	M.M. ADV M.MEM. A-ONE A-ONE A-ONE A-ONE O.ECL.OR COPY COPY COPY COPY COPY COPY COPY COPY	TO FROM TO FROM TO	C 323 T 176 C 121 C 121 C 125 C 103 T 130 T 129 T 140 T 139 T 154 T 153 T 164 T 153 T 164 T 173 T 184 T 193 C 103 C 104 C 104 C 104 T 296 T 297 C 327 T 323 T 0 15 TO 16		,C 199 ,C 199 ,C 106 ,T 199 ,C 199 ,T 199 ,T 199 ,T 332 ,C 332 ,C 327 ,C 327 ,C 329	,C 330	
3200 T 1	1664 23 , T	A -B -ONE	FROM	T 312	- 315	, C 511	, T 121	, T 122
3207	1671 1674	A -B -ONE A -B -ONE	TO FROM	T 332 T 316	- 335 - 320	, T 320 , T 125	, T 126	, T 127
3 2 2 0 3 2 2 4	1680 1684	A -B -ONE M , M . ADV ROM ADR .	TO FROM FROM GO		- 339	, T 320	, C 331	
3232 3234 3237 3243 3246 3250 3253	1688 1690 1692 (1895 1699 1702 1704 1707 1711	OR OR CONSTANT 302 } TO A+B A+B A+B A+B DECODER NOP	FROM TO T 320 FROM TO FROM TO	T 318	7 - 335 - 335 - 340	, C 511 , T 340 , C 331 , T 233		

```
3260 1712
          ROM ADR: TO T 499 - 510 , STORE ROM ADR: 1713
3262 1714
           ROM ADR. FROM T 224 - 235
                      GO TO 1534
3264 1716
           O. ECL. OR TO C 1 - 24
3266 1718
           PIN DRV TO T 506 - 536
           O. ECL. OR TO C 281 - 282 , C 285 , T 511
3270 1720
           ROM ADR. FROM T 320 - 331
3274 1724
                      GO TO MAIN MEMORY AS P. ROGRAM SOURCE
                      GO TO 1730
           M.M. ADV FROM C 304 - 311
3276 1726
           ROM ADR. FROM T 320 - 331
3300 1728
                      GO TO MAIN MEMORY AS PROGRAM SOURCE
           CONSTANT TO T 150 - 151
3302 1730
          276 ) TO T 152 - 159
          65 ) TO T 160 - 167
         ( 371 ) TO T 168 - 175
         ( 363 ) TO T 176 - 183
         (5) TO T 184 - 191
         ( 0 ) TO T 192 - 199
3312 1738 M.M. ADV FROM T 192 - 199
3314 1740 M.MEM. FROM T 164 - 187
3316 1742 O. ECL. OR TO C 507 - 507
3320 1744 ROM ADR. FROM T 152 - 163
                     GO TO 1470 (NEXT TEST)
        -( 1746-1761) PRINT OUT "FAIL PIN ---"
3322 1746 CONSTANT TO T 292 - 293
        ( 352 ) TO T 294 - 301
        ( 116 ) TO T 302 - 309
        ( 2 ) TO T 310 - 317
        ( 201 ) TO T 318 - 325
        ( 114 ) TO T 326 - 333
        ( 22 ) TO T 334 - 341
        ( 30 ) TO T 342 - 349
3333 1755 CONSTANT TO T 499 - 500
        ( 23 ) TO T 501 - 508
3336 1758 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 1759
3340 1760 ROM ADR. FROM T 499 - 510
                      GO TO 1100
        -( 1762-1807) PIN STATE PRINTOUT SUBROUT!NE
3342 1762 CONSTANT TO T 230 - 231
        ( 344 ) TO T 232 - 239
         ( 307 ) TO T 240 - 247
        ( 140 ) TO T 248 - 255
         ( 101 ) TO T 256 - 263
        ( 5 ) TO T 264 - 271
        ( 324 ) TO T 272 - 279
        ( 304 ) TO T 280 - 287
       ( 162 ) TO T 288 - 295
3354 1772 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 1773
3356 1774 ROM ADR. FROM T 284 - 295
                     GO TO 1836
```

```
3360 1776 CONSTANT TO T 230 - 231
        ( 0 ) TO T 232 - 239
        ( 202 ) TO T 240 - 247
        ( 40 ) TO T 248 - 255
        ( 10 ) TO T 256 - 263
        ( 72 ) TO T 264 - 271
        ( 11 ) TO T 272 - 279
        ( 344 ) TO T 280 - 287
      ( 162 ) TO T 288 - 295
3372 1786 ROM ADR. TO T 448 - 459 , STORE ROM ADR: 1787
3374 1788 ROM AOR, FROM T 284 - 295
                      GO TO 1838
3376 1790 CONSTANT TO T 230 - 231
      ( 0 ) TO T 232 - 239
        ( 122 ) TO T 240 - 247
        ( 103 ) TO T 248 - 255
        ( 41 ) TO T 256 - 263
     ( 111 ) TO T 264 - 271
        ( 317 ) TO T 272 - 279
        ( 300 ) TO T 280 - 287
        ( 162 ) TO T 288 - 295
3410 1800 A-ONE FROM C 460 - 460
3412 1802 A-ONE TO T 448 - 455 , C 456 , T 350
3416 1806 ROM ADR. FROM T 284 - 295
                     GO TO 1836 RTN 1810 CONTINUE ON FAIL
                     RTN 1812
        -( 1808-1834) CHECK FOR V. I. PRINT OUT
        -TITLE SEARCH FOR PASS/ FAIL INFORMATION
        -PRINT OUT
3420 1808 M.MEM. TO T 230 - 253
3422 1810
         Q. ECL. OR TO T 461 - 461
3424 1812
          A-ONE TO C 500 - 505
3426 1814
          A-ONE
                 FROM T 461 - 461
3430 1816
          A-ONE
                 TO C 501 - 501 , T 503 , T 507 , T 509
T 510
3436 1822
          COPY
                 FROM C 487 ~ 490
3440 1824
          COPY
                 TO C 400 - 407
3442 1826 CONSTANT TO T 463 - 464
        ( 22 ) TO T 465 - 472
        ( 42 ) TO T 473 - 480
        ( 360 ) TO T 481 - 488
        ( 377 ) TO T 489 - 496
3450 1832 DECODER TO C 436 - 446
3452 1834
          ROM ADR. FROM T 465 - 476
                    GO TO 530 RTN 1908
                      GO TO 2664 V-I PRINT OUT
3454 1836
          COPY
                   FROM T 208 - 212
                   TO C 404 - 412 , T 411 , C 204
3456 1838
          COPY
          ROM AOR. TO T 499 - 510 , STORE ROM ADR: 1843
3462 1842
3464 1844
          COPY
                   FROM T 1 - 10
3466 1846
          COPY
                   TO T 0 - 9
3470 1848
          COPY
                   FROM T 15 - 24
3472 1850
          COPY
                   TO T 16 - 24 , T 351
3475 1853
          COPY
                   FROM T 11 - 12 , T 0 , T 351 , T 13
, T 14
3503 1859
          COPY
                   TO T 10 - 15
```

```
~(2048-2091) D/A INPUT OR OUTPUT INFO
        -SUBROUTINE FOR ONE PIN
                   FROM T 286 - 293
4000 2048 D/A
4002 2050
           EXT. CONT TO T 381 - 384
4004 2052
          DECODER FROM T 379 - 379 , C 384
4007 2055
           DECODER TO C 381 - 381 , T 382
           COPY
                    FROM T 382 - 382
4012 2058
           COPY
                    TO T 383 - 383
4014 2060
          ROM ADR. FROM T 380 - 391
4016 2062
                      GO TO 2050 WAITING FOR 'READY' SIGNAL FROM D/A
                      GO TO 2064 WRITE DATA INTO D/A
                      GO TO 2078 READ DATA FROM D/A
        -TRANSFER INFORMATION TO D/A
                    TO T 224 - 229
4020 2064 D/A
                    FROM T 302 - 314
4022 2066
          D/A
4024 2068
                    FROM T 404 - 408
          D/A
4026 2070
                    FROM T 314 - 332
          D/A
                    FROM T 326 - 344
4030 2072
          D/A
                    FROM T 338 - 350
4032 2074
          D/A
          ROM ADR. FROM T 212 - 223
4034 2076
                     GO TO 512 FINISHED WRITING DATA INTO D/A
        -TRANSFER INFORMATION FROM D/A
4036 2078 D/A
                   TO T 302 - 307
                   TO
                        T 302 - 314
4040 2080 D/A
         D/A
                        T 404 - 408
                   TO
4042 2082
                   TO
                        T 314 - 332
4044 2084
          D/A
                        T 326 - 344
4046 2086
          D/A
                   TO
                    TO T 338 - 350
4050 2088
          D/A
          ROM ADR. FROM T 212 - 223
4052 2090
                     GO TO 512 FINISHED READING DATA FROM D/A
        -(2092-2151) CONVERT BINARY DATA FROM D/A
        -TO DECIMAL INTERCHANGE DATA POSITION
                   FROM T 231 - 240
4054 2092 COPY
                    TO C 231 - 240
4056 2094
          COPY
         Q.ECL.OR TO C 410 - 410 ,C 412 ,C 415
4060 2096
         A-ONE FROM C 240 - 240
4064 2100
                   TO T 381 - 381 , T 383 , T 386
4066 2102 A-ONE
                    FROM C 239 - 239
        A -ONE
4072 2106
4074 2108 A-ONE
                  TO T 385 - 385 , T 387
                    FROM T 238 - 238 , T 237 , T 236 , T 235
4077 2111 COPY
T 234 T 233 T 232 T 231
                    TO T 389 - 396
4110 2120 COPY
                    FROM T 233 - 234 ,T 511 ,T 233 ,T 232
           COPY
4112 2122
T 231
4120 2128
           COPY
                    TO T 419 - 433
                    FROM T 457 - 466
4122 2130
           COPY
                    TO T 281 - 290
           COPY
4124 2132
           COPY
                    FROM T 467 - 473
4126 2134
          COPY
                    TO T 291 - 297
4130 2136
          ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2139
4132 2138
           ROM ADR. FROM T 255 - 266
4134 2140
                      GO TO 390 RTN 2142
```

```
FROM T 234 - 234 ,T 232 ,T 231
           COPY
4136 2142
                    TO T 419 ~ 421
4142 2146
           COPY
                    TO T 499 - 510 , STORE ROM ADR: 2149
4144 2148
           ROM ADR.
                    FROM T 255 - 266
4146 2150
           ROM ADR.
                       GO TO 390 RTN 2152
         -(2152-2191) MULTIPLIER PRDGRAMMABLE
         -THRU 448
                        -455
4150 2152
           COPY
                    FROM T 381 - 390
4152 2154
           COPY
                    TO T 231 - 240
4154 2156
           COPY
                    FROM T 391 - 399
4156 2158
           COPY
                    TO
                         T 241 - 249
           O.ECL.OR TO
                         T. 381 - 404
4160 2160
                    FROM T 448 - 451
4182 2162
           A -ONE
                    TO T 448 - 451 , T 456
4164 2164
           A-ONE
                    FROM T 452 - 456
4167 2167
           A-ONE
4171 2169
           A-ONE
                    TO T 452 - 455
                    FROM T 448 - 455
4173 2171
           OR
                    TO T 500 - 500
4175 2173
           OR
                    FROM C 500 - 500
4177 2175
           A-ONE
                    TO T 502 - 507 ,C 501 ,C 502 ,T 503
           A-ONE
4201 2177
                   FROM T 231 - 240
42062182
          COPY
                    TO T 410 - 419
           COPY
4210 2184
           COPY
                    FROM T 241 - 249
4212 2186
                    TO T 420 - 433
4214 2188
           COPY
           ROM ADR. FROM T 255 - 266
4216 2190
                       GO TO 390 RTN 2162
                       GO TO 2192
4220 2192
           ROM ADR. FROM T 267 - 278
                       GO TO 2330
                       GO TO 2338
                       GO TO 2346
         -(2194-2328) READ SET UP DATA FROM D/A
         -SELECTS ONE OF -I +I
         -REPLACE NON CONTINUOUS OPPOSITE I WITH O
          COPY
                    FROM T 381 - 390
4222 2194
                    TO T 465 - 474
4224 2196
           COPY
                    FROM T 395 - 402
4226 2198
           COPY
                    TO T 479 - 486
           COPY
4230 2200
                    FROM T 425 - 430
4232 2202
           COPY
                    TO T 457 - 463
4234 2204
           COPY
                    FROM T 493 - 497
4236 2206
           COPY
4240 2208
           COPY
                    TO
                         C 289 - 293
4242 2210
           DECODER
                    TO
                         T 379 - 390 ,C 391 ,C 287
                         T 499 - 510 ,STORE ROM ADR: 2215
4248 2214
           ROM ADR.
                    TO
4250 2216
           ROM ADR. FROM T 380 - 391
                      GO TO 2048 RTN 2218
4252 2218
           DECODER TO
                         T 290 - 301
           CONSTANT TO T 214 - 215
4254 2220
         ( 70 ) TO T 216 - 223
4257 2223
                    FROM T 392 - 392 ,T 406 ,C 406
           OUAD OR
                    TO T 406 - 406 , T 484
4263 2227
           OUAD OR
          O.ECL.OR FROM C 406 - 406 ,T 394
4266 2230
4271 2233
          Q.ECL.OR TO T 394 - 394
```

```
4273 2235
               DECODER
                        FROM C 392 - 393
   4275 2237
                        TO T 388 ~ 390
               DECODER
   4277 2239
               DECODER
                        FROM T 392 - 394
   4301 2241
               DECODER
                       TO T 381 - 387
   4303 2243
                        FROM T 407 - 407 , T 383 , T 387 , T 387
               AND OR
   4310 2248
               AND OR
                        TO T 386 - 386
   4312 2250
                        FROM C 404 - 404 , T 381 , T 385 , T 385
               AND OR
   4317 2255
               AND OR
                        TO T 385 - 385
   4321 2257
                       FROM T 385 - 386 ,T 385 ,T 390
               OUAD OR
   4325 2261
                       TO T 432 - 433 ,C 431
              OUAD OR
   4330 2264
              OR
                        FROM T 432 - 433 ,T 388
   4333 2267
               OR
                        TO C 434 - 434
   4335 2269
              NOP
   4336 2270
              ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2271
   4340 2272
               ROM ADR. FROM T 212 - 223
                          GO TO 896 RTN 2274
   4342 2274
              CONSTANT TO T 253 - 254
           ( 206 ) TO T 255 - 262
            ( 241 ) TO T 263 - 270
            ( 221 ) TO T 271 - 278
   4347 2279
             AND OR FROM T 408 - 408 , T 386 , C 405 , T 385
   4354 2284
              AND OR
                       TO T 271 - 271
   4356 2286
              DECODER FROM C 392 - 392 , T 241 , T 271
   4362 2290
              DECODER TO T 448 - 449
              DECODER FROM C 241 - 241 , T 271
   4364 2292
   4367 2295
              DECODER TO T 450 - 452 ,C 270
   4372 2298
              QUAD OR FROM T 271 - 271 , T 392 , T 271 , T 392
   4377 2303
              OUAD OR TO
                            C 271 - 271 T 272
   4402 2306
              O.ECL.OR TO
                            T 451 - 455
              AND OR FROM C 392 - 392 , T 241 , C 270 , C 270
   4404 2308
   4411 2313
              AND OR TO
                            T 452 ~ 452
   4413 2315
              O ECL OR TO
                            T 381 - 404
              O ECL.OR TO T 410 - 428
   4415 2317
   4417 2319
             CONSTANT TO T 499 ~ 500
            ( 13 ) TO T 501 ~ 508
   4422 2322
                       FROM T 502 - 505 , T 230
              A + B
   4425 2325
              A +B
                       TO T 502 - 505
4427 2327
              ROM ADR. FROM T 499 - 510
                          GO TO 2092
                          GO TO 2100
            -4 BIT SHIFT REGISTER
            -DIV 10 EACH
            -4 BIT SHIFT REGISTER
            -DIV 10
            -DIV 1
  4432 2330
                       FROM T 385 - 394
              COPY
  4434 2332
              COPY
                       TO T 381 - 390
  4436 2334
                       FROM T 395 - 404
              COPY
  4440 2336
                       TO T 391 - 404
              COPY
  4442 2338
                       FROM T 385 - 394
              COPY
  4444 2340
              COPY
                       TO T 381 - 390
  4446 2342
              COPY
                       FROM T 395 - 404
  4450 2344
                       TO T 391 - 404
              COPY
  4452 2346
              COPY
                       FROM C 281 - 287
  4454 2348
              COPY
```

TO C 500 - 507

```
4456 2350 ROM ADR. FROM T 212 - 223
                      GO TO 512 RTN 2364
                                    2376
                                    2414
        -(2352-2522) STATE AND V.I.
        -PIN SET UP PRINT OUT
4460 2352 CONSTANT TO T 413 - 414
        ( '64 ) TO T 415 - 422
        ( 161 ) TO T 423 - 430
4464 2356 COPY FROM T 511 - 511 ,T 511 ,C 492
4470 2360
          COPY
                    TO T 392 - 394
4472 2362 ROM ADR. FROM T 416 - 427
                     GO TO 2202 READ IN -1 RTN 2364
                    FROM T 391 - 394 ,T 492
4474 2364
          COPY
                   TO T 475 - 478 , T 394
4477 2367
         COPY
          DECODER TO C 392 - 393
4502 2370
4504 2372 CONSTANT TO T 413 - 414
        ( 111 ) TO T 415 - 422
        ( 214 ) TO T 423 - 430
4510 2376 ROM ADR. FROM T 414 - 425
                      GO TO 2194 READ IN +1 RTN 2378
4512 2378
          COPY
                    FROM T 289 - 297
4514 2380
          COPY
                    TO C 410 - 418
4516 2382
          COPY
                   FROM T 474 - 476
          COPY
                    TO C 419 - 421
4520 2384
                   FROM T 477 - 486
4522 2386
          COPY
                    TO C 422 - 433
4524 2388
          COPY
4526 2390 CONSTANT TO T 228 - 229
       ( 204 ) TO T 230 - 237
        ( 1 ) TO T 238 - 245
4532 2394 ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2395
4534 2396 ROM ADR. FROM T 230 - 241
                      GO TO 388
        -GO TO DEC SUBTRACT
                -(+1)(-1)
                 FROM T 391 - 394 ,T 434 ,T 492
4536 2398
          COPY
4542 2402
          COPY
                    TO T 475 - 478 , T 491 , T 393 , C 392 , T
394
4550 2408
         CONSTANT TO T 413 - 414
       ( 111 ) TO T 415 - 422
        ( 324 ) TO T 423 - 430
4554 2412 ROM ADR. FROM T 414 - 425
                      GO TO 2194 READ + OR - V
4556 2414
                   FROM T 289 - 297
          COPY
4560 2416
                   TO T 465 - 473
          COPY
4562 2418
          COPY
                   FROM T 397 - 403 ,C 230
4565 2421
          COPY
                    TO T 401 - 408
4567 2423
          NO P
4570 2424
          CONSTANT TO T 417 - 418
     ( 224 ) TO T 419 - 426
       ( 364 ) TO T 427 - 434
4574 2428 ROM ADR. TO T 499 - 510 ,STORE ROM ADR: 2429
4576 2430
         ROM ADR. FROM T 417 - 428
                      GO TO 592 LOAD BLANK IN PRINT OUT FIELD
```

```
DECODER TO C 397 - 400 ,T 301 ,C 294
4600 2432
           DECODER FROM T 351 - 351 , C 204
4604 2436
4607 2439
           DECODER TO T 409 - 410
4611 2441
           CONSTANT TO C 500 - 501
        ( 275 ) TO C 502 - 509
           ROM ADR. TO T 412 - 423 , STORE ROM ADR: 2445
4614 2444
4616 2446
                    FROM T 212 - 223
           ROM ADR.
                      GO TO 512 THEN 2586 RTN 2448
                                (FORMAT FOR V PRINTOUT)
4620 2448
                    FROM C 465 - 474
           COPY
4622 2450
           COPY
                    TO C 381 - 396 , C 235 , C 294
4626 2454
           NOP
4627 2455
           COPY
                    FROM T 475 ~ 476 ,C 491 ,T 410
                    TO T 391 - 392 ,T 408 ,T 409 ,T 393
4633 2459
           COPY
                    FROM T 477 ~ 486
4640 2464
           COPY
4642 2466
           COPY
                    TO T 397 - 407
4644 2468
           DECODER TO T 429 - 430 ,T 277
4647 2471
           CONSTANT TO C 500 - 501
         ( 275 ) TO C 502 - 509
4652 2474
           ROM ADR. TO T 412 - 423 ,STORE ROM ADR: 2475
4654 2476
           ROM ADR. FROM T 212 - 223
                      GO TO 512 THEN 2586 (FORMAT FOR I PRINTOUT)
            -(2478-2496) FORMAT FOR 1 PRINTER
         -CONVERT PIN NUMBER FROM B INTO DECIMAL
         -USING DECIMAL ADDER
                   FROM T 435 - 439
4656 2478
         COPY
4660 2480
                    TO T 381 - 404
           COPY
4662 2482
           COPY
                   FROM T 439 - 439 ,T 439
                   TO T 411 - 433 ,C 410
4665 2485 COPY
                 TO T 291 - 295
4670 2488
         A -ONE
4672 2490 CONSTANT TO T 462 - 463
        ( 206 ) TO T 464 -471
        ( 1 ) TO T 472 - 479
4771111
        ( 1 ) TO T 472 - 479
4676 2494 ROM ADR. TO T 499 - 510 STORE ROM ADR: 2495
4700 2496 ROM ADR. FROM T 464 - 475
                      GO TO 390
         -CONVERT DECIMAL TO 6 BIT ASCII
         -SURPRESS LEADING ZERO SET UP '1'
                    FROM T 381 - 386
4702 2498
           COPY
4704 2500
           COPY
                    TO T 338 - 341 , T 344 , T 345 , C 342
                    FROM T 344 - 347
4711 2505
           OR
                    TO T 348 - 348
4713 2507
           OR
                    TO T 236 - 241 ,T 237 ,C 230 ,T 293
4715 2509
           A-ONE
                    FROM T 440 - 446
4722 2514
           COPY
4724 2516
           COPY
                    TO T 500 - 507 , C 508 , C 391 , C 203
           ROM ADR. FROM T 212 - 223
4731 2521
                      GO TO 512
4734 2524
          O.ECL.OR TO C 326 - 349
4736 2526
         PIN DRV TO T 319 - 349
4740 2528 CONSTANT TO C 500 - 501
        ( 210 ) TO C 502 - 509
```

4743 4744 4746 4750 4753 4756 4762 4766 4777 4777 5001 5003	2532 25334 25336 25339 25446 25554 25552 25554 25557 25561	NOP (2532-2564) PRINT OUT COPY A-ONE A-ONE COPY COPY COPY COPY COPY COPY COPY COPY	FROM TO FROM	CCTTTTTTTCT	493 319 320 320 326 325 331 330 341 340 223 217 212	-	DATA - 497 - 324 - 323 - 323 - 329 - 349 - 349 - 349 - 223 - 222 - 223	, T , T , T	3 1 9 2 2 3 3 1 9 3 2 5	3 9 , 7 9 , T	- 223 - 215		
			GO GO		254 2512								
5006 2 5011 2 5013 2 5015 2 5020 2 5024 2	2569 2571 2573 2576 2580	DECODER DECODER DECODER DECODER COPY	FROM TO FROM TO FROM TO	T C T		-	409 382 409 384 408 381	, T , T	203 294 383 384	, c	408 429	, т	408
, 0 430	- (2586-2663)	FORMA	TTE	ROF	٧	I PRII	NT (TUC				
	- 1 - 2	ST PASS V T ND PASS I	TRUNCA: TRUNCA:	TE TE	AND		STIFY STIFY						
5032 2	2586	COPY	FROM				384						
5034 2		COPY	TO				293						
5036 2 5040 2		COPY	FROM TO	T T	385 381		394 390						
5042 2		COPY	FROM		395		404						
5044 2	596	COPY	ТО		391		400						
5046 2		COPY	FROM		405	-	407						
5050 2		COPY	TO		401		407						
5052 2 5056 2		DECODER DECODER	FROM TO		291 424		292 428	, T	293	, T	290		
5060 2		AND OR	FROM		427		428	, C	294	. С	294	. С	412
,C 412													. –
5066 2 5070 2	614	AND OR	TO		412		412	_					
	619	OR OR	FROM TO	T T	396 412	_	402 412	, T	412				
	621	AND OR	FROM	Ť	428		430	C	294				
5100 2	624	AND OR	ТО	Ċ	294		294	, 0	204				
	626	OR	FROM	T	381	-	388						
5104 2		OR	ТО	Т	427		427						
5106 2 5110 2	630	O.ECL.OR ROM ADR.	TO TO		219		220			5011			
5112 2		ROM ADR.	FROM	Т	499 212		5 1 0 2 2 3	, 51	ORE	HOM	ADR:	263	3
			GO	TO	896								
5114 2	636	OR	FROM	Т	390	_	394	Ť	497	, T	429	_	120
5121 2	641	OR	TO		503		503	, :	761	, 1	740	, C	763
5123 2	643	COPY	FROM		502	-	503	, C	337	, C	337	, T	412

```
5374 2812
          DECODER
                    TO T 379 - 390
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2815
5376 2814
           ROM ADR. FROM T 380 - 391
5400 2816
                       GO TO 2048
         -LOGIC TO CONTROL V OR I
         -MANIPULATION AND RETURN CONTROL
          CONSTANT TO T 460 - 461
5402 2818
         ( 200 ) TO T 462 - 469
         ( 243 ) TO T 470 - 477
         ( 56 ) TO T 478 - 485
           AND OR FROM C 204 - 204 , T 376
5407 2823
                         T 505 - 505
                   TO
           AND OR
5412 2826
                    TO C 499 - 504 .C 414
           A -ONE
5414 2828
           O.ECL.OR FROM T 351 - 351 .T 461
5417 2831
           O.ECL.OR TO T 378 - 390 ,C 431
5422 2834
           AND OR FROM C 406 - 406 , T 351
5425 2837
                   TO T 440 - 446
5430 2840
           AND OR
           O.ECL.OR FROM C 509 - 511 ,T 351 ,T 492 ,T 440
5432 2842
           O.ECL.OR TO C 441 - 445
5437 2847
                    FROM T 493 - 497 ,C 406 ,T 204 ,T 505
5441 2849
           COPY
T 351
                         C 289 - 293 ,T 288 ,C 500 ,C 507
5447 2855
           COPY
T 376 ,C 465
                    FROM T 442 - 444
5456 2862
           COPY
                     TO T 432 - 434
5460 2864
           COPY
                   FROM T 380 - 391
           ROM ADR.
5462 2866
                       GO TO 2048 RTN 2678 FINISHED PININFO PRINTOUT
                                  RTN 2870 GO TO VI TWEEK
                                  RTN 2868 TERMINATE PRINTOUT
           ROM ADR. FROM T 461 - 472
5464 2868
                       GO TO 1808
           O.ECL.OR TO T 465 - 465
5466 2870
           ROM ADR, FROM T 462 - 473
5470 2872
                       GO TO 896 SELECT REF LEVEL TO BE ADJUSTED
                    FROM T 442 - 444 ,C 278
           AND OR
5472 2874
                    TO T 417 - 417
           AND OR
5475 2877
           O.ECL.OR FROM T 378 - 378 , T 492
5477 2879
           O.ECL.OR TO C 418 - 420 ,T 419 ,T 434
5502 2882
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2887
5506 2886
           ROM ADR. FROM T 474 - 485
5510 2888
                       GO TO 746 (A + / -1) (A + / -16) B
         -(2890-2833) PRESET RANGE LIMITS
           DECODER FROM C 442 - 442
5512 2890
           DECODER TO C 502 - 504 ,C 416
5514 2892
5517 2895
           NOP
           O.ECL.OR FROM C 415 - 418 ,T 289
5520 2896
           O.ECL.OR TO T 431 - 433
5523 2899
           CONSTANT TO
                         T 228 - 229
5525 2901
         ( 175 ) TO T 230 - 237
         ( 31 ) TO T 238 - 245
         ( 126 ) TO T 246 - 253
         ( 103 ) TO T 254 - 261
         ( 22 ) TO T 262 - 269
         ( 0 ) TO T 270 - 277
```

```
5535 2909 CONSTANT TO T 300 - 301
        ( 175 ) TO T 302 - 309
         (21 ) TO T 310 - 317
         ( 126 ) TO T 318 - 325
         ( 203 ) TO T 326 ~ 333
         ( 23 ) TO T 334 - 341
         ( 276 ) TO T 342 - 349
5545 2917 AND OR FROM C 441 - 443 ,T 408 ,T 443 ,C 405
5552 2922 'AND OR
                    TO T 434 - 434
5554 2924
           ROM ADR. FROM T 212 - 223
                       GO TO 512 THEN 2926 SPECIAL V SET-UP
                                 RTN 2934
5556 2926 CONSTANT TO C 306 - 307
        ( 261 ) TO C 308 - 315
         ( 105 ) TO C 316 - 323
        ( 22 ) TO C 324 - 331
5563 2931 DECODER TO T 303 - 304 ,T 338
5566 2934 Q.ECL.OR FROM T 432 - 434 ,T 433 ,C 418
5572 2938 O.ECL.OR TO C 429 - 430 .C 203
5575 2941 QUAD OR FROM C 429 - 432
         QUAD OR TO T 448 - 448 ,T 418 ,T 420 ,C 441
5577 2943
5604 2948
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2949
5606 2950
           ROM ADR. FROM T 462 - 473
                      GO TO 896 SELECT CORRECT RANGE LIMIT
5610 2952
           Q.ECL.OR TO T 433 - 433
5612 2954 ROM ADR. FROM T 474 - 485
                      GO TO 746 COMPARE (A+B), (A-B) A
         -(2956-2975) COMPARE RANGE LIMIT
         -WITH ADJUST V OR I
5614 2956
           DECODER TO T 431 - 434
5616 2958
           O.ECL.OR FROM T 284 - 284 ,C 418 ,T 430 ,C 418
.C 418
5624 2964
           Q.ECL.OR TO C 449 - 449 ,C 416 ,T 433
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2969
5630 2968
           ROM ADR. FROM T 462 - 473
5632 2970
                      GO TO 896 RTN 2972
5634 972
          O.ECL, OR TO T 414 - 414
          ROM ADR, FROM T 462 - 473
5636 2974
                      GO TO 896 RTN 2976
5640 2976
           DECODER FROM T 448 - 449 , T 416
5643 2979
           DECODER TO T 204 - 204 ,C 434
5646 2982
           COPY
                    FROM T 392 - 392
5650 2984
           COPY
                    TO C 419 - 420
5652 2986
           ROM ADR. TO T 499 - 510 , STORE ROM ADR: 2987
          ROM ADR. FROM T 474 - 485
5654 2988
                      GO TO 746 PRESET B.A.AB
5656 2990
           COPY
                    FROM T 441 - 444 ,T 434 ,T 416
5662 2994
           COPY
                   TO T 431 - 434 , T 444 , C 222
5666 2998
           DECODER FROM T 443 - 444 ,C 289
5671 3001
          DECODER TO T 419 - 420
5673 3003
          O.ECL.OR TO C 236 - 243
```

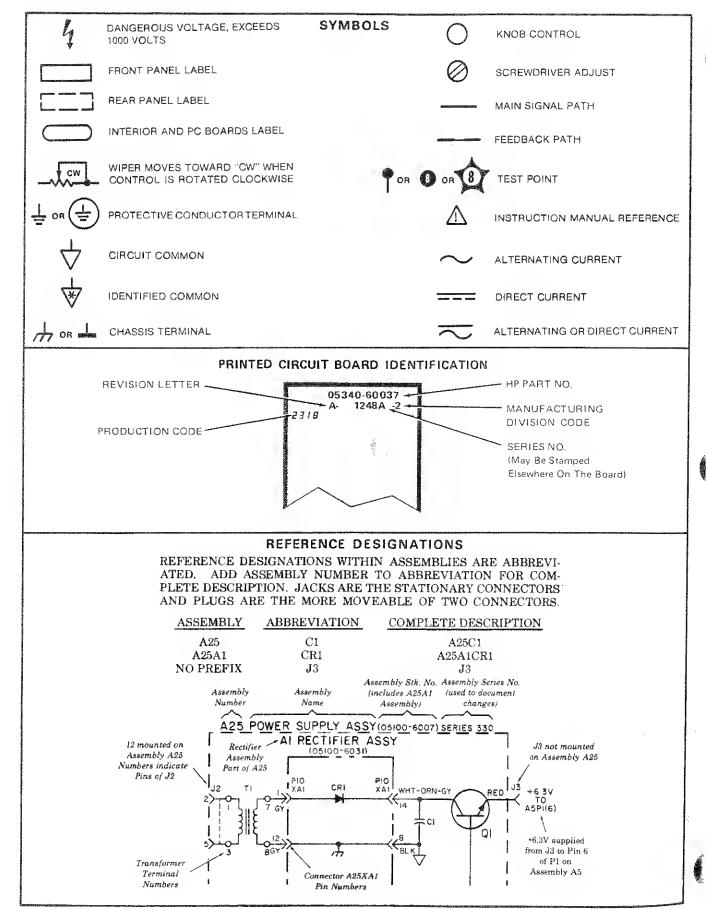


Figure 8-9. Schematic Diagram Notes

8-164. The two main program sources (ROM and Main Memory) control the flow of serial data to and from those blocks located on the left of the block diagram. For example, data needed to test an IC can flow from the Magnetic Card Reader through the RAM where it is formatted and routed to the Main Memory. It can then be sent, via the RAM, to the ALU (Arithmetic Unit), which helps simulate, for reference purposes, the IC under test. Other data passes to the Reference Voltage Generator and Control block. This block converts the data from a binary code into four lines of reference levels that are strobed to the Pin Drivers. The Pin Drivers are responsible for driving the test socket pins with the correct voltages and currents.

8-165. The Memories

8-166. Of major importance are the three memories that control the tester's operation. These are the ROM, the Main Memory, and the RAM. These memories are described in the following paragraphs.

8-167. THE ROM. The ROM (Read Only Memory) contains 36,864 bits (3072 x 12) of fixed information. This memory stores the tester's basic operating routine. It allows the tester to follow a given procedure but with the ability to vary its algorithm in accordance with the result of the completed operation and the front panel switch positions. It can also relinquish control to other portions of the tester (e.g., the Main Memory). The ROM controls the tester's operation by way 12 Program Control lines (described later).

8-168. Notice that selection of the ROM program codes (12 lines) is controlled by the ROM Address Register. The Address Register provides 12 address lines to the ROM that enable specific locations (or addresses) within the ROM. The ROM will then output the data contained in the addressed location. The address code can be sequentially advanced by pulsing the Program Advance line, or it can be radically changed (as in a "go-to" statement by enabling the Transfer line and serially clocking in a new address from the RAM. (It must be noted that any information contained in the RAM originated from some other source.) The 11th and 12th lines from the ROM Address Register control whether the program source is the ROM or the Main Memory when both lines are true (11).

8-169. THE MAIN MEMORY. The Main Memory contains up to 6144 bits of information that is taken from the magnetic program card. Therefore, this memory contains information pertaining to the testing of a specific IC plus the PASS/FAIL count. Basically, there are four types of information stored in this memory:

- 1. Header information, which is the IC number and the type of test (pass/fail or diagnostic).
- 2. The Setup Data for the IC to be tested, i.e., the codes for the voltages and currents that will be applied to the IC under test.
- 3. The Logic Model program, i.e., the information that will simulate a logic function and generate a stimulus to that function. This produces a reference to which the device under test can be compared.
- 4. The Test Sequence information. This combines 2 and 3 into a specific test. Also, the Main Memory initially stores the check-sum number at the end of the card. If the number of bits transferred from the card agrees with this number, the number is replaced with Pass/Fail storage locations, i.e., locations that hold numbers representing the number of IC's that passed or failed their tests. If the check-sum number does not agree with the counted bits from the card, the word "RELOAD" is printed out.

8-170. These four types of information are serially transferred from the magnetic program card (three bits at a time) and stored in the Main Memory in words that are 24 bits long. Once all the information is stored, it can be removed serially as data to the RAM or as parallel 12-bit words to the Program Control lines.

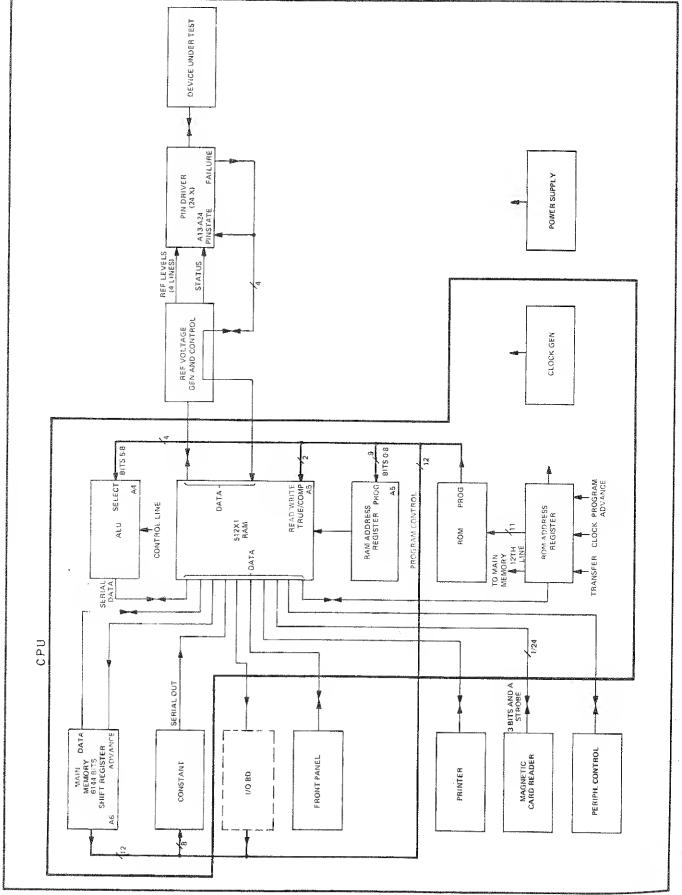


Figure 8-10. Simplified Block Diagram

- 8-171. During the testing of an IC, the ROM relinquishes program control to the Main Memory's logic Model program. This allows the tester to *simulate* the device under test (a model) and to apply a stimulus pattern to the model. This information is then stored in the RAM for access by the ROM program and is-then applied to the actual device under test.
- 8-172. THE RAM. As previously mentioned, any exchange of data between blocks is accomplished serially and by way of the RAM. The storage capacity of this device is 512 bits long by one-bit wide (512 x 1); expressed differently, there are 512 data locations, each having the capacity of storing one bit of data. This data is stored and retrieved by addressing the RAM Address Register with the nine least-significant bits of the Program Control lines. This method is referred to as presetting. Once preset, however, the address code can be sequentially advanced by clocking the register (for example, if the data word is more than one-bit long). Although described later in more detail, it should be noted that before the RAM is addressed with a RAM Address code, the Processor Memory must first receive another 12-bit code that designates certain operations and functions to be performed within the tester.
- 8-173. Included in this first code is the number of data bits to be automatically transferred to or from the RAM. The subsequent RAM Address code specifies the starting location (presetting) after which, the addresses are automatically and sequentially stepped through until the specified number of bits have been transferred. At this point, additional RAM Address codes may be used to address individual locations within the RAM, one at a time and at specified locations. The tester, however, is still under control of the first 12-bit word that specifies the transmitter or receiver of data.
- 8-174. Figure 8-11 shows the RAM and the particular blocks associated with data transfer. Note that some blocks are strictly senders of data, while others are receivers of data, and still others are bidirectional. Again, none of the blocks can exchange data directly between themselves—data must go from one block, through the RAM and then to the second block.
- 8-175. THE ALU. The block located immediately above the RAM (Figure 8-10) represents the tester's ALU (Arithmetic Logic Unit). The ALU functions as a decision-making block as the CPU steps through its algorithm. It also serves as a logic model simulator. This section, which can be viewed as a group of "building blocks", performs either logic functions or arithmetic operations, as determined by a control line. Once the operating mode has been established, four of the Program Control lines (bits 5-8) select the actual function to be performed. For example, assume the control line has chosen a Logic Function operation. The four-line code, then must select the specific function to be performed for example, an eight input OR gate, an Exclusive OR, or perhaps a D type flip-flop. Selection of the logic function is in accordance with the device under test and is accomplished by arranging the "building blocks" so they can simulate a logic function.
- 8-176. Input data is needed, however, for the ALU to actually perform an operation. If no input data is specified, the data inputs are initialized to zero. In the case of the eight-input OR gate, assume that one of the input pins is in the "1" state. The output, then, is also a "1".
- 8-177. Notice that this setup data (i.e., the stimulus for the model) enters the ALU serially—it is internally converted to parallel and placed across the OR gate's inputs. The resultant data (the "1" state output from the model OR gate) uses this same block diagram line when it is sent to the RAM for storage.
- 8-178. Each of the first 24 bits in the RAM contains one bit of information that relates to the same pin of the device under test, e.g., RAM address 6 relates to pin 6 of the device. These first 24 bits select the appropriate logic state applied to the device. The logic states are stored in each pin driver and will be described later. The "1" state output of the OR logic model, then, takes its proper place in the RAM to help determine what the device's output should be.

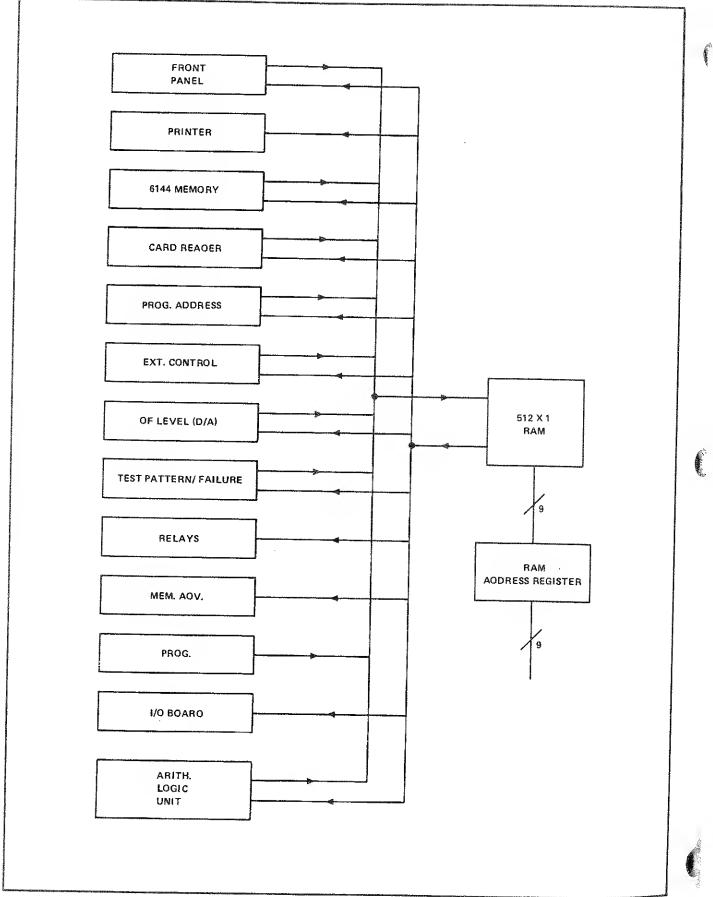


Figure 8-11. Serial Bus Data Flow

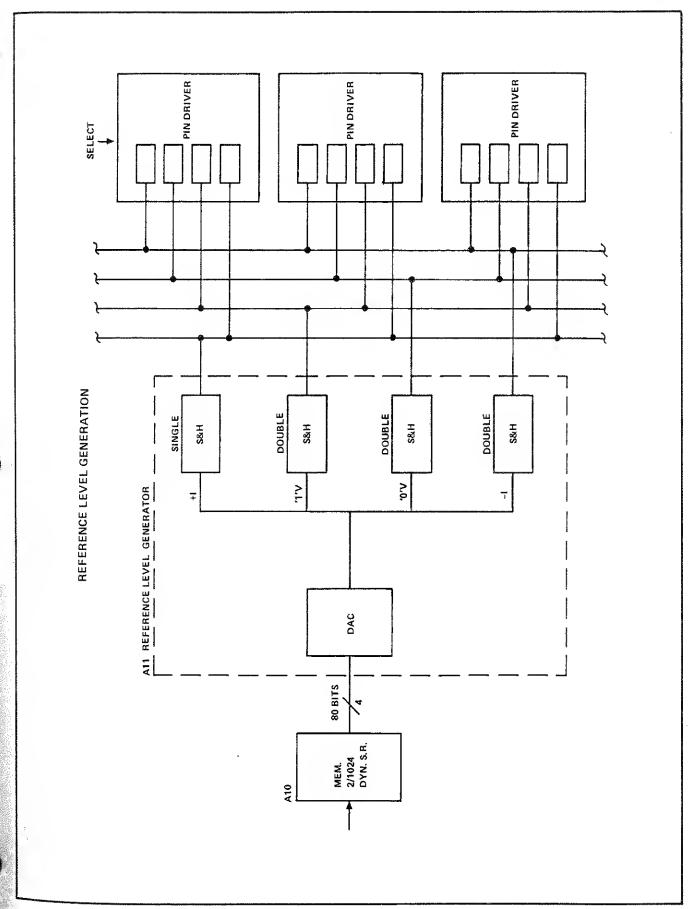


Figure 8-12. Reference Level Generation

8-179. Reference Voltages and Pin Drivers

8-180. The upper right portion of the Block Diagram depicts the Refrence Voltage Generator and Control section, along with the Pin Drivers, which drive the Device Under Test. Refer to Figure 8-12, which diagrams these sections in greater detail.

8-181. The memory shown on the left is the Reference Level Storage (RLS) Memory, located on the A10 board. This memory stores setup data that was originally stored on the magnetic program card. The data was accessed by the Card Reader, fed through the RAM, and stored in the Main Memory in the form of 24-bit words. The data is then serially transferred in 24-bit words from the Main Memory and into the RAM, where the data is reconfigured under control of the ROM program. The data is then fed into the Reference Level Storage Memory. A 12-bit Set-up Data word enters the Digital-to-Analog Converter (DAC) in a specific manner: the first four most-significant bits enter the DAC in parallel, followed by the remaining eight bits which, are sent in four 2-bit parallel transfers. This method of transfer allows faster settling time in the DAC than if all data were transferred serially.

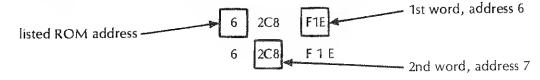
8-182. The DAC converts 11 bits of the 12-bit Setup Data word into a voltage, where upon it is clocked into a Sample and Hold (S&H) circuit (the 12th bit is used to control the range). Once done, the DAC converts the next 12-bit word into a voltage and stores that in the next S&H circuit. This process continues until all four storage circuits are filled (bottom to top), at which time the four voltages are strobed into four other S&H circuits located on the Pin Driver board. There are 12 Pin Driver boards available. Each board contains two "Pin Drivers". The first board drives pins 1 and 2 of the Device Under Test; the second board drives pins 3 and 4, etc., therefore, 12 boards for a 24-pin device.

8-183. This process of transferring data to the DAC, strobing the resultant voltages into Sample and Hold circuits, and transferring that information into the Pin Driver S&H circuits continues until all Pin Drivers contain the required information. This is a continuous operation. At the same time that each pin driver is having its reference levels strobed in, five select lines (also have the RLS memory) strobe that particular pin driver with information that controls certain functions on the Pin Driver boards. For example, to configure the pin driver circuits so they function as an input or an output. Refer to Figures 8-17 and 8-18.

8-184. In addition to the four reference levels and the five control lines, each pin driver must be given logic state information; i.e., is the pin driver's output going to be a logic "1" or a logic "0"? Again, this information is contained in the RAM as a 24-bit word (one bit for each pin driver). The RAM transfers this word, four bits at a time, onto another four-line bus (not the reference level bus), whereupon six strobe pulses fill all pin drivers with logic state data (6 x 4 = 24). Each pin driver circuit places its bit of data into temporary storage until all pin drivers have been set up. Then, another strobe line clocks all pin drivers to simultaneously change state.

8-185. ROM PROGRAM CONTROL THEORY

8-186. Table 8-6 lists all program words stored in the ROM. These words are listed in hexadecimal form, Table 8-7 shows the hexadecimal-to-binary conversion. The codes are grouped in a six-character format and are shown next to their respective ROM address codes. Notice, however, that the addresses are given in even numbers only. Actually, each character group contains two three-character words, with the first word being the three characters on the right-hand side and corresponding to the ROM address listed to the left. The second three-character word is on the left, and its address is the listed address plus one. For example:



8-187. Recall that all ROM information transfers onto the Program Control lines in the form of a 12-bit word. Therefore, each three-character word, shown above, translates into a 12-bit word.

8-188. There are four types of words stored in the ROM and these are shown in Table 8-8. Notice that each word is 12 bits long and that the MSB is bit 11. The three most-significant bits designate the type of word or mode of operation:

- 1. A RAM address code.
- 2. A Logic Function or Arithmetic Computation code.
- c. A Data word (specifies a location, e.g., the pin driver, for the purpose of transferring data to or from the RAM).
- 4. A space or NOP (no operation).

8-189. In every transfer of information, the sender and receiver of data must be specified. The following paragraphs offer a closer examination of these Program Control codes and how they affect the tester's operation, followed by examples of decoding some of the words found in the ROM listing.

Table 8-6. Hexadecimal ROM Code List

		THE PARTY										A OYOU							4 00000	TO T		(0) (5) (4) (4)			T I III	t uller	T U U	T USEL										
					Post of the second seco									DO HOL									T T T T											10 13 13 13 13 13 15 15			すす (2) (3) (4)	
	LL VA ON									(C)			LL CA CA CA	(1) (1) (1)	LL の 材 い	10 10 10 10 10 10				TO THE COLUMN				ID S S S S S	다 당 당 ()	小司 证言的				T T T								
				FT TT CO							A TOTAL							(3)(4)(5)(6)(7)(7)(8)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)(9)<	THUCK O			A CARLO					(T) (D) (D) (T)					(P) (L) (L) (L) (T)				# 1550 C4		
		(7) (T) LL (0) LL								(1) (I) (I) (I) (I)		(7) (7) (LL (1)	7- 70 11 10 10		5 6 1 1 1 1						7 L C O			(7) (A) (L) (C) (L)					(1) (3) (4) (5)									
	4	ti D	u")	E)	1	UD.	1.0	ŧΩ	1. <u> </u>	W	U	Ţ~	7	ř*	F	Ē,	O	Ü	ÇO:	00	00	ijŢ'n	QT:	(T)	Ç'n.	ুটি :		3	Œ.	CD.	T)	-24-4-5	04 04 04		· gran việ	ry mil		
	04 05 05		(h. Ll. (i) (i)				آب ش ن		00 00 04	00 LU N-									人人员甘																			Ĭ
	î⊢	[*·•	*****		00	OÜ!		00	₽'n	<u> </u>	(Th	Ē	(Th	ingi ingi	S)	(II) 	CO grand grand	<u> </u>	-1	and and		-	-2+++4j			P.J. I	(U)	(Pol)		(1) :	(<u>"</u>	ermi EG	drwif.	-(•••-) -(••)	-hd (-j)-	ilmi ilili	ndr ndr	
																ES4C	0280						in Li T	Ch LL CO LL							(h) Eq.: Th:							LL
_ _ 		OJ.	rife i	TO .	ÇQ.	<u> </u>	[\] 1		-0	ijj ijj	(A)	NI NI	d N	UD I	Ņ.	<u>s</u>	04 70	चा (१)	10 17	(,) ())	ত্র যৌ	(\d \d	ti zir	LD VÝ	1304 H		N :			00 i	10 I	04 10	ਹ ! 'D'	D	00 10		j'har	

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Table 8-6. Hexadecimal ROM Code List (Continued)

7889-7-7-7-7-0-1-0-0-0-0-0-0-0-0-0-0-0-0-0-0	
$ar{a}$ $$	© (2 C) ←-
VT0 0	
0.00000000000000000000000000000000000	(4) 10 10 10 10 th th
0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.0.	
NNGUUUUUUUUUUUUUUUUUUUUUUUUUUUUUUUUUUU	mamana ta
049010000000000000000000000000000000000	
\mathcal{M} AN MANAMANAMANAMANAMANAMANAMANAMANAMANA	ാ ഈ ഈ താ ത ത
000000000000000000000000000000000000	1404204 004-44 164441 144441
$egin{array}{cccccccccccccccccccccccccccccccccccc$	The speed speed speed speed 170.8
00000000000000000000000000000000000000	4000000 7000000 4000000
V - V -	0 (C) (C) of of of of of CI
186999999999999999999999999999999999999	TENUNTES
—————UNNUNNOOOOOA4444RRRRRR BU4RRRRRRRRRRRRRRRRRRRRRRRRRR	0.000000 HU 1.00000 K 1.0000 K

LIST DATA

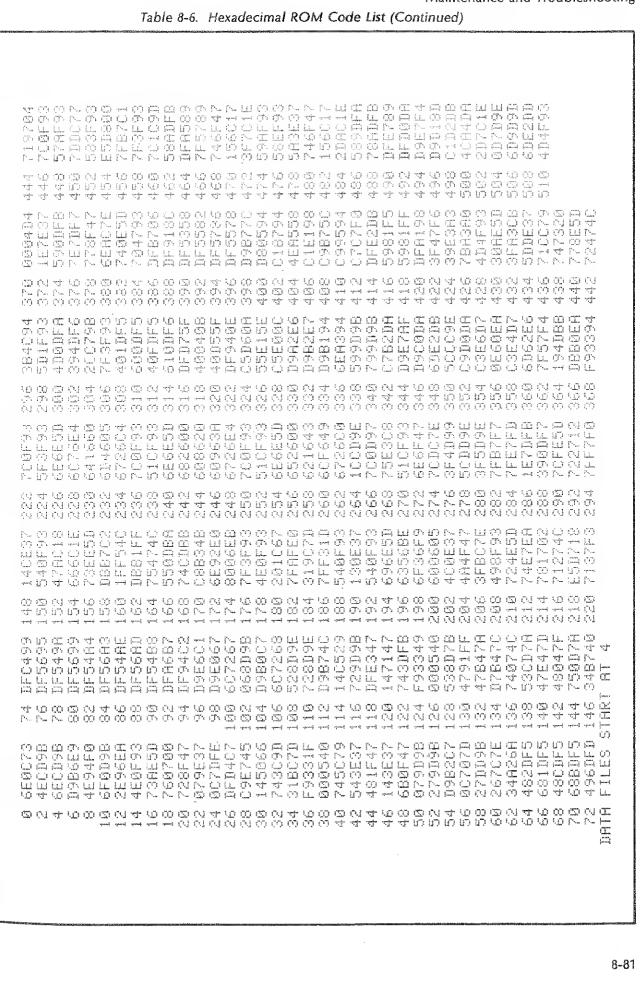
8-79

Table 8-6. Hexadecimal ROM Code List (Continued)

																												[] [] []			LL. (%) (%) (%) (%)					
- contra	nuls.	and-	£ ,	T 1" "	3 (**)	1775	4	1.75	1.172	5.2%	3.4%	1:3	75	5"	11	75	100	133	1113	133	111	60 -	GG.	1111	1.11	1.13	1,00	1.564	100	1.34		200	. be. 1.1			
ű		600		9					(0) (2) (3)		914			2	SECS		200			当日		# 9				153		1.1.1 1.1	Ğ.	Ē	Kuo	10 10	Be	\$ LC 65.65 \$ L		
\$1.	1**.	Ph.	37+.	Ph.	11111	1"2"1	2"1"2	1,44,4	1"1"3		(T)	200	177	-11	(3.7)	4554	150	130			-years)	green)		grand	1.53	1.34	1.53	1.53	5.54	1, 1, 1	1, 1, 5	7,17	41.7	50 50 50	1,1	19.3
				00000				TESTI.					REDI		204 D4							(7) (h. (l. (i)		0000						BEDF7					09 05 LL 00 LL	
. ~ 24_		, mm.	· marrie	,,,,,,,,,,		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,						12.2	2 2 1	-0.1	179.5	47.4	7 7	1 1 1	2 4 2	: 3 2	3 7 8	-21-24	4.50	.7.1	4.1	7.3	13 3	12 J	14 J	2.5 3	3.5 /	2.5		41 143 173	- 5.	7.4.7
11 71 171	12 11 10		型	FUDE			00	H T T				L T							H F				L O		ur F- U)	ur Ur Ur	10 P= 10		r E I	in U	Z W					
C.i	-71 <u>1</u> -	ហ្គ	00	(E)	Qi oo	mj.	LO CO	00	<u></u>	્ય ન	র	Ú	00 रहे	(<u>区</u>)	Cui Ich	d IO	io io	00	© Uil	Cu to	មា ពេ	up i	W Lū	© 	CU P	ur Pu	io N-	00 r.	<u>5</u>	() (0)	ਚਾ 00	1,0 00	00	四 (万) (M	CVI Or	T) (J)
0 9 1			INC	4074 0704	1201										16C1m							(1) (1) (1) (2)	(0) (7) (1)											T L L L		
-	2,000	2,444	11.00	5.m.	2,000	÷	3 (7)		3 173	1 2 x		FA.	F*4_		£5	1 1	1 2 3	111	111	311	111	1111	1 2 2	1 1 2	3.50		10.0	1.5.2	2		.tenne	-5000-12	mani		,,,,,,,	1,14
Or Li	L L	100				EC9		EED.	E41	寸	异类		ING(1071	HIS.							laka lawa upana upana	LL							1946				
'7:J" }`-	4 <u>1</u> 11 	00 N-	(<u>C</u>) (C)	0.1 00	7:17 000	<u>ن</u> 00	00 00	CS) CF)	[]-j	noje Ljira	W On	oo G	150	453	450	<u> 3</u>	E3	-grand	17111	4 franch	-grand	નામનું	U.S.	O.		(43)	13.	ĻĘ.	1,1,1	1,13	1,1,1	3,1,1	11:30	(5) 10]* 10**	-c1	-53
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Maintenance and Troubleshooting

Model 5045A



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Table 8-6. Hexadecimal ROM Code List (Continued)

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	4 N 00 Z) OJ	TŤ	1 <u>.</u>	60	E.	OI	S.Š	O		Φ	Ç4	73	LD.	00	<u></u>	(M	<u> </u>	W)	00	E.	G.		10 17	O G	Œ.	OJ OG	평 (항)	1.0	00	: <u></u>	₽.	지 <u>수</u>	<u>.T</u> i	ÇÜ 	S Cu	
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Table 8-6. Hexadecimal ROM Code List (Continued)

	# 1 4 - 32 - 4 5 6 9 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	
	$ar{a}$	
	000-0000000000000000000000000000000000	
	0.0.000000000000000000000000000000000	
	CLEMBY 2015 CONTROL CO	
	M M M M M M M M M M	
	OFOR $0V-V$ messes of V	
	AGGGGGGGGGGGGGGGGGGGGGGGGGGGGGGGGGGGG	
	$^{+}$ 000004-0000000000000000000000000000000	
	$\begin{array}{c}$	
	400004-00/6/4-04000/4/0/40000010000/6/4/4/ 4000-1100/6/404004000004000000000000000000000	
	$\begin{array}{c} 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 \\ 0 $	
	01-00-00-00-00-00-00-00-00-00-00-00-00-0	
10°) 10°) 10°)	\Box	

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Table 8-7. Hexadecimal-to-Binary Conversion

Character	8	4	2	1
0	0	0	0	0
1	0	0	0	1
2	0	0	1	0
3	0	0	1	1
4	0	1	0	0
5	0	1	0	1
6	0	1	1	0
7	0	1	1	1
8	1	0	0	0
9	1	0	0	1
A	1	0	1	0
В	1	0	1	1
С	1	1	0	0
D	1	1	0	1
E	1	1	1	0
F	1	1	1	1

Table 8-8. Processor Instruction Decoder

Bit Number	RAM Address	Logic Function/ Arith Computation	Data Entry/Exit	No Op	Not Used
0 1 2 3 4	RAM Address	Numbe Bits in W (Take Compler	/ o rd e	0 0 0 0 0	Not Used
5 6 7 8	Address	↑ Op Code	Data Location Code	0 0 0 0	
9	Read/Write (0) (1)	. 0	1	0	1
10	True/Comp (1) (0)	1	1	0	0
11	0	1	1	1	1

8-190. Logic Function/Arithmetic Computation

8-191. As previously mentioned, the second column in Table 8-8 contains codes that represent either a Logic Function or Arithmetic Computation, i.e., a function of the ALU. Again, the first three bits (110) are responsible for selecting this column, or, rather, the mode itself. The result is that whatever serial data is subsequently exchanged will be with respect to the ALU.

8-192. The second four bits designate the op code (operation code), i.e., the specific operation to be performed. These four bits represent an octal code that corresponds to one of those found in Figure 8-13. For example, the octal number representing the AN OR Logic Function is 02. Bits 5 through 8 would contain the binary equivalent of this octal number:

0 2

0 010

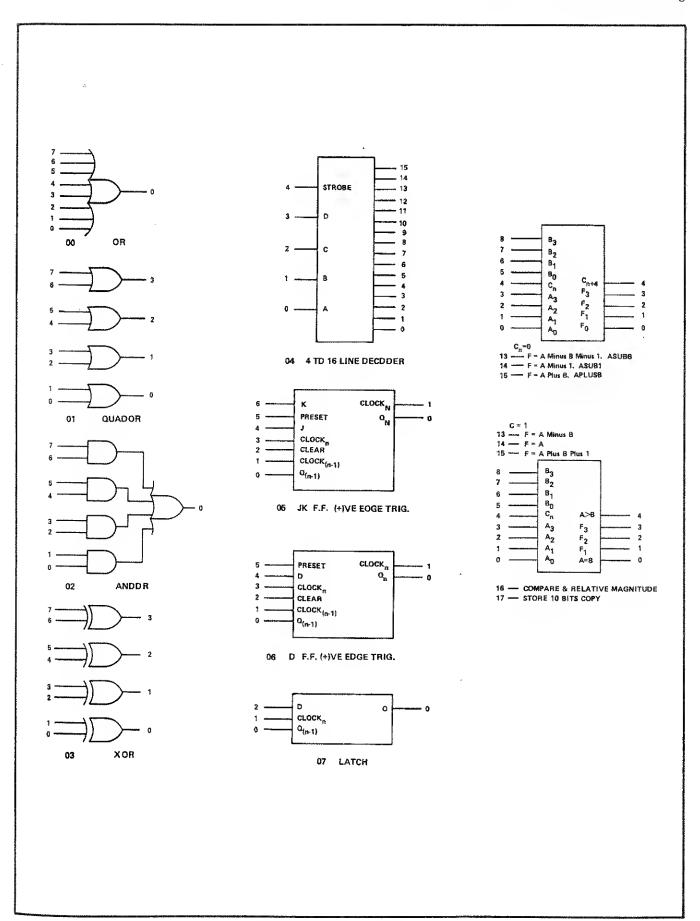


Figure 8-13. Op Code Guide

8-193. The last five bits (Bits 0-4) of the 12-bit word specifies the number of bits involved in the forthcoming data transfer. If the purpose of this transfer were to place a stimulus on the AND OR logic model, up to eight bits of information would be needed (one for each input of the model). Those inputs not specified are set to "0". To place a "1" on each input would require a binary eight; however, the binary code used in this portion of the word is always the complement of the desired number. (The tester keeps track of the number of bits transferred by storing this code into a 5-bit counter. As each bit is transferred, the counter is clocked until it overflows.) Since the

5-bit code is weighted in-binary $\begin{pmatrix} bit - \frac{4}{10} & \frac{3}{10} & \frac{2}{10} & \frac{1}{10} & \frac{4}{10} & \frac{3}{10} & \frac{2}{10} & \frac{1}{10} \end{pmatrix}$, an eight would appear as $\begin{pmatrix} \frac{43210}{10111} & \frac{43210}{10100} & \frac{43210}{10100} & \frac{43210}{10100} & \frac{43210}{10100} & \frac{43210}{101000} & \frac{43210}{1010000} & \frac{43210}{101000} & \frac{43210}{1010000} & \frac{43210}{1010000} & \frac{43210}{1010000} & \frac{43210}{1010000} & \frac{43210}{1010000} & \frac{4$

8-194. Now that the ALU function has been selected and the number of bits involved in the transfer has been specified, another Program Control word is needed to regulate the process of transferring serial data. This word-type is found in column 1 of Table 8-8 and is called, simply, the RAM Address code.

8-195. RAM Address

8-196. The MSB of the code is a "0" and is responsible for designating this word as a RAM address. The second MSB (bit number 10) determines whether or not the serial data transferring either to or from the RAM is to be complemented (inverted in state). Bit number nine specifies the direction of the transferring data: 0 = "read from the RAM", 1= "write into the RAM". The

8-197. To complete the above example, assume data is being read from the RAM and to the ALU; therefore, the RAM must already contain the information to be sent. (The result of a previous data transfer.) Also, the RAM has been addressed to its starting location by the RAM address code, which was stored in the RAM Address Register. Each time a bit of data is clocked from the RAM, the RAM Address Register advances one location and the "bit counter" increments by one count. This continues until all data bits are transferred from the RAM, at which time the bit counter overflows and ends the transfer process. The Processor Memory sends out a program advance signal and then examines the next Program Control code. This could be another ALU function, for example, or another RAM Address code or a series of these codes that would address individual RAM locations for the purpose of transferring single bits of data.

8-198. Data Entry/Exit

8-199. The next column to be examined is DATA ENTRY/EXIT. This type of word is used when sections of the tester, other than the ALU, require the transfer of serial data to or from the RAM. The code's first three bits (111) specify it as being a DATA ENTRY/EXIT word. The next four bits (Bit numbers 5 through 8) designate the other section of the tester involved in the forthcoming data transfer (the RAM is always one of the two). Table 8-9 shows the octal characters that are found in this portion of the Program Control Word and the corresponding section it represents.

8-200. The last five bits of the word specify the number of serial bits to be transferred. Again, this number is expressed as the complement of the number. Once the Processor Memory has accepted this code (in the same manner as the Logic Function example), a RAM address code is needed to determine the direction of data flow and the starting RAM address.

Table 8-9. Data Entry/Exit Codes

Code	Data Location
00	Relay
01	Main Memory Advance
02	Data read from eight least significant bits of the Program Control lines
03	I/O Board .
108	Front Panel* (each bit is transferred in order)
118	Printer
128	Magnetic Card Reader
138	Main Memory
148	ROM Address Counter
158	External Control**
168	Digital-to-Analog Converter
17,8	Pin Driver Board (bit pattern, failure data)
(1) (2) (3) (4) (5) (6) (7) (8)	Cont. Lamp Pass/Fail (Sort/Access) from Front Panel: Load Write Terminate Test Continue on Fail End on Failure Test Printer I & V
**Exterr 2º	nal Control from the CPU (from the RAM) Record 1 = Read, 0 - Write
21	Load light
22	SRQ - I/O Board
2 ³	Pin Driver on
24	End of Test
25	(Not Used)
26	(Not Used)
. 27	Sort (reject)
Exter	nal Control to the CPU (to the RAM)
20	Card in
21	MFL (sync)
22	End of Card Record
23	Ready (D/A)
24	Request (printer)

8-201. In this example, as with the Logic Function example, the RAM address word always follows the Logic Function/Arithmetic Computation and Data Entry/Exit words. This is not true of the Special code, found in column 4 of Table 8-8. This code is a no op (no operation) code and performs no actual function. It does not address the RAM Address Register, but it does generate a Program Advance signal to advance the ROM program.

8-202. DECODING THE ROM WORDS

8-203. Now that the ROM words have been examined as to their type and function, the following paragraphs will describe the process of decoding the hexadecimal words into 12-bit Program Control words. ROM addresses 6 and 7 will serve as an example for this decoding. Table 8-6 lists these addresses as "6 2C8FIE".

8-204. The decoding process begins by first examining ROM address 6, which contains the word FIE. Referring to Table 8-7, Hexadecimal-to-Binary Conversion, the codes appear as shown below.

8-205. Once the word is converted to this form, Table 8-8 can be used in determining the type of word it is. Notice that the three-most significant bits are all 1's. Locating this in Table 8-8 reveals the word to be a DATA ENTRY/EXIT word.

8-206. The next step is to separate the coded word into sections, as its particular word type demands. In this case

111	1000	11110.
Specifies DATA ENTRY EXIT	Specifies Data Location (108)	Specifies Number of Bits in word in complement form

8-207. The Middle portion of the word is expressed in octal with the first three bits on the right being the LSD. Therefore, this code translates to octal 10. Table 8-9 reveals this Data Location to be the front panel.

8-208. The last step in decoding this word is to examine the last five bits (11110). Table 8-8 points out that this specifies the number of bits in the data word to be transferred and that this information is given in complement form. Taking the complement reveals that only one data bit will be transferred:

8-209. Again, an easier method is to consider the zeros to be true. The second part of the transmission information (RAM Address 7) can now be translated. The word in this location is 2C8. This translates as shown.

8-210. A zero in the MSB designates this word as a RAM address code. It can then be sectioned into the particular word-type format, as outlined in Table 8-3.

0 0 1 011001000

8-211. The '0' located in bit 10 specifies that the data bit to be transferred will be inverted in state. The '1' located in bit 9 means the data bit will be written into the RAM. The last step is to decode the RAM address information. The data bit will be written into this location. This conversion appears as follows: 256 128 64 32 16 8 4 2 1 --- weight

0 1 1 0 0 1 0 0 0 --- bit

Therefore, 128 + 64 + 8 = RAM Address 200.

8-212. The two words have been combined to give all information necessary for governing the transfer of data. The codes have decreed that one data bit from th front panel is to be written into RAM location 200. Knowing this, Table 8-9 can be referred to, once again, to determine the purpose of the data bit. Noting the asterisk that references "Data from the Front Panel," the transfer of a single bit of data from the front panel means that the bit will be load information. Specifically, "was the LOAD button pushed?" To determine the position of the PRINTER switch, for example, requires transferring seven bits of data; only the seventh bit is of importance. The RAM will store the previous six bits but may later write over that information.

8-213. The tester's ROM sequence and operation is outlined in paragraph 8-149. ROM Mnemonic Code List. Refer to the decimal side of the ROM Address column. The ROM Address 6 line outlines the previous example: front panel data, TO the RAM, take the complement (c) of the transferring data, and place it in RAM location 200 (first or starting address is 200, ending address is 200).

8-214. A4 ARITHMETIC/LOGIC UNIT OVERVIEW

8-215. The main purpose of the Arithmetic/Logic Unit board (A4) is to simulate a logic model, as described in the Block Diagram Theory. The simulators, themselves, are actually groups of blocks on the board that may be combined to form a particular function (refer to A4 schematic). The simulators are the ALU (U8) and those groups designated on the schematic: the JK simulator, the 4-16 Line Decoder simulator, etc. The operation involves using a portion of the 12 bit Program Control word (the Op code) to specify the function to be performed (OR, D type F-F, A=8, etc. See Figure 8-13. Once this is determined, serial data is received from the RAM and converted to a parallel format so it can be presented to the inputs of the Model. The results of this operation are then transferred serially back to the RAM (A5) on command.

8-216. The OP CODE-DATA LOC lines entering U22 are also sent to U23. If the lines contain a Data Location code, this code enables one of U23's outputs, provided G₁ and G₂ are Low. This output enables one of the blocks inside the tester (printer, front panel, etc.) to receive data from the RAM. This particular function is unrelated to the other operations on the ALU board and can be thought of as part of the Processor Memory, A5.

8-217. If the OP CODE-DATA LOC lines entering U22 contain an Op code, then U22 and the encoder gates (U16D, U14A, B, and C, and U13E) present a Select code to the ALU, U8. Once U8 has been coded to perform a function, the data can be placed across the A and 8 inputs of U8.

8-218. The ALU board accepts the input data on pin 7, the RAM MEM OUT line. The data input control circuit (U11C, U17A, B and U2) controls the loading of data into the Logic Simulation Setup Storage circuit (U3 and U4). This circuit is cleared to '0' prior to use so that only the '1' state data bits change the storage data. The data is not loaded directly into U3 and U4 but, rather, controls whether the devices are preset to accept logic levels from U2. To begin with, U2 is preset such that a '1' is placed on the OA output. Since U17A alternately selects either U10B or U10C to pass the data latched in U11C, then U3(IE) will preset to the same level as the data input. On the next clock pulse, a new bit of '1' state data may be preset into U4(E) in the same manner. (It should be noted that the clock input of U3 and U4 are disabled throughout this process.) After the second clock pulse, the '1' in U2 has shifted to the OD output, which enables the D inputs of U3 and U4 to be preset by incoming data. This process continues until all data is loaded (up to 10 bits) into U3 and U4. The data goes to the different simulators on the board.

8-219. The results of the simulation is fed to the D inputs of U15. When the DATA XFER/LOGIC FUNC line is Low, it enables the STROBE input, which activates the IC. This IC then uses the Op code to select one of the inputs to pass simulator data to U7 where it is shifted back to the RAM on A5.

8-220. A5 PROCESSOR MEMORY OVERVIEW

- 8-221. The Processor Memory board contains the 512-bit RAM and its associated Address Register and Word Counter (refer to A5 schematic). Also located on this board are the Constant Converter, the Input Data Selector, and a storage element for the Op Code or Data Location. These blocks operate in accordance with the type of Program Control word placed on Program Control lines, PROG BITS 0-11. The following is a brief statement on each of the schematic blocks.
- 8-222. 512-Bit RAM. The RAM consists of two Read/Write Memories, U10 and U11. Only one of these memories is addressed at a time. U10 contains locations from 0-255 while U11 covers locations 256-511. Before these memories can be used, PROG BIT 11 must be a "0". This bit is stored in U6A. PROG BIT 8 selects either U10 or U11 for operation, and PROG BIT 9 (through U12) selects the Read or Write mode. Bit 10, stored in U12D(6,12), determines if data into or out of the RAM is to be true or complement.
- 8-223. RAM Address Register. This register is responsible for addressing the ROM and is formed by U15, U18, and the first bit of U12. The second bit of U12 is an overflow. A new address is loaded into the register when the Q output of U6B is low. Once loaded, the register's address can be incremented by clock pulses. Clocking is controlled by U13A and U13C.
- 8-224. Word Counter. The Word Counter consists of U16 and the first bit of U9. Loading is enabled by U13B. The number stored in this counter is the complement of the number of bits in the word to be transferred. Counter overflows when all bits have been transferred.
- 8-225. Register/Word Counter Load Control. Depending on the state of the Word Counter, U6B will enable the RAM Address Register to load another address or it will enable U13B to load the Word Counter when the appropriate Program Control word demands this operation.
- 8-226. **Program Advance Counter.** Under all conditions except a Special code, U1 is loading a binary 15(1111). Whether or not the device outputs a carry to the Program Advance line depends on the output of U2A. With a Constant Code, the device loads a binary 9(1001) one clock pulse after it loads a 15.
- 8-227. Op Code or Data Location Storage. When U13B's output is low, U19 stores either the Op Code or Data Location Code, available on PROG BITS 5-8. This information is fed to A4, as well as being used on A5.
- 8-228. RAM Input Data Selector. The data on the A, B, and Cinput lines can be an Op Code or a Data Location Code. If it is a Data Location code, U13C enables U20 to pass data from the selected data source, through U3A, U4B, and into the RAM. If data is transferred fro the RAM, Program Bits 5 through 8 are used by A4U23 to select the recipient of the data.
- 8-229. Constant Converter. The Constant Converter, U14, is used when the tester reads the eight least-significant bits from the Program Control lines into RAM storage. This process requires a parallel-to-serial conversion, which U14 provides. Once the 8-bit word is loaded into U14, it is clocked out serially and into the RAM via U7C, U3A, and U4B.

8-230. EXAMPLE OF OPERATION

8-231. The following example will outline the Processor Memory's operation with a Data Entry/Exit Code and then a RAM Address code. Refer for a moment to Table 8-8 and note the format

of the Data Entry/Exit word. The first two bits and the High \overline{Q} output of U6B allow U13B to store the 4-bit Data Location code into U19. The Low output of U13B also loads PROG BITS 0-4 into the Word Counter, U16 and U9. At this time, the Q outputs of U6A and U6B are High and disable the RAM and the LOAD line of the RAM Address Register. The low \overline{Q} output of the Bit 11 Latch, U6A, disables U13C until the RAM Address Code is presented. When the Data Entry/Exit word is accepted, U13B enables U2A, which allows U1 to output a PROGRAM ADVANCE signal. This is a signal for the program source to present the next Program Control word.

8-232. Once the RAM Address code appears on the Program Control lines, the address (PROG BITS 0-8) is loaded into the RAM Address Register. This is done with the Low Q output of U6B. The same clock pulse that initiates this action also clocks the "0" of PROG BIT 11 onto the Q output of U6A, thus enabling the RAM. If PROG BIT 9 is a "1", it allows data to be written into the RAM by enabling U13A. In this mode, U13C causes U20 to select a data source and transfer the data through U20A, U3A, and the Exclusive OR, U4B. If bit 9 were a "0", the mode would be "read from the RAM". Data would then pass through U2D, U5D, and U5E and out on the RAM MEM OUT line.

8-233. Transferring bits of data, either to or from the RAM, occurs with each clock pulse. These pulses advance both the RAM Address Register and the Word Counter. When in the Write mode, these clock pulses also generate a Read/Write operation on the RAM. After all data bits are transferred, the Word Counter is at a binary 15. This enables U2A, thereby allowing U1 to output a Program Advance.

8-234. A6 MAIN MEMORY OVERVIEW

8-235. The Main Memory circuitry is represented on the schematic diagram Figure 8-11. As mentioned in the Block Diagram theory, the Main Memory stores all informatio taken from the magnetic program card. Data enters the memory serially and can be removed serially or in parallel. If removed in parallel, it is in the form of a 12-bit Program Control word and is sent to the Processor Memory board — A5. If removed serially, it is also sent to A5, but it will enter the RAM. During a Logic Model simulation, this memory, not the ROM, has full program control of the tester.

8-236. The actual memory is shown on Sheet 2 of the two schematics representing A6. The top three IC's (U34, 33, and 32) are data switches. Depending on the state of the select line, these IC's transfer a 12-bit word from either the ROM or the Main Memory onto the Program Control lines.

8-237. The middle row of IC's (U36, 26, 19, etc.) are 4-bit Shift Registers that can be loaded with data in two ways: (1) enabled and clocked in a serial mode or (2) enabled and clocked in a parallel mode. These registers never function as anything more than a temporary storage location.

8-238. The bottom row of IC's (U35, 25, 18, etc.) comprise the actual memory. Each IC contains four rows of data with each row being 256 bits long. Data is serially shifted in each row with two clock signals. These clocks are generated on A6 and are shown on Sheet 1. They are basically the same signal but 180° out of phase with one another, hence Ø1 and Ø2. Each clock phase clocks in data

8-239. A characteristic of the Main Memory is that it is a dynamic shift register. This means that once data is stored, the contents of the memory must somehow be changed within a period of time; otherwise, the energy level holding that data bit in memory will decay, and the data will be lost. The memory is changed when Ø1 or Ø2 clock signals occur; however, these signals are not always present. They occur only when the memory is accessed or if new data has not entered within a set period of time (about 0.5 msec). If approximately 0.5 msec elapses with no access of data, the memory goes into a refresh mode, which means that the memory shifts itself 256 pieces. This refreshes the memory's energy level and replaces the data to its position prior to the refresh mode.



- 8-241. Loading into the memory is done with the help of a circuit (U31 and U22F) shown on the upper right corner of Sheet 1. Recall that when serial data enters the memory, it is in the form of two 12-bit words. This data comes from the RAM and enters A6 on pin 7. The two AND gates of U31 are alternately clocked to pass data from both the RAM MEM OUT line and the Qc output of U17 (Sheet 2). These alternate bits of data enter pin 1 of U36 and are shifted through the middle row of shift registers at twice the rate as data input on the board. After the first 12 bits of data are entered, they appear on the QA and QC outputs of each IC, with the QB and QD outputs holding whatever was being shifted out of U17(11).
- 8-242. The next 12 bits, the second word, is now entered in the same manner: one bit of RAM data then one bit of data from U17(11). This time, however, data from U17(11) will be the first 12-bit data word previously entered. After the second 12 bits are entered, the loading operation is complete. The first word appears on the QA and QC outputs and the second words appears on the QB and QD outputs. (Note the connections to the switching IC's.)
- 8-243. The outputs of the 4-bit shift registers connect to the inputs of the memory shift registers. This data is now loaded into memory with each phase of the two-phase clock.
- 8-244. When memory data is to be passed onto the Program Control lines, the data to be transferred (both 12-bit words) appears on the memory's output lines. It is then parallel loaded into the middle row of shift registers. The 12-bit word on the QB and QD outputs pass through the switches and onto the Program Control lines. Then a *shift-right* operation is performed on the register and the second 12-bit word is read out.
- 8-245. The circuitry represented on Sheet 1 controls the Main Memory's operation. For example, U1 and U2 are presettable binary counters and are used to regulate the 256-bit cycle when the Main Memory is in the refresh mode. Although the counter does not keep track of memory locations during normal data transfer, it can be used to advance the program by N bits. This information is inserted into the Dp input of U1 in a serial manner (8 parallel load operation) and is the complement of the number of bits to be advanced.
- 8-246. When the memory outputs its Setup Data, it is a continuous process and the refresh mode is not needed. Should the memory stop outputting, e.g., if a failure is detected in the Hold on Fail/Step mode, then the refresh mode is necessary.
- 8-247. Assume that the memory has stopped outputting data but the Refresh One-Shot, U12, has not yet timed out. At this point, the outputs of the Main Memory Advance Counter, U1 and U2, are sitting at all one's, including the Carry Output.
- 8-248. The next clock pulse does not clock the counter, because the High on U3B(5) causes U11B to disable the counter. However, because the Refresh One-Shot has not yet timed out, U29A(2) will be High, and this clock pulse will cause U29A to set. This places a High on U11B(5), which keeps the counter disabled through subsequent clock pulses, until the one-shot times out. When this occurs, U29A switches state on the next clock pulse and allows the countr to function, once again. The first clock pulse into the counter sets the carry output Low, which results in clearing U29.
- 8-249. As the counter is being stepped through the counts in the refresh mode, or any other mode, U3B continues to toggle with the clock pulses. This alternately enables and disables the counter. This allows the counter, which is clocked up with 8 MHz, to follow the Main Memory at 4 MHz. This process continues until U1's Carry Output goes high, once again. This removes the Low on U29A(1) and allows the next clock pulse to set the counter with the High on the D input.

8-250. Other elements on Sheet 1 are U27A and B, U29A, and U12, which control the refresh mode. U12 is a retriggerable one-shot. The Q output of the one-shot stays Low as long as it is being triggered by the two gated clock signals. Once these signals stop, the one-shot will time out 0.5 m5 later and the refresh operation will begin.

8-251. The Main Memory's phase 1 and phase 2 clock signals are generated by U5A and B, Q1, Q2, and U6. These devices are controlled by U13A. The circuitry to the left of the clock generators are associated with generating the mode control (serial or parallel operation of the Main Memory) and the two clocks for the 24-bit shift register. It is also used for multiplexing the data in and out of the memory.

8-252. U28B prevents the ROM or Main Memory from outputting data onto the Program Control bus. When U28A is clocked, it latches a data bit that indicates whether the program source is the ROM (Q=H) or the Main Memory (Q=L). U29B passes serial data from the Main Memory to the RAM on A5. Since the data is staggered in the memory, the operation for removing it is similar to that of entering it. The data is shifted through the shift register twice. One 12-bit word is read out on the first pass while the second word is temporarily ignored. On the second shift through the shift register, the second 12-bit word is read out.

8-253. A7 I/O BOARD BLOCK DIAGRAM THEORY OF OPERATION

8-254. The A7 I/O board (Figure 8-14) is used to interface, control, and format the data exchanged between the HP 9825A Desk Top Computer and the HP 5045A Digital IC Tester.

8-255. The A7 provides a standard HP-IB interface for these units. After the standard HP-IB handshake routine establishes that the 5045A is to receive (LI5TEN mode) or send (TALK mode) data to or from the 982SA, the A7 I/O board accepts the data from the initiating unit and formats the data for use by the receiving unit.

8-256. LISTEN Mode

8-257. When the A7 I/O board is in the LISTEN mode of operation data is being received from the 982SA and transmitted to the 504SA. A typical sequence of operation is as follows:

- a. The information is loaded in from the HP-IB bus by specifying the letter "I" which initializes the address counter.
- b. The data is then loaded into the Program Buffer Memory.
- c. The Run Flip-Flop is then set by specifying the letter "R" and the data stored in the Program Buffer Memory is transferred to the 5045A Digital IC Tester.

8-258. TALK Mode

8-259. The sequence of operation for transferring data from the 5045A to the 9825A requires that a program first be loaded from the 9825A during the listen mode that will generate the data that is to be transferred back to the 9825A. The data generated by the 5045A is then transferred via the serial-to-parallel converter and data selector to the Data Buffer or return address storage. When the A7 I/O board is set to the talk mode, this data is automatically transferred to the 9825A.

8-260. A8 PROM BOARD OVERVIEW

8-261. The PROM (programmable read only memory) board contains 36, 864 bits of fixed information arranged in 3072, 12-bit words (refer to A8 schematic). This memory stores the tester's basic operating routine. See Tables 8-6 and 8-7 of the information in hexadecimal and mnemonic operator form. The board is controlled by the 12 ROM ADD lines, the I/O ADDRESS line, and the ROM ADD CNTR XFER EN line. The three most-significant bits of the address lines are decoded in U23, which enables one set of three ROM's (along the horizontal plane of the schematic).

8-93

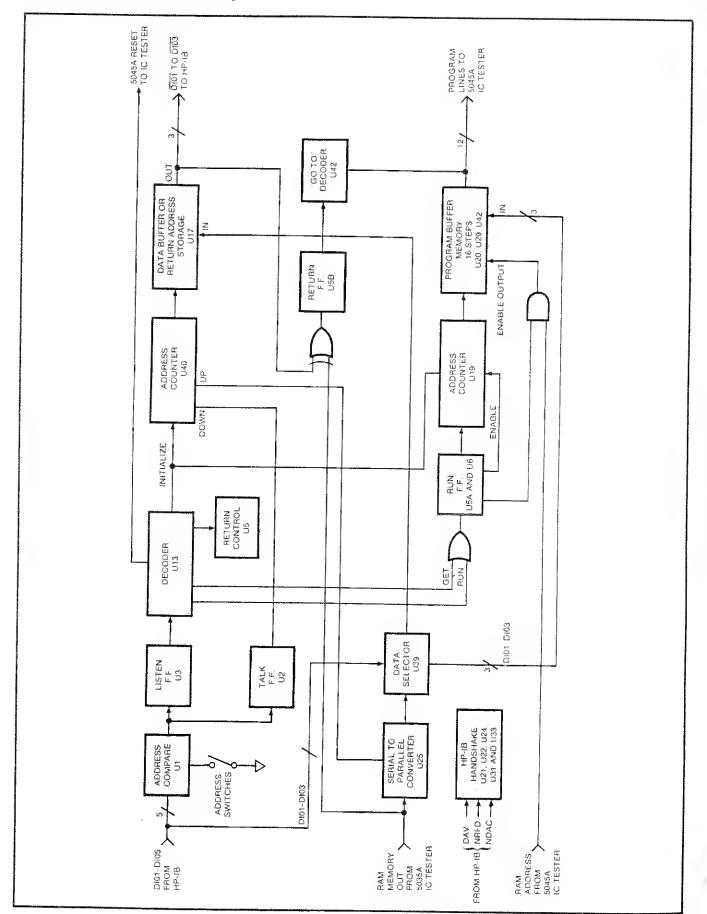


Figure 8-14. A7 I/O Board Block Diagram

- 8-262. Once a three-ROM set is enabled by U23, ROM ADD lines 2-256 drive the "A' inputs on the three devices, thereby, addressing a specific location within each ROM. The "0" outputs of the ROM's present their stored data to the output multiplexers, U8, U16, and U24. Each multiplexer will accept only four of the ROM's eight output lines at a time, as determined by the ROM ADD 1 line, which feeds the selected inputs. When the select input is a logical '0', the multiplexers select the first word, and select the second word with a logical "1". The selected bits exit the multiplexers as 12-bit Program Control words.
- 8-263. When appropriate, U7A and B and U15B act to force a logical "1" in Bit 11 of the Program Control word. This forces the Processor Memory (A5) to interpret any instruction on the lines as Data Entry/Exit or Logic Function/Computation rather than a RAM Address code.
- 8-264. The I/O ADDRES5 line inhibits U8, U16, and U24 when ROM addresses 0-15 are selected and the RUN I/O PROG (A9) lines are both active.

8-265. A9 ADDRESS BOARD OVERVIEW

- 8-266. The primary function of this board is set up ROM addresses. The ROM Address Register is comprised of U17, U20, and U12 (refer to A9 schematic). The register outputs a binary weighted, 12-bit ROM address code, which goes directly to the ROM board, A8. Under normal operation, the register's code increments with each gated clock pulse in a binary fashion. The PROGRAM ADVANCE line goes High for one clock pulse after the Data Location code is entered and again after the data is actually transferred (following the RAM Address code). If the address is to be changed by many counts, e.g., in a "GO TO" statement, the counter is preset with new address. This is done by pulling the register's LOAD inputs Low while the PROGRAM ADVANCE line is low and clocking in the new address code, which is presented serially on the RAM MEM OUT line. Notice that this line goes to the Dp input of U12. Once the first bit of the new code is clocked in, it is presented on the Qp input. Following this output shows that is is connected to the Dc input. On the next clock pulse, then, the bitthat was clocked in first will appear on the Qc output while the second bit appears on the Qp output. This left-shift technique continues until all 12-bits are entered when the ROM ADD CNTR XFER EN line goes High. The last bit entered is the most-significant bit.
- 8-267. Anytime the address is not being loaded and the Qc and QD outputs are High, gate U4A is enabled and allows the multiplexers on A6 to select the Main Memory as the program source. Otherwise, the ROM functions as the program source. However, any time the ROM Address Register is being loaded with a new address (either advance or transfer), U2D is enabled and the resultant Low on the INHIBIT READ PROG line disables the A6 multiplexers from passing any data.
- 8-268. U5A, in the lower left corner of the schematic, generates the 8 MHz clock signal. U2A ANDs 4 and 8 MHz to give a 4 MHz signal with narrow pulses. This signal indirectly clocks the ROM Address Register. U15B divides the signal by two to provide a 4 MH signal. When the Main Memory is being accessed, it uses the 8 MHz signal; when it is being refreshed it uses the 8 MHz signal. U9A controls whether U11 passes the 8 or 4 MHz signal onto the MEM CLOCK line. U3A is also gated by U7B to pass the 4 MHz clock signal out to all boards except the pin drivers. This is the main data transfer clock.
- 8-269. When the instrument is first turned on, it is necessary to preset several circuits within the tester to some initial point, e.g., the ROM Address Register is reset to zero. The circuit that does this is R10 and C4, Q1, U10B, U16B, and their associated components. When the instrument first turns on, C4 conducts current rapidly and appears as a short to ground. This keeps Q1 turned off and allows U10B to clear U16B. The resultant High on the \overline{Q} output pulls the \overline{RESET} line Low through inverter U3B. Once C4 charges positive enough to turn on Q1, the inverter releases the Low on the CLR line. The D Flip-Flop sets on the next clock pulse, as a result of U1C(8) being High.



8-270. When the Program Control Lines contain a Data Entry/Exit Code that has a Data Location code of 158, it causes A4U23 to pull the EXT CNTL XFER EN line Low. This line disables U4B and causes U21 to perform a paralle load of control lines states available on its inputs. The state of these lines indicate the condition of certain peripheral circuits that are external to the CPU. Once the states are loaded, they can be clocked out serially to the A5 board, where the data bit will be placed in the RAM.

8-271. U13 (External Clock Input) is a serial shift register that accepts data from the RAM on the RAM MEM OUT line. Once the data is fully loaded into this shift register, it is clocked into U18, a buffer/latch device. This second device prevents data from rippling across the output lines as it is being clocked into storage. Once the data is shifted into U18, it is fed out as control lines for other circuits throughout the instrument.

8-272. A10 D/A AND PIN DRIVER CONTROL OVERVIEW

8-273. The main function of this board is to store the pin driver voltage and current information. This data is fed to the D/A converter, where it is strobed out to the appropriate pin drivers.

8-274. The Reference Level Storage circuitry is comprised of U6 and U12, which form a 2K shift-register memory (two parallel 1K memories). U18 controls the encoding and decoding of the information. To store data into the memory, the Processor Memory (A5) outputs this data serially to the serial input of U18. It then exits this device on the Qc and Qp outputs, which are connected to the Da inputs on U6 and U12. The data enters the memory in a staggered format, much like the Main Memory. When information is later removed from the memory, it exits on the Qc outputs and is parallel loaded into the Da and DB inputs of U18 via U5A and B. For the VI printout, data can be read out of the memory to the A5 board through U23B, U13F.

8-275. The memory runs at a slower rate than does the information being fed into it: U18 is clocked at a 4 MHz rate while the memory runs at 2 MHz. Actually, there are two clock signals that operate the register (Ø1 and Ø2). Each of these signals are 1 MHz and are out of phase with each other. The phases of the clock are generated by U7B, U11, and the outputs of U1 (Q_B) and U3 (Q_A). The signals are then level shifted by RC circuitry R30, R33, C6, C8, R19, CR3 and CR2 (clamps). When data is being read from the memory, U18 is in the parallel mode and the parallel clock used is 2 MHz (from U1 Q_A).

8-276. The Reference Level Storage has space available for 80 bits of information per pin. There are 24 valid pins plus one extra pin that is set aside as a "sratch pad"; in addition, there are some extra locations that are not used. Table 8-10 shows the data configuration for a given pin. U1, U2, and U3 form a Stack Counter which keeps track of the information in the memory. Although the memory is not regulated by specific locations, or addresses, the position of the data is known by knowing the total number of available locations and by selecting an arbitrary starting point and keeping track of that point. This starting point is defined by the overflow of U2. Notice that an overflow condition (U2 pin 15 goes High) causes U15B to preset the Stack Counter to a predetermined number (506). This absorbs the extra capacity of the counter which is not needed in this specific application. U1 is a decade counter, while U3 and U2 are binary counters. Starting at the left, then, and working across, the D inputs are weighted as follows: 1, 2, 4, 8 (but counts to 10 only) 10, 20, 40, 80, and 160, 320, 640, 1280.

8-277. A second counting circuit Pin Locator Counter is needed to assign groups of bits inside U6 and U12 as those pertaining to a specific pin number. This is done in U1, U4, and U17. U17 and DD input of U4 comprise the Pin Number Locator. By loading the complement (plus one) of the pin number into this counter, the counter will overflow after it has been clocked by the same number of pulses as represents the pin number (e.g., pin 12 would require 11 clock pulses into U4D and U17 to produce an overflow). Since each pin represents 80 bits of data location in the memory, the Pin Number Locator must advance one pin number for every 80 clock pulses

because these pulses are also advancing the Memory and the 5tack Counter. U1 provides a \div 10 circuit and the first three bits of U4 provide a \div 8 circuit, together they form a \div 80 prescaler for the Pin Driver Locator.

8-278. An example of the entire sequence would be as follows. First, the pin number data (in complement form plus one) is loaded from the Processor Memory (A5) into the Pin Number Locator circuit. This is done by enabling U9C via the D/A XFER EN line. The circuit is disabled from counting, however, due to the states of U16A and U22C. The circuit remains disabled until the Stack Counter overflows at U2(1S), which signals the reference point. U16A and U22C release the disable level and all three circuits (Stack Counter, Pin Number Locator, and Reference Level Storage) begin counting. After 80 clock pulses pass, the Pin Number Locator is clocked once and the Reference Level 5torage is at the beginning of the pin 2 data group. When U17 reaches the desired pin number, the counter overflows and outputs a READY FOR SETUP DATA signal. When the CPU is ready to input the setup data, it sets the DA XFER EN line Low, once again. This results in U9B(6) going Low, which clears U4 and U17 and enables U18 to accept serial data from the RAM. This setup data is stagger-loaded into the memory, U6 and U12.

Table 8-10. Setup Data Configurati	itior	igurai	Conf	Data	Setup	8-10.	Table
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Bit No.	1st Group -I Source	2nd Group -V Source	3rd Group +1 Source	4th Group +V Source
1	1 (MSB)	1 (M5B)	1 (MSB)	1 (M5B)
2	2	2	2	2
3	3	3	3	3
4	4	4	4	4
5	5	5	5	5
6	6	6	6	6
7	7	7	7	7
8	8	8	8	8
9	9	9	9	9
10	10	10	10	10
11	11	11	11	11
12	12 (L5B)	12 (LSB)	12 (LSB)	12 (L5B)
13	ศ	Ø	k	k
14	p	Ø	R	R
15	-Gen Continuous	Ø	p	k
16	-Gen Hi/Lo I	Ø	k	b
17	Input	k	B	k
18	+Gen Continuous	R	k	k
19	+Gen Hi/Lo I	b	p	b
20	ß	R	ß	þ

8-279. Once setup data has been loaded for all pins, the data can be placed on the bus and strobed into the appropriate circuits. Refer once again to Table 8-10. The first 12 bits under each category of information (-l, -V, +l, +V) is the actual Setup Data word. This word enters the Digital-to-Analog Converter (DAC) on A11 and is converted to an analog level that will ultimately setup the value of a voltage or current source of a pin driver. This data leaves the board on pin 18 through 21 in the following manner: the first four most-significant bits enter the DAC in parallel, followed by the remaining eight bits which are sent in four 2-bit parallel transfers on the DELAYED 1 and DELAYED 2 lines. The remaining five bits of data (-Gen Continuous, etc.) are then clocked into U19 and are clocked into U24 after the three remaining reference levels are set up and as they transfer to the pin driver.

8-280. A11 REFERENCE LEVEL GENERATOR OVERVIEW

8-281. This board generates the reference voltages for the plus and minus voltage sources and the plus and minus current sources, located on the pin driver boards. (Refer to A11 schematic.) The board accepts four separate groups of digital data, each of which sets up a reference generator on this board. In order: —I, -V, +I, +V. The four reference voltages are fed onto a four-line bus that goes to all 12 pin driver boards. The reference generators are loaded twice for each pin drivers per board. The pin drivers are loaded sequentially, starting with A13 and ending with A24. This sequence is controlled by the outputs of U25A&B and U24B, which enable the specific pin driver board along with the odd pin and even pin strobe lines, which enable the specific pin drivers. As one set of voltages is being strobed out, another group of data is being converted into an analog level. This keeps the time between groups as short as possible. It also requires only one D/A converter; however, this system calls for two stages of sample and hold circuits.

8-282. The four most-significant bits of data are parallel loaded into U16A&B and U22A&B. The remaining eight bits of the data group are parallel loaded two bits at a time into shift registers U30A&B. The MSB is the sign bit (+ or -), while the remaining 10 bits determine the magnitude. The state of the L5B (available at U30A pin 13) controls some switching circuits, which are described later.

8-283. The outputs of the data latches are fed through buffers U23 and U29 and into a resistor ladder network contained in R76. The summation of this information is presented to one side of op amp U5, while U6 provides a 10.3V reference (3.4V at U5 pin 3) to the other side. The output level of U5 can now be entered into the first sample and hold circuit of the -I reference generator. This is done by holding the 5TROBE 5ETUP VOLTAGE High while pulsing the CLOCK 1 line at the same time. This places a High on U19A Q and enables the electronic switch, U21B, to pass the -I reference level from U5, through the buffer amps U20 and U21B where it charges the storage capacitor, C18.

8-284. Once this is done, the other storage capacitors in the remaining reference generators are set up in a like manner. The latches (U16A&B, U22A&B, and U30A&B) accept the next group of data and convert it into an analog level. The 5TROBE 5ETUP VOLTAGE line is set low and remains Low for the next three clock pulses of the LOCK 1 line (one clock pulse for each data group). The second clock pulse, then, will cause U19A \overline{Q} to go Low, but before that can happen, this same clock pulse clocks the High present on U19A \overline{Q} into the D input of U24A. This turns off Q2 and turns on switch U21D, which allows the -V level from U5 to charge C8. The third clock pulse causes U24A pin 12 to go High, which sets up the +I reference generator by enabling U21C and charging C16. The fourth clock pulse causes U24A pin 11 to go High; this turns off Q4 and sets up the +V reference generator by enabling U15D and charging C7.

8-285. The same line that enables the electronic switch U15D at pin 12 also enables, at the same time, switches U15C, U15B, and U15A, which allow the capacitors in the second sample and hold circuits to be charged; these are, respectively, C13, C9, and C29. During the time each group of data bits was being clocked into the first-stage storage capacitors, the least-significant bit of each group, available at U30A pin 13, was being inverted in Q13 and clocked in shift register U27. At the end of the third clock pulse, the least-significant bit of each of the first three groups is present on the outputs of U27. The LSB of the fourth group is present on the D input of U10A. These four bits are used to select the high or low operating range of the reference generators. When the fourth clock arrives, it enables the range selecting devices and also places the reference levels onto the bus. The setup of each generator is individually described below.

8-286. - 1 Reference Generator — U9A passes the level of U27 Qc onto range capacitor C26, which enables or disables the range switch U9C.

8-287. +1 Reference Generator — U9B passes the level of U27 QA onto range capacitor C25, which enables or disables the range switch U9D.

8-288. -V Reference Generator — The QB output of U27 is present on the D input of U10B. When fourth clock plse occurs, it clocks this level onto the Q output. The outputs of U10B turn on one of the range switches — U17C (low range) or U17B (high range). This same clock pulse also turns Q6 on and allows U8 to charge the secondary storage capacitor, C3.

8-289. +V Reference Generator — The LSB of the fourth group is present on the D input of U10A. When the fourth clock pulse occurs, it causes U24 QD to go High, and this clocks the level onto the Q output. The outputs of U10A turn on one of the range switches — U17D (low range) or U17A (high range). This same clock pulse also turns Q1 on and allows U7 to charge the secondary storage capacitor, C2.

8-290. A12 PIN DRIVER CONTROL OVERVIEW

8-291. This board controls several of the operations that are necessary just prior to testing of a device and, also, once the testing has started. The board supplies the '1' and '0' state setup data to the pin driver boards (A13-A24) and controls the strobing of that information onto boards. It also controls the fast edge circuitry on the socket driver assembles and the relay operation of the socket assembly. Finally, the A12 board examines the failure data returning from the pin driver boards to determine whether or not the device passed the test. (Refer to the A12 schematic.)

8-292. The six lines located at the upper right of the schematic control the strobing of information onto the pin driver boards. These are the TEST PATTERN/FAILURE STROBE lines and only one line is active at a time. They are driven by the 4-10 line decoder, U1B, which is controlled by the DATA SHIFT BIT 2- lines. These lines are directly received from the Word Counter on the Processor Memory board, A5. As the '1' and '0' state setup bits serially enter U11, four bits at a time, the Word Counter on A5 increments its count as each bit is transferred, but U18 does not change state. The timing of the this circuit is as follows. On the first clock pulse into U13A, the DATA SHIFT BIT lines 20 and 21 go high. On the fourth clock pulse, all three inputs to U13A are low. This disables U13B and places a High on the D input of U1B. Since this device is a 4 to 10 line decoder the D input enables one of the upper two output lines, which are not used. This effectively disables the lower half of the device. At this time, the next four bits of '1' and '0' setup data are sitting on the outputs of U5 and are now clocked into U5 where they are presented to the pin drivers. The next clock pulse increments the three most significant DATA SHIFT BIT lines and, once again; enables U13B, which returns control to the lower half of U1B. This process continues until all pin drivers are loaded with '1' and '0' setup data.

8-293. When the test is initiated, a particular group of information is to be loaded in the Read/Write Memory, U2 when the test is initiated. This data designates which pairs of the device under test are inputs and which are outputs. This information is important because when testing begins, it will cause the fast edge circuits to generate a fast rise time when driving an input pin. In the case of an output pin, the fast edge circuits are not used and the output stage of the device, itself, controls the rise time. The data enters the board serially from the Processor Memory, A5, and is loaded into the DA input of U6. There are six bits needed for each pin number. These bits continue being loaded into U6 and are shift-load, as a string, into U7. When all six bits are entered, the last bit entered appears on the QA output of U6 and is used as a select line for the multiplier, U1. The first bit entered appears on the QB output of U6 and is fed through U1 and is presented to either the DA or DB input of U2. The remaining four bit are present on the output lines of U7 and serve as address lines for U2. Once each group of bits has been setup, as described, the write enable (WE) input of U2 goes Low to store this data in a particular address of the memory.

8-294. After all the '1' and '0' state setup voltages are strobed into the pin drivers, pin 9 of U18 goes Low and resets the counter assembly of U7 and U6. Just prior to each test, clock pulses begin incrementing this counter. The outputs address the memory and pass the fast-edge data through the multiplexer and to the fast-edge circuits via U3D.

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Maintenance and Troubleshooting

8-295. The A12 board also examines the failure data from the pin drivers. These line comparators of U15, U19, U16, and U20 and the levels are compared to a reference. T of the comparators are parallel loaded into U11. They are then right-shifted one bit at a til to the clear (CLR) input of U10. If this line is High, it is interpreted as a failure; however, are examined for a failure during the test. The Processor Memory, then supplies data to designates whether or not a particular pin should be examined for failure data. This is acc on the D input of U10. If pin 12 is High, the tester will examine the pin for failure data state is then clocked into U10, unless the CLR input is being held Low, and is available output. The state of the Q output is the failure information: '1' = failure, '0' = no

8-296. At the beginning of the test, the Processor Memory, A5, is sending relay data to board via U3C and U3B. This data governs the closure of these relays. When closed, provide a ground for a particular pin on the device under test that is very near the pin. Th problems associated with long ground lines.

8-297. A13-A24 PIN DRIVER OVERVIEW

8-298. The Pin Driver board contains 5 major blocks of circuitry, as shown in the A13-A2 tic diagram. The first four are the positive current source, the "1" voltage source, the source, and the negative current source. The fifth block is the Gating Circuitry that careference level generators' operation. These generators are configured to either drive ar an input or load and monitor an output of the device under test (DUT):

Input = "1" and
$$\pm 1$$
 or "0" and ± 1
Output = "1" and ± 1 or "0" and ± 1

8-299. Electronic switches, control gates, and diodes control the various functions generators. (This is represented in a simplified drawing of the generators, Figure 8-15, sh "1" and "0" voltage sources, with the current sources being listed as either +I or -I

8-300. The four reference lines from the Reference Level Generators (A11) are strobed Pin Driver board through electronic switches. Storage capacitors hold these reference noninverting input (+) of each operational amplifier (op amp). The inverting side (-) of the sense side and monitors the same pin on the device under test as the pin driver in driver.

8-301. As an example of driving an input, if the reference level and the sense level are amplifier is balanced and no failure data is generated. If they differ, the voltage source op into saturation and activates the failure line ('1' voltage source shows failure when it goe '0' voltage source shows failure when it goes negative). When a source is not being acti the gates and switches are arranged to balance the op amp.

8-302. Each current source has 3 CMOS gates that are drawn as negative input AND g one of these gates is enabled at a time, as controlled by the Gating Circuitry. When enabl amp output is transferred from the gate's VDD input (for the negative current source) to pin where it controls the current-pass transistor. Two of the gates select either the hij current mode (Low = $5 \mu A - 2.5 mA$, High = 2.5 mA - 200 mA), and the third gate routes th output onto the sense line when that current generator is not being used to drive the

8-303. The two voltage sources operate in much the same manner as the current source cuit operation relies on a balanced op amp, which controls the drive voltage through a E transistor pair. When not actively used, the op amp remains balanced through an electror The RC time constant circuit ensures that the feedback switch and shunt switch are not on time during the transition. This ensures that the op amp has a feedback path while the changing.

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The cirirlington c switch. he same tates are

PIN DRIVER MODE CONF

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